



TMS320F28004x Piccolo™ Microcontrollers

1 Device Overview

1.1 Features

- TMS320C28x 32-Bit CPU
 - 100 MHz
 - IEEE 754 Single-Precision Floating-Point Unit (FPU)
 - Trigonometric Math Unit (TMU)
 - 3×-Cycle to 4×-Cycle Improvement for Common Trigonometric Functions Versus Software Libraries
 - 13-Cycle Park Transform
 - Viterbi/Complex Math Unit (VCU-I)
 - Ten Hardware Breakpoints
- Programmable Control Law Accelerator (CLA)
 - 100 MHz
 - IEEE 754 Single-Precision Floating-Point Instructions
 - Executes Code Independently of Main CPU
- On-Chip Memory
 - 256KB (128KW) of Flash (ECC-Protected) Across Two Independent Banks
 - 100KB (50KW) of RAM (ECC-Protected or Parity-Protected)
 - Dual-Zone Security Supporting Third-Party Development
- Clock and System Control
 - Two Internal Zero-Pin 10-MHz Oscillators
 - On-Chip Crystal Oscillator and External Clock Input
 - Windowed Watchdog Timer Module
 - Missing Clock Detection Circuitry
- 1.2-V Core, 3.3-V I/O Design
 - Internal VREG or DC-DC for 1.2-V Generation Allows for Single-Supply Designs
- System Peripherals
 - 6-Channel Direct Memory Access (DMA) Controller
 - 40 Individually Programmable Multiplexed General-Purpose Input/Output (GPIO) Pins
 - 21 Digital Inputs on Analog Pins
 - Enhanced Peripheral Interrupt Expansion (ePIE) Module
 - Multiple Low-Power Mode (LPM) Support With External Wakeup
 - InstaSPIN-FOC™ and InstaSPIN-MOTION™
 - Complete Three-Phase Motor and Motion-Control Library in On-chip ROM Memory
- Communications Peripherals
 - One Power Management Bus (PMBus) Interface
 - One Inter-Integrated Circuit (I2C) Interface (Pin-Bootable)
 - Two Controller Area Network (CAN) Bus Ports (Pin-Bootable)
 - Two Serial Peripheral Interface (SPI) Ports (Pin-Bootable)
 - Two Serial Communication Interfaces (SCIs) (Pin-Bootable)
 - One Local Interconnect Network (LIN)
 - One Fast Serial Interface (FSI) With a Transmitter and Receiver
- Analog System
 - Three 3.45-MSPS, 12-Bit Analog-to-Digital Converters (ADCs)
 - Up to 21 External Channels
 - Four Integrated Post-Processing Blocks (PPB) per ADC
 - Seven Windowed Comparators (CMPSS) With 12-Bit Reference Digital-to-Analog Converters (DACs)
 - Digital Glitch Filters
 - Two 12-Bit Buffered DAC Outputs
 - Seven Programmable Gain Amplifiers (PGAs)
 - Programmable Gain Settings: 3, 6, 12, 24
 - Programmable Output Filtering
- Enhanced Control Peripherals
 - 16 ePWM Channels With High-Resolution Capability (150-ps Resolution)
 - Integrated Dead-Band Support With High Resolution
 - Integrated Hardware Trip Zones (TZs)
 - Seven Enhanced Capture (eCAP) Modules
 - High-Resolution Capture (HRCAP) Available on Two Modules
 - Two Enhanced Quadrature Encoder Pulse (eQEP) Modules With Support for CW/CCW Operation Modes
 - Four Sigma-Delta Filter Module (SDFM) Input Channels (Two Parallel Filters per Channel)
 - Standard SDFM Data Filtering
 - Comparator Filter for Fast Action for Overvalue or Undervalue Condition
- Configurable Logic Block (CLB)
 - Augments Existing Peripheral Capability
 - Supports Position Manager Solutions



- Package Options:
 - 100-Pin Low-Profile Quad Flatpack (LQFP) [PZ Suffix]
 - 64-Pin LQFP [PM Suffix]
 - 56-Pin Very Thin Quad Flatpack No-Lead (VQFN) [RSH Suffix]
- Temperature Options:
 - S: –40°C to 125°C Junction
 - Q: –40°C to 125°C Free-Air (AEC Q100 Qualification for Automotive Applications)

1.2 Applications

- [Appliances](#)
- [Building Automation](#)
- [Electric Vehicle/Hybrid Electric Vehicle \(EV/HEV\) Powertrain](#)
- [Factory Automation](#)
- [Grid Infrastructure](#)
- [Industrial Transport](#)
- [Medical, Healthcare and Fitness](#)
- [Motor Drives](#)
- [Power Delivery](#)
- [Telecom Infrastructure](#)
- [Test and Measurement](#)

1.3 Description

The Piccolo™ TMS320F28004x (F28004x) is a powerful 32-bit floating-point microcontroller unit (MCU) that lets designers incorporate crucial control peripherals, differentiated analog, and nonvolatile memory on a single device.

The real-time control subsystem is based on TI's 32-bit C28x CPU, which provides 100 MHz of signal processing performance. The C28x CPU is further boosted by the new TMU extended instruction set, which enables fast execution of algorithms with trigonometric operations commonly found in transforms and torque loop calculations; and the VCU-I extended instruction set, which reduces the latency for complex math operations commonly found in encoded applications.

The CLA allows significant offloading of common tasks from the main C28x CPU. The CLA is an independent 32-bit floating-point math accelerator that executes in parallel with the CPU. Additionally, the CLA has its own dedicated memory resources and it can directly access the key peripherals that are required in a typical control system. Support of a subset of ANSI C is standard, as are key features like hardware breakpoints and hardware task-switching.

The F28004x supports up to 256KB (128KW) of flash memory divided into two 128KB (64KW) banks, which enables programming and execution in parallel. Up to 100KB (50KW) of on-chip SRAM is also available in blocks of 4KB (2KW) and 16KB (8KW) for efficient system partitioning. Flash ECC, SRAM ECC/parity, and dual-zone security are also supported.

High-performance analog blocks are integrated on the F28004x MCU to further enable system consolidation. Three separate 12-bit ADCs provide precise and efficient management of multiple analog signals, which ultimately boosts system throughput. Seven PGAs on the analog front end enable on-chip voltage scaling before conversion. Seven analog comparator modules provide continuous monitoring of input voltage levels for trip conditions.

The TMS320C2000™ devices contain industry-leading control peripherals with frequency-independent ePWM/HRPWM and eCAP allow for a best-in-class level of control to the system. The built-in 4-channel SDFM allows for seamless integration of an oversampling sigma-delta modulator across an isolation barrier.

Connectivity is supported through various industry-standard communication ports (such as SPI, SCI, I2C, LIN, and CAN) and offers multiple muxing options for optimal signal placement in a variety of applications. New to the C2000™ platform is the fully compliant PMBus. Additionally, in an industry first, the FSI enables high-speed, robust communication to complement the rich set of peripherals that are embedded in the device.

Specially enabled device variants, TMS320F28004xC and TMS320F28004xM, allow access to the Configurable Logic Block (CLB) for additional interfacing features and allow access to the secure ROM, which includes libraries to enable InstaSPIN-FOC™ and InstaSPIN-MOTION™. See [Device Comparison](#) for more information.

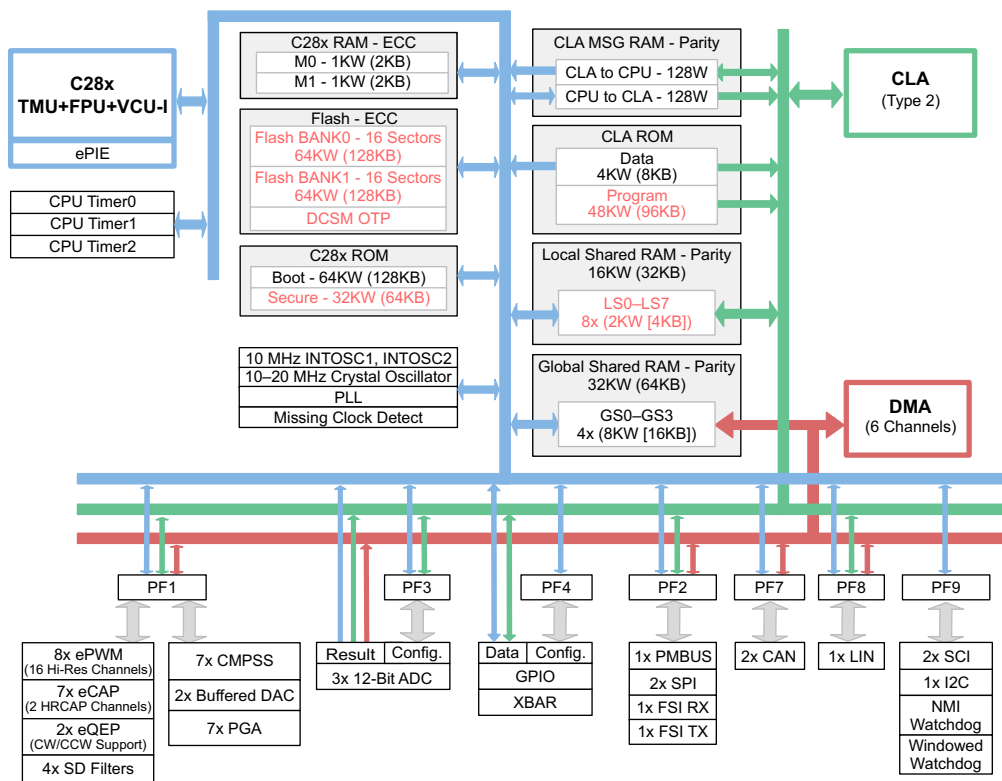
Device Information⁽¹⁾

PART NUMBER	PACKAGE	BODY SIZE
TMS320F280049PZ	LQFP (100)	14.0 mm × 14.0 mm
TMS320F280049CPZ	LQFP (100)	14.0 mm × 14.0 mm
TMS320F280049MPZ	LQFP (100)	14.0 mm × 14.0 mm
TMS320F280045PZ	LQFP (100)	14.0 mm × 14.0 mm
TMS320F280041PZ	LQFP (100)	14.0 mm × 14.0 mm
TMS320F280041CPZ	LQFP (100)	14.0 mm × 14.0 mm
TMS320F280049PM	LQFP (64)	10.0 mm × 10.0 mm
TMS320F280049CPM	LQFP (64)	10.0 mm × 10.0 mm
TMS320F280049MPM	LQFP (64)	10.0 mm × 10.0 mm
TMS320F280048PM	LQFP (64)	10.0 mm × 10.0 mm
TMS320F280048CPM	LQFP (64)	10.0 mm × 10.0 mm
TMS320F280045PM	LQFP (64)	10.0 mm × 10.0 mm
TMS320F280041PM	LQFP (64)	10.0 mm × 10.0 mm
TMS320F280041CPM	LQFP (64)	10.0 mm × 10.0 mm
TMS320F280040PM	LQFP (64)	10.0 mm × 10.0 mm
TMS320F280040CPM	LQFP (64)	10.0 mm × 10.0 mm
TMS320F280049RSH	VQFN (56)	7.0 mm × 7.0 mm
TMS320F280049CRSH	VQFN (56)	7.0 mm × 7.0 mm
TMS320F280049MRSH	VQFN (56)	7.0 mm × 7.0 mm
TMS320F280045RSH	VQFN (56)	7.0 mm × 7.0 mm
TMS320F280041RSH	VQFN (56)	7.0 mm × 7.0 mm
TMS320F280041CRSH	VQFN (56)	7.0 mm × 7.0 mm

(1) For more information on these devices, see [Mechanical Packaging and Orderable Information](#).

1.4 Functional Block Diagram

Figure 1-1 shows the CPU system and associated peripherals.



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Figure 1-1. Functional Block Diagram

Table of Contents

1 Device Overview	1	5.10 Control Peripherals	127
1.1 Features	1	5.11 Communications Peripherals	147
1.2 Applications	2	6 Detailed Description	180
1.3 Description	3	6.1 Overview	180
1.4 Functional Block Diagram	5	6.2 Functional Block Diagram	181
2 Revision History	7	6.3 Memory	182
3 Device Comparison	10	6.4 Identification	189
3.1 Related Products	12	6.5 Bus Architecture – Peripheral Connectivity	190
4 Terminal Configuration and Functions	13	6.6 C28x Processor	191
4.1 Pin Diagrams	13	6.7 Control Law Accelerator (CLA)	194
4.2 Pin Attributes	17	6.8 Direct Memory Access (DMA)	196
4.3 Signal Descriptions	30	6.9 Boot ROM and Peripheral Booting	197
4.4 Pin Multiplexing	41	6.10 Configurable Logic Block (CLB)	201
4.5 Pins With Internal Pullup and Pulldown	52	7 Device and Documentation Support	202
4.6 Connections for Unused Pins	53	7.1 Device and Development Support Tool Nomenclature	202
5 Specifications	54	7.2 Tools and Software	203
5.1 Absolute Maximum Ratings	54	7.3 Documentation Support	205
5.2 ESD Ratings – Commercial	55	7.4 Related Links	206
5.3 ESD Ratings – Automotive	55	7.5 Community Resources	206
5.4 Recommended Operating Conditions	55	7.6 Trademarks	206
5.5 Power Consumption Summary	56	7.7 Electrostatic Discharge Caution	206
5.6 Electrical Characteristics	62	7.8 Glossary	206
5.7 Thermal Resistance Characteristics	63	8 Mechanical Packaging and Orderable Information	207
5.8 System	65	8.1 Packaging Information	207
5.9 Analog Peripherals	96		

2 Revision History

Changes from January 25, 2017 to August 22, 2017 (from SPRS945 Revision (January 2017) to SPRS945A Revision)

Page

• Global: Added TMS320F280049C, TMS320F280048, TMS320F280048C, TMS320F280045, TMS320F280041, TMS320F280041C, TMS320F280040, and TMS320F280040C.....	1
• Section 1.1 (Features): Updated section.	1
• Section 1.2 (Applications): Updated section.	2
• Section 1.3 (Description): Updated section.....	3
• Section 1.3 : Updated Device Information table	3
• Figure 1-1 (Functional Block Diagram): Updated figure.	5
• Section 3 (Device Comparison): Updated section.	10
• Table 3-1 (Device Comparison): Updated table. Added footnote about InstaSPIN™ devices.....	10
• Table 4-3 (Digital Signals): I2CA_SDA: Added "0" to GPIO column.	30
• Table 4-3 : Added VFBSW, VSW, and X2.	30
• Section 4.4.1 (GPIO Muxed Pins): Added NOTE about unavailable GPIO pins.	41
• Table 4-7 (Digital Signals by GPIO): Added VFBSW, VSW, and X2.	44
• Section 4.4.2 (Digital Inputs on ADC Pins (AIOs)): Updated section.	49
• Table 4-9 (Pins With Internal Pullup and Pulldown): Added "(including AIOs)" to GPIOx.	52
• Table 4-10 (Connections for Unused Pins): Updated table.	53
• Section 5.1 (Absolute Maximum Ratings): Updated section.	54
• Section 5.4 (Recommended Operating Conditions): Updated section.	54
• Section 5.6 (Electrical Characteristics): Updated section.	54
• Section 5.5 (Power Consumption Summary): Added reference to Section 5.5.1 , Operating Mode Test Description..	56
• Section 5.5 : Removed "Flash Erase/Program Currents at 100-MHz SYSCLK" table.	56
• Table 5-1 (System Current Consumption (External Supply)): Updated table.	56
• Table 5-2 (System Current Consumption (Internal VREG)): Updated table.	56
• Table 5-3 (System Current Consumption (DCDC)): Updated table.....	56
• Section 5.5.1 (Operating Mode Test Description): Added section title. Updated section.	59
• Section 5.5.2 (Current Consumption Graphs): Added section.	60
• Table 5-4 (Typical I _{DD} Current Reduction per Disabled Peripheral (at 100-MHz SYSCLK)): Changed title from "Typical Current Consumption per Peripheral (at 100-MHz SYSCLK)" to "Typical I _{DD} Current Reduction per Disabled Peripheral (at 100-MHz SYSCLK)".	61
• Table 5-4 : Updated table.	61
• Section 5.8.1 (Power Management): Added NOTE about using same system voltage regulator to drive VDDIO and VDDIO_SW.	65
• Section 5.8.1.1 (Internal 1.2-V LDO Voltage Regulator (VREG)): Updated section.	65
• Section 5.8.1.2 (Internal 1.2-V Switching Regulator (DC-DC)): Updated section.....	65
• Section 5.8.1.3 (Power Sequencing): Added "The VREFHI voltage should not exceed VDDA at any time" to "An external power supply must be used to supply 3.3 V to VDDIO ..." paragraph.	67
• Figure 5-6 (Reset Circuit): Updated figure.	68
• Table 5-17 (XTAL Oscillator Characteristics): Updated table.....	73
• Table 5-20 (Internal Clock Frequencies): Changed MIN f _(PLLRAWCLK) value from 120 MHz to 15 MHz.	74
• Figure 5-11 (Single-ended 3.3-V External Clock): Updated figure.	75
• Table 5-26 (INTOSC Characteristics): Updated table.	78
• Section 5.8.4 (Flash Parameters): Updated section.	79
• Table 5-27 (Minimum Required Flash Wait States with Different Clock Sources and Frequencies): Updated table and footnotes.	79
• Table 5-28 (Flash Parameters): Changed table title from "Flash Parameters at 100 MHz" to "Flash Parameters". Updated table and footnotes.	79
• Table 5-28 : Moved data from "Flash/OTP Endurance" table and "Flash Data Retention Duration" table into "Flash Parameters" table. Removed "Flash/OTP Endurance" table and "Flash Data Retention Duration" table.....	79
• Figure 5-14 (Application Code With Heavy 32-Bit Floating-Point Math Instructions): Added figure.	79
• Figure 5-15 (Application Code With 16-Bit If-Else Instructions): Added figure.	79
• Section 5.8.5 (Emulation/JTAG): Updated section.	81
• Figure 5-16 (Connecting to the 14-Pin JTAG Header): Updated footnote.	82
• Figure 5-17 (Connecting to the 20-Pin JTAG Header): Updated footnote.	82
• Table 5-29 (JTAG Timing Requirements): Updated table.	83
• Table 5-30 (JTAG Switching Characteristics): Updated table.	83

• Table 5-31 (cJTAG Timing Requirements): Updated table.	84
• Table 5-32 (cJTAG Switching Characteristics): Updated table.	84
• Section 5.8.6.1 (GPIO – Output Timing): Changed "GPO" to "GPIO".	85
• Table 5-33 (General-Purpose Output Switching Characteristics), Toggling frequency: Changed "t _{IGPO} " to "f _{GPIO} ". ...	85
• Table 5-43 (HALT Mode Switching Characteristics): Changed "CPU1" to "CPU".	94
• Section 5.9 (Analog Peripherals): Updated list of analog subsystem features.	96
• Figure 5-29 (Analog Subsystem Block Diagram (64-Pin PM LQFP)): Added footnote.	98
• Figure 5-30 (Analog Subsystem Block Diagram (56-Pin RSH VQFN)): Added footnote.	99
• Figure 5-31 (Analog Group Connections): Updated figure.	100
• Section 5.9.1 (Analog-to-Digital Converter (ADC)): Updated list of ADC features.	104
• Figure 5-32 (ADC Module Block Diagram): Updated figure.	105
• Table 5-47 (ADC Operating Conditions): Updated table.	107
• Table 5-48 (ADC Characteristics): Updated table.	107
• Table 5-50 (Per-Channel Parasitic Capacitance): Updated table.	111
• Section 5.9.2 (Programmable Gain Amplifier (PGA)): Updated list of PGA features.	114
• Table 5-52 (PGA Characteristics): Updated table.	115
• Table 5-53 (Temperature Sensor Characteristics): Updated table.	117
• Section 5.9.4 (Buffered Digital-to-Analog Converter (DAC)): Updated section.	118
• Figure 5-36 (DAC Module Block Diagram): Updated figure.	118
• Table 5-54 (Buffered DAC Electrical Characteristics): Updated table.	119
• Section 5.9.5 (Comparator Subsystem (CMPSS)): Added NOTE about CMPSS pins.	122
• Section 5.9.5 : Removed "CMPSS Connectivity (64-Pin PM)" figure.	122
• Section 5.9.5 : Removed "CMPSS Connectivity (56-Pin RSH)" figure.	122
• Figure 5-40 (CMPSS Connectivity): Changed figure title from "CMPSS Connectivity (100-Pin PZ)" to "CMPSS Connectivity".	122
• Table 5-55 (Comparator Electrical Characteristics): Updated table.	123
• Table 5-56 (CMPSS DAC Static Electrical Characteristics): Updated table.	123
• Section 5.10.1 (Enhanced Capture (eCAP)): Updated section.	127
• Figure 5-46 (eCAP Block Diagram): Updated figure and added footnote.	128
• Table 5-57 (eCAP Timing Requirements): Updated table.	129
• Table 5-58 (eCAP Switching Characteristics): Updated table.	129
• Section 5.10.2 (High-Resolution Capture Submodule (HRCAP6–HRCAP7)): Updated section.	130
• Figure 5-47 (HRCAP Block Diagram): Updated figure and added footnote.	131
• Section 5.10.2.1 (HRCAP Electrical Data and Timing): Updated section.	132
• Table 5-59 (HRCAP Switching Characteristics): Updated table.	132
• Figure 5-48 (HRCAP Accuracy Precision and Resolution): Added figure.	132
• Figure 5-49 (HRCAP Standard Deviation Characteristics): Updated figure and footnotes.	133
• Figure 5-50 (ePWM Submodules and Critical Internal Signal Interconnects): Updated figure.	135
• Figure 5-51 (ePWM Trip Input Connectivity): Updated figure.	136
• Table 5-60 (ePWM Timing Requirements): Updated table.	138
• Table 5-61 (ePWM Switching Characteristics): Updated table.	138
• Section 5.10.5 (Enhanced Quadrature Encoder Pulse (eQEP)): Updated section.	141
• Table 5-65 (eQEP Timing Requirements): Updated table.	142
• Table 5-66 (eQEP Switching Characteristics): Updated table.	142
• Section 5.10.6 (Sigma-Delta Filter Module (SDFM)): Updated list of SDFM features.	143
• Figure 5-56 (SDFM Block Diagram): Updated figure.	144
• Table 5-67 (SDFM Timing Requirements): Updated table.	145
• Section 5.11.1 (Controller Area Network (CAN)): Changed "D_CAN" to "DCAN".	147
• Figure 5-61 (CAN Block Diagram): Updated figure.	148
• Section 5.11.2 (Inter-Integrated Circuit (I2C)): Updated list of I2C module features.	149
• Table 5-68 (I2C Timing Requirements): Updated table.	151
• Table 5-69 (I2C Switching Characteristics): Updated table.	151
• Section 5.11.3 (Power Management Bus (PMBus) Interface): Added "Support for I2C mode" feature.	152
• Section 5.11.3 : Updated "Fast Mode+: 1000 kHz" feature.	152
• Table 5-70 (PMBus Electrical Characteristics): Updated table.	153
• Table 5-71 (PMBus Fast Mode Switching Characteristics): Updated table.	153
• Table 5-72 (PMBus Standard Mode Switching Characteristics): Updated table.	153
• Section 5.11.5.1 (SPI Electrical Data and Timing): Updated section.	159
• Figure 5-67 (SPI Master Mode External Timing (Clock Phase = 1)): Updated figure.	162
• Figure 5-69 (SPI Slave Mode External Timing (Clock Phase = 1)): Updated figure.	164

• Figure 5-71 (High-Speed SPI Master Mode External Timing (Clock Phase = 1)): Updated figure.	167
• Figure 5-73 (High-Speed SPI Slave Mode External Timing (Clock Phase = 1)): Updated figure.	169
• Section 5.11.6 (Local Interconnect Network (LIN)): Updated list of LIN features.	170
• Section 5.11.7 (Fast Serial Interface (FSI)): Updated section.	172
• Section 5.11.7.1 (FSI Transmitter): Updated section.	172
• Figure 5-76 (FSITX Block Diagram): Changed "FSI Transmitter" to "FSITX".	174
• Table 5-83 (FSI Transmitter Switching Characteristics): Updated table.	175
• Section 5.11.7.2 (FSI Receiver): Updated section.	176
• Figure 5-79 (FSIRX Block Diagram): Changed "FSI Reciever" to "FSIRX".	177
• Table 5-84 (FSI Receiver Timing Requirements): Updated table.	178
• Section 5.11.7.3 (FSI SPI Compatibility Mode): Added section.	179
• Section 6.1 (Overview): Updated section.	180
• Figure 6-1 (Functional Block Diagram): Updated figure.	181
• Section 6.3.1 (C28x Memory Map): Updated section.	182
• Table 6-1 (C28x Memory Map): Updated table.	182
• Section 6.3.2 (Flash Memory Map): Updated section.	183
• Table 6-3 (Addresses of Flash Sectors for F280041 and F280040): Added table.	184
• Section 6.3.3 (Peripheral Registers Memory Map): Added section.	185
• Section 6.3.4.3 (Global Shared RAM (GSx RAM)): Updated section.	188
• Table 6-6 (Global Shared RAM): Added table.	188
• Table 6-7 (Device Identification Registers): Updated PARTIDH.	189
• Table 6-7 : Added REVID for silicon revision B.	189
• Section 6.5 (Bus Architecture – Peripheral Connectivity): Updated section.	190
• Table 6-8 (Bus Master Peripheral Access): Updated table. Added footnote about ADC result registers.	190
• Figure 6-3 (DMA Block Diagram): Updated figure.	196
• Figure 7-1 (Device Nomenclature): Updated figure. Removed footnote about InstaSPIN devices.	203
• Section 7.2 (Tools and Software): Updated section.	203
• Section 7.4 (Related Links): Added section.	206

3 Device Comparison

Table 3-1 lists the features of the TMS320F28004x devices.

Table 3-1. Device Comparison

FEATURE ⁽¹⁾		F280049 F280049C F280049M	F280048 F280048C	F280045	F280041 F280041C	F280040 F280040C
PROCESSOR AND ACCELERATORS						
C28x	Frequency (MHz)	100				
	FPU	Yes				
	VCU-I	Yes				
	TMU – Type 0	Yes				
CLA – Type 2	Available	Yes	No			
	Frequency (MHz)	100	–			
6-Channel DMA – Type 0		Yes				
MEMORY						
Flash		256KB (128KW)			128KB (64KW)	
RAM	Dedicated and Local Shared RAM	36KB (18KW)				
	Global Shared RAM	64KB (32KW)				
	TOTAL RAM	100KB (50KW)				
Code security for on-chip flash, RAM, and OTP blocks		Yes				
Boot ROM		Yes				
User-configurable DCSM OTP		4KB (2KW)				
SYSTEM ⁽²⁾						
Configurable Logic Block (CLB)		F280049C F280049M	F280048C	–	F280041C	F280040C
InstaSPIN-FOC™		F280049C F280049M	F280048C	–	F280041C	F280040C
InstaSPIN-MOTION™ (includes InstaSPIN-FOC and CLB)		F280049M	–	–	–	–
32-bit CPU timers		3				
Watchdog timers		1				
Nonmaskable Interrupt Watchdog (NMIWD) timers		1				
Crystal oscillator/External clock input		1				
0-pin internal oscillator		2				
GPIO pins	100-pin PZ	40	–	40	40	–
	64-pin PM	26	24	26	26	24
	56-pin RSH	25	–	25	25	–
AIO inputs	100-pin PZ	21				
	64-pin PM	14				
	56-pin RSH	12				
External interrupts		5				

Table 3-1. Device Comparison (continued)

FEATURE ⁽¹⁾		F280049 F280049C F280049M	F280048 F280048C	F280045	F280041 F280041C	F280040 F280040C
ANALOG PERIPHERALS						
ADC 12-bit	Number of ADCs		3			
	MSPS		3.45			
	Conversion Time (ns) ⁽³⁾		300			
ADC channels (single-ended)	100-pin PZ		21			
	64-pin PM		14			
	56-pin RSH		12			
Temperature sensor		1				
Buffered DAC		2				
CMPSS (each CMPSS has two comparators and two internal DACs)	100-pin PZ		7			
	64-pin PM		6			
	56-pin RSH		5			
PGAs (Gain Settings: 3, 6, 12, 24)	100-pin PZ		7			
	64-pin PM		5			
	56-pin RSH		4			
CONTROL PERIPHERALS ⁽⁴⁾						
eCAP/HRCAP modules – Type 1		7 (2 with HRCAP capability)				
ePWM/HRPWM channels – Type 4		16				
eQEP modules – Type 1	100-pin PZ		2			
	64-pin PM		1			
	56-pin RSH		1			
SDFM channels – Type 1	100-pin PZ		4			
	64-pin PM		3			
	56-pin RSH		3			
COMMUNICATION PERIPHERALS ⁽⁴⁾						
CAN – Type 0		2				
I2C – Type 1		1				
SCI – Type 0		2				
SPI – Type 2		2				
LIN – Type 1		1				
PMBus – Type 0		1				
FSI – Type 0		1				
PACKAGE OPTIONS, TEMPERATURE, AND QUALIFICATION						
Junction Temperature (T _J)	S: –40°C to 125°C	100-pin PZ	–	100-pin PZ	100-pin PZ	–
		64-pin PM	–	64-pin PM	64-pin PM	–
		56-pin RSH	–	56-pin RSH	56-pin RSH	–
Free-Air Temperature (T _A)	Q: –40°C to 125°C ⁽⁵⁾	100-pin PZ	64-pin PM	–	100-pin PZ	64-pin PM

- (1) A type change represents a major functional feature difference in a peripheral module. Within a peripheral type, there may be minor differences between devices that do not affect the basic functionality of the module. For more information, see the [C2000 Real-Time Control Peripherals Reference Guide](#).
- (2) For more information about InstaSPIN-FOC™ and InstaSPIN-MOTION™ devices, see [Section 7.3](#) for a list of InstaSPIN Technical Reference Manuals.
- (3) Time between start of sample-and-hold window to start of sample-and-hold window of the next conversion.
- (4) For devices that are available in more than one package, the peripheral count listed in the smaller package is reduced because the smaller package has less device pins available. The number of peripherals internally present on the device is not reduced compared to the largest package offered within a part number. See [Section 4](#) to identify which peripheral instances are accessible on pins in the smaller package.
- (5) The letter Q refers to AEC Q100 qualification for automotive applications.

3.1 Related Products

For information about other devices in this family of products, see the following links:

[TMS320F2837xD Dual-Core Delfino™ Microcontrollers](#)

The Delfino™ TMS320F2837xD is a powerful 32-bit floating-point microcontroller unit (MCU) designed for advanced closed-loop control applications such as industrial drives and servo motor control; solar inverters and converters; digital power; transportation; and power line communications. Complete development packages for digital power and industrial drives are available as part of the powerSUITE and DesignDRIVE initiatives. While the Delfino product line is not new to the TMS320C2000™ portfolio, the F2837xD supports a new dual-core C28x architecture that significantly boosts system performance. The integrated analog and control peripherals also let designers consolidate control architectures and eliminate multiprocessor use in high-end systems.

[TMS320F2837xS Single-Core Delfino™ Microcontrollers](#)

The Delfino™ TMS320F2837xS is a powerful 32-bit floating-point microcontroller unit (MCU) designed for advanced closed-loop control applications such as industrial drives and servo motor control; solar inverters and converters; digital power; transportation; and power line communications. Complete development packages for digital power and industrial drives are available as part of the powerSUITE and DesignDRIVE initiatives.

[TMS320F2807x Piccolo™ Microcontrollers](#)

The TMS320F2807x microcontroller platform is part of the Piccolo™ family and is suited for advanced closed-loop control applications such as industrial drives and servo motor control; solar inverters and converters; digital power; transportation; and power line communications. Complete development packages for digital power and industrial drives are available as part of the powerSUITE and DesignDRIVE initiatives.

[TMS320F2833x Delfino™ Microcontrollers](#)

The TMS320F28335, TMS320F28334, and TMS320F28332 devices, members of the TMS320C28x/Delfino™ DSC/MCU generation, are highly integrated, high-performance solutions for demanding control applications.

[TMS320F2823x Delfino™ Digital Signal Controllers](#)

The TMS320F28235, TMS320F28234, and TMS320F28232 devices, members of the TMS320C28x/Delfino™ DSC/MCU generation, are highly integrated, high-performance solutions for demanding control applications.

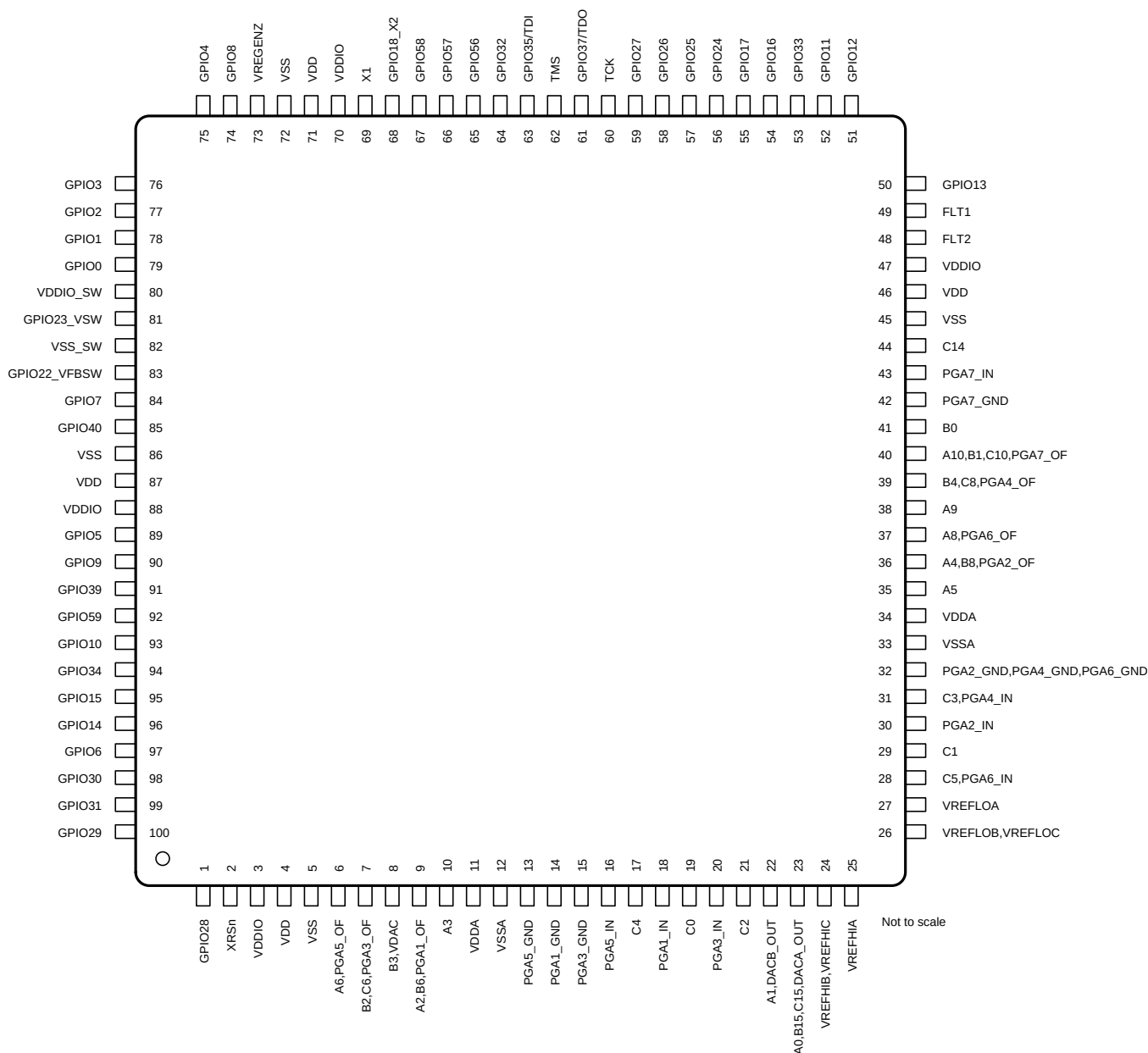
[TMS320C2834x Delfino™ Microcontrollers](#)

The TMS320C2834x (C2834x) Delfino™ microcontroller unit (MCU) devices build on TI's existing F2833x high-performance floating-point microcontrollers. The C2834x delivers up to 300 MHz of floating-point performance, and has up to 516KB of on-chip RAM. Designed for real-time control applications, the C2834x is based on the C28x core, making it code-compatible with all C28x microcontrollers. The on-chip peripherals and low-latency core make the C2834x an excellent solution for performance-hungry real-time control applications.

4 Terminal Configuration and Functions

4.1 Pin Diagrams

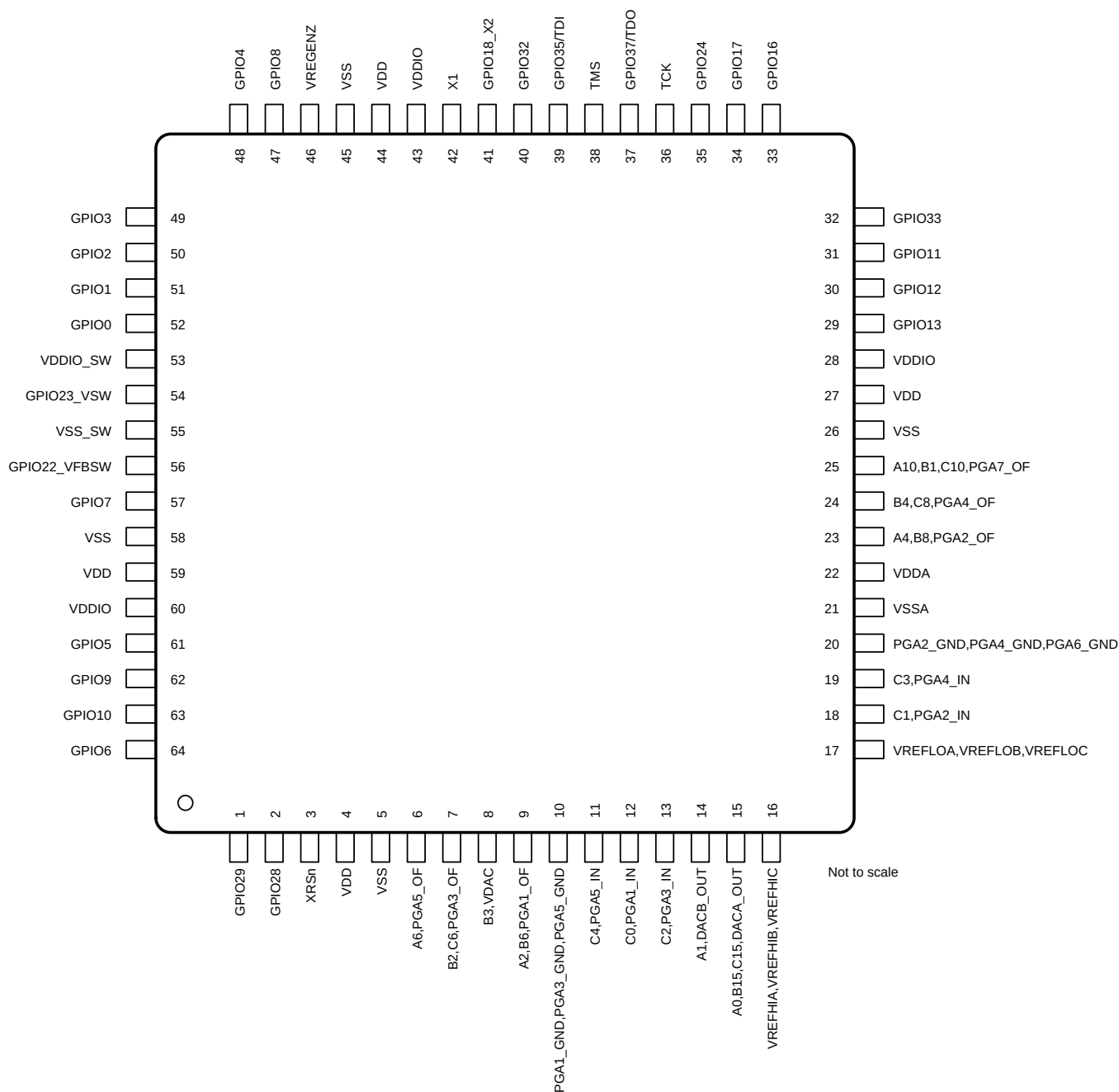
Figure 4-1 shows the pin assignments on the 100-pin PZ Low-Profile Quad Flatpack. Figure 4-2 shows the pin assignments on the 64-Pin PM Low-Profile Quad Flatpack. Figure 4-3 shows the pin assignments on the 64-Pin PM Low-Profile Quad Flatpack for the Q-temperature device. Figure 4-4 shows the pin assignments on the 56-Pin RSH Very Thin Quad Flatpack No-Lead.



ADVANCE INFORMATION

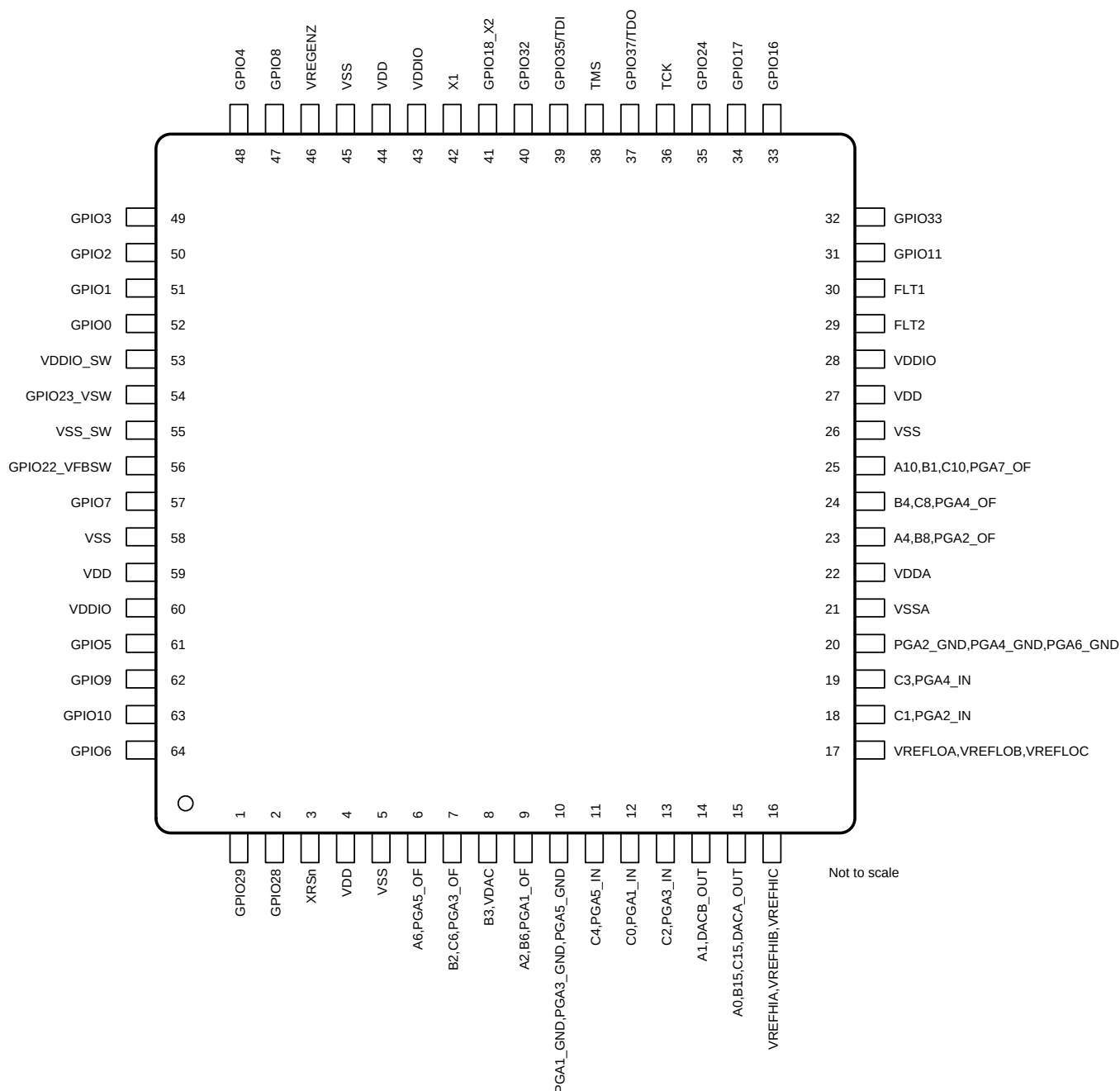
A. Only the GPIO function is shown on GPIO terminals. See Section 4.3 for the complete, muxed signal name.

Figure 4-1. 100-Pin PZ Low-Profile Quad Flatpack (Top View)



A. Only the GPIO function is shown on GPIO terminals. See [Section 4.3](#) for the complete, muxed signal name.

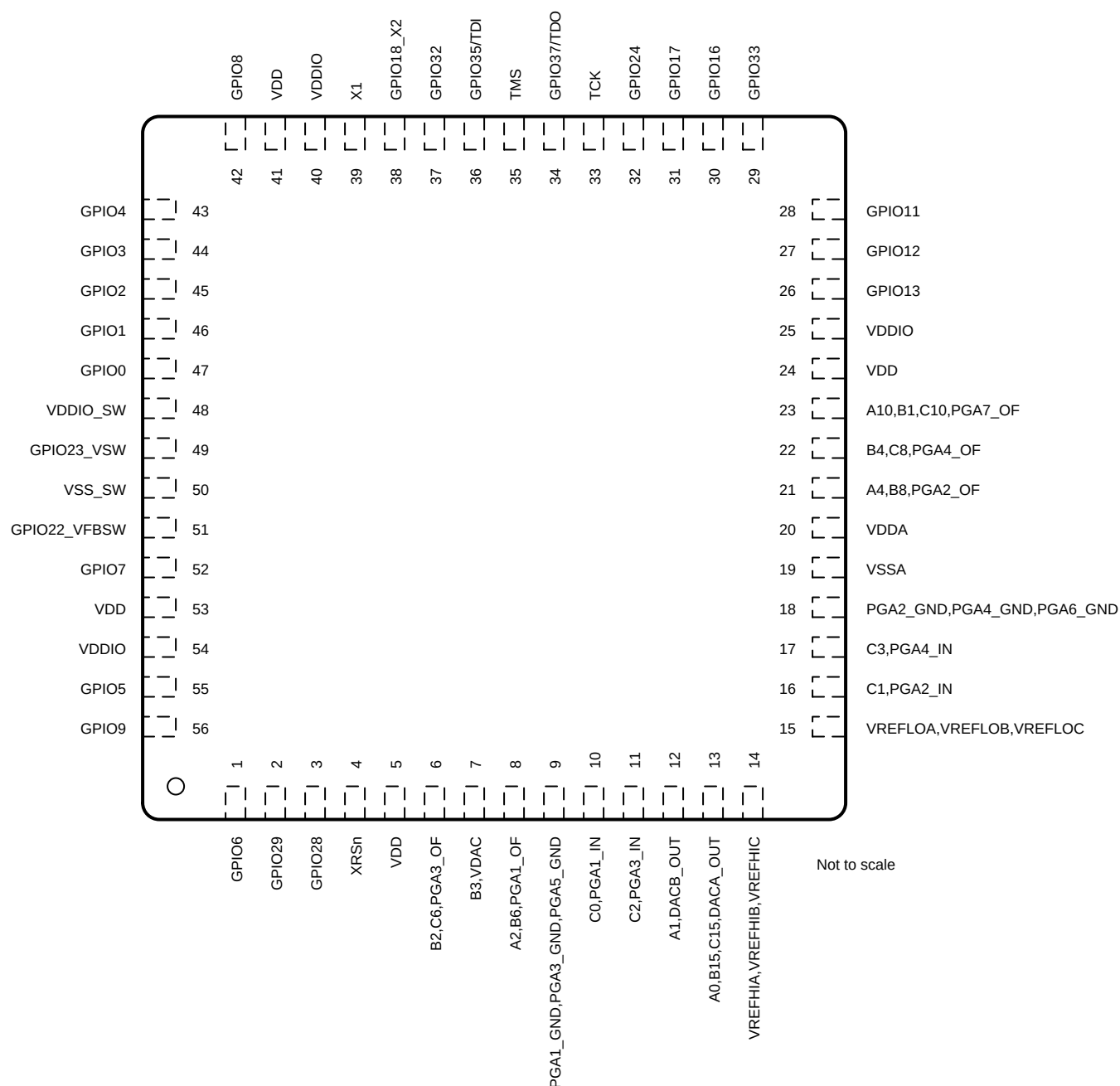
Figure 4-2. F280049/C/M, F280045, F280041/C 64-Pin PM Low-Profile Quad Flatpack (Top View)



ADVANCE INFORMATION

A. Only the GPIO function is shown on GPIO terminals. See [Section 4.3](#) for the complete, muxed signal name.

Figure 4-3. F280048/C, F280040/C 64-Pin PM Low-Profile Quad Flatpack — Q-Temperature (Top View)



- Only the GPIO function is shown on GPIO terminals. See [Section 4.3](#) for the complete, muxed signal name.
- This figure shows the top view of the 56-pin RSH package. The terminals are actually on the bottom side of the package. See [Section 8](#) for the 56-pin RSH mechanical drawing.

Figure 4-4. 56-Pin RSH Very Thin Quad Flatpack No-Lead (Top View)

4.2 Pin Attributes

Table 4-1. Pin Attributes

SIGNAL NAME	MUX POSITION	100 PZ	64 PM	64 PMQ	56 RSH	PIN TYPE	DESCRIPTION
ANALOG							
A0						I	ADC-A Input 0
B15						I	ADC-B Input 15
C15		23	15	15	13	I	ADC-C Input 15
DACA_OUT						O	Buffered DAC-A Output
AIO231						I	Digital Input-231 on ADC Pin
A1						I	ADC-A Input 1
DACB_OUT		22	14	14	12	O	Buffered DAC-B Output
AIO232						I	Digital Input-232 on ADC Pin
A10						I	ADC-A Input 10
B1						I	ADC-B Input 1
C10						I	ADC-C Input 10
PGA7_OF		40	25	25	23	O	PGA-7 Output Filter (Optional)
CMP7_HP0						I	CMPSS-7 High Comparator Positive Input 0
CMP7_LP0						I	CMPSS-7 Low Comparator Positive Input 0
AIO230						I	Digital Input-230 on ADC Pin
A2						I	ADC-A Input 2
B6						I	ADC-B Input 6
PGA1_OF		9	9	9	8	O	PGA-1 Output Filter (Optional)
CMP1_HP0						I	CMPSS-1 High Comparator Positive Input 0
CMP1_LP0						I	CMPSS-1 Low Comparator Positive Input 0
AIO224						I	Digital Input-224 on ADC Pin
A3						I	ADC-A Input 3
CMP1_HP3						I	CMPSS-1 High Comparator Positive Input 3
CMP1_HN0						I	CMPSS-1 High Comparator Negative Input 0
CMP1_LP3		10				I	CMPSS-1 Low Comparator Positive Input 3
CMP1_LN0						I	CMPSS-1 Low Comparator Negative Input 0
AIO233						I	Digital Input-233 on ADC Pin
A4						I	ADC-A Input 4
B8						I	ADC-B Input 8
PGA2_OF		36	23	23	21	O	PGA-2 Output Filter (Optional)
CMP2_HP0						I	CMPSS-2 High Comparator Positive Input 0
CMP2_LP0						I	CMPSS-2 Low Comparator Positive Input 0
AIO225						I	Digital Input-225 on ADC Pin
A5						I	ADC-A Input 5
CMP2_HP3						I	CMPSS-2 High Comparator Positive Input 3
CMP2_HN0						I	CMPSS-2 High Comparator Negative Input 0
CMP2_LP3		35				I	CMPSS-2 Low Comparator Positive Input 3
CMP2_LN0						I	CMPSS-2 Low Comparator Negative Input 0
AIO234						I	Digital Input-234 on ADC Pin
A6						I	ADC-A Input 6
PGA5_OF		6	6	6		O	PGA-5 Output Filter (Optional)
CMP5_HP0						I	CMPSS-5 High Comparator Positive Input 0
CMP5_LP0						I	CMPSS-5 Low Comparator Positive Input 0
AIO228						I	Digital Input-228 on ADC Pin

Table 4-1. Pin Attributes (continued)

SIGNAL NAME	MUX POSITION	100 PZ	64 PM	64 PMQ	56 RSH	PIN TYPE	DESCRIPTION
A8 PGA6_OF CMP6_HP0 CMP6_LP0 AIO229		37				I O I I I	ADC-A Input 8 PGA-6 Output Filter (Optional) CMPSS-6 High Comparator Positive Input 0 CMPSS-6 Low Comparator Positive Input 0 Digital Input-229 on ADC Pin
A9 CMP6_HP3 CMP6_HN0 CMP6_LP3 CMP6_LN0 AIO236		38				I I I I I I	ADC-A Input 9 CMPSS-6 High Comparator Positive Input 3 CMPSS-6 High Comparator Negative Input 0 CMPSS-6 Low Comparator Positive Input 3 CMPSS-6 Low Comparator Negative Input 0 Digital Input-236 on ADC Pin
B0 CMP7_HP3 CMP7_HN0 CMP7_LP3 CMP7_LN0 AIO241		41				I I I I I I	ADC-B Input 0 CMPSS-7 High Comparator Positive Input 3 CMPSS-7 High Comparator Negative Input 0 CMPSS-7 Low Comparator Positive Input 3 CMPSS-7 Low Comparator Negative Input 0 Digital Input-241 on ADC Pin
B2 C6 PGA3_OF CMP3_HP0 CMP3_LP0 AIO226		7	7	7	6	I I O I I I	ADC-B Input 2 ADC-C Input 6 PGA-3 Output Filter (Optional) CMPSS-3 High Comparator Positive Input 0 CMPSS-3 Low Comparator Positive Input 0 Digital Input-226 on ADC Pin
B3 VDAC CMP3_HP3 CMP3_HN0 CMP3_LP3 CMP3_LN0 AIO242		8	8	8	7	I I I I I I I	ADC-B Input 3 Optional external reference voltage for on-chip DACs. There is a 100-pF capacitor to VSSA on this pin whether used for ADC input or DAC reference which cannot be disabled. If this pin is being used as a reference for the on-chip DACs, place at least a 1-μF capacitor on this pin. CMPSS-3 High Comparator Positive Input 3 CMPSS-3 High Comparator Negative Input 0 CMPSS-3 Low Comparator Positive Input 3 CMPSS-3 Low Comparator Negative Input 0 Digital Input-242 on ADC Pin
B4 C8 PGA4_OF CMP4_HP0 CMP4_LP0 AIO227		39	24	24	22	I I O I I I	ADC-B Input 4 ADC-C Input 8 PGA-4 Output Filter (Optional) CMPSS-4 High Comparator Positive Input 0 CMPSS-4 Low Comparator Positive Input 0 Digital Input-227 on ADC Pin
C0 CMP1_HP1 CMP1_HN1 CMP1_LP1 CMP1_LN1 AIO237		19	12	12	10	I I I I I I	ADC-C Input 0 CMPSS-1 High Comparator Positive Input 1 CMPSS-1 High Comparator Negative Input 1 CMPSS-1 Low Comparator Positive Input 1 CMPSS-1 Low Comparator Negative Input 1 Digital Input-237 on ADC Pin

Table 4-1. Pin Attributes (continued)

SIGNAL NAME	MUX POSITION	100 PZ	64 PM	64 PMQ	56 RSH	PIN TYPE	DESCRIPTION
C1 CMP2_HP1 CMP2_HN1 CMP2_LP1 CMP2_LN1 AIO238		29	18	18	16	I I I I I I	ADC-C Input 1 CMPSS-2 High Comparator Positive Input 1 CMPSS-2 High Comparator Negative Input 1 CMPSS-2 Low Comparator Positive Input 1 CMPSS-2 Low Comparator Negative Input 1 Digital Input-238 on ADC Pin
C14 CMP7_HP1 CMP7_HN1 CMP7_LP1 CMP7_LN1 AIO246		44				I I I I I I	ADC-C Input 14 CMPSS-7 High Comparator Positive Input 1 CMPSS-7 High Comparator Negative Input 1 CMPSS-7 Low Comparator Positive Input 1 CMPSS-7 Low Comparator Negative Input 1 Digital Input-246 on ADC Pin
C2 CMP3_HP1 CMP3_HN1 CMP3_LP1 CMP3_LN1 AIO244		21	13	13	11	I I I I I I	ADC-C Input 2 CMPSS-3 High Comparator Positive Input 1 CMPSS-3 High Comparator Negative Input 1 CMPSS-3 Low Comparator Positive Input 1 CMPSS-3 Low Comparator Negative Input 1 Digital Input-244 on ADC Pin
C3 CMP4_HP1 CMP4_HN1 CMP4_LP1 CMP4_LN1 AIO245		31	19	19	17	I I I I I I	ADC-C Input 3 CMPSS-4 High Comparator Positive Input 1 CMPSS-4 High Comparator Negative Input 1 CMPSS-4 Low Comparator Positive Input 1 CMPSS-4 Low Comparator Negative Input 1 Digital Input-245 on ADC Pin
C4 CMP5_HP1 CMP5_HN1 CMP5_LP1 CMP5_LN1 AIO239		17	11	11		I I I I I I	ADC-C Input 4 CMPSS-5 High Comparator Positive Input 1 CMPSS-5 High Comparator Negative Input 1 CMPSS-5 Low Comparator Positive Input 1 CMPSS-5 Low Comparator Negative Input 1 Digital Input-239 on ADC Pin
C5 CMP6_HP1 CMP6_HN1 CMP6_LP1 CMP6_LN1 AIO240		28				I I I I I I	ADC-C Input 5 CMPSS-6 High Comparator Positive Input 1 CMPSS-6 High Comparator Negative Input 1 CMPSS-6 Low Comparator Positive Input 1 CMPSS-6 Low Comparator Negative Input 1 Digital Input-240 on ADC Pin
PGA1_GND		14	10	10	9	I	PGA-1 Ground
PGA1_IN CMP1_HP2 CMP1_LP2		18	12	12	10	I I I	PGA-1 Input CMPSS-1 High Comparator Positive Input 2 CMPSS-1 Low Comparator Positive Input 2
PGA2_GND		32	20	20	18	I	PGA-2 Ground
PGA2_IN CMP2_HP2 CMP2_LP2		30	18	18	16	I I I	PGA-2 Input CMPSS-2 High Comparator Positive Input 2 CMPSS-2 Low Comparator Positive Input 2
PGA3_GND		15	10	10	9	I	PGA-3 Ground

Table 4-1. Pin Attributes (continued)

SIGNAL NAME	MUX POSITION	100 PZ	64 PM	64 PMQ	56 RSH	PIN TYPE	DESCRIPTION
PGA3_IN						I	PGA-3 Input
CMP3_HP2		20	13	13	11	I	CMPSS-3 High Comparator Positive Input 2
CMP3_LP2						I	CMPSS-3 Low Comparator Positive Input 2
PGA4_GND		32	20	20	18	I	PGA-4 Ground
PGA4_IN						I	PGA-4 Input
CMP4_HP2		31	19	19	17	I	CMPSS-4 High Comparator Positive Input 2
CMP4_LP2						I	CMPSS-4 Low Comparator Positive Input 2
PGA5_GND		13	10	10	9	I	PGA-5 Ground
PGA5_IN						I	PGA-5 Input
CMP5_HP2		16	11	11		I	CMPSS-5 High Comparator Positive Input 2
CMP5_LP2						I	CMPSS-5 Low Comparator Positive Input 2
PGA6_GND		32	20	20	18	I	PGA-6 Ground
PGA6_IN						I	PGA-6 Input
CMP6_HP2		28				I	CMPSS-6 High Comparator Positive Input 2
CMP6_LP2						I	CMPSS-6 Low Comparator Positive Input 2
PGA7_GND		42				I	PGA-7 Ground
PGA7_IN						I	PGA-7 Input
CMP7_HP2		43				I	CMPSS-7 High Comparator Positive Input 2
CMP7_LP2						I	CMPSS-7 Low Comparator Positive Input 2
VREFHIA		25	16	16	14	I/O	ADC-A High Reference. In external reference mode, externally drive the high reference voltage onto this pin. In internal reference mode, a voltage is driven onto this pin by the device. In either mode, place at least a 2.2-μF capacitor on this pin. This capacitor should be placed as close to the device as possible between the VREFHIA and VREFLOA pins. Do not load this pin externally in either internal or external reference mode.
VREFHIB		24	16	16	14	I/O	ADC-B High Reference. In external reference mode, externally drive the high reference voltage onto this pin. In internal reference mode, a voltage is driven onto this pin by the device. In either mode, place at least a 2.2-μF capacitor on this pin. This capacitor should be placed as close to the device as possible between the VREFHIB and VREFLOB pins. Do not load this pin externally in either internal or external reference mode.
VREFHIC		24	16	16	14	I/O	ADC-C High Reference. In external reference mode, externally drive the high reference voltage onto this pin. In internal reference mode, a voltage is driven onto this pin by the device. In either mode, place at least a 2.2-μF capacitor on this pin. This capacitor should be placed as close to the device as possible between the VREFHIC and VREFLOC pins. Do not load this pin externally in either internal or external reference mode.
VREFLOA		27	17	17	15	I	ADC-A Low Reference
VREFLOB		26	17	17	15	I	ADC-B Low Reference
VREFLOC		26	17	17	15	I	ADC-C Low Reference
GPIO							
GPIO0	0, 4, 8, 12					I/O	General-Purpose Input Output 0
EPWM1_A	1	79	52	52	47	O	ePWM-1 Output A
I2CA_SDA	6					I/OD	I2C-A Open-Drain Bidirectional Data
GPIO1	0, 4, 8, 12					I/O	General-Purpose Input Output 1
EPWM1_B	1	78	51	51	46	O	ePWM-1 Output B
I2CA_SCL	6					I/OD	I2C-A Open-Drain Bidirectional Clock

Table 4-1. Pin Attributes (continued)

SIGNAL NAME	MUX POSITION	100 PZ	64 PM	64 PMQ	56 RSH	PIN TYPE	DESCRIPTION
GPIO2	0, 4, 8, 12					I/O	General-Purpose Input Output 2
EPWM2_A	1					O	ePWM-2 Output A
OUTPUTXBAR1	5	77	50	50	45	O	Output X-BAR Output 1
PMBUS_A_SDA	6					I/OD	PMBus-A Open-Drain Bidirectional Data
SCIA_TX	9					O	SCI-A Transmit Data
FSIRXA_D1	10					I	FSIRX-A Optional Additional Data Input
GPIO3	0, 4, 8, 12					I/O	General-Purpose Input Output 3
EPWM2_B	1					O	ePWM-2 Output B
OUTPUTXBAR2	2, 5					O	Output X-BAR Output 2
PMBUS_A_SCL	6	76	49	49	44	I/OD	PMBus-A Open-Drain Bidirectional Clock
SPIA_CLK	7					I/O	SPI-A Clock
SCIA_RX	9					I	SCI-A Receive Data
FSIRXA_D0	10					I	FSIRX-A Primary Data Input
GPIO4	0, 4, 8, 12					I/O	General-Purpose Input Output 4
EPWM3_A	1					O	ePWM-3 Output A
OUTPUTXBAR3	5	75	48	48	43	O	Output X-BAR Output 3
CANA_TX	6					O	CAN-A Transmit
FSIRXA_CLK	10					I	FSIRX-A Input Clock
GPIO5	0, 4, 8, 12					I/O	General-Purpose Input Output 5
EPWM3_B	1					O	ePWM-3 Output B
OUTPUTXBAR3	3	89	61	61	55	O	Output X-BAR Output 3
CANA_RX	6					I	CAN-A Receive
SPIA_STE	7					I/O	SPI-A Slave Transmit Enable (STE)
FSITXA_D1	9					O	FSITX-A Optional Additional Data Output
GPIO6	0, 4, 8, 12					I/O	General-Purpose Input Output 6
EPWM4_A	1					O	ePWM-4 Output A
OUTPUTXBAR4	2					O	Output X-BAR Output 4
SYNCOUT	3	97	64	64	1	O	External ePWM Synchronization Pulse
EQEP1_A	5					I	eQEP-1 Input A
CANB_TX	6					O	CAN-B Transmit
SPIB_SOMI	7					I/O	SPI-B Slave Out, Master In (SOMI)
FSITXA_D0	9					O	FSITX-A Primary Data Output
GPIO7	0, 4, 8, 12					I/O	General-Purpose Input Output 7
EPWM4_B	1					O	ePWM-4 Output B
OUTPUTXBAR5	3					O	Output X-BAR Output 5
EQEP1_B	5	84	57	57	52	I	eQEP-1 Input B
CANB_RX	6					I	CAN-B Receive
SPIB_SIMO	7					I/O	SPI-B Slave In, Master Out (SIMO)
FSITXA_CLK	9					O	FSITX-A Output Clock

Table 4-1. Pin Attributes (continued)

SIGNAL NAME	MUX POSITION	100 PZ	64 PM	64 PMQ	56 RSH	PIN TYPE	DESCRIPTION
GPIO8	0, 4, 8, 12					I/O	General-Purpose Input Output 8
EPWM5_A	1					O	ePWM-5 Output A
CANB_TX	2					O	CAN-B Transmit
ADCSOCAO	3					O	ADC Start of Conversion A Output for External ADC (from ePWM modules)
EQEP1_STROBE	5	74	47	47	42	I/O	eQEP-1 Strobe
SCIA_TX	6					O	SCI-A Transmit Data
SPIA_SIMO	7					I/O	SPI-A Slave In, Master Out (SIMO)
I2CA_SCL	9					I/OD	I2C-A Open-Drain Bidirectional Clock
FSITXA_D1	10					O	FSITX-A Optional Additional Data Output
GPIO9	0, 4, 8, 12					I/O	General-Purpose Input Output 9
EPWM5_B	1					O	ePWM-5 Output B
SCIB_TX	2					O	SCI-B Transmit Data
OUTPUTXBAR6	3					O	Output X-BAR Output 6
EQEP1_INDEX	5	90	62	62	56	I/O	eQEP-1 Index
SCIA_RX	6					I	SCI-A Receive Data
SPIA_CLK	7					I/O	SPI-A Clock
FSITXA_D0	10					O	FSITX-A Primary Data Output
GPIO10	0, 4, 8, 12					I/O	General-Purpose Input Output 10
EPWM6_A	1					O	ePWM-6 Output A
CANB_RX	2					I	CAN-B Receive
ADCSOCBO	3					O	ADC Start of Conversion B Output for External ADC (from ePWM modules)
EQEP1_A	5	93	63	63		I	eQEP-1 Input A
SCIB_TX	6					O	SCI-B Transmit Data
SPIA_SOMI	7					I/O	SPI-A Slave Out, Master In (SOMI)
I2CA_SDA	9					I/OD	I2C-A Open-Drain Bidirectional Data
FSITXA_CLK	10					O	FSITX-A Output Clock
GPIO11	0, 4, 8, 12					I/O	General-Purpose Input Output 11
EPWM6_B	1					O	ePWM-6 Output B
SCIB_RX	2, 6					I	SCI-B Receive Data
OUTPUTXBAR7	3	52	31	31	28	O	Output X-BAR Output 7
EQEP1_B	5					I	eQEP-1 Input B
SPIA_STE	7					I/O	SPI-A Slave Transmit Enable (STE)
FSIRXA_D1	9					I	FSIRX-A Optional Additional Data Input
GPIO12	0, 4, 8, 12					I/O	General-Purpose Input Output 12
EPWM7_A	1					O	ePWM-7 Output A
CANB_TX	2					O	CAN-B Transmit
EQEP1_STROBE	5	51		30	27	I/O	eQEP-1 Strobe
SCIB_TX	6					O	SCI-B Transmit Data
PMBUS_CTL	7					I	PMBus-A Control Signal
FSIRXA_D0	9					I	FSIRX-A Primary Data Input

Table 4-1. Pin Attributes (continued)

SIGNAL NAME	MUX POSITION	100 PZ	64 PM	64 PMQ	56 RSH	PIN TYPE	DESCRIPTION
GPIO13	0, 4, 8, 12	50		29	26	I/O	General-Purpose Input Output 13
EPWM7_B	1					O	ePWM-7 Output B
CANB_RX	2					I	CAN-B Receive
EQEP1_INDEX	5					I/O	eQEP-1 Index
SCIB_RX	6					I	SCI-B Receive Data
PMBUS_A_ALERT	7					I/OD	PMBus-A Open-Drain Bidirectional Alert Signal
FSIRXA_CLK	9					I	FSIRX-A Input Clock
GPIO14	0, 4, 8, 12	96				I/O	General-Purpose Input Output 14
EPWM8_A	1					O	ePWM-8 Output A
SCIB_TX	2					O	SCI-B Transmit Data
OUTPUTXBAR3	6					O	Output X-BAR Output 3
PMBUS_A_SDA	7					I/OD	PMBus-A Open-Drain Bidirectional Data
SPIB_CLK	9					I/O	SPI-B Clock
EQEP2_A	10					I	eQEP-2 Input A
GPIO15	0, 4, 8, 12	95				I/O	General-Purpose Input Output 15
EPWM8_B	1					O	ePWM-8 Output B
SCIB_RX	2					I	SCI-B Receive Data
OUTPUTXBAR4	6					O	Output X-BAR Output 4
PMBUS_SCL	7					I/OD	PMBus-A Open-Drain Bidirectional Clock
SPIB_STE	9					I/O	SPI-B Slave Transmit Enable (STE)
EQEP2_B	10					I	eQEP-2 Input B
GPIO16	0, 4, 8, 12	54	33	33	30	I/O	General-Purpose Input Output 16
SPIA_SIMO	1					I/O	SPI-A Slave In, Master Out (SIMO)
CANB_TX	2					O	CAN-B Transmit
OUTPUTXBAR7	3					O	Output X-BAR Output 7
EPWM5_A	5					O	ePWM-5 Output A
SCIA_TX	6					O	SCI-A Transmit Data
SD1_D1	7					I	SDFM-1 Channel 1 Data Input
EQEP1_STROBE	9					I/O	eQEP-1 Strobe
PMBUS_SCL	10					I/OD	PMBus-A Open-Drain Bidirectional Clock
XCLKOUT	11					O	External Clock Output. This pin outputs a divided-down version of a chosen clock signal from within the device.
GPIO17	0, 4, 8, 12	55	34	34	31	I/O	General-Purpose Input Output 17
SPIA_SOMI	1					I/O	SPI-A Slave Out, Master In (SOMI)
CANB_RX	2					I	CAN-B Receive
OUTPUTXBAR8	3					O	Output X-BAR Output 8
EPWM5_B	5					O	ePWM-5 Output B
SCIA_RX	6					I	SCI-A Receive Data
SD1_C1	7					I	SDFM-1 Channel 1 Clock Input
EQEP1_INDEX	9					I/O	eQEP-1 Index
PMBUS_A_SDA	10					I/OD	PMBus-A Open-Drain Bidirectional Data

Table 4-1. Pin Attributes (continued)

SIGNAL NAME	MUX POSITION	100 PZ	64 PM	64 PMQ	56 RSH	PIN TYPE	DESCRIPTION
GPIO18_X2	0, 4, 8, 12					I/O	General-Purpose Input Output 18. This pin and its digital mux options can only be used when the system is clocked by INTOSC and X1 has an external pulldown resistor (recommended 1 kΩ).
SPIA_CLK	1					I/O	SPI-A Clock
SCIB_TX	2					O	SCI-B Transmit Data
CANA_RX	3					I	CAN-A Receive
EPWM6_A	5	68	41	41	38	O	ePWM-6 Output A
I2CA_SCL	6					I/OD	I2C-A Open-Drain Bidirectional Clock
SD1_D2	7					I	SDFM-1 Channel 2 Data Input
EQEP2_A	9					I	eQEP-2 Input A
PMBUSA_CTL	10					I	PMBus-A Control Signal
XCLKOUT	11					O	External Clock Output. This pin outputs a divided-down version of a chosen clock signal from within the device.
X2	ALT					I/O	Crystal oscillator output
GPIO20	0					I/O	General-Purpose Input Output 20
GPIO21	0					I/O	General-Purpose Input Output 21
GPIO22_VFBSW	0, 4, 8, 12					I/O	General-Purpose Input Output 22. If the internal DC-DC regulator is not used, this can be configured as General-Purpose Input Output 22.
EQEP1_STROBE	1					I/O	eQEP-1 Strobe
SCIB_TX	3					O	SCI-B Transmit Data
SPIB_CLK	6	83	56	56	51	I/O	SPI-B Clock
SD1_D4	7					I	SDFM-1 Channel 4 Data Input
LINA_TX	9					O	LIN-A Transmit
VFBSW	ALT					-	Internal DC-DC regulator feedback signal. If the internal DC-DC regulator is used, tie this pin to the node where L(VSW) connects to the VDD rail (as close as possible to the device).
GPIO23_VSW	0	81	54	54	49	I/O	General-Purpose Input Output 23. If the internal DC-DC regulator is not used, this pin can be configured as General-Purpose Input Output 23. This pin has an internal capacitance of approximately 100 pF. TI Recommends using an alternate GPIO, or using this pin only for applications which do not require a fast switching response.
VSW	ALT					-	Switching output of the internal DC-DC regulator
GPIO24	0, 4, 8, 12					I/O	General-Purpose Input Output 24
OUTPUTXBAR1	1					O	Output X-BAR Output 1
EQEP2_A	2					I	eQEP-2 Input A
EPWM8_A	5					O	ePWM-8 Output A
SPIB_SIMO	6	56	35	35	32	I/O	SPI-B Slave In, Master Out (SIMO)
SD1_D1	7					I	SDFM-1 Channel 1 Data Input
PMBUSA_SCL	10					I/OD	PMBus-A Open-Drain Bidirectional Clock
SCIA_TX	11					O	SCI-A Transmit Data
ERRORSTS	13					O	Error Status Output. This signal requires an external pullup.

Table 4-1. Pin Attributes (continued)

SIGNAL NAME	MUX POSITION	100 PZ	64 PM	64 PMQ	56 RSH	PIN TYPE	DESCRIPTION
GPIO25	0, 4, 8, 12	57				I/O	General-Purpose Input Output 25
OUTPUTXBAR2	1					O	Output X-BAR Output 2
EQEP2_B	2					I	eQEP-2 Input B
SPIB_SOMI	6					I/O	SPI-B Slave Out, Master In (SOMI)
SD1_C1	7					I	SDFM-1 Channel 1 Clock Input
FSITXA_D1	9					O	FSITX-A Optional Additional Data Output
PMBUSA_SDA	10					I/OD	PMBus-A Open-Drain Bidirectional Data
SCIA_RX	11					I	SCI-A Receive Data
GPIO26	0, 4, 8, 12	58				I/O	General-Purpose Input Output 26
OUTPUTXBAR3	1, 5					O	Output X-BAR Output 3
EQEP2_INDEX	2					I/O	eQEP-2 Index
SPIB_CLK	6					I/O	SPI-B Clock
SD1_D2	7					I	SDFM-1 Channel 2 Data Input
FSITXA_D0	9					O	FSITX-A Primary Data Output
PMBUSA_CTL	10					I	PMBus-A Control Signal
I2CA_SDA	11					I/OD	I2C-A Open-Drain Bidirectional Data
GPIO27	0, 4, 8, 12	59				I/O	General-Purpose Input Output 27
OUTPUTXBAR4	1, 5					O	Output X-BAR Output 4
EQEP2_STROBE	2					I/O	eQEP-2 Strobe
SPIB_STE	6					I/O	SPI-B Slave Transmit Enable (STE)
SD1_C2	7					I	SDFM-1 Channel 2 Clock Input
FSITXA_CLK	9					O	FSITX-A Output Clock
PMBUSA_ALERT	10					I/OD	PMBus-A Open-Drain Bidirectional Alert Signal
I2CA_SCL	11					I/OD	I2C-A Open-Drain Bidirectional Clock
GPIO28	0, 4, 8, 12	1	2	2	3	I/O	General-Purpose Input Output 28
SCIA_RX	1					I	SCI-A Receive Data
EPWM7_A	3					O	ePWM-7 Output A
OUTPUTXBAR5	5					O	Output X-BAR Output 5
EQEP1_A	6					I	eQEP-1 Input A
SD1_D3	7					I	SDFM-1 Channel 3 Data Input
EQEP2_STROBE	9					I/O	eQEP-2 Strobe
LINA_TX	10					O	LIN-A Transmit
SPIB_CLK	11					I/O	SPI-B Clock
ERRORSTS	13					O	Error Status Output. This signal requires an external pullup.
GPIO29	0, 4, 8, 12	100	1	1	2	I/O	General-Purpose Input Output 29
SCIA_TX	1					O	SCI-A Transmit Data
EPWM7_B	3					O	ePWM-7 Output B
OUTPUTXBAR6	5					O	Output X-BAR Output 6
EQEP1_B	6					I	eQEP-1 Input B
SD1_C3	7					I	SDFM-1 Channel 3 Clock Input
EQEP2_INDEX	9					I/O	eQEP-2 Index
LINA_RX	10					I	LIN-A Receive
SPIB_STE	11					I/O	SPI-B Slave Transmit Enable (STE)
ERRORSTS	13					O	Error Status Output. This signal requires an external pullup.

Table 4-1. Pin Attributes (continued)

SIGNAL NAME	MUX POSITION	100 PZ	64 PM	64 PMQ	56 RSH	PIN TYPE	DESCRIPTION
GPIO30	0, 4, 8, 12	98				I/O	General-Purpose Input Output 30
CANA_RX	1					I	CAN-A Receive
SPIB_SIMO	3					I/O	SPI-B Slave In, Master Out (SIMO)
OUTPUTXBAR7	5					O	Output X-BAR Output 7
EQEP1_STROBE	6					I/O	eQEP-1 Strobe
SD1_D4	7					I	SDFM-1 Channel 4 Data Input
GPIO31	0, 4, 8, 12	99				I/O	General-Purpose Input Output 31
CANA_TX	1					O	CAN-A Transmit
SPIB_SOMI	3					I/O	SPI-B Slave Out, Master In (SOMI)
OUTPUTXBAR8	5					O	Output X-BAR Output 8
EQEP1_INDEX	6					I/O	eQEP-1 Index
SD1_C4	7					I	SDFM-1 Channel 4 Clock Input
FSIRXA_D1	9					I	FSIRX-A Optional Additional Data Input
GPIO32	0, 4, 8, 12	64	40	40	37	I/O	General-Purpose Input Output 32
I2CA_SDA	1					I/OD	I2C-A Open-Drain Bidirectional Data
SPIB_CLK	3					I/O	SPI-B Clock
EPWM8_B	5					O	ePWM-8 Output B
LINA_TX	6					O	LIN-A Transmit
SD1_D3	7					I	SDFM-1 Channel 3 Data Input
FSIRXA_D0	9					I	FSIRX-A Primary Data Input
CANA_TX	10					O	CAN-A Transmit
GPIO33	0, 4, 8, 12	53	32	32	29	I/O	General-Purpose Input Output 33
I2CA_SCL	1					I/OD	I2C-A Open-Drain Bidirectional Clock
SPIB_STE	3					I/O	SPI-B Slave Transmit Enable (STE)
OUTPUTXBAR4	5					O	Output X-BAR Output 4
LINA_RX	6					I	LIN-A Receive
SD1_C3	7					I	SDFM-1 Channel 3 Clock Input
FSIRXA_CLK	9					I	FSIRX-A Input Clock
CANA_RX	10					I	CAN-A Receive
GPIO34	0, 4, 8, 12	94				I/O	General-Purpose Input Output 34
OUTPUTXBAR1	1					O	Output X-BAR Output 1
PMBUS_A_SDA	6					I/OD	PMBus-A Open-Drain Bidirectional Data
GPIO35	0, 4, 8, 12	63	39	39	36	I/O	General-Purpose Input Output 35
SCIA_RX	1					I	SCI-A Receive Data
I2CA_SDA	3					I/OD	I2C-A Open-Drain Bidirectional Data
CANA_RX	5					I	CAN-A Receive
PMBUS_A_SCL	6					I/OD	PMBus-A Open-Drain Bidirectional Clock
LINA_RX	7					I	LIN-A Receive
EQEP1_A	9					I	eQEP-1 Input A
PMBUS_A_CTL	10					I	PMBus-A Control Signal
TDI	15					I	JTAG Test Data Input (TDI) - TDI is the default mux selection for the pin. The internal pullup is disabled by default. The internal pullup should be enabled or an external pullup added on the board if this pin is used as JTAG TDI to avoid a floating input.

Table 4-1. Pin Attributes (continued)

SIGNAL NAME	MUX POSITION	100 PZ	64 PM	64 PMQ	56 RSH	PIN TYPE	DESCRIPTION
GPIO37	0, 4, 8, 12	61	37	37	34	I/O	General-Purpose Input Output 37
OUTPUTXBAR2	1					O	Output X-BAR Output 2
I2CA_SCL	3					I/OD	I2C-A Open-Drain Bidirectional Clock
SCIA_TX	5					O	SCI-A Transmit Data
CANA_TX	6					O	CAN-A Transmit
LINA_TX	7					O	LIN-A Transmit
EQEP1_B	9					I	eQEP-1 Input B
PMBUSA_ALERT	10					I/OD	PMBus-A Open-Drain Bidirectional Alert Signal
TDO	15	91				O	JTAG Test Data Output (TDO) - TDO is the default mux selection for the pin. The internal pullup is disabled by default. The TDO function will be in a tri-state condition when there is no JTAG activity, leaving this pin floating; the internal pullup should be enabled or an external pullup added on the board to avoid a floating GPIO input.
GPIO39	0, 4, 8, 12					I/O	General-Purpose Input Output 39
CANB_RX	6					I	CAN-B Receive
FSIRXA_CLK	7					I	FSIRX-A Input Clock
GPIO40	0, 4, 8, 12	85				I/O	General-Purpose Input Output 40
PMBUSA_SDA	6					I/OD	PMBus-A Open-Drain Bidirectional Data
FSIRXA_D0	7					I	FSIRX-A Primary Data Input
SCIB_TX	9					O	SCI-B Transmit Data
EQEP1_A	10					I	eQEP-1 Input A
GPIO41	0					I/O	General-Purpose Input Output 41
GPIO42	0					I/O	General-Purpose Input Output 42
GPIO43	0					I/O	General-Purpose Input Output 43
GPIO44	0					I/O	General-Purpose Input Output 44
GPIO45	0					I/O	General-Purpose Input Output 45
GPIO46	0					I/O	General-Purpose Input Output 46
GPIO47	0					I/O	General-Purpose Input Output 47
GPIO48	0					I/O	General-Purpose Input Output 48
GPIO49	0					I/O	General-Purpose Input Output 49
GPIO50	0					I/O	General-Purpose Input Output 50
GPIO51	0					I/O	General-Purpose Input Output 51
GPIO52	0					I/O	General-Purpose Input Output 52
GPIO53	0					I/O	General-Purpose Input Output 53
GPIO54	0					I/O	General-Purpose Input Output 54
GPIO55	0					I/O	General-Purpose Input Output 55
GPIO56	0, 4, 8, 12	65				I/O	General-Purpose Input Output 56
SPIA_CLK	1					I/O	SPI-A Clock
EQEP2_STROBE	5					I/O	eQEP-2 Strobe
SCIB_TX	6					O	SCI-B Transmit Data
SD1_D3	7					I	SDFM-1 Channel 3 Data Input
SPIB_SIMO	9					I/O	SPI-B Slave In, Master Out (SIMO)
EQEP1_A	11					I	eQEP-1 Input A

Table 4-1. Pin Attributes (continued)

SIGNAL NAME	MUX POSITION	100 PZ	64 PM	64 PMQ	56 RSH	PIN TYPE	DESCRIPTION
GPIO57	0, 4, 8, 12	66				I/O	General-Purpose Input Output 57
SPIA_STE	1					I/O	SPI-A Slave Transmit Enable (STE)
EQEP2_INDEX	5					I/O	eQEP-2 Index
SCIB_RX	6					I	SCI-B Receive Data
SD1_C3	7					I	SDFM-1 Channel 3 Clock Input
SPIB_SOMI	9					I/O	SPI-B Slave Out, Master In (SOMI)
EQEP1_B	11					I	eQEP-1 Input B
GPIO58	0, 4, 8, 12	67				I/O	General-Purpose Input Output 58
OUTPUTXBAR1	5					O	Output X-BAR Output 1
SPIB_CLK	6					I/O	SPI-B Clock
SD1_D4	7					I	SDFM-1 Channel 4 Data Input
LINA_TX	9					O	LIN-A Transmit
CANB_TX	10					O	CAN-B Transmit
EQEP1_STROBE	11					I/O	eQEP-1 Strobe
GPIO59	0, 4, 8, 12	92				I/O	General-Purpose Input Output 59
OUTPUTXBAR2	5					O	Output X-BAR Output 2
SPIB_STE	6					I/O	SPI-B Slave Transmit Enable (STE)
SD1_C4	7					I	SDFM-1 Channel 4 Clock Input
LINA_RX	9					I	LIN-A Receive
CANB_RX	10					I	CAN-B Receive
EQEP1_INDEX	11					I/O	eQEP-1 Index
TEST, JTAG, VOLTAGE REGULATOR, AND RESET							
FLT1		49	30			I/O	Flash test pin 1. Reserved for TI. Must be left unconnected.
FLT2		48	29			I/O	Flash test pin 2. Reserved for TI. Must be left unconnected.
TCK		60	36	36	33	I	JTAG test clock with internal pullup.
TMS		62	38	38	35	I	JTAG test-mode select (TMS) with internal pullup. This serial control input is clocked into the TAP controller on the rising edge of TCK. This device does not have a TRSTn pin. An external pullup resistor (recommended 2.2 kΩ) on the TMS pin to VDDIO should be placed on the board to keep JTAG in reset during normal operation.
VREGENZ		73	46	46		I	Internal voltage regulator enable with internal pulldown. Tie directly to VSS (low) to enable the internal VREG. Tie directly to VDDIO (high) to use an external supply.
X1		69	42	42	39	I/O	Crystal oscillator input or single-ended clock input. The device initialization software must configure this pin before the crystal oscillator is enabled. To use this oscillator, a quartz crystal circuit must be connected to X1 and X2. This pin can also be used to feed a single-ended 3.3-V level clock.
XRSn		2	3	3	4	I/OD	Device Reset (in) and Watchdog Reset (out). During a power-on condition, this pin is driven low by the device. An external circuit may also drive this pin to assert a device reset. This pin is also driven low by the MCU when a watchdog reset occurs. During watchdog reset, the XRSn pin is driven low for the watchdog reset duration of 512 OSCCLK cycles. A resistor with a value from 2.2 kΩ to 10 kΩ should be placed between XRSn and VDDIO. If a capacitor is placed between XRSn and VSS for noise filtering, it should be 100 nF or smaller. These values allow the watchdog to properly drive the XRSn pin to VOL within 512 OSCCLK cycles when the watchdog reset is asserted. The output buffer of this pin is an open-drain with an internal pullup. If this pin is driven by an external device, TI recommends using an open-drain device.

Table 4-1. Pin Attributes (continued)

SIGNAL NAME	MUX POSITION	100 PZ	64 PM	64 PMQ	56 RSH	PIN TYPE	DESCRIPTION
POWER AND GROUND							
VDD		4, 46, 71, 87	4, 27, 44, 59	4, 27, 44, 59	5, 24, 41, 53		1.2-V Digital Logic Power Pins. TI recommends placing a decoupling capacitor near each VDD pin with a minimum total capacitance of approximately 20 μ F. When not using the internal voltage regulator, the exact value of the decoupling capacitance should be determined by your system voltage regulation solution.
VDDA		11, 34	22	22	20		3.3-V Analog Power Pins. Place a minimum 2.2- μ F decoupling capacitor to VSSA on each pin.
VDDIO		3, 47, 70, 88	28, 43, 60	28, 43, 60	25, 40, 54		3.3-V Digital I/O Power Pins. Place a minimum 0.1- μ F decoupling capacitor on each pin.
VDDIO_SW		80	53	53	48		Supply pin for the internal DC-DC regulator. If the internal DC-DC regulator is used, a bulk input capacitance of 20- μ F should be placed on this pin. If the internal DC-DC regulator is not used, this pin should be treated as a VDDIO pin.
VSS		5, 45, 72, 86	5, 26, 45, 58	5, 26, 45, 58			Digital Ground
VSSA		12, 33	21	21	19		Analog Ground
VSS_SW		82	55	55	50		Internal DC-DC regulator ground. If the internal DC-DC regulator is not used, this pin must be treated as a VSS pin.

4.3 Signal Descriptions

4.3.1 Analog Signals

Table 4-2. Analog Signals

SIGNAL NAME	DESCRIPTION	PIN TYPE	GPIO	100 PZ	64 PM	64 PMQ	56 RSH
A0	ADC-A Input 0	I		23	15	15	13
A1	ADC-A Input 1	I		22	14	14	12
A2	ADC-A Input 2	I		9	9	9	8
A3	ADC-A Input 3	I		10			
A4	ADC-A Input 4	I		36	23	23	21
A5	ADC-A Input 5	I		35			
A6	ADC-A Input 6	I		6	6	6	
A8	ADC-A Input 8	I		37			
A9	ADC-A Input 9	I		38			
A10	ADC-A Input 10	I		40	25	25	23
AIO224	Digital Input-224 on ADC Pin	I		9	9	9	8
AIO225	Digital Input-225 on ADC Pin	I		36	23	23	21
AIO226	Digital Input-226 on ADC Pin	I		7	7	7	6
AIO227	Digital Input-227 on ADC Pin	I		39	24	24	22
AIO228	Digital Input-228 on ADC Pin	I		6	6	6	
AIO229	Digital Input-229 on ADC Pin	I		37			
AIO230	Digital Input-230 on ADC Pin	I		40	25	25	23
AIO231	Digital Input-231 on ADC Pin	I		23	15	15	13
AIO232	Digital Input-232 on ADC Pin	I		22	14	14	12
AIO233	Digital Input-233 on ADC Pin	I		10			
AIO234	Digital Input-234 on ADC Pin	I		35			
AIO236	Digital Input-236 on ADC Pin	I		38			
AIO237	Digital Input-237 on ADC Pin	I		19	12	12	10
AIO238	Digital Input-238 on ADC Pin	I		29	18	18	16
AIO239	Digital Input-239 on ADC Pin	I		17	11	11	
AIO240	Digital Input-240 on ADC Pin	I		28			
AIO241	Digital Input-241 on ADC Pin	I		41			
AIO242	Digital Input-242 on ADC Pin	I		8	8	8	7
AIO244	Digital Input-244 on ADC Pin	I		21	13	13	11
AIO245	Digital Input-245 on ADC Pin	I		31	19	19	17
AIO246	Digital Input-246 on ADC Pin	I		44			
B0	ADC-B Input 0	I		41			
B1	ADC-B Input 1	I		40	25	25	23
B2	ADC-B Input 2	I		7	7	7	6
B3	ADC-B Input 3	I		8	8	8	7
B4	ADC-B Input 4	I		39	24	24	22
B6	ADC-B Input 6	I		9	9	9	8
B8	ADC-B Input 8	I		36	23	23	21
B15	ADC-B Input 15	I		23	15	15	13
C0	ADC-C Input 0	I		19	12	12	10
C1	ADC-C Input 1	I		29	18	18	16
C2	ADC-C Input 2	I		21	13	13	11
C3	ADC-C Input 3	I		31	19	19	17

Table 4-2. Analog Signals (continued)

SIGNAL NAME	DESCRIPTION	PIN TYPE	GPIO	100 PZ	64 PM	64 PMQ	56 RSH
C4	ADC-C Input 4	I		17	11	11	
C5	ADC-C Input 5	I		28			
C6	ADC-C Input 6	I		7	7	7	6
C8	ADC-C Input 8	I		39	24	24	22
C10	ADC-C Input 10	I		40	25	25	23
C14	ADC-C Input 14	I		44			
C15	ADC-C Input 15	I		23	15	15	13
CMP1_HN0	CMPSS-1 High Comparator Negative Input 0	I		10			
CMP1_HN1	CMPSS-1 High Comparator Negative Input 1	I		19	12	12	10
CMP1_HP0	CMPSS-1 High Comparator Positive Input 0	I		9	9	9	8
CMP1_HP1	CMPSS-1 High Comparator Positive Input 1	I		19	12	12	10
CMP1_HP2	CMPSS-1 High Comparator Positive Input 2	I		18	12	12	10
CMP1_HP3	CMPSS-1 High Comparator Positive Input 3	I		10			
CMP1_LN0	CMPSS-1 Low Comparator Negative Input 0	I		10			
CMP1_LN1	CMPSS-1 Low Comparator Negative Input 1	I		19	12	12	10
CMP1_LP0	CMPSS-1 Low Comparator Positive Input 0	I		9	9	9	8
CMP1_LP1	CMPSS-1 Low Comparator Positive Input 1	I		19	12	12	10
CMP1_LP2	CMPSS-1 Low Comparator Positive Input 2	I		18	12	12	10
CMP1_LP3	CMPSS-1 Low Comparator Positive Input 3	I		10			
CMP2_HN0	CMPSS-2 High Comparator Negative Input 0	I		35			
CMP2_HN1	CMPSS-2 High Comparator Negative Input 1	I		29	18	18	16
CMP2_HP0	CMPSS-2 High Comparator Positive Input 0	I		36	23	23	21
CMP2_HP1	CMPSS-2 High Comparator Positive Input 1	I		29	18	18	16
CMP2_HP2	CMPSS-2 High Comparator Positive Input 2	I		30	18	18	16
CMP2_HP3	CMPSS-2 High Comparator Positive Input 3	I		35			
CMP2_LN0	CMPSS-2 Low Comparator Negative Input 0	I		35			
CMP2_LN1	CMPSS-2 Low Comparator Negative Input 1	I		29	18	18	16
CMP2_LP0	CMPSS-2 Low Comparator Positive Input 0	I		36	23	23	21
CMP2_LP1	CMPSS-2 Low Comparator Positive Input 1	I		29	18	18	16
CMP2_LP2	CMPSS-2 Low Comparator Positive Input 2	I		30	18	18	16
CMP2_LP3	CMPSS-2 Low Comparator Positive Input 3	I		35			
CMP3_HN0	CMPSS-3 High Comparator Negative Input 0	I		8	8	8	7
CMP3_HN1	CMPSS-3 High Comparator Negative Input 1	I		21	13	13	11
CMP3_HP0	CMPSS-3 High Comparator Positive Input 0	I		7	7	7	6
CMP3_HP1	CMPSS-3 High Comparator Positive Input 1	I		21	13	13	11
CMP3_HP2	CMPSS-3 High Comparator Positive Input 2	I		20	13	13	11
CMP3_HP3	CMPSS-3 High Comparator Positive Input 3	I		8	8	8	7
CMP3_LN0	CMPSS-3 Low Comparator Negative Input 0	I		8	8	8	7
CMP3_LN1	CMPSS-3 Low Comparator Negative Input 1	I		21	13	13	11
CMP3_LP0	CMPSS-3 Low Comparator Positive Input 0	I		7	7	7	6
CMP3_LP1	CMPSS-3 Low Comparator Positive Input 1	I		21	13	13	11
CMP3_LP2	CMPSS-3 Low Comparator Positive Input 2	I		20	13	13	11
CMP3_LP3	CMPSS-3 Low Comparator Positive Input 3	I		8	8	8	7
CMP4_HN1	CMPSS-4 High Comparator Negative Input 1	I		31	19	19	17
CMP4_HP0	CMPSS-4 High Comparator Positive Input 0	I		39	24	24	22
CMP4_HP1	CMPSS-4 High Comparator Positive Input 1	I		31	19	19	17
CMP4_HP2	CMPSS-4 High Comparator Positive Input 2	I		31	19	19	17

Table 4-2. Analog Signals (continued)

SIGNAL NAME	DESCRIPTION	PIN TYPE	GPIO	100 PZ	64 PM	64 PMQ	56 RSH
CMP4_LN1	CMPSS-4 Low Comparator Negative Input 1	I		31	19	19	17
CMP4_LP0	CMPSS-4 Low Comparator Positive Input 0	I		39	24	24	22
CMP4_LP1	CMPSS-4 Low Comparator Positive Input 1	I		31	19	19	17
CMP4_LP2	CMPSS-4 Low Comparator Positive Input 2	I		31	19	19	17
CMP5_HN1	CMPSS-5 High Comparator Negative Input 1	I		17	11	11	
CMP5_HP0	CMPSS-5 High Comparator Positive Input 0	I		6	6	6	
CMP5_HP1	CMPSS-5 High Comparator Positive Input 1	I		17	11	11	
CMP5_HP2	CMPSS-5 High Comparator Positive Input 2	I		16	11	11	
CMP5_LN1	CMPSS-5 Low Comparator Negative Input 1	I		17	11	11	
CMP5_LP0	CMPSS-5 Low Comparator Positive Input 0	I		6	6	6	
CMP5_LP1	CMPSS-5 Low Comparator Positive Input 1	I		17	11	11	
CMP5_LP2	CMPSS-5 Low Comparator Positive Input 2	I		16	11	11	
CMP6_HN0	CMPSS-6 High Comparator Negative Input 0	I		38			
CMP6_HN1	CMPSS-6 High Comparator Negative Input 1	I		28			
CMP6_HP0	CMPSS-6 High Comparator Positive Input 0	I		37			
CMP6_HP1	CMPSS-6 High Comparator Positive Input 1	I		28			
CMP6_HP2	CMPSS-6 High Comparator Positive Input 2	I		28			
CMP6_HP3	CMPSS-6 High Comparator Positive Input 3	I		38			
CMP6_LN0	CMPSS-6 Low Comparator Negative Input 0	I		38			
CMP6_LN1	CMPSS-6 Low Comparator Negative Input 1	I		28			
CMP6_LP0	CMPSS-6 Low Comparator Positive Input 0	I		37			
CMP6_LP1	CMPSS-6 Low Comparator Positive Input 1	I		28			
CMP6_LP2	CMPSS-6 Low Comparator Positive Input 2	I		28			
CMP6_LP3	CMPSS-6 Low Comparator Positive Input 3	I		38			
CMP7_HN0	CMPSS-7 High Comparator Negative Input 0	I		41			
CMP7_HN1	CMPSS-7 High Comparator Negative Input 1	I		44			
CMP7_HP0	CMPSS-7 High Comparator Positive Input 0	I		40	25	25	23
CMP7_HP1	CMPSS-7 High Comparator Positive Input 1	I		44			
CMP7_HP2	CMPSS-7 High Comparator Positive Input 2	I		43			
CMP7_HP3	CMPSS-7 High Comparator Positive Input 3	I		41			
CMP7_LN0	CMPSS-7 Low Comparator Negative Input 0	I		41			
CMP7_LN1	CMPSS-7 Low Comparator Negative Input 1	I		44			
CMP7_LP0	CMPSS-7 Low Comparator Positive Input 0	I		40	25	25	23
CMP7_LP1	CMPSS-7 Low Comparator Positive Input 1	I		44			
CMP7_LP2	CMPSS-7 Low Comparator Positive Input 2	I		43			
CMP7_LP3	CMPSS-7 Low Comparator Positive Input 3	I		41			
DACA_OUT	Buffered DAC-A Output	O		23	15	15	13
DACB_OUT	Buffered DAC-B Output	O		22	14	14	12
PGA1_GND	PGA-1 Ground	I		14	10	10	9
PGA1_IN	PGA-1 Input	I		18	12	12	10
PGA1_OF	PGA-1 Output Filter (Optional)	O		9	9	9	8
PGA2_GND	PGA-2 Ground	I		32	20	20	18
PGA2_IN	PGA-2 Input	I		30	18	18	16
PGA2_OF	PGA-2 Output Filter (Optional)	O		36	23	23	21
PGA3_GND	PGA-3 Ground	I		15	10	10	9
PGA3_IN	PGA-3 Input	I		20	13	13	11
PGA3_OF	PGA-3 Output Filter (Optional)	O		7	7	7	6

Table 4-2. Analog Signals (continued)

SIGNAL NAME	DESCRIPTION	PIN TYPE	GPIO	100 PZ	64 PM	64 PMQ	56 RSH
PGA4_GND	PGA-4 Ground	I		32	20	20	18
PGA4_IN	PGA-4 Input	I		31	19	19	17
PGA4_OF	PGA-4 Output Filter (Optional)	O		39	24	24	22
PGA5_GND	PGA-5 Ground	I		13	10	10	9
PGA5_IN	PGA-5 Input	I		16	11	11	
PGA5_OF	PGA-5 Output Filter (Optional)	O		6	6	6	
PGA6_GND	PGA-6 Ground	I		32	20	20	18
PGA6_IN	PGA-6 Input	I		28			
PGA6_OF	PGA-6 Output Filter (Optional)	O		37			
PGA7_GND	PGA-7 Ground	I		42			
PGA7_IN	PGA-7 Input	I		43			
PGA7_OF	PGA-7 Output Filter (Optional)	O		40	25	25	23
VDAC	Optional external reference voltage for on-chip DACs. There is a 100-pF capacitor to VSSA on this pin whether used for ADC input or DAC reference which cannot be disabled. If this pin is being used as a reference for the on-chip DACs, place at least a 1-μF capacitor on this pin.	I		8	8	8	7
VREFHIA	ADC-A High Reference. In external reference mode, externally drive the high reference voltage onto this pin. In internal reference mode, a voltage is driven onto this pin by the device. In either mode, place at least a 2.2-μF capacitor on this pin. This capacitor should be placed as close to the device as possible between the VREFHIA and VREFLOA pins. Do not load this pin externally in either internal or external reference mode.	I/O		25	16	16	14
VREFHIB	ADC-B High Reference. In external reference mode, externally drive the high reference voltage onto this pin. In internal reference mode, a voltage is driven onto this pin by the device. In either mode, place at least a 2.2-μF capacitor on this pin. This capacitor should be placed as close to the device as possible between the VREFHIB and VREFLOB pins. Do not load this pin externally in either internal or external reference mode.	I/O		24	16	16	14
VREFHIC	ADC-C High Reference. In external reference mode, externally drive the high reference voltage onto this pin. In internal reference mode, a voltage is driven onto this pin by the device. In either mode, place at least a 2.2-μF capacitor on this pin. This capacitor should be placed as close to the device as possible between the VREFHIC and VREFLOC pins. Do not load this pin externally in either internal or external reference mode.	I/O		24	16	16	14
VREFLOA	ADC-A Low Reference	I		27	17	17	15
VREFLOB	ADC-B Low Reference	I		26	17	17	15
VREFLOC	ADC-C Low Reference	I		26	17	17	15

4.3.2 Digital Signals

Table 4-3. Digital Signals

SIGNAL NAME	DESCRIPTION	PIN TYPE	GPIO	100 PZ	64 PM	64 PMQ	56 RSH
ADCSOAO	ADC Start of Conversion A Output for External ADC (from ePWM modules)	O	8	74	47	47	42
ADCSOCBO	ADC Start of Conversion B Output for External ADC (from ePWM modules)	O	10	93	63	63	
CANA_RX	CAN-A Receive	I	18, 30, 33, 35, 5	53, 63, 68, 89, 98	32, 39, 41, 61	32, 39, 41, 61	29, 36, 38, 55
CANA_TX	CAN-A Transmit	O	31, 32, 37, 4	61, 64, 75, 99	37, 40, 48	37, 40, 48	34, 37, 43
CANB_RX	CAN-B Receive	I	10, 13, 17, 39, 59, 7	50, 55, 84, 91, 92, 93	34, 57, 63	29, 34, 57, 63	26, 31, 52
CANB_TX	CAN-B Transmit	O	12, 16, 58, 6, 8	51, 54, 67, 74, 97	33, 47, 64	30, 33, 47, 64	1, 27, 30, 42
EPWM1_A	ePWM-1 Output A	O	0	79	52	52	47
EPWM1_B	ePWM-1 Output B	O	1	78	51	51	46
EPWM2_A	ePWM-2 Output A	O	2	77	50	50	45
EPWM2_B	ePWM-2 Output B	O	3	76	49	49	44
EPWM3_A	ePWM-3 Output A	O	4	75	48	48	43
EPWM3_B	ePWM-3 Output B	O	5	89	61	61	55
EPWM4_A	ePWM-4 Output A	O	6	97	64	64	1
EPWM4_B	ePWM-4 Output B	O	7	84	57	57	52
EPWM5_A	ePWM-5 Output A	O	16, 8	54, 74	33, 47	33, 47	30, 42
EPWM5_B	ePWM-5 Output B	O	17, 9	55, 90	34, 62	34, 62	31, 56
EPWM6_A	ePWM-6 Output A	O	10, 18	68, 93	41, 63	41, 63	38
EPWM6_B	ePWM-6 Output B	O	11	52	31	31	28
EPWM7_A	ePWM-7 Output A	O	12, 28	1, 51	2	2, 30	27, 3
EPWM7_B	ePWM-7 Output B	O	13, 29	100, 50	1	1, 29	2, 26
EPWM8_A	ePWM-8 Output A	O	14, 24	56, 96	35	35	32
EPWM8_B	ePWM-8 Output B	O	15, 32	64, 95	40	40	37
EQEP1_A	eQEP-1 Input A	I	10, 28, 35, 40, 56, 6	1, 63, 65, 85, 93, 97	2, 39, 63, 64	2, 39, 63, 64	1, 3, 36
EQEP1_B	eQEP-1 Input B	I	11, 29, 37, 57, 7	100, 52, 61, 66, 84	1, 31, 37, 57	1, 31, 37, 57	2, 28, 34, 52
EQEP1_INDEX	eQEP-1 Index	I/O	13, 17, 31, 59, 9	50, 55, 90, 92, 99	34, 62	29, 34, 62	26, 31, 56
EQEP1_STROBE	eQEP-1 Strobe	I/O	12, 16, 22, 30, 58, 8	51, 54, 67, 74, 83, 98	33, 47, 56	30, 33, 47, 56	27, 30, 42, 51
EQEP2_A	eQEP-2 Input A	I	14, 18, 24	56, 68, 96	35, 41	35, 41	32, 38
EQEP2_B	eQEP-2 Input B	I	15, 25	57, 95			
EQEP2_INDEX	eQEP-2 Index	I/O	26, 29, 57	100, 58, 66	1	1	2
EQEP2_STROBE	eQEP-2 Strobe	I/O	27, 28, 56	1, 59, 65	2	2	3

Table 4-3. Digital Signals (continued)

SIGNAL NAME	DESCRIPTION	PIN TYPE	GPIO	100 PZ	64 PM	64 PMQ	56 RSH
ERRORSTS	Error Status Output. This signal requires an external pullup.	O	24, 28, 29	1, 100, 56	1, 2, 35	1, 2, 35	2, 3, 32
FSIRXA_CLK	FSIRX-A Input Clock	I	13, 33, 39, 4	50, 53, 75, 91	32, 48	29, 32, 48	26, 29, 43
FSIRXA_D0	FSIRX-A Primary Data Input	I	12, 3, 32, 40	51, 64, 76, 85	40, 49	30, 40, 49	27, 37, 44
FSIRXA_D1	FSIRX-A Optional Additional Data Input	I	11, 2, 31	52, 77, 99	31, 50	31, 50	28, 45
FSITXA_CLK	FSITX-A Output Clock	O	10, 27, 7	59, 84, 93	57, 63	57, 63	52
FSITXA_D0	FSITX-A Primary Data Output	O	26, 6, 9	58, 90, 97	62, 64	62, 64	1, 56
FSITXA_D1	FSITX-A Optional Additional Data Output	O	25, 5, 8	57, 74, 89	47, 61	47, 61	42, 55
GPIO0	General-Purpose Input Output 0	I/O	0	79	52	52	47
GPIO1	General-Purpose Input Output 1	I/O	1	78	51	51	46
GPIO2	General-Purpose Input Output 2	I/O	2	77	50	50	45
GPIO3	General-Purpose Input Output 3	I/O	3	76	49	49	44
GPIO4	General-Purpose Input Output 4	I/O	4	75	48	48	43
GPIO5	General-Purpose Input Output 5	I/O	5	89	61	61	55
GPIO6	General-Purpose Input Output 6	I/O	6	97	64	64	1
GPIO7	General-Purpose Input Output 7	I/O	7	84	57	57	52
GPIO8	General-Purpose Input Output 8	I/O	8	74	47	47	42
GPIO9	General-Purpose Input Output 9	I/O	9	90	62	62	56
GPIO10	General-Purpose Input Output 10	I/O	10	93	63	63	
GPIO11	General-Purpose Input Output 11	I/O	11	52	31	31	28
GPIO12	General-Purpose Input Output 12	I/O	12	51		30	27
GPIO13	General-Purpose Input Output 13	I/O	13	50		29	26
GPIO14	General-Purpose Input Output 14	I/O	14	96			
GPIO15	General-Purpose Input Output 15	I/O	15	95			
GPIO16	General-Purpose Input Output 16	I/O	16	54	33	33	30
GPIO17	General-Purpose Input Output 17	I/O	17	55	34	34	31
GPIO18_X2	General-Purpose Input Output 18. This pin and its digital mux options can only be used when the system is clocked by INTOSC and X1 has an external pulldown resistor (recommended 1 kΩ).	I/O	18	68	41	41	38
GPIO20	General-Purpose Input Output 20	I/O	20				
GPIO21	General-Purpose Input Output 21	I/O	21				
GPIO22_VFBSW	General-Purpose Input Output 22. If the internal DC-DC regulator is not used, this can be configured as General-Purpose Input Output 22.	I/O	22	83	56	56	51
GPIO23_VSW	General-Purpose Input Output 23. If the internal DC-DC regulator is not used, this pin can be configured as General-Purpose Input Output 23. This pin has an internal capacitance of approximately 100 pF. TI Recommends using an alternate GPIO, or using this pin only for applications which do not require a fast switching response.	I/O	23	81	54	54	49
GPIO24	General-Purpose Input Output 24	I/O	24	56	35	35	32
GPIO25	General-Purpose Input Output 25	I/O	25	57			

Table 4-3. Digital Signals (continued)

SIGNAL NAME	DESCRIPTION	PIN TYPE	GPIO	100 PZ	64 PM	64 PMQ	56 RSH
GPIO26	General-Purpose Input Output 26	I/O	26	58			
GPIO27	General-Purpose Input Output 27	I/O	27	59			
GPIO28	General-Purpose Input Output 28	I/O	28	1	2	2	3
GPIO29	General-Purpose Input Output 29	I/O	29	100	1	1	2
GPIO30	General-Purpose Input Output 30	I/O	30	98			
GPIO31	General-Purpose Input Output 31	I/O	31	99			
GPIO32	General-Purpose Input Output 32	I/O	32	64	40	40	37
GPIO33	General-Purpose Input Output 33	I/O	33	53	32	32	29
GPIO34	General-Purpose Input Output 34	I/O	34	94			
GPIO35	General-Purpose Input Output 35	I/O	35	63	39	39	36
GPIO37	General-Purpose Input Output 37	I/O	37	61	37	37	34
GPIO39	General-Purpose Input Output 39	I/O	39	91			
GPIO40	General-Purpose Input Output 40	I/O	40	85			
GPIO41	General-Purpose Input Output 41	I/O	41				
GPIO42	General-Purpose Input Output 42	I/O	42				
GPIO43	General-Purpose Input Output 43	I/O	43				
GPIO44	General-Purpose Input Output 44	I/O	44				
GPIO45	General-Purpose Input Output 45	I/O	45				
GPIO46	General-Purpose Input Output 46	I/O	46				
GPIO47	General-Purpose Input Output 47	I/O	47				
GPIO48	General-Purpose Input Output 48	I/O	48				
GPIO49	General-Purpose Input Output 49	I/O	49				
GPIO50	General-Purpose Input Output 50	I/O	50				
GPIO51	General-Purpose Input Output 51	I/O	51				
GPIO52	General-Purpose Input Output 52	I/O	52				
GPIO53	General-Purpose Input Output 53	I/O	53				
GPIO54	General-Purpose Input Output 54	I/O	54				
GPIO55	General-Purpose Input Output 55	I/O	55				
GPIO56	General-Purpose Input Output 56	I/O	56	65			
GPIO57	General-Purpose Input Output 57	I/O	57	66			
GPIO58	General-Purpose Input Output 58	I/O	58	67			
GPIO59	General-Purpose Input Output 59	I/O	59	92			
I2CA_SCL	I2C-A Open-Drain Bidirectional Clock	I/OD	1, 18, 27, 33, 37, 8	53, 59, 61, 68, 74, 78	32, 37, 41, 47, 51	32, 37, 41, 47, 51	29, 34, 38, 42, 46
I2CA_SDA	I2C-A Open-Drain Bidirectional Data	I/OD	0, 10, 26, 32, 35	58, 63, 64, 79, 93	39, 40, 52, 63	39, 40, 52, 63	36, 37, 47
LINA_RX	LIN-A Receive	I	29, 33, 35, 59	100, 53, 63, 92	1, 32, 39	1, 32, 39	2, 29, 36
LINA_TX	LIN-A Transmit	O	22, 28, 32, 37, 58	1, 61, 64, 67, 83	2, 37, 40, 56	2, 37, 40, 56	3, 34, 37, 51
OUTPUTXBAR1	Output X-BAR Output 1	O	2, 24, 34, 58	56, 67, 77, 94	35, 50	35, 50	32, 45
OUTPUTXBAR2	Output X-BAR Output 2	O	25, 3, 37, 59	57, 61, 76, 92	37, 49	37, 49	34, 44
OUTPUTXBAR3	Output X-BAR Output 3	O	14, 26, 4, 5	58, 75, 89, 96	48, 61	48, 61	43, 55

Table 4-3. Digital Signals (continued)

SIGNAL NAME	DESCRIPTION	PIN TYPE	GPIO	100 PZ	64 PM	64 PMQ	56 RSH
OUTPUTXBAR4	Output X-BAR Output 4	O	15, 27, 33, 6	53, 59, 95, 97	32, 64	32, 64	1, 29
OUTPUTXBAR5	Output X-BAR Output 5	O	28, 7	1, 84	2, 57	2, 57	3, 52
OUTPUTXBAR6	Output X-BAR Output 6	O	29, 9	100, 90	1, 62	1, 62	2, 56
OUTPUTXBAR7	Output X-BAR Output 7	O	11, 16, 30	52, 54, 98	31, 33	31, 33	28, 30
OUTPUTXBAR8	Output X-BAR Output 8	O	17, 31	55, 99	34	34	31
PMBUSA_ALERT	PMBus-A Open-Drain Bidirectional Alert Signal	I/OD	13, 27, 37	50, 59, 61	37	29, 37	26, 34
PMBUSA_CTL	PMBus-A Control Signal	I	12, 18, 26, 35	51, 58, 63, 68	39, 41	30, 39, 41	27, 36, 38
PMBUSA_SCL	PMBus-A Open-Drain Bidirectional Clock	I/OD	15, 16, 24, 3, 35	54, 56, 63, 76, 95	33, 35, 39, 49	33, 35, 39, 49	30, 32, 36, 44
PMBUSA_SDA	PMBus-A Open-Drain Bidirectional Data	I/OD	14, 17, 2, 25, 34, 40	55, 57, 77, 85, 94, 96	34, 50	34, 50	31, 45
SCIA_RX	SCI-A Receive Data	I	17, 25, 28, 3, 35, 9	1, 55, 57, 63, 76, 90	2, 34, 39, 49, 62	2, 34, 39, 49, 62	3, 31, 36, 44, 56
SCIA_TX	SCI-A Transmit Data	O	16, 2, 24, 29, 37, 8	100, 54, 56, 61, 74, 77	1, 33, 35, 37, 47, 50	1, 33, 35, 37, 47, 50	2, 30, 32, 34, 42, 45
SCIB_RX	SCI-B Receive Data	I	11, 13, 15, 57	50, 52, 66, 95	31	29, 31	26, 28
SCIB_TX	SCI-B Transmit Data	O	10, 12, 14, 18, 22, 40, 56, 9	51, 65, 68, 83, 85, 90, 93, 96	41, 56, 62, 63	30, 41, 56, 62, 63	27, 38, 51, 56
SD1_C1	SDFM-1 Channel 1 Clock Input	I	17, 25	55, 57	34	34	31
SD1_C2	SDFM-1 Channel 2 Clock Input	I	27	59			
SD1_C3	SDFM-1 Channel 3 Clock Input	I	29, 33, 57	100, 53, 66	1, 32	1, 32	2, 29
SD1_C4	SDFM-1 Channel 4 Clock Input	I	31, 59	92, 99			
SD1_D1	SDFM-1 Channel 1 Data Input	I	16, 24	54, 56	33, 35	33, 35	30, 32
SD1_D2	SDFM-1 Channel 2 Data Input	I	18, 26	58, 68	41	41	38
SD1_D3	SDFM-1 Channel 3 Data Input	I	28, 32, 56	1, 64, 65	2, 40	2, 40	3, 37
SD1_D4	SDFM-1 Channel 4 Data Input	I	22, 30, 58	67, 83, 98	56	56	51
SPIA_CLK	SPI-A Clock	I/O	18, 3, 56, 9	65, 68, 76, 90	41, 49, 62	41, 49, 62	38, 44, 56
SPIA_SIMO	SPI-A Slave In, Master Out (SIMO)	I/O	16, 8	54, 74	33, 47	33, 47	30, 42
SPIA_SOMI	SPI-A Slave Out, Master In (SOMI)	I/O	10, 17	55, 93	34, 63	34, 63	31
SPIA_STE	SPI-A Slave Transmit Enable (STE)	I/O	11, 5, 57	52, 66, 89	31, 61	31, 61	28, 55
SPIB_CLK	SPI-B Clock	I/O	14, 22, 26, 28, 32, 58	1, 58, 64, 67, 83, 96	2, 40, 56	2, 40, 56	3, 37, 51
SPIB_SIMO	SPI-B Slave In, Master Out (SIMO)	I/O	24, 30, 56, 7	56, 65, 84, 98	35, 57	35, 57	32, 52
SPIB_SOMI	SPI-B Slave Out, Master In (SOMI)	I/O	25, 31, 57, 6	57, 66, 97, 99	64	64	1

Table 4-3. Digital Signals (continued)

SIGNAL NAME	DESCRIPTION	PIN TYPE	GPIO	100 PZ	64 PM	64 PMQ	56 RSH
SPIB_STE	SPI-B Slave Transmit Enable (STE)	I/O	15, 27, 29, 33, 59	100, 53, 59, 92, 95	1, 32	1, 32	2, 29
SYNCOUT	External ePWM Synchronization Pulse	O	6	97	64	64	1
TDI	JTAG Test Data Input (TDI) - TDI is the default mux selection for the pin. The internal pullup is disabled by default. The internal pullup should be enabled or an external pullup added on the board if this pin is used as JTAG TDI to avoid a floating input.	I	35	63	39	39	36
TDO	JTAG Test Data Output (TDO) - TDO is the default mux selection for the pin. The internal pullup is disabled by default. The TDO function will be in a tri-state condition when there is no JTAG activity, leaving this pin floating; the internal pullup should be enabled or an external pullup added on the board to avoid a floating GPIO input.	O	37	61	37	37	34
VFBSW	Internal DC-DC regulator feedback signal. If the internal DC-DC regulator is used, tie this pin to the node where L(VSW) connects to the VDD rail (as close as possible to the device).	-	22	83	56	56	51
VSW	Switching output of the internal DC-DC regulator	-	23	81	54	54	49
X2	Crystal oscillator output	I/O	18	68	41	41	38
XCLKOUT	External Clock Output. This pin outputs a divided-down version of a chosen clock signal from within the device.	O	16, 18	54, 68	33, 41	33, 41	30, 38

4.3.3 Power and Ground

Table 4-4. Power and Ground

SIGNAL NAME	DESCRIPTION	PIN TYPE	GPIO	100 PZ	64 PM	64 PMQ	56 RSH
VDD	1.2-V Digital Logic Power Pins. TI recommends placing a decoupling capacitor near each VDD pin with a minimum total capacitance of approximately 20 μ F. When not using the internal voltage regulator, the exact value of the decoupling capacitance should be determined by your system voltage regulation solution.			4, 46, 71, 87	27, 4, 44, 59	27, 4, 44, 59	24, 41, 5, 53
VDDA	3.3-V Analog Power Pins. Place a minimum 2.2- μ F decoupling capacitor to VSSA on each pin.			11, 34	22	22	20
VDDIO	3.3-V Digital I/O Power Pins. Place a minimum 0.1- μ F decoupling capacitor on each pin.			3, 47, 70, 88	28, 43, 60	28, 43, 60	25, 40, 54
VDDIO_SW	Supply pin for the internal DC-DC regulator. If the internal DC-DC regulator is used, a bulk input capacitance of 20- μ F should be placed on this pin. If the internal DC-DC regulator is not used, this pin should be treated as a VDDIO pin.			80	53	53	48
VSS	Digital Ground			45, 5, 72, 86	26, 45, 5, 58	26, 45, 5, 58	
VSSA	Analog Ground			12, 33	21	21	19
VSS_SW	Internal DC-DC regulator ground. If the internal DC-DC regulator is not used, this pin must be treated as a VSS pin.			82	55	55	50

4.3.4 Test, JTAG, Voltage Regulator, and Reset

Table 4-5. Test, JTAG, Voltage Regulator, and Reset

SIGNAL NAME	DESCRIPTION	PIN TYPE	GPIO	100 PZ	64 PM	64 PMQ	56 RSH
FLT1	Flash test pin 1. Reserved for TI. Must be left unconnected.	I/O		49	30		
FLT2	Flash test pin 2. Reserved for TI. Must be left unconnected.	I/O		48	29		
TCK	JTAG test clock with internal pullup.	I		60	36	36	33
TMS	JTAG test-mode select (TMS) with internal pullup. This serial control input is clocked into the TAP controller on the rising edge of TCK. This device does not have a TRSTn pin. An external pullup resistor (recommended 2.2 k Ω) on the TMS pin to VDDIO should be placed on the board to keep JTAG in reset during normal operation.	I		62	38	38	35
VREGENZ	Internal voltage regulator enable with internal pulldown. Tie directly to VSS (low) to enable the internal VREG. Tie directly to VDDIO (high) to use an external supply.	I		73	46	46	
X1	Crystal oscillator input or single-ended clock input. The device initialization software must configure this pin before the crystal oscillator is enabled. To use this oscillator, a quartz crystal circuit must be connected to X1 and X2. This pin can also be used to feed a single-ended 3.3-V level clock.	I/O		69	42	42	39
XRSn	Device Reset (in) and Watchdog Reset (out). During a power-on condition, this pin is driven low by the device. An external circuit may also drive this pin to assert a device reset. This pin is also driven low by the MCU when a watchdog reset occurs. During watchdog reset, the XRSn pin is driven low for the watchdog reset duration of 512 OSCCLK cycles. A resistor with a value from 2.2 k Ω to 10 k Ω should be placed between XRSn and VDDIO. If a capacitor is placed between XRSn and VSS for noise filtering, it should be 100 nF or smaller. These values allow the watchdog to properly drive the XRSn pin to VOL within 512 OSCCLK cycles when the watchdog reset is asserted. The output buffer of this pin is an open-drain with an internal pullup. If this pin is driven by an external device, TI recommends using an open-drain device.	I/OD		2	3	3	4

4.4 Pin Multiplexing

4.4.1 GPIO Muxed Pins

[Table 4-6](#) lists the GPIO muxed pins. The default mode for each GPIO pin is the GPIO function, except GPIO35 and GPIO37, which default to TDI and TDO, respectively. Secondary functions can be selected by setting both the GPyGMUXn.GPIOz and GPyMUXn.GPIOz register bits. The GPyGMUXn register should be configured before the GPyMUXn to avoid transient pulses on GPIOs from alternate mux selections. Columns that are not shown and blank cells are reserved GPIO Mux settings.

NOTE

GPIO20, GPIO21, GPIO41–GPIO55 are not available on any packages. Boot ROM enables pullups on these pins. For more details, see [Section 4.5](#).

Table 4-6. GPIO Muxed Pins

0, 4, 8, 12	1	2	3	5	6	7	9	10	11	13	15
GPIO0	EPWM1_A				I2CA_SDA						
GPIO1	EPWM1_B				I2CA_SCL						
GPIO2	EPWM2_A			OUTPUTXBAR1	PMBUSA_SDA		SCIA_TX	FSIRXA_D1			
GPIO3	EPWM2_B	OUTPUTXBAR2		OUTPUTXBAR2	PMBUSA_SCL	SPIA_CLK	SCIA_RX	FSIRXA_D0			
GPIO4	EPWM3_A			OUTPUTXBAR3	CANA_TX			FSIRXA_CLK			
GPIO5	EPWM3_B		OUTPUTXBAR3		CANA_RX	SPIA_STE	FSITXA_D1				
GPIO6	EPWM4_A	OUTPUTXBAR4	SYNCOUT	EQEP1_A	CANB_TX	SPIB_SOMI	FSITXA_D0				
GPIO7	EPWM4_B		OUTPUTXBAR5	EQEP1_B	CANB_RX	SPIB_SIMO	FSITXA_CLK				
GPIO8	EPWM5_A	CANB_TX	ADCSOCAO	EQEP1_STROBE	SCIA_TX	SPIA_SIMO	I2CA_SCL	FSITXA_D1			
GPIO9	EPWM5_B	SCIB_TX	OUTPUTXBAR6	EQEP1_INDEX	SCIA_RX	SPIA_CLK		FSITXA_D0			
GPIO10	EPWM6_A	CANB_RX	ADCSOCBO	EQEP1_A	SCIB_TX	SPIA_SOMI	I2CA_SDA	FSITXA_CLK			
GPIO11	EPWM6_B	SCIB_RX	OUTPUTXBAR7	EQEP1_B	SCIB_RX	SPIA_STE	FSIRXA_D1				
GPIO12	EPWM7_A	CANB_TX		EQEP1_STROBE	SCIB_TX	PMBUSA_CTL	FSIRXA_D0				
GPIO13	EPWM7_B	CANB_RX		EQEP1_INDEX	SCIB_RX	PMBUSA_ALERT	FSIRXA_CLK				
GPIO14	EPWM8_A	SCIB_TX			OUTPUTXBAR3	PMBUSA_SDA	SPIB_CLK	EQEP2_A			
GPIO15	EPWM8_B	SCIB_RX			OUTPUTXBAR4	PMBUSA_SCL	SPIB_STE	EQEP2_B			
GPIO16	SPIA_SIMO	CANB_TX	OUTPUTXBAR7	EPWM5_A	SCIA_TX	SD1_D1	EQEP1_STROBE	PMBUSA_SCL	XCLKOUT		
GPIO17	SPIA_SOMI	CANB_RX	OUTPUTXBAR8	EPWM5_B	SCIA_RX	SD1_C1	EQEP1_INDEX	PMBUSA_SDA			
GPIO18_X2	SPIA_CLK	SCIB_TX	CANA_RX	EPWM6_A	I2CA_SCL	SD1_D2	EQEP2_A	PMBUSA_CTL	XCLKOUT		
GPIO20											
GPIO21											
GPIO22_VFBSW	EQEP1_STROBE		SCIB_TX		SPIB_CLK	SD1_D4	LINA_TX				
GPIO23_VSW											
GPIO24	OUTPUTXBAR1	EQEP2_A		EPWM8_A	SPIB_SIMO	SD1_D1		PMBUSA_SCL	SCIA_TX	ERRORSTS	
GPIO25	OUTPUTXBAR2	EQEP2_B			SPIB_SOMI	SD1_C1	FSITXA_D1	PMBUSA_SDA	SCIA_RX		
GPIO26	OUTPUTXBAR3	EQEP2_INDEX		OUTPUTXBAR3	SPIB_CLK	SD1_D2	FSITXA_D0	PMBUSA_CTL	I2CA_SDA		
GPIO27	OUTPUTXBAR4	EQEP2_STROBE		OUTPUTXBAR4	SPIB_STE	SD1_C2	FSITXA_CLK	PMBUSA_ALERT	I2CA_SCL		
GPIO28	SCIA_RX		EPWM7_A	OUTPUTXBAR5	EQEP1_A	SD1_D3	EQEP2_STROBE	LINA_TX	SPIB_CLK	ERRORSTS	
GPIO29	SCIA_TX		EPWM7_B	OUTPUTXBAR6	EQEP1_B	SD1_C3	EQEP2_INDEX	LINA_RX	SPIB_STE	ERRORSTS	
GPIO30	CANA_RX		SPIB_SIMO	OUTPUTXBAR7	EQEP1_STROBE	SD1_D4					
GPIO31	CANA_TX		SPIB_SOMI	OUTPUTXBAR8	EQEP1_INDEX	SD1_C4	FSIRXA_D1				
GPIO32	I2CA_SDA		SPIB_CLK	EPWM8_B	LINA_TX	SD1_D3	FSIRXA_D0	CANA_TX			
GPIO33	I2CA_SCL		SPIB_STE	OUTPUTXBAR4	LINA_RX	SD1_C3	FSIRXA_CLK	CANA_RX			
GPIO34	OUTPUTXBAR1				PMBUSA_SDA						
GPIO35	SCIA_RX		I2CA_SDA	CANA_RX	PMBUSA_SCL	LINA_RX	EQEP1_A	PMBUSA_CTL			TDI
GPIO37	OUTPUTXBAR2		I2CA_SCL	SCIA_TX	CANA_TX	LINA_TX	EQEP1_B	PMBUSA_ALERT			TDO
GPIO39					CANB_RX	FSIRXA_CLK					
GPIO40					PMBUSA_SDA	FSIRXA_D0	SCIB_TX	EQEP1_A			
GPIO41											

Table 4-6. GPIO Muxed Pins (continued)

0, 4, 8, 12	1	2	3	5	6	7	9	10	11	13	15
GPIO42											
GPIO43											
GPIO44											
GPIO45											
GPIO46											
GPIO47											
GPIO48											
GPIO49											
GPIO50											
GPIO51											
GPIO52											
GPIO53											
GPIO54											
GPIO55											
GPIO56	SPIA_CLK			EQEP2_STROBE	SCIB_TX	SD1_D3	SPIB_SIMO		EQEP1_A		
GPIO57	SPIA_STE			EQEP2_INDEX	SCIB_RX	SD1_C3	SPIB_SOMI		EQEP1_B		
GPIO58				OUTPUTXBAR1	SPIB_CLK	SD1_D4	LINA_TX	CANB_TX	EQEP1_STROBE		
GPIO59				OUTPUTXBAR2	SPIB_STE	SD1_C4	LINA_RX	CANB_RX	EQEP1_INDEX		

Table 4-7 lists all muxed signals available and the respective GPIO within each package.

Table 4-7. Digital Signals by GPIO

SIGNAL NAME	PIN TYPE	DESCRIPTION	100 PZ	64 PM	64 PMQ	56 RSH
ADCSOCAO	O	ADC Start of Conversion A Output for External ADC (from ePWM modules)	GPIO8	GPIO8	GPIO8	GPIO8
ADCSOCBO	O	ADC Start of Conversion B Output for External ADC (from ePWM modules)	GPIO10	GPIO10	GPIO10	
CANA_RX	I	CAN-A Receive	GPIO5 GPIO18_X2 GPIO30 GPIO33 GPIO35/TDI	GPIO5 GPIO18_X2 GPIO33 GPIO35/TDI	GPIO5 GPIO18_X2 GPIO33 GPIO35/TDI	GPIO5 GPIO18_X2 GPIO33 GPIO35/TDI
CANA_TX	O	CAN-A Transmit	GPIO4 GPIO31 GPIO32 GPIO37/TDO	GPIO4 GPIO32 GPIO37/TDO	GPIO4 GPIO32 GPIO37/TDO	GPIO4 GPIO32 GPIO37/TDO
CANB_RX	I	CAN-B Receive	GPIO7 GPIO10 GPIO13 GPIO17 GPIO39 GPIO59	GPIO7 GPIO10 GPIO17	GPIO7 GPIO10 GPIO13 GPIO17	GPIO7 GPIO13 GPIO17
CANB_TX	O	CAN-B Transmit	GPIO6 GPIO8 GPIO12 GPIO16 GPIO58	GPIO6 GPIO8 GPIO16	GPIO6 GPIO8 GPIO12 GPIO16	GPIO6 GPIO8 GPIO12 GPIO16
EPWM1_A	O	ePWM-1 Output A	GPIO0	GPIO0	GPIO0	GPIO0
EPWM1_B	O	ePWM-1 Output B	GPIO1	GPIO1	GPIO1	GPIO1
EPWM2_A	O	ePWM-2 Output A	GPIO2	GPIO2	GPIO2	GPIO2
EPWM2_B	O	ePWM-2 Output B	GPIO3	GPIO3	GPIO3	GPIO3
EPWM3_A	O	ePWM-3 Output A	GPIO4	GPIO4	GPIO4	GPIO4
EPWM3_B	O	ePWM-3 Output B	GPIO5	GPIO5	GPIO5	GPIO5
EPWM4_A	O	ePWM-4 Output A	GPIO6	GPIO6	GPIO6	GPIO6
EPWM4_B	O	ePWM-4 Output B	GPIO7	GPIO7	GPIO7	GPIO7
EPWM5_A	O	ePWM-5 Output A	GPIO8 GPIO16	GPIO8 GPIO16	GPIO8 GPIO16	GPIO8 GPIO16
EPWM5_B	O	ePWM-5 Output B	GPIO9 GPIO17	GPIO9 GPIO17	GPIO9 GPIO17	GPIO9 GPIO17
EPWM6_A	O	ePWM-6 Output A	GPIO10 GPIO18_X2	GPIO10 GPIO18_X2	GPIO10 GPIO18_X2	GPIO18_X2
EPWM6_B	O	ePWM-6 Output B	GPIO11	GPIO11	GPIO11	GPIO11
EPWM7_A	O	ePWM-7 Output A	GPIO12 GPIO28	GPIO28	GPIO12 GPIO28	GPIO12 GPIO28
EPWM7_B	O	ePWM-7 Output B	GPIO13 GPIO29	GPIO29	GPIO13 GPIO29	GPIO13 GPIO29
EPWM8_A	O	ePWM-8 Output A	GPIO14 GPIO24	GPIO24	GPIO24	GPIO24
EPWM8_B	O	ePWM-8 Output B	GPIO15 GPIO32	GPIO32	GPIO32	GPIO32

Table 4-7. Digital Signals by GPIO (continued)

SIGNAL NAME	PIN TYPE	DESCRIPTION	100 PZ	64 PM	64 PMQ	56 RSH
EQEP1_A	I	eQEP-1 Input A	GPIO6 GPIO10 GPIO28 GPIO35/T DI GPIO40 GPIO56	GPIO6 GPIO10 GPIO28 GPIO35/T DI	GPIO6 GPIO10 GPIO28 GPIO35/T DI	GPIO6 GPIO28 GPIO35/T DI
EQEP1_B	I	eQEP-1 Input B	GPIO7 GPIO11 GPIO29 GPIO37/T DO GPIO57	GPIO7 GPIO11 GPIO29 GPIO37/T DO	GPIO7 GPIO11 GPIO29 GPIO37/T DO	GPIO7 GPIO11 GPIO29 GPIO37/T DO
EQEP1_INDEX	I/O	eQEP-1 Index	GPIO9 GPIO13 GPIO17 GPIO31 GPIO59	GPIO9 GPIO17	GPIO9 GPIO13 GPIO17	GPIO9 GPIO13 GPIO17
EQEP1_STROBE	I/O	eQEP-1 Strobe	GPIO8 GPIO12 GPIO16 GPIO22_ VFBSW GPIO30 GPIO58	GPIO8 GPIO16 GPIO22_ VFBSW	GPIO8 GPIO12 GPIO16 GPIO22_ VFBSW	GPIO8 GPIO12 GPIO16 GPIO22_ VFBSW
EQEP2_A	I	eQEP-2 Input A	GPIO14 GPIO18_ X2 GPIO24	GPIO18_ X2 GPIO24	GPIO18_ X2 GPIO24	GPIO18_ X2 GPIO24
EQEP2_B	I	eQEP-2 Input B	GPIO15 GPIO25			
EQEP2_INDEX	I/O	eQEP-2 Index	GPIO26 GPIO29 GPIO57	GPIO29	GPIO29	GPIO29
EQEP2_STROBE	I/O	eQEP-2 Strobe	GPIO27 GPIO28 GPIO56	GPIO28	GPIO28	GPIO28
ERRORSTS	O	Error Status Output. This signal requires an external pullup.	GPIO24 GPIO28 GPIO29	GPIO24 GPIO28 GPIO29	GPIO24 GPIO28 GPIO29	GPIO24 GPIO28 GPIO29
FSIRXA_CLK	I	FSIRX-A Input Clock	GPIO4 GPIO13 GPIO33 GPIO39	GPIO4 GPIO33	GPIO4 GPIO13 GPIO33	GPIO4 GPIO13 GPIO33
FSIRXA_D0	I	FSIRX-A Primary Data Input	GPIO3 GPIO12 GPIO32 GPIO40	GPIO3 GPIO32	GPIO3 GPIO12 GPIO32	GPIO3 GPIO12 GPIO32
FSIRXA_D1	I	FSIRX-A Optional Additional Data Input	GPIO2 GPIO11 GPIO31	GPIO2 GPIO11	GPIO2 GPIO11	GPIO2 GPIO11
FSITXA_CLK	O	FSITX-A Output Clock	GPIO7 GPIO10 GPIO27	GPIO7 GPIO10	GPIO7 GPIO10	GPIO7
FSITXA_D0	O	FSITX-A Primary Data Output	GPIO6 GPIO9 GPIO26	GPIO6 GPIO9	GPIO6 GPIO9	GPIO6 GPIO9
FSITXA_D1	O	FSITX-A Optional Additional Data Output	GPIO5 GPIO8 GPIO25	GPIO5 GPIO8	GPIO5 GPIO8	GPIO5 GPIO8

Table 4-7. Digital Signals by GPIO (continued)

SIGNAL NAME	PIN TYPE	DESCRIPTION	100 PZ	64 PM	64 PMQ	56 RSH
I2CA_SCL	I/OD	I2C-A Open-Drain Bidirectional Clock	GPIO1 GPIO8 GPIO18_ X2 GPIO27 GPIO33 GPIO37/T DO	GPIO1 GPIO8 GPIO18_ X2 GPIO33 GPIO37/T DO	GPIO1 GPIO8 GPIO18_ X2 GPIO33 GPIO37/T DO	GPIO1 GPIO8 GPIO18_ X2 GPIO33 GPIO37/T DO
I2CA_SDA	I/OD	I2C-A Open-Drain Bidirectional Data	GPIO0 GPIO10 GPIO26 GPIO32 GPIO35/T DI	GPIO0 GPIO10 GPIO32 GPIO35/T DI	GPIO0 GPIO10 GPIO32 GPIO35/T DI	GPIO0 GPIO32 GPIO35/T DI
LINA_RX	I	LIN-A Receive	GPIO29 GPIO33 GPIO35/T DI GPIO59	GPIO29 GPIO33 GPIO35/T DI	GPIO29 GPIO33 GPIO35/T DI	GPIO29 GPIO33 GPIO35/T DI
LINA_TX	O	LIN-A Transmit	GPIO22_ VFBSW GPIO28 GPIO32 GPIO37/T DO GPIO58	GPIO22_ VFBSW GPIO28 GPIO32 GPIO37/T DO	GPIO22_ VFBSW GPIO28 GPIO32 GPIO37/T DO	GPIO22_ VFBSW GPIO28 GPIO32 GPIO37/T DO
OUTPUTXBAR1	O	Output X-BAR Output 1	GPIO2 GPIO24 GPIO34 GPIO58	GPIO2 GPIO24	GPIO2 GPIO24	GPIO2 GPIO24
OUTPUTXBAR2	O	Output X-BAR Output 2	GPIO3 GPIO25 GPIO37/T DO GPIO59	GPIO3 GPIO37/T DO	GPIO3 GPIO37/T DO	GPIO3 GPIO37/T DO
OUTPUTXBAR3	O	Output X-BAR Output 3	GPIO4 GPIO5 GPIO14 GPIO26	GPIO4 GPIO5	GPIO4 GPIO5	GPIO4 GPIO5
OUTPUTXBAR4	O	Output X-BAR Output 4	GPIO6 GPIO15 GPIO27 GPIO33	GPIO6 GPIO33	GPIO6 GPIO33	GPIO6 GPIO33
OUTPUTXBAR5	O	Output X-BAR Output 5	GPIO7 GPIO28	GPIO7 GPIO28	GPIO7 GPIO28	GPIO7 GPIO28
OUTPUTXBAR6	O	Output X-BAR Output 6	GPIO9 GPIO29	GPIO9 GPIO29	GPIO9 GPIO29	GPIO9 GPIO29
OUTPUTXBAR7	O	Output X-BAR Output 7	GPIO11 GPIO16 GPIO30	GPIO11 GPIO16	GPIO11 GPIO16	GPIO11 GPIO16
OUTPUTXBAR8	O	Output X-BAR Output 8	GPIO17 GPIO31	GPIO17	GPIO17	GPIO17
PMBUSA_ALERT	I/OD	PMBus-A Open-Drain Bidirectional Alert Signal	GPIO13 GPIO27 GPIO37/T DO	GPIO37/T DO	GPIO13 GPIO37/T DO	GPIO13 GPIO37/T DO
PMBUSA_CTL	I	PMBus-A Control Signal	GPIO12 GPIO18_ X2 GPIO26 GPIO35/T DI	GPIO18_ X2 GPIO35/T DI	GPIO12 GPIO18_ X2 GPIO35/T DI	GPIO12 GPIO18_ X2 GPIO35/T DI

Table 4-7. Digital Signals by GPIO (continued)

SIGNAL NAME	PIN TYPE	DESCRIPTION	100 PZ	64 PM	64 PMQ	56 RSH
PMBUSA_SCL	I/OD	PMBus-A Open-Drain Bidirectional Clock	GPIO3 GPIO15 GPIO16 GPIO24 GPIO35/T DI	GPIO3 GPIO16 GPIO24 GPIO35/T DI	GPIO3 GPIO16 GPIO24 GPIO35/T DI	GPIO3 GPIO16 GPIO24 GPIO35/T DI
PMBUSA_SDA	I/OD	PMBus-A Open-Drain Bidirectional Data	GPIO2 GPIO14 GPIO17 GPIO25 GPIO34 GPIO40	GPIO2 GPIO17	GPIO2 GPIO17	GPIO2 GPIO17
SCIA_RX	I	SCI-A Receive Data	GPIO3 GPIO9 GPIO17 GPIO25 GPIO28 GPIO35/T DI	GPIO3 GPIO9 GPIO17 GPIO28 GPIO35/T DI	GPIO3 GPIO9 GPIO17 GPIO28 GPIO35/T DI	GPIO3 GPIO9 GPIO17 GPIO28 GPIO35/T DI
SCIA_TX	O	SCI-A Transmit Data	GPIO2 GPIO8 GPIO16 GPIO24 GPIO29 GPIO37/T DO	GPIO2 GPIO8 GPIO16 GPIO24 GPIO29 GPIO37/T DO	GPIO2 GPIO8 GPIO16 GPIO24 GPIO29 GPIO37/T DO	GPIO2 GPIO8 GPIO16 GPIO24 GPIO29 GPIO37/T DO
SCIB_RX	I	SCI-B Receive Data	GPIO11 GPIO13 GPIO15 GPIO57	GPIO11	GPIO11 GPIO13	GPIO11 GPIO13
SCIB_TX	O	SCI-B Transmit Data	GPIO9 GPIO10 GPIO12 GPIO14 GPIO18_ X2 GPIO22_ VFBSW GPIO40 GPIO56	GPIO9 GPIO10 GPIO18_ X2 GPIO22_ VFBSW	GPIO9 GPIO10 GPIO12 GPIO18_ X2 GPIO22_ VFBSW	GPIO9 GPIO12 GPIO18_ X2 GPIO22_ VFBSW
SD1_C1	I	SDFM-1 Channel 1 Clock Input	GPIO17 GPIO25	GPIO17	GPIO17	GPIO17
SD1_C2	I	SDFM-1 Channel 2 Clock Input	GPIO27			
SD1_C3	I	SDFM-1 Channel 3 Clock Input	GPIO29 GPIO33 GPIO57	GPIO29 GPIO33	GPIO29 GPIO33	GPIO29 GPIO33
SD1_C4	I	SDFM-1 Channel 4 Clock Input	GPIO31 GPIO59			
SD1_D1	I	SDFM-1 Channel 1 Data Input	GPIO16 GPIO24	GPIO16 GPIO24	GPIO16 GPIO24	GPIO16 GPIO24
SD1_D2	I	SDFM-1 Channel 2 Data Input	GPIO18_ X2 GPIO26	GPIO18_ X2	GPIO18_ X2	GPIO18_ X2
SD1_D3	I	SDFM-1 Channel 3 Data Input	GPIO28 GPIO32 GPIO56	GPIO28 GPIO32	GPIO28 GPIO32	GPIO28 GPIO32
SD1_D4	I	SDFM-1 Channel 4 Data Input	GPIO22_ VFBSW GPIO30 GPIO58	GPIO22_ VFBSW	GPIO22_ VFBSW	GPIO22_ VFBSW

Table 4-7. Digital Signals by GPIO (continued)

SIGNAL NAME	PIN TYPE	DESCRIPTION	100 PZ	64 PM	64 PMQ	56 RSH
SPIA_CLK	I/O	SPI-A Clock	GPIO3 GPIO9 GPIO18_ X2 GPIO56	GPIO3 GPIO9 GPIO18_ X2	GPIO3 GPIO9 GPIO18_ X2	GPIO3 GPIO9 GPIO18_ X2
SPIA_SIMO	I/O	SPI-A Slave In, Master Out (SIMO)	GPIO8 GPIO16	GPIO8 GPIO16	GPIO8 GPIO16	GPIO8 GPIO16
SPIA_SOMI	I/O	SPI-A Slave Out, Master In (SOMI)	GPIO10 GPIO17	GPIO10 GPIO17	GPIO10 GPIO17	GPIO17
SPIA_STE	I/O	SPI-A Slave Transmit Enable (STE)	GPIO5 GPIO11 GPIO57	GPIO5 GPIO11	GPIO5 GPIO11	GPIO5 GPIO11
SPIB_CLK	I/O	SPI-B Clock	GPIO14 GPIO22_ VFBSW GPIO26 GPIO28 GPIO32 GPIO58	GPIO22_ VFBSW GPIO28 GPIO32	GPIO22_ VFBSW GPIO28 GPIO32	GPIO22_ VFBSW GPIO28 GPIO32
SPIB_SIMO	I/O	SPI-B Slave In, Master Out (SIMO)	GPIO7 GPIO24 GPIO30 GPIO56	GPIO7 GPIO24	GPIO7 GPIO24	GPIO7 GPIO24
SPIB_SOMI	I/O	SPI-B Slave Out, Master In (SOMI)	GPIO6 GPIO25 GPIO31 GPIO57	GPIO6	GPIO6	GPIO6
SPIB_STE	I/O	SPI-B Slave Transmit Enable (STE)	GPIO15 GPIO27 GPIO29 GPIO33 GPIO59	GPIO29 GPIO33	GPIO29 GPIO33	GPIO29 GPIO33
SYNCOUT	O	External ePWM Synchronization Pulse	GPIO6	GPIO6	GPIO6	GPIO6
TDI	I	JTAG Test Data Input (TDI) - TDI is the default mux selection for the pin. The internal pullup is disabled by default. The internal pullup should be enabled or an external pullup added on the board if this pin is used as JTAG TDI to avoid a floating input.	GPIO35/T DI	GPIO35/T DI	GPIO35/T DI	GPIO35/T DI
TDO	O	JTAG Test Data Output (TDO) - TDO is the default mux selection for the pin. The internal pullup is disabled by default. The TDO function will be in a tri-state condition when there is no JTAG activity, leaving this pin floating; the internal pullup should be enabled or an external pullup added on the board to avoid a floating GPIO input.	GPIO37/T DO	GPIO37/T DO	GPIO37/T DO	GPIO37/T DO
VFBSW	-	Internal DC-DC regulator feedback signal. If the internal DC-DC regulator is used, tie this pin to the node where L(VSW) connects to the VDD rail (as close as possible to the device).	GPIO22_ VFBSW	GPIO22_ VFBSW	GPIO22_ VFBSW	GPIO22_ VFBSW
VSW	-	Switching output of the internal DC-DC regulator	GPIO23_ VSW	GPIO23_ VSW	GPIO23_ VSW	GPIO23_ VSW
X2	I/O	Crystal oscillator output	GPIO18_ X2	GPIO18_ X2	GPIO18_ X2	GPIO18_ X2
XCLKOUT	O	External Clock Output. This pin outputs a divided-down version of a chosen clock signal from within the device.	GPIO16 GPIO18_ X2	GPIO16 GPIO18_ X2	GPIO16 GPIO18_ X2	GPIO16 GPIO18_ X2

4.4.2 Digital Inputs on ADC Pins (AIOs)

GPIOs on port H (GPIO224–GPIO255) are multiplexed with analog pins. These are also referred to as AIOs. These pins can only function in input mode. By default, these pins will function as analog pins and the GPIOs are in a high-Z state. The GPHAMSEL register is used to configure these pins for digital or analog operation.

NOTE

If digital signals with sharp edges (high dv/dt) are connected to the AIOs, cross-talk can occur with adjacent analog signals. The user should therefore limit the edge rate of signals connected to AIOs if adjacent channels are being used for analog functions.

4.4.3 GPIO Input X-BAR

The Input X-BAR is used to route signals from a GPIO to many different IP blocks such as the ADCs, eCAPs, ePWMs, and external interrupts (see [Figure 4-5](#)). [Table 4-8](#) lists the input X-BAR destinations. For details on configuring the Input X-BAR, see the Crossbar (X-BAR) chapter of the [TMS320F28004x Piccolo Microcontrollers Technical Reference Manual](#).

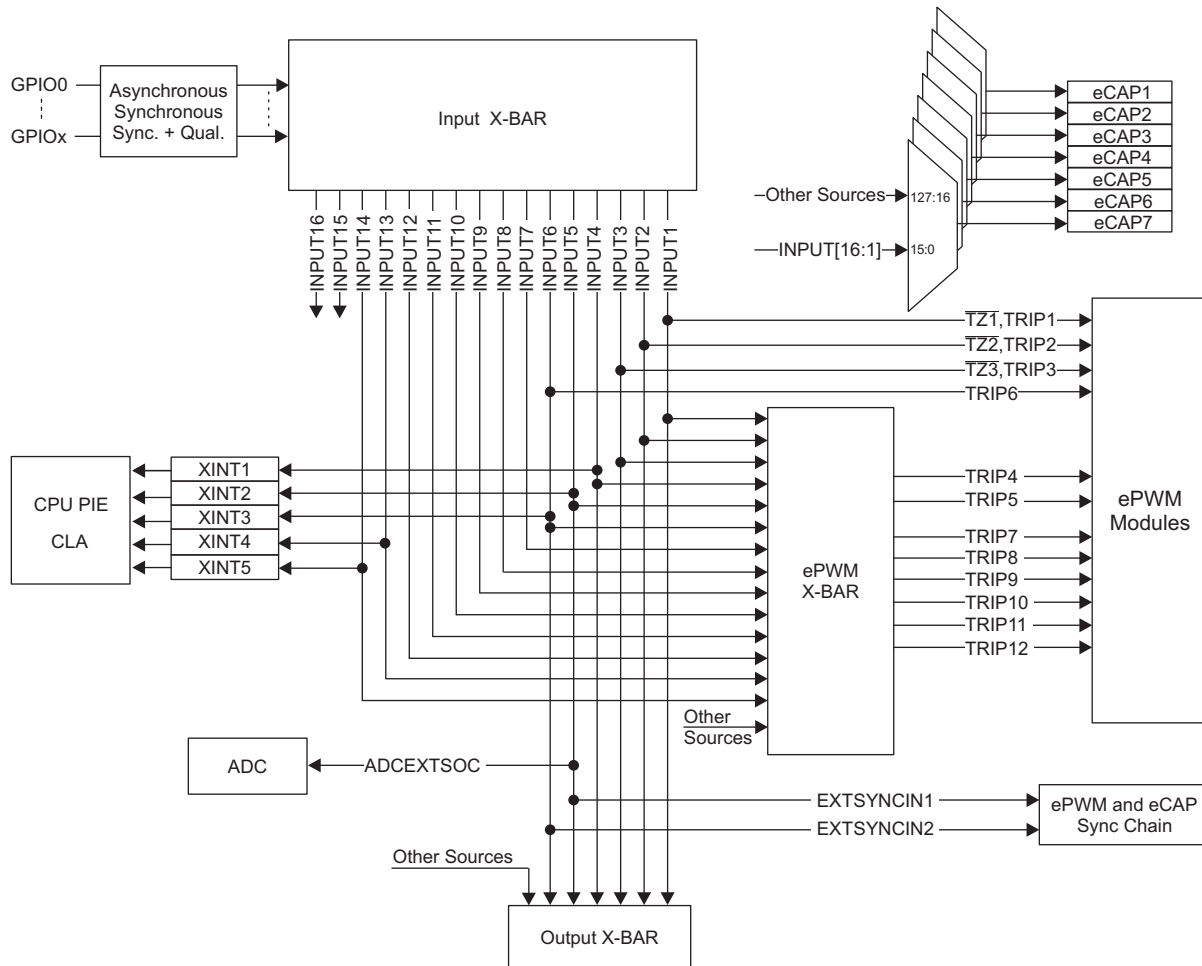


Figure 4-5. Input X-BAR

Table 4-8. Input X-BAR Destinations

INPUT	DESTINATIONS
INPUT1	eCAPx, ePWM X-BAR, ePWM[TZ1,TRIP1], Output X-BAR
INPUT2	eCAPx, ePWM X-BAR, ePWM[TZ2,TRIP2], Output X-BAR
INPUT3	eCAPx, ePWM X-BAR, ePWM[TZ3,TRIP3], Output X-BAR
INPUT4	eCAPx, ePWM X-BAR, XINT1, Output X-BAR
INPUT5	eCAPx, ePWM X-BAR, XINT2, ADCEXTSOC, EXTSYN CIN1, Output X-BAR
INPUT6	eCAPx, ePWM X-BAR, XINT3, ePWM[TRIP6], EXTSYN CIN2, Output X-BAR
INPUT7	eCAPx, ePWM X-BAR
INPUT8	eCAPx, ePWM X-BAR
INPUT9	eCAPx, ePWM X-BAR
INPUT10	eCAPx, ePWM X-BAR
INPUT11	eCAPx, ePWM X-BAR
INPUT12	eCAPx, ePWM X-BAR
INPUT13	eCAPx, ePWM X-BAR, XINT4
INPUT14	eCAPx, ePWM X-BAR, XINT5
INPUT15	eCAPx
INPUT16	eCAPx

4.4.4 GPIO Output X-BAR and ePWM X-BAR

The Output X-BAR has eight outputs which are routed to the GPIO module. The ePWM X-BAR has eight outputs which are routed to each ePWM module. Figure 4-6 shows the sources for both the Output X-BAR and ePWM X-BAR. For details on the Output X-BAR and ePWM X-BAR, see the Crossbar (X-BAR) chapter of the [TMS320F28004x Piccolo Microcontrollers Technical Reference Manual](#).

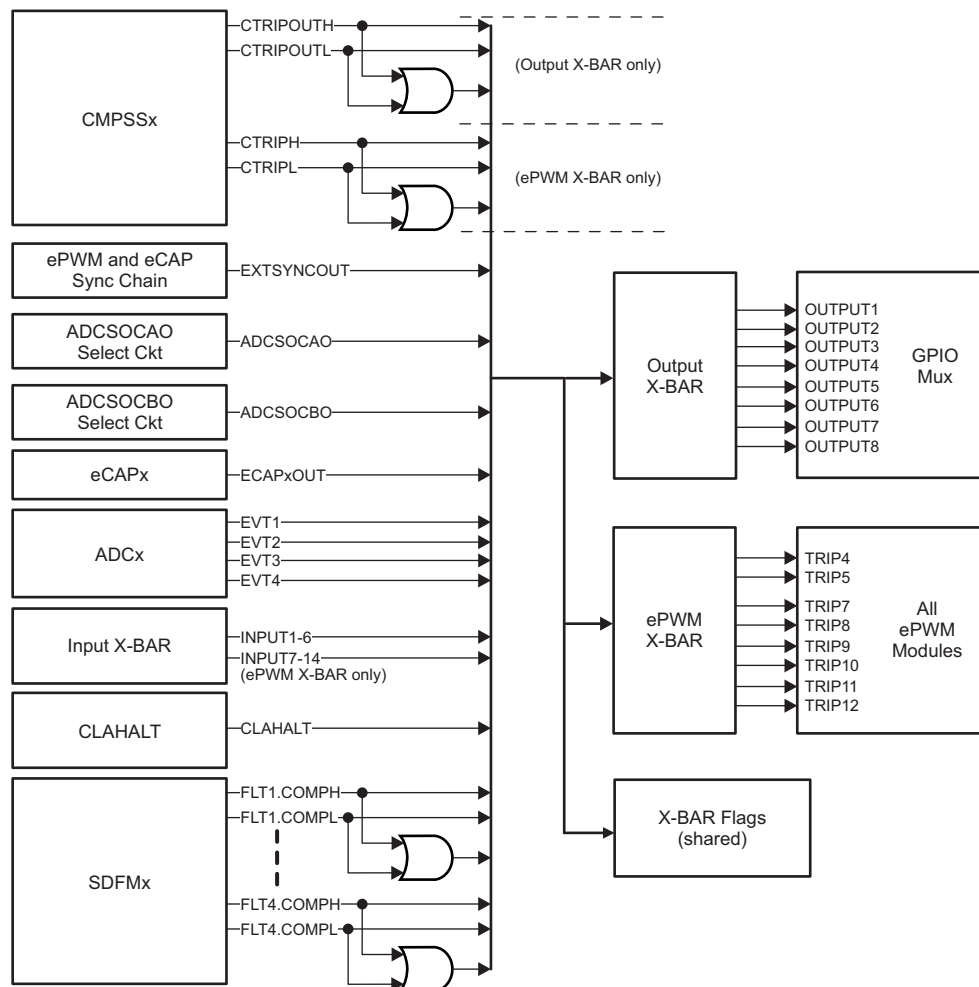


Figure 4-6. Output X-BAR and ePWM X-BAR Sources

4.5 Pins With Internal Pullup and Pulldown

Some pins on the device have internal pullups or pulldowns. [Table 4-9](#) lists the pull direction and when it is active. The pullups on GPIO pins are disabled by default and can be enabled through software. To avoid any floating unbonded inputs, the Boot ROM will enable internal pullups on GPIO pins that are not bonded out in a particular package. Other pins noted in [Table 4-9](#) with pullups and pulldowns are always on and cannot be disabled.

Table 4-9. Pins With Internal Pullup and Pulldown

PIN	RESET (XRSn = 0)	DEVICE BOOT	APPLICATION
GPIOx (including AIOs)	Pullup disabled	Pullup disabled ⁽¹⁾	Application defined
GPIO35/TDI	Pullup disabled		Application defined
GPIO37/TDO	Pullup disabled		Application defined
TCK	Pullup active		
TMS	Pullup active		
VREGENZ	Pulldown active		
XRSn	Pullup active		
Other pins	No pullup or pulldown present		

(1) Pins not bonded out in a given package will have the internal pullups enabled by the Boot ROM.

4.6 Connections for Unused Pins

For applications that do not need to use all functions of the device, [Table 4-10](#) lists acceptable conditioning for any unused pins. When multiple options are listed in [Table 4-10](#), any option is acceptable. Pins not listed in [Table 4-10](#) must be connected according to [Section 4](#).

Table 4-10. Connections for Unused Pins

SIGNAL NAME	ACCEPTABLE PRACTICE
ANALOG	
Analog input pins with DACx_OUT	- No Connect - Tie to VSSA through 4.7-kΩ or larger resistor
Analog input pins with PGAx_OUTF	- No Connect - Tie to VSSA through 4.7-kΩ or larger resistor
Analog input pins (except for DACx_OUT and PGAx_OUTF)	- No Connect - Tie to VSSA - Tie to VSSA through resistor
PGAx_GND	Tie to VSSA
VREFHlx	Tie to VDDA
VREFLOx	Tie to VSSA
DIGITAL	
FLT1 (Flash Test pin 1)	- No Connect - Tie to VSS through 4.7-kΩ or larger resistor
FLT2 (Flash Test pin 2)	- No Connect - Tie to VSS through 4.7-kΩ or larger resistor
GPIOx	- Input mode with internal pullup enabled - Input mode with external pullup or pulldown resistor - Output mode with internal pullup disabled
GPIO35/TDI	When TDI mux option is selected (default), the GPIO is in Input mode. - Internal pullup enabled - External pullup resistor
GPIO37/TDO	When TDO mux option is selected (default), the GPIO is in Output mode only during JTAG activity; otherwise, it is in a tri-state condition. The pin must be biased to avoid extra current on the input buffer. - Internal pullup enabled - External pullup resistor
TCK	- No Connect - Pullup resistor
TMS	Pullup resistor
VREGENZ	Tie to VDDIO if internal regulator is not used
X1	Tie to VSS
X2	No Connect
POWER AND GROUND	
VDD	All VDD pins must be connected per Section 4.3 .
VDDA	If a dedicated analog supply is not used, tie to VDDIO.
VDDIO	All VDDIO pins must be connected per Section 4.3 .
VDDIO_SW	Must always be tied to VDDIO
VSS	All VSS pins must be connected to board ground.
VSS_SW	Tie to VSS
VSSA	If an analog ground is not used, tie to VSS.

5 Specifications

5.1 Absolute Maximum Ratings⁽¹⁾⁽²⁾

over operating free-air temperature range (unless otherwise noted)

		MIN	MAX	UNIT
Supply voltage	VDDIO with respect to VSS	–0.3	4.6	V
	VDDA with respect to VSSA	–0.3	4.6	
	VDD with respect to VSS	–0.3	1.5	
Voltage difference between VDDIO and VDDIO_SW pins			±0.3	V
Input voltage	V _{IN} (3.3 V)	–0.3	4.6	V
Output voltage	V _O	–0.3	4.6	V
Input clamp current	Digital input (per pin), I _{IK} (V _{IN} < VSS or V _{IN} > VDDIO)	–20	20	mA
	Analog input (per pin), I _{IKANALOG} (V _{IN} < VSSA or V _{IN} > VDDA)	–20	20	
	Total for all inputs, I _{IKTOTAL} (V _{IN} < VSS/VSSA or V _{IN} > VDDIO/VDDA)	–20	20	
Output current	Digital output (per pin), I _{OUT}	–20	20	mA
Free-Air temperature	T _A	–40	125	°C
Operating junction temperature	T _J	–40	150	°C
Storage temperature ⁽³⁾	T _{stg}	–65	150	°C

- (1) Stresses beyond those listed under *Absolute Maximum Ratings* may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under [Section 5.4](#) is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
- (2) All voltage values are with respect to VSS, unless otherwise noted.
- (3) Long-term high-temperature storage or extended use at maximum temperature conditions may result in a reduction of overall device life. For additional information, see the *IC Package Thermal Metrics Application Report* ([SPRA953](#)).

5.2 ESD Ratings – Commercial

			VALUE	UNIT
F28004x in 64-pin PM package (Commercial)				
V _(ESD)	Electrostatic discharge (ESD)	Human-body model (HBM), per ANSI/ESDA/JEDEC JS-001 ⁽¹⁾	±2000	V
		Charged-device model (CDM), per JEDEC specification JESD22-C101 ⁽²⁾	±500	
F28004x in 56-pin RSH package				
V _(ESD)	Electrostatic discharge (ESD)	Human-body model (HBM), per ANSI/ESDA/JEDEC JS-001 ⁽¹⁾	±2000	V
		Charged-device model (CDM), per JEDEC specification JESD22-C101 ⁽²⁾	±500	

(1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.

(2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.

5.3 ESD Ratings – Automotive

			VALUE	UNIT	
F28004x in 100-pin PZ package					
V _(ESD)	Electrostatic discharge	Human body model (HBM), per AEC Q100-002 ⁽¹⁾	All pins	±2000	V
		Charged device model (CDM), per AEC Q100-011	All pins	±500	
			Corner pins on 100-pin PZ: 1, 25, 26, 50, 51, 75, 76, 100	±750	
F28004x in 64-pin PM package (Automotive)					
V _(ESD)	Electrostatic discharge	Human body model (HBM), per AEC Q100-002 ⁽¹⁾	All pins	±2000	V
		Charged device model (CDM), per AEC Q100-011	All pins	±500	
			Corner pins on 64-pin PM: 1, 16, 17, 32, 33, 48, 49, 64	±750	

(1) AEC Q100-002 indicates HBM stressing is done in accordance with the ANSI/ESDA/JEDEC JS-001 specification.

5.4 Recommended Operating Conditions

		MIN	NOM	MAX	UNIT
Device supply voltage, VDDIO		3.0	3.3	3.63	V
Analog supply voltage, VDDA		2.97	3.3	3.63	V
Device supply voltage, VDD		1.14	1.2	1.32	V
Device ground, VSS			0		V
Analog ground, VSSA			0		V
Junction temperature, T _J	S version ⁽¹⁾	–40		125	°C
Free-Air temperature, T _A	Q version ⁽¹⁾ (AEC Q100 qualification)	–40		125	°C

(1) Operation above T_J = 105°C for extended duration will reduce the lifetime of the device. See [Calculating Useful Lifetimes of Embedded Processors](#) for more information.

5.5 Power Consumption Summary

Current values listed in this section are representative for the test conditions given and not the absolute maximum possible. The actual device currents in an application will vary with application code and pin configurations. [Table 5-1](#) lists the system current consumption values for an external supply. [Table 5-2](#) lists the system current consumption values for the internal VREG. [Table 5-3](#) lists the system current consumption values for the DCDC. See [Section 5.5.1](#) for a detailed description of the test case run while measuring the current consumption in operating mode.

Table 5-1. System Current Consumption (External Supply)

over operating free-air temperature range (unless otherwise noted).

TYP : V_{nom} , 30°C

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
OPERATING MODE						
I _{DD}	VDD current consumption during operational usage	See Section 5.5.1 .	61	90		mA
I _{DDIO}	VDDIO current consumption during operational usage		26	45		mA
I _{DDA}	VDDA current consumption during operational usage		12	30		mA
IDLE MODE						
I _{DD}	VDD current consumption while device is in Idle mode	- CPU is in IDLE mode - Flash is powered down - XCLKOUT is turned off	18	40		mA
I _{DDIO}	VDDIO current consumption while device is in Idle mode		1.2	4		mA
I _{DDA}	VDDA current consumption while device is in Idle mode		0.9	1.2		mA
STANDBY MODE						
I _{DD}	VDD current consumption while device is in Standby mode	- CPU is in STANDBY mode - Flash is powered down - XCLKOUT is turned off	8	29		mA
I _{DDIO}	VDDIO current consumption while device is in Standby mode		1.2	4		mA
I _{DDA}	VDDA current consumption while device is in Standby mode		0.2	0.5		mA
HALT MODE						
I _{DD}	VDD current consumption while device is in Halt mode	- CPU is in HALT mode - Flash is powered down - XCLKOUT is turned off	0.9	20		mA
I _{DDIO}	VDDIO current consumption while device is in Halt mode		0.8	4		mA
I _{DDA}	VDDA current consumption while device is in Halt mode		0.2	0.5		mA
FLASH ERASE/PROGRAM ⁽¹⁾						
I _{DD}	VDD Current consumption during Erase/Program cycle	- CPU is running from Flash, performing Erase and Program on the unused sector. - VREG is disabled. - SYSCLK is running at 100 MHz. - I/Os are inputs with pullups enabled. - Peripheral clocks are turned OFF.	40	70		mA
I _{DDIO}	VDDIO Current consumption during Erase/Program cycle		33	75		mA
I _{DDA}	VDDA Current consumption during Erase/Program cycle		0.1	2.5		mA

(1) Brown-out events during flash programming can corrupt flash data and permanently lock the device. Programming environments using alternate power sources (such as a USB programmer) must be capable of supplying the rated current for the device and other system components with sufficient margin to avoid supply brown-out conditions.

Table 5-2. System Current Consumption (Internal VREG)

over operating free-air temperature range (unless otherwise noted).

TYP : V_{nom} , 30°C

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
OPERATING MODE						
I _{DDIO}	VDDIO current consumption during operational usage	See Section 5.5.1 .	86	113	mA	
I _{DDA}	VDDA current consumption during operational usage		12	30	mA	
IDLE MODE						
I _{DDIO}	VDDIO current consumption while device is in Idle mode	- CPU is in IDLE mode - Flash is powered down - XCLKOUT is turned off	19.2	36	mA	
I _{DDA}	VDDA current consumption while device is in Idle mode		0.9	1.2	mA	
STANDBY MODE						
I _{DDIO}	VDDIO current consumption while device is in Standby mode	- CPU is in STANDBY mode - Flash is powered down - XCLKOUT is turned off	9.2	26	mA	
I _{DDA}	VDDA current consumption while device is in Standby mode		0.2	0.5	mA	
HALT MODE						
I _{DDIO}	VDDIO current consumption while device is in Halt mode	- CPU is in HALT mode - Flash is powered down - XCLKOUT is turned off	1.7	18	mA	
I _{DDA}	VDDA current consumption while device is in Halt mode		0.2	0.5	mA	
FLASH ERASE/PROGRAM ⁽¹⁾						
I _{DDIO}	VDDIO current consumption during Erase/Program cycle	- CPU is running from Flash, performing Erase and Program on the unused sector. - Internal VREG is enabled. - SYSCCLK is running at 100 MHz. - I/Os are inputs with pullups enabled. - Peripheral clocks are turned OFF.	72	106	mA	
I _{DDA}	VDDA current consumption during Erase/Program cycle		0.1	2.5	mA	

(1) Brown-out events during flash programming can corrupt flash data and permanently lock the device. Programming environments using alternate power sources (such as a USB programmer) must be capable of supplying the rated current for the device and other system components with sufficient margin to avoid supply brown-out conditions.

Table 5-3. System Current Consumption (DCDC)

over operating free-air temperature range (unless otherwise noted).

TYP : V_{nom} , 30°C

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
OPERATING MODE						
I _{DDIO}	VDDIO current consumption during operational usage	See Section 5.5.1 .	52	70		mA
I _{DDA}	VDDA current consumption during operational usage		12	25		mA
IDLE MODE						
I _{DDIO}	VDDIO current consumption while device is in Idle mode	• CPU is in IDLE mode • Flash is powered down • XCLKOUT is turned off	9.2	28		mA
I _{DDA}	VDDA current consumption while device is in Idle mode		0.9	1.5		mA
STANDBY MODE						
I _{DDIO}	VDDIO current consumption while device is in Standby mode	• CPU is in STANDBY mode • Flash is powered down • XCLKOUT is turned off	5.2	21		mA
I _{DDA}	VDDA current consumption while device is in Standby mode		0.2	1.5		mA
HALT MODE						
I _{DDIO}	VDDIO current consumption while device is in Halt mode	• CPU is in HALT mode • Flash is powered down • XCLKOUT is turned off	1.7	17		mA
I _{DDA}	VDDA current consumption while device is in Halt mode		0.2	1.5		mA
FLASH ERASE/PROGRAM ⁽¹⁾						
I _{DDIO}	VDDIO current consumption during Erase/Program cycle	• CPU is running from Flash, performing Erase and Program on the unused sector. • DCDC is enabled. • SYSCLK is running at 100 MHz. • I/Os are inputs with pullups enabled. • Peripheral clocks are turned OFF.	60	85		mA
I _{DDA}	VDDA current consumption during Erase/Program cycle		0.25	2.5		mA

(1) Brown-out events during flash programming can corrupt flash data and permanently lock the device. Programming environments using alternate power sources (such as a USB programmer) must be capable of supplying the rated current for the device and other system components with sufficient margin to avoid supply brown-out conditions.

5.5.1 Operating Mode Test Description

Table 5-1, Table 5-2, and Table 5-3 list the current consumption values for the operational mode of the device. The operational mode provides an estimation of what an application might encounter. The test case run to achieve the values shown does the following in a loop. Peripherals that are not on the following list have had their clocks disabled.

- Code is executing from RAM.
- FLASH is read and kept in active state.
- No external components are driven by I/O pins.
- All of the communication peripherals are exercised: SPI-A to SPI-C; SCI-A to SCI-C; I2C-A; CAN-A to CAN-C; LIN-A; PMBUS-A; and FSI-A.
- ePWM-1 to ePWM-3 generate a 5-MHz output on 6 pins.
- ePWM-4 to ePWM-7 are in HRPWM mode and generating 25 MHz on 6 pins.
- CPU timers are active.
- CPU does FIR16 calculations.
- DMA does continuous 32-bit transfers.
- CLA-1 is executing a 1024-point DFT in a background task.
- All ADCs perform continuous conversions.
- All DACs vary voltage at the loop frequency ~11 kHz.
- All PGAs are enabled.
- All CMPSSs generate a square wave with a 100-kHz frequency.
- SDFM peripheral clock is enabled.
- eCAP-1 to eCAP-7 are in APWM mode, toggling at 250 kHz.
- All eQEP watchdogs are enabled and counting.
- System watchdog is enabled and counting.

5.5.2 Current Consumption Graphs

Figure 5-1, Figure 5-2, and Figure 5-3 show a typical representation of the relationship between frequency and current consumption on the device. The operational test from Table 5-1 was run across frequency at V_{NOM} and room temperature. Actual results will vary based on the system implementation and conditions.

Leakage current on the VDD core supply will increase with operating temperature in an exponential manner as seen in Figure 5-4. The current consumption in HALT mode is primarily leakage current as there is no active switching if the internal oscillator has been powered down.

Figure 5-4 shows the typical leakage current across temperature. The device was placed into HALT mode under nominal voltage conditions.

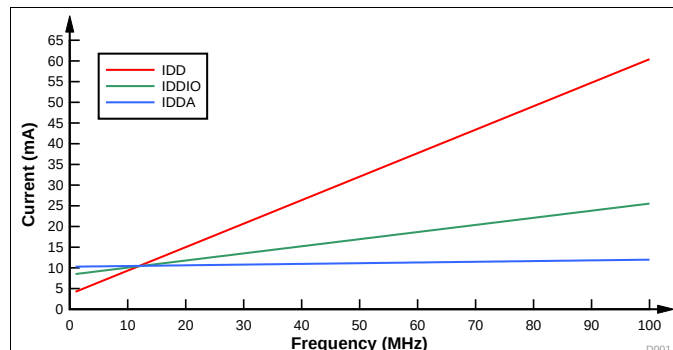


Figure 5-1. Current Versus Frequency — External Supply

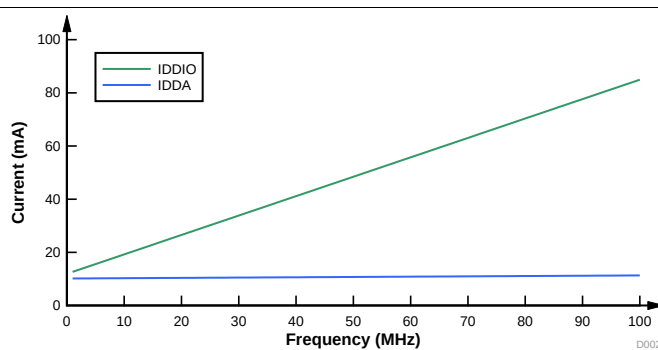


Figure 5-2. Current Versus Frequency — Internal VREG

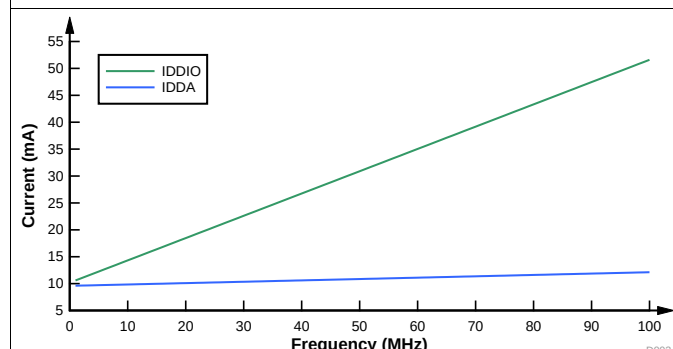


Figure 5-3. Current Versus Frequency — DCDC

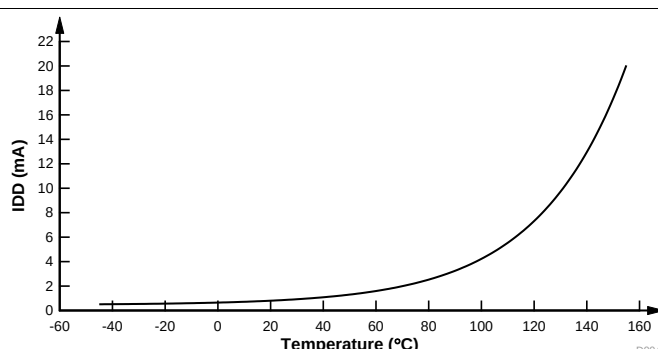


Figure 5-4. Halt Current Versus Temperature (°C)

5.5.3 Reducing Current Consumption

All C2000™ microcontrollers provide some methods to reduce the device current consumption:

- Any one of the three low-power modes—IDLE, STANDBY, and HALT—could be entered to reduce the current consumption even further during idle periods in the application.
- The flash module may be powered down if the code is run from RAM.
- Disable the pullups on pins that assume an output function.
- Each peripheral has an individual clock-enable bit (PCLKCRx). Reduced current consumption may be achieved by turning off the clock to any peripheral that is not used in a given application. [Table 5-4](#) lists the typical current consumption value per peripheral at 100-MHz SYSCLK.

Table 5-4. Typical I_{DD} Current Reduction per Disabled Peripheral (at 100-MHz SYSCLK)⁽¹⁾

PERIPHERAL	I_{DD} CURRENT REDUCTION (mA)
ADC ⁽²⁾	0.8
CAN	1.1
CLA	0.4
CLB	1.1
CMPSS ⁽²⁾	0.4
CPU TIMER	0.1
DAC ⁽²⁾	0.2
DMA	0.5
eCAP1 to eCAP5	0.1
eCAP6 to eCAP7 ⁽³⁾	0.4
ePWM	0.7
eQEP	0.1
FSI	0.7
HRPWM	0.8
I2C	0.3
LIN	0.4
PGA ⁽²⁾	0.2
PMBUS	0.3
SCI	0.2
SDFM	0.9
SPI	0.2
DCC	0.1
PLL at 100 MHz	22.9

- (1) All peripherals are disabled upon reset. Use the PCLKCRx register to individually enable peripherals. For peripherals with multiple instances, the current quoted is for a single module.
- (2) This current represents the current drawn by the digital portion of the each module.
- (3) eCAP6 and eCAP7 can also be configured as HRCAP.

5.6 Electrical Characteristics

over recommended operating conditions (unless otherwise noted)

PARAMETER			TEST CONDITIONS	MIN	TYP	MAX	UNIT
V _{OH}	High-level output voltage		I _{OH} = I _{OH} MIN	VDDIO * 0.8			V
			I _{OH} = -100 μ A	VDDIO - 0.2			
V _{OL}	Low-level output voltage		I _{OL} = I _{OL} MIN			0.4	V
			I _{OL} = 100 μ A			0.2	
I _{OH}	High-level output source current for all output pins			-4			mA
I _{OL}	Low-level output sink current for all output pins					4	mA
V _{IH}	High-level input voltage (3.3V)			2.0	VDDIO + 0.3		V
V _{IL}	Low-level input voltage (3.3V)			VSS - 0.3		0.8	V
V _{HYSTERESIS}	Input hysteresis				150		mV
I _{PULLDOWN}	Input current	Inputs with pulldown ⁽¹⁾	VDDIO = 3.3 V V _{IN} = VDDIO		100		μ A
I _{PULLUP}	Input current	Digital inputs with pullup enabled ⁽¹⁾	VDDIO = 3.3 V V _{IN} = 0 V		160		μ A
		Analog inputs with pullup enabled ⁽¹⁾	VDDA = 3.3 V V _{IN} = 0 V		160		μ A
I _{LEAK}	Pin leakage	All GPIOs except GPIO23_VSW	Pullups and outputs disabled 0 V $\leq$ V _{IN} $\leq$ VDDIO			2	μ A
		GPIO23_VSW				45	
		Analog Pins (except ADCINB3/VDAC)	Analog drivers disabled 0 V $\leq$ V _{IN} $\leq$ VDDA			2	
		ADCINB3/VDAC			2	11	
C _I	Input capacitance	All digital GPIOs except GPIO23_VSW			2		pF
		GPIO23_VSW			100		
		Analog pins ⁽²⁾					
V _{VREG}	Internal voltage regulator output		Internal VREG On		1.2		V
V _{DC-DC}	Internal switching regulator output		Internal DC-DC On		1.2		V

(1) See [Table 4-9](#) for a list of pins with a pullup or pulldown.

(2) The analog pins are specified separately; see [Table 5-50](#).

5.7 Thermal Resistance Characteristics

5.7.1 PZ Package

		°C/W ⁽¹⁾	AIR FLOW (lfm) ⁽²⁾
R _{θJC}	Junction-to-case thermal resistance	7.6	N/A
R _{θJB}	Junction-to-board thermal resistance	24.2	N/A
R _{θJA} (High k PCB)	Junction-to-free air thermal resistance	46.1	0
R _{θJMA}	Junction-to-moving air thermal resistance	37.3	150
		34.8	250
		32.6	500
Psi _{JT}	Junction-to-package top	0.2	0
		0.4	150
		0.4	250
		0.6	500
Psi _{JB}	Junction-to-board	23.8	0
		22.8	150
		22.4	250
		21.9	500

- (1) These values are based on a JEDEC-defined 2S2P system (with the exception of the Theta JC [R_{θJC}] value, which is based on a JEDEC-defined 1S0P system) and will change based on environment as well as application. For more information, see these EIA/JEDEC standards:

- JESD51-2, *Integrated Circuits Thermal Test Method Environmental Conditions - Natural Convection (Still Air)*
- JESD51-3, *Low Effective Thermal Conductivity Test Board for Leaded Surface Mount Packages*
- JESD51-7, *High Effective Thermal Conductivity Test Board for Leaded Surface Mount Packages*
- JESD51-9, *Test Boards for Area Array Surface Mount Package Thermal Measurements*

- (2) lfm = linear feet per minute

5.7.2 PM Package

		°C/W ⁽¹⁾	AIR FLOW (lfm) ⁽²⁾
R _{θJC}	Junction-to-case thermal resistance	12.4	N/A
R _{θJB}	Junction-to-board thermal resistance	25.6	N/A
R _{θJA} (High k PCB)	Junction-to-free air thermal resistance	51.8	0
R _{θJMA}	Junction-to-moving air thermal resistance	42.2	150
		39.4	250
		36.5	500
Psi _{JT}	Junction-to-package top	0.5	0
		0.9	150
		1.1	250
		1.4	500
Psi _{JB}	Junction-to-board	25.1	0
		23.8	150
		23.4	250
		22.7	500

- (1) These values are based on a JEDEC-defined 2S2P system (with the exception of the Theta JC [R_{θJC}] value, which is based on a JEDEC-defined 1S0P system) and will change based on environment as well as application. For more information, see these EIA/JEDEC standards:

- JESD51-2, *Integrated Circuits Thermal Test Method Environmental Conditions - Natural Convection (Still Air)*
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- JESD51-7, *High Effective Thermal Conductivity Test Board for Leaded Surface Mount Packages*
- JESD51-9, *Test Boards for Area Array Surface Mount Package Thermal Measurements*

- (2) lfm = linear feet per minute

5.7.3 RSH Package

		°C/W ⁽¹⁾	AIR FLOW (lfm) ⁽²⁾
R θ_{JC}	Junction-to-case thermal resistance	11.9	N/A
R θ_{JB}	Junction-to-board thermal resistance	3.3	N/A
R θ_{JA} (High k PCB)	Junction-to-free air thermal resistance	25.8	0
R θ_{JMA}	Junction-to-moving air thermal resistance	17.4	150
		15.1	250
		13.4	500
Psi $_{JT}$	Junction-to-package top	0.2	0
		0.3	150
		0.4	250
		0.4	500
Psi $_{JB}$	Junction-to-board	3.3	0
		3.2	150
		3.2	250
		3.2	500
R $\theta_{JC, bottom}$	Junction-to-bottom case thermal resistance	0.7	0

(1) These values are based on a JEDEC-defined 2S2P system (with the exception of the Theta JC [R θ_{JC}] value, which is based on a JEDEC-defined 1S0P system) and will change based on environment as well as application. For more information, see these EIA/JEDEC standards:

- JESD51-2, *Integrated Circuits Thermal Test Method Environmental Conditions - Natural Convection (Still Air)*
- JESD51-3, *Low Effective Thermal Conductivity Test Board for Leaded Surface Mount Packages*
- JESD51-7, *High Effective Thermal Conductivity Test Board for Leaded Surface Mount Packages*
- JESD51-9, *Test Boards for Area Array Surface Mount Package Thermal Measurements*

(2) lfm = linear feet per minute

5.8 System

5.8.1 Power Management

TMS320F28004x MCUs can be configured to operate with one of three options to supply the required 1.2 V to the core (VDD):

- An external supply (not available for 56-pin RSH package configurations)
- Internal 1.2-V LDO Voltage Regulator (VREG)
- Internal 1.2-V Switching Regulator (DC-DC)

The system requirements will dictate which supply option best suits the application.

NOTE

The same system voltage regulator must be used to drive both VDDIO and VDDIO_SW.

5.8.1.1 Internal 1.2-V LDO Voltage Regulator (VREG)

The internal VREG is supplied by VDDIO and generates the 1.2 V required to power the VDD pins. Enable this functionality by pulling the VREGENZ pin low to VSS. The smaller pin-count packages may not include the VREGENZ pin; therefore, the internal VREG is always enabled and, as such, is the required supply source for the VDD pins. Review the description of VREGENZ in [Table 4-5](#) to determine package configuration. Although the internal VREG eliminates the need to use an external power supply for VDD, decoupling capacitors are required on each VDD pin for VREG stability. There are two recommended capacitor configurations (described in the list that follows) for the VDD rail when using the internal VREG. The signal description for VDD can be found in [Table 4-4](#).

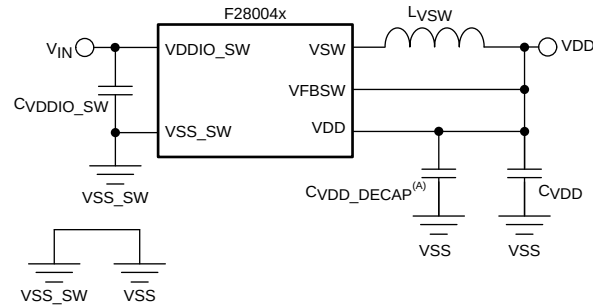
- Configuration 1: Place a small decoupling capacitor to VSS on each pin as close to the device as possible. In addition, a bulk capacitance must be placed on the VDD node to VSS (one 20-μF capacitor or two parallel 10-μF capacitors).
- Configuration 2: Distribute the total capacitance to VSS evenly across all VDD pins (total capacitance divided by four VDD pins).

5.8.1.2 Internal 1.2-V Switching Regulator (DC-DC)

The internal DC-DC regulator offers increased efficiency over the LDO for converting 3.3 V to 1.2 V. The internal DC-DC regulator is supplied by the VDDIO_SW pin and generates the 1.2 V required to power the VDD pins. To use the internal switching regulator, the core domain must power up initially using the internal LDO VREG supply (tie the VREGENZ pin low to VSS) and then transition to the DC-DC regulator through application software by setting the DCDCEN bit in the DCDCCTL register. The DC-DC regulator also requires external components (inductor, input capacitance, and output capacitance). The output of internal DC-DC regulator is not internally fed to the VDD rail and requires an external connection. [Table 5-5](#) lists the internal switching regulator characteristics. [Figure 5-5](#) shows the schematic implementation.

Table 5-5. Internal Switching Regulator Characteristics

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Power efficiency			80%		



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A. One decoupling capacitor per each of the four VDD pins

Figure 5-5. DC-DC Circuit Schematic

The VDDIO_SW supply pin (V_{IN}) requires a 3.3-V level voltage. A total input capacitance (C_{VDDIO_SW}) of 20 μ F is required on VDDIO_SW. Due to the capacitor specification requirements detailed in Table 5-7, two parallel 10- μ F capacitors in parallel is the recommended configuration. Decoupling capacitors of 100 nF should also be placed on each VDD pin as close to the device as possible.

Table 5-6. DC-DC Inductor (L_{VSW}) Specifications Requirements

VALUE AND VARIATION	VALUE AT SATURATION	DCR	RATED CURRENT	SATURATION CURRENT	TEMPERATURE
2.2 μ H $\pm$ 20%	1.54 μ H $\pm$ 20%	80 m Ω $\pm$ 25%	>1000 mA	>600 mA	–40°C to 125°C

Table 5-7. DC-DC Capacitor (C_{VDDIO_SW} and C_{VDD}) Specifications Requirements

VALUE AND VARIATION AT 0 V	VALUE AT 1.2 V	VALUE AT 125°C	ESR	RATED VOLTAGE	TEMPERATURE
10 μ F $\pm$ 20%	10 μ F $\pm$ 20%	8 μ F $\pm$ 20%	<10 m Ω	4 V or 6.3 V	–40°C to 125°C

Table 5-8. DC-DC Circuit Component Values

COMPONENT	MIN	NOM	MAX	UNIT	NOTES
Inductor	1.76	2.2	2.64	μ H	20% variance
Input capacitor	8	10	12	μ F	20% variance, two such capacitors in parallel
Output capacitor	8	10	12	μ F	20% variance, two such capacitors in parallel

5.8.1.2.1 PCB Layout and Component Guidelines

For optimal performance the application board layout and component selection is important. The list that follows is a high-level guideline for laying out the DC-DC circuit.

- TI recommends star-connecting VDDIO_SW and VDDIO to the same 3.3-V supply.
- All external components should be placed as close to the pins as possible.
- The loop formed by the VDDIO_SW, input capacitor (C_{VDDIO_SW}), and VSS_SW must be as short as possible.
- The feedback trace must be as short as possible and kept away from any noise source such as the switching output (VSW).
- It is necessary to have a separate island or surgical cut in the ground plane for the input cap (C_{VDDIO_SW}) and VSS_SW.
- A VDD plane is recommended for connecting the VDD node to the L_{VSW} - C_{VDD} point to minimize parasitic resistance and inductance.

Table 5-9. Recommended External Components

			MIN	TYP	MAX	UNIT
C _{VDDIO}	Bulk capacitance on VDDIO	Based on External Supply IC Requirements ⁽¹⁾		0.1		μF
C _{VDDIO_DECAP}	Decoupling capacitor on each VDDIO pin			0.1		μF
C _{VDDA}	Capacitor on VDDA pins			2.2		μF
C _{VDDIO_SW}	Capacitor on VDDIO_SW pin	For DC-DC operation ⁽²⁾		20		μF
		For LDO-only operation		0.1		
C _{VDD}	Bulk capacitance on VDD	For DC-DC operation ⁽²⁾		20		μF
		For LDO-only operation ⁽³⁾	12	20	27	
C _{VDD_DECAP}	Decoupling capacitor on each VDD pin	For DC-DC operation ⁽²⁾		0.1		μF
		For LDO-only operation ⁽³⁾	0.1		6.75	
L _{VSW}	Inductor between VSW pin and VDD node for DC-DC			2.2		μH
R _{LVSU-DCR}	Allowed DCR for L _{VSW}			80		mΩ
I _{SAT-LVSW}	L _{VSW} saturation current		600			mA

(1) Bulk capacitance on this supply should be based on supply IC requirements.

(2) See [Section 5.8.1.2](#) for details.

(3) See [Section 5.8.1.1](#) for details.

5.8.1.3 Power Sequencing

An external power supply must be used to supply 3.3 V to VDDIO, VDDIO_SW, and VDDA. TI recommends powering up VDDIO, VDDIO_SW, and VDDA together and keeping them within 0.3 V of each other during operation. Before powering the device, no voltage larger than 0.3 V above VDDIO can be applied to any digital pin, and no voltage larger than 0.3 V above VDDA can be applied to any analog pin. The VREFHI voltage should not exceed VDDA at any time.

An external supply can be used to supply 1.2 V to the VDD pins when VREGENZ is pulled high to VDDIO. When using an external source to supply VDD, the voltage on VDDIO must be greater than VDD or no less than 0.3 V below VDD at all times. When using the internal VREG, the power sequence is handled internally. [Table 5-10](#) lists the supply ramp rate.

Table 5-10. Supply Ramp Rate

		MIN	MAX	UNIT
Supply ramp rate	VDDIO, VDD, VDDA with respect to VSS.	330	10 ⁵	V/s

5.8.1.4 Power-On-Reset (POR)

An internal power-on-reset (POR) circuit holds the device in reset and keeps the I/Os in a high-impedance state during power up. The POR is in control and forces XRSn low internally until the voltage on VDDIO crosses the POR threshold.

5.8.2 Reset Timing

XRSn is the device reset pin. It functions as an input and open-drain output. The device has a built-in power-on reset (POR). During power up, the POR circuit drives the XRSn pin low. A watchdog or NMI watchdog reset will also drive the pin low. An external circuit may drive the pin to assert a device reset.

A resistor with a value from 2.2 kΩ to 10 kΩ should be placed between XRSn and VDDIO. A capacitor should be placed between XRSn and VSS for noise filtering, it should be 100 nF or smaller. These values will allow the watchdog to properly drive the XRSn pin to V_{OL} within 512 OSCCLK cycles when the watchdog reset is asserted. Figure 5-6 shows the recommended reset circuit.

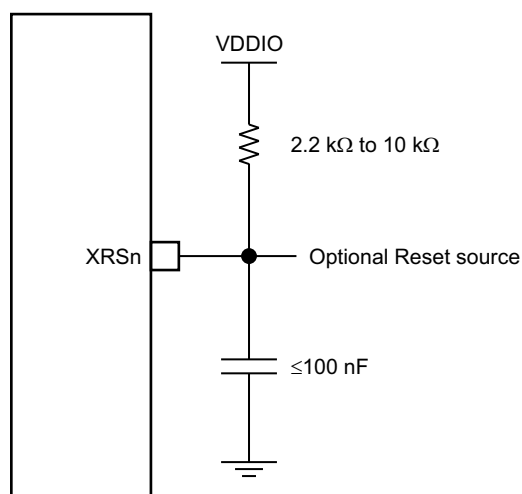


Figure 5-6. Reset Circuit

5.8.2.1 Reset Sources

Table 5-11 summarizes the various reset signals and their effect on the device.

Table 5-11. Reset Signals

RESET SOURCE	CPU CORE RESET (C28x, FPU, VCU)	PERIPHERALS RESET	JTAG/ DEBUG LOGIC RESET	I/Os	XRSn OUTPUT
POR	Yes	Yes	Yes	Hi-Z	Yes
XRSn Pin	Yes	Yes	Yes	Hi-Z	–
WDRS	Yes	Yes	Yes	Hi-Z	Yes
NMIWDRS	Yes	Yes	Yes	Hi-Z	Yes
SYSRS (Debugger Reset)	Yes	Yes	No	Hi-Z	No
SCCRESET	Yes	Yes	Yes	Hi-Z	No

The parameter $t_{h(\text{boot-mode})}$ must account for a reset initiated from any of these sources.

See the Resets section of the System Control chapter in the [TMS320F28004x Piccolo Microcontrollers Technical Reference Manual](#).

CAUTION

Some reset sources are internally driven by the device. Some of these sources will drive XRSn low, use this to disable any other devices driving the boot pins. The SCCRESET and debugger reset sources do not drive XRSn; therefore, the pins used for boot mode should not be actively driven by other devices in the system. The boot configuration has a provision for changing the boot pins in OTP; for more details, see the [TMS320F28004x Piccolo Microcontrollers Technical Reference Manual](#).

5.8.2.2 Reset Electrical Data and Timing

Table 5-12 lists the reset (XRSn) timing requirements. Table 5-13 lists the reset (XRSn) switching characteristics. Figure 5-7 shows the power-on reset. Figure 5-8 shows the warm reset.

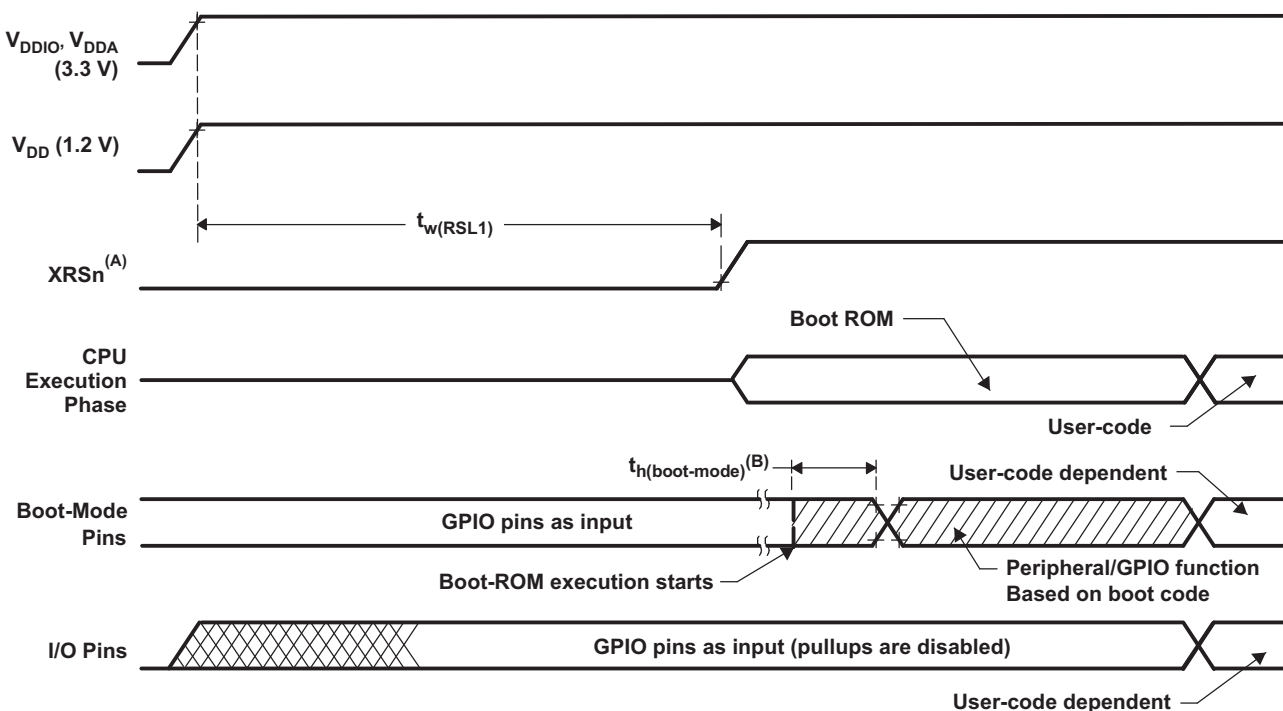
Table 5-12. Reset (XRSn) Timing Requirements

		MIN	MAX	UNIT
$t_{h(\text{boot-mode})}$	Hold time for boot-mode pins	1.5		ms
$t_{w(\text{RSL2})}$	Pulse duration, XRSn low on warm reset	3.2		μs

Table 5-13. Reset (XRSn) Switching Characteristics

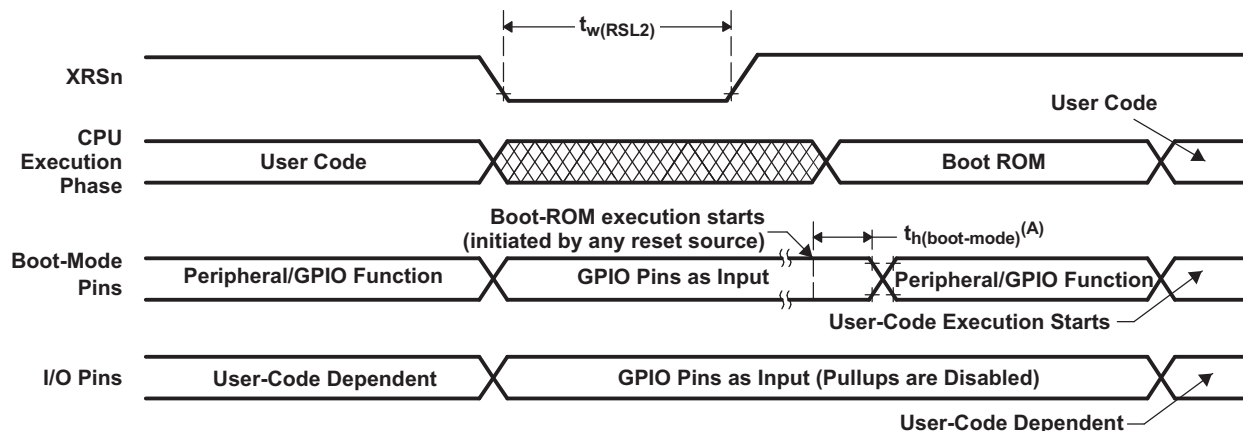
over recommended operating conditions (unless otherwise noted)

PARAMETER		MIN	TYP	MAX	UNIT
$t_{w(\text{RSL1})}$	Pulse duration, XRSn driven low by device after supplies are stable		100		μs
$t_{w(\text{WDRS})}$	Pulse duration, reset pulse generated by watchdog		$512t_{c(\text{OSCCLK})}$		cycles



- The XRSn pin can be driven externally by a supervisor or an external pullup resistor, see Table 4-1. On-chip POR logic will hold this pin low until the supplies are in a valid range.
- After reset from any source (see Section 5.8.2.1), the boot ROM code samples Boot Mode pins. Based on the status of the Boot Mode pin, the boot code branches to destination memory or boot code function. If boot ROM code executes after power-on conditions (in debugger environment), the boot code execution time is based on the current SYSCLK speed. The SYSCLK will be based on user environment and could be with or without PLL enabled.

Figure 5-7. Power-on Reset



- A. After reset from any source (see [Section 5.8.2.1](#)), the Boot ROM code samples BOOT Mode pins. Based on the status of the Boot Mode pin, the boot code branches to destination memory or boot code function. If Boot ROM code executes after power-on conditions (in debugger environment), the Boot code execution time is based on the current SYSCLK speed. The SYSCLK will be based on user environment and could be with or without PLL enabled.

Figure 5-8. Warm Reset

5.8.3 Clock Specifications

5.8.3.1 Clock Sources

[Table 5-14](#) lists three possible clock sources. [Figure 5-9](#) shows the clocking system. [Figure 5-10](#) shows the system PLL.

Table 5-14. Possible Reference Clock Sources

CLOCK SOURCE	MODULES CLOCKED	COMMENTS
INTOSC1	Can be used to provide clock for: - Watchdog block - Main PLL - CPU-Timer 2	Internal oscillator 1. Zero-pin overhead 10-MHz internal oscillator.
INTOSC2 ⁽¹⁾	Can be used to provide clock for: - Main PLL - CPU-Timer 2	Internal oscillator 2. Zero-pin overhead 10-MHz internal oscillator.
X1 (XTAL)	Can be used to provide clock for: - Main PLL - CPU-Timer 2	External crystal or resonator connected between the X1 and X2 pins or single-ended clock connected to the X1 pin.

(1) On reset, internal oscillator 2 (INTOSC2) is the default clock source for the system PLL (OSCCLK).

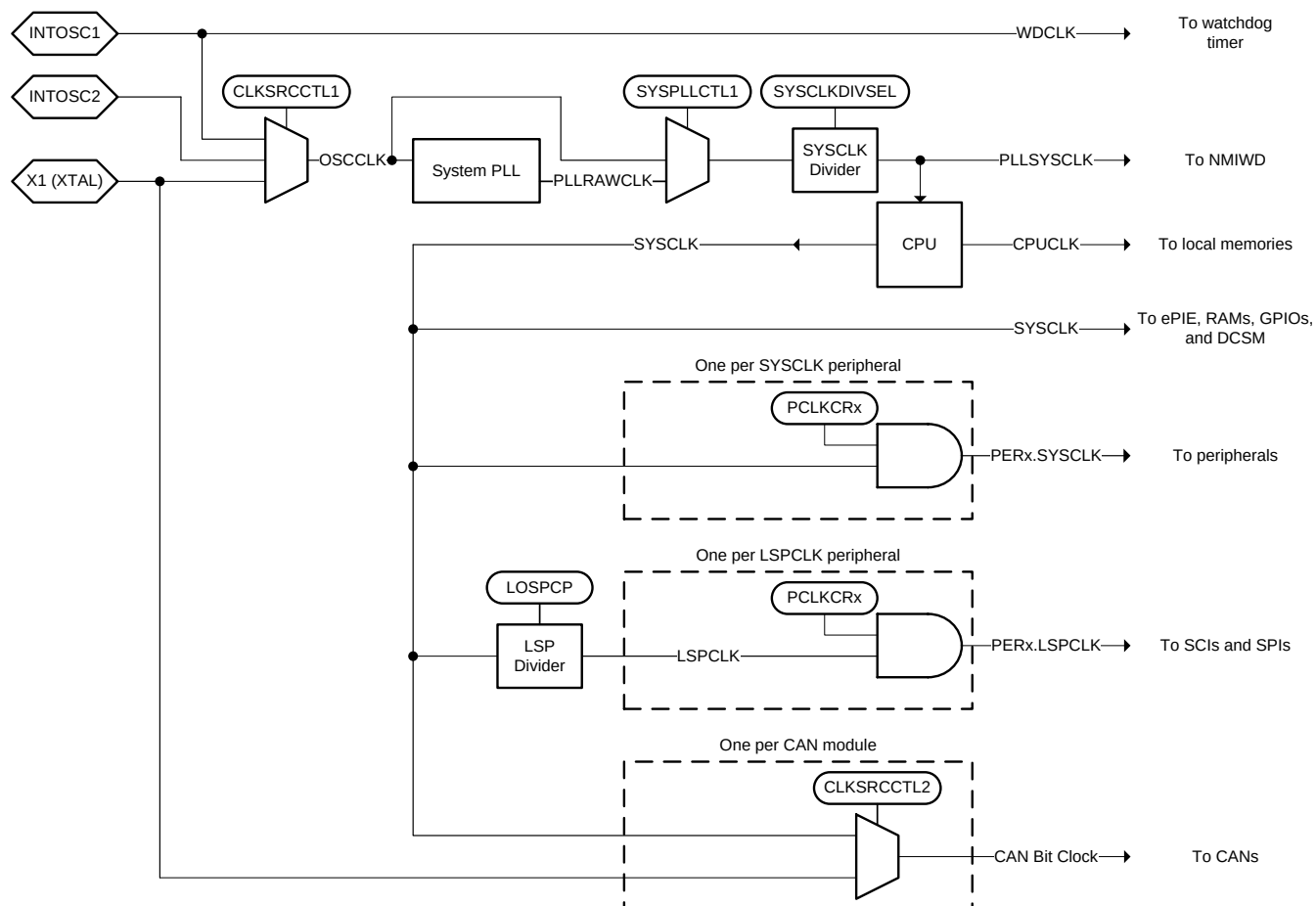


Figure 5-9. Clocking System

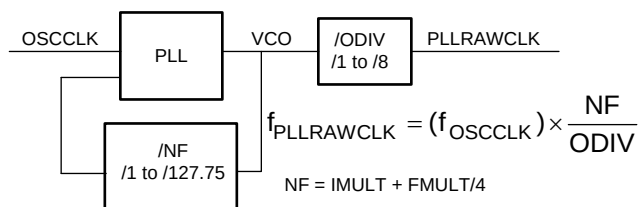


Figure 5-10. System PLL

5.8.3.2 Clock Frequencies, Requirements, and Characteristics

This section provides the frequencies and timing requirements of the input clocks, PLL lock times, frequencies of the internal clocks, and the frequency and switching characteristics of the output clock.

5.8.3.2.1 Input Clock Frequency and Timing Requirements, PLL Lock Times

Table 5-15 lists the frequency requirements for the input clocks. Table 5-16 lists the X1 input level characteristics when using an external clock source. Table 5-17 lists the XTAL oscillator characteristics. Table 5-18 lists the X1 timing requirements. Table 5-19 lists the PLL lock times for the Main PLL.

Table 5-15. Input Clock Frequency

		MIN	MAX	UNIT
$f_{(XTAL)}$	Frequency, X1/X2, from external crystal or resonator	10	20	MHz
$f_{(X1)}$	Frequency, X1, from external oscillator (PLL enabled)	2	20	MHz
	Frequency, X1, from external oscillator (PLL disabled)	2	100	

Table 5-16. X1 Input Level Characteristics When Using an External Clock Source (Not a Crystal)

over recommended operating conditions (unless otherwise noted)

PARAMETER		MIN	MAX	UNIT
X1 V_{IL}	Valid low-level input voltage	−0.3	$0.3 * V_{DDIO}$	V
X1 V_{IH}	Valid high-level input voltage	$0.7 * V_{DDIO}$	$V_{DDIO} + 0.3$	V

Table 5-17. XTAL Oscillator Characteristics

over recommended operating conditions (unless otherwise noted)

PARAMETER		MIN	TYP	MAX	UNIT
X1 V_{IL}	Valid low-level input voltage	−0.3		$0.3 * V_{DDIO}$	V
X1 V_{IH}	Valid high-level input voltage	$0.7 * V_{DDIO}$		$V_{DDIO} + 0.3$	V

Table 5-18. X1 Timing Requirements

		MIN	MAX	UNIT
$t_{f(X1)}$	Fall time, X1		6	ns
$t_{r(X1)}$	Rise time, X1		6	ns
$t_{w(X1L)}$	Pulse duration, X1 low as a percentage of $t_{c(X1)}$	45%	55%	
$t_{w(X1H)}$	Pulse duration, X1 high as a percentage of $t_{c(X1)}$	45%	55%	

Table 5-19. PLL Lock Times

		MIN	NOM	MAX	UNIT
$t_{(PLL)}$	Lock time, Main PLL		$25.5 \mu s + 1024 * t_{c(OSCCLK)}$		μs

5.8.3.2.2 Internal Clock Frequencies

Table 5-20 provides the clock frequencies for the internal clocks.

Table 5-20. Internal Clock Frequencies

		MIN	NOM	MAX	UNIT
f_{SYSCLK}	Frequency, device (system) clock	2		100	MHz
$t_{\text{c(SYSCLK)}}$	Period, device (system) clock	10		500	ns
f_{VCO}	Frequency, PLL VCO (before output divider)	120		400	MHz
$f_{\text{PLLRAWCLK}}$	Frequency, system PLL output (before SYSCLK divider)	15		200	MHz
f_{PLL}	Frequency, PLLSYSCLK	2		100	MHz
f_{LSP}	Frequency, LSPCLK ⁽¹⁾	2		100	MHz
$t_{\text{c(LSPCLK)}}$	Period, LSPCLK	10		500	ns
f_{OSCCLK}	Frequency, OSCCLK (INTOSC1 or INTOSC2 or XTAL or X1)	See respective clock			MHz
f_{HRPWM}	Frequency, HRPWMCLK	60		100	MHz

(1) Lower LSPCLK will reduce device power consumption. The default at reset is SYSCLK/4.

5.8.3.2.3 Output Clock Frequency and Switching Characteristics

Table 5-21 provides the frequency of the output clock. Table 5-22 lists the switching characteristics of the output clock, XCLKOUT.

Table 5-21. Output Clock Frequency

		MIN	MAX	UNIT
f_{XCO}	Frequency, XCLKOUT		50	MHz

Table 5-22. XCLKOUT Switching Characteristics (PLL Bypassed or Enabled)⁽¹⁾⁽²⁾

over recommended operating conditions (unless otherwise noted)

PARAMETER		MIN	MAX	UNIT
$t_{\text{f(XCO)}}$	Fall time, XCLKOUT		5	ns
$t_{\text{r(XCO)}}$	Rise time, XCLKOUT		5	ns
$t_{\text{w(XCOL)}}$	Pulse duration, XCLKOUT low	H – 2	H + 2	ns
$t_{\text{w(XCOH)}}$	Pulse duration, XCLKOUT high	H – 2	H + 2	ns

(1) A load of 40 pF is assumed for these parameters.

(2) $H = 0.5t_{\text{c(XCO)}}$

5.8.3.3 Input Clocks and PLLs

NOTE

GPIO18* and its mux options can be used only when the system is clocked by INTOSC and X1 has an external pulldown resistor.

In addition to the internal 0-pin oscillators, three types of external clock sources are supported:

- A single-ended 3.3-V external clock. The clock signal should be connected to X1, as shown in [Figure 5-11](#). With the XTALCR.SE bit set to 1, X2 remains in GPIO mode.

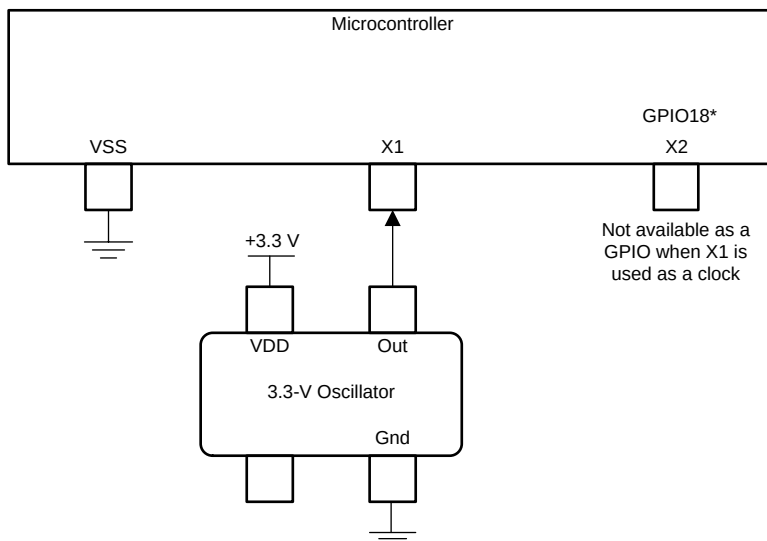


Figure 5-11. Single-ended 3.3-V External Clock

- An external crystal. The crystal should be connected across X1 and X2 with its load capacitors connected to VSS as shown in [Figure 5-12](#).

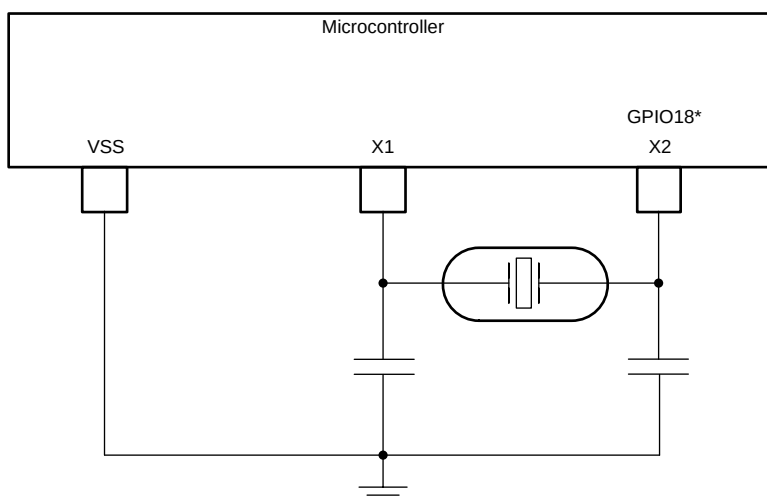


Figure 5-12. External Crystal

- An external resonator. The resonator should be connected across X1 and X2 with its ground connected to VSS as shown in [Figure 5-13](#).

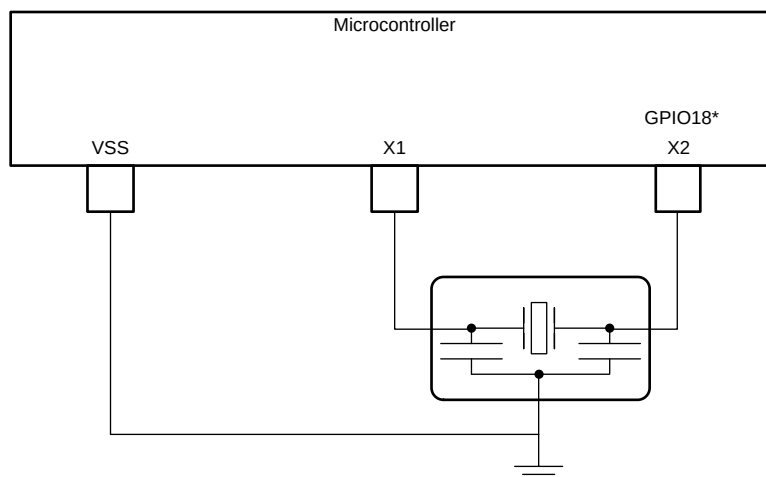


Figure 5-13. External Resonator

5.8.3.4 Crystal Oscillator

When using a quartz crystal, it may be necessary to include a damping resistor (R_D) in the crystal circuit to prevent overdriving the crystal (drive level can be found in the crystal data sheet). In higher-frequency applications (10 MHz or greater), R_D is generally not required. If a damping resistor is required, R_D should be as small as possible because the size of the resistance affects start-up time (smaller R_D = faster start-up time). TI recommends that the crystal manufacturer characterize the crystal with the application board. [Table 5-23](#) lists the crystal oscillator parameters. [Table 5-24](#) lists the crystal equivalent series resistance (ESR) requirements. [Table 5-25](#) lists the crystal oscillator electrical characteristics.

Table 5-23. Crystal Oscillator Parameters

		MIN	MAX	UNIT
CL1, CL2	Load capacitance	12	24	pF
C0	Crystal shunt capacitance		7	pF

Table 5-24. Crystal Equivalent Series Resistance (ESR) Requirements⁽¹⁾⁽²⁾

CRYSTAL FREQUENCY (MHz)	MAXIMUM ESR (Ω) (CL1 = CL2 = 12 pF)	MAXIMUM ESR (Ω) (CL1 = CL2 = 24 pF)
10	55	110
12	50	95
14	50	90
16	45	75
18	45	65
20	45	50

(1) Crystal shunt capacitance (C0) should be less than or equal to 7 pF.

(2) ESR = Negative Resistance/3

Table 5-25. Crystal Oscillator Electrical Characteristics

over recommended operating conditions (unless otherwise noted)

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Start-up time ⁽¹⁾	f = 20 MHz ESR MAX = 50 Ω CL1 = CL2 = 24 pF C0 = 7 pF		2		ms
Crystal drive level (DL)				1	mW

(1) Start-up time is dependent on the crystal and tank circuit components. TI recommends that the crystal vendor characterize the application with the chosen crystal.

5.8.3.5 Internal Oscillators

To reduce production board costs and application development time, all F28004x devices contain two independent internal oscillators, referred to as INTOSC1 and INTOSC2. By default, both oscillators are enabled at power up. INTOSC2 is set as the source for the system reference clock (OSCCLK) and INTOSC1 is set as the backup clock source. INTOSC1 can also be manually configured as the system reference clock (OSCCLK). [Table 5-26](#) provides the electrical characteristics of the internal oscillators to determine if this module meets the clocking requirements of the application.

Table 5-26. INTOSC Characteristics

over recommended operating conditions (unless otherwise noted)

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
f_{INTOSC}	Frequency, INTOSC1 and INTOSC2		9.7	10	10.3	MHz
$f_{\text{INTOSC-STABILITY}}$	Frequency stability at room temperature	30°C, Nominal VDD		±0.1%		
	Frequency stability over VDD	30°C		±0.2%		
	Frequency stability		–3%		3%	
$t_{\text{INTOSC-ST}}$	Start-up and settling time				20	µs

5.8.4 Flash Parameters

Table 5-27 lists the minimum required Flash wait states with different clock sources and frequencies.

Table 5-27. Minimum Required Flash Wait States with Different Clock Sources and Frequencies⁽¹⁾

CPUCLK (MHz)	EXTERNAL OSCILLATOR OR CRYSTAL		INTOSC1 OR INTOSC2	
	FLASH READ OR EXECUTE	PROGRAM, ERASE, BANK SLEEP, OR PUMP SLEEP	FLASH READ OR EXECUTE	PROGRAM, ERASE, BANK SLEEP, OR PUMP SLEEP ⁽²⁾
97 < CPUCLK ≤ 100	4		4	5
80 < CPUCLK ≤ 97				4
77 < CPUCLK ≤ 80	3		3	4
60 < CPUCLK ≤ 77				3
58 < CPUCLK ≤ 60	2		2	3
40 < CPUCLK ≤ 58				2
38 < CPUCLK ≤ 40	1		1	2
20 < CPUCLK ≤ 38				1
19 < CPUCLK ≤ 20	0		0	1
CPUCLK ≤ 19				0

- (1) Minimum required FRDCNTL[RWAIT].
- (2) PROGRAM, ERASE, or SLEEP operations require an extra wait state when using INTOSC as the clock source for the frequency ranges indicated. Any wait state FRDCNTL[RWAIT] change must be made before beginning a PROGRAM, ERASE, or SLEEP mode operation. This setting impacts both flash banks. Applications which perform simultaneous READ of one bank and PROGRAM or ERASE of the other bank must use the higher RWAIT setting during the PROGRAM or ERASE operation or use a clock source or frequency with a common wait state setting.

The F28004x devices have an improved 128-bit prefetch buffer that provides high flash code execution efficiency across wait states. Figure 5-14 and Figure 5-15 illustrate typical efficiency across wait-state settings compared to previous-generation devices with a 64-bit prefetch buffer. Wait-state execution efficiency with a prefetch buffer will depend on how many branches are present in application software. Two examples of linear code and if-then-else code are provided.

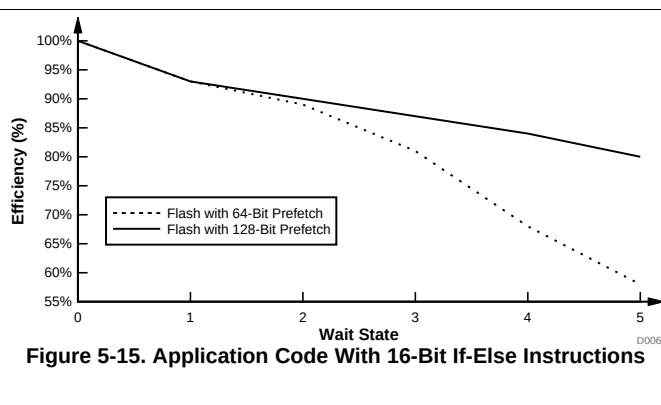
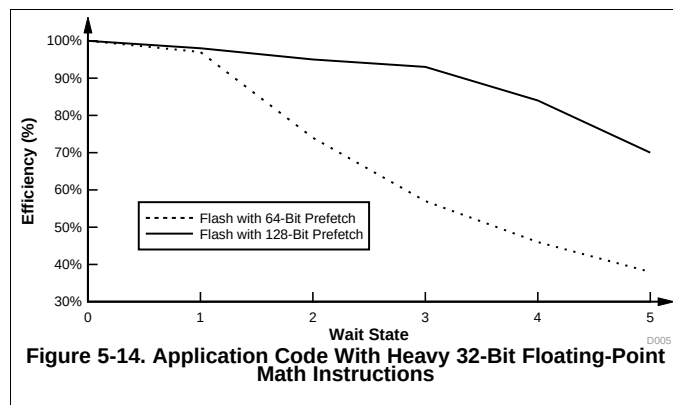


Table 5-28 lists the Flash parameters.

Table 5-28. Flash Parameters

PARAMETER		MIN	TYP	MAX	UNIT
Program Time ⁽¹⁾	128 data bits + 16 ECC bits		150	TBD	μs
	8KB sector		50	TBD	ms
EraseTime ⁽²⁾ at < 25 cycles	8KB sector		15	TBD	ms
EraseTime ⁽²⁾ at 20K cycles	8KB sector		120	TBD	ms
N _{wec} Write/Erase Cycles				20000	cycles
t _{retention} Data retention duration at T _J = 85°C		20			years

(1) Program time is at the maximum device frequency. Program time includes overhead of the flash state machine but does not include the time to transfer the following into RAM:

- Code that uses flash API to program the flash
- Flash API itself
- Flash data to be programmed

In other words, the time indicated in this table is applicable after all the required code/data is available in the device RAM, ready for programming. The transfer time will significantly vary depending on the speed of the emulator used.

Program time calculation is based on programming 144 bits at a time at the specified operating frequency. Program time includes Program verify by the CPU. The program time does not degrade with write/erase (W/E) cycling, but the erase time does.

Erase time includes Erase verify by the CPU and does not involve any data transfer.

(2) Erase time includes Erase verify by the CPU.

NOTE

The Main Array flash programming must be aligned to 64-bit address boundaries and each 64-bit word may only be programmed once per write/erase cycle.

The DCSM OTP programming must be aligned to 128-bit address boundaries and each 128-bit word may only be programmed once. The exceptions are:

1. The DCSM Zx-LINKPOINTER1 and Zx-LINKPOINTER2 values in the DCSM OTP should be programmed together, and may be programmed 1 bit at a time as required by the DCSM operation.
2. The DCSM Zx-LINKPOINTER3 values in the DCSM OTP may be programmed 1 bit at a time on a 64-bit boundary to separate it from Zx-PSWDLOCK, which must only be programmed once.

5.8.5 Emulation/JTAG

The JTAG (IEEE Standard 1149.1-1990 Standard Test Access Port and Boundary Scan Architecture) port has four dedicated pins: TMS, TDI, TDO, and TCK. The cJTAG has two pins: TMS and TCK.

Typically, no buffers are needed on the JTAG signals when the distance between the MCU target and the JTAG header is smaller than 6 inches (15.24 cm), and no other devices are present on the JTAG chain. Otherwise, each signal should be buffered. Additionally, for most emulator operations at 10 MHz, no series resistors are needed on the JTAG signals. However, if high emulation speeds are expected (35 MHz or so), 22-Ω resistors should be placed in series on each JTAG signal.

The PD (Power Detect) terminal of the emulator header should be connected to the board's 3.3-V supply. Header GND terminals should be connected to board ground. TDIS (Cable Disconnect Sense) should also be connected to board ground. The JTAG clock should be looped from the header TCK output terminal back to the RTCK input terminal of the header (to sense clock continuity by the emulator). This MCU does not support the EMU0 and EMU1 signals that are present on 14-pin and 20-pin emulation headers. These signals should always be pulled up at the emulation header through a pair of board pullup resistors ranging from 2.2 kΩ to 4.7 kΩ (depending on the drive strength of the debugger ports). Typically, a 2.2-kΩ value is used.

Header terminal $\overline{\text{RESET}}$ is an open-drain output from the emulator header that enables board components to be reset through emulator commands (available only through the 20-pin header). [Figure 5-16](#) shows how the 14-pin JTAG header connects to the MCU's JTAG port signals. [Figure 5-17](#) shows how to connect to the 20-pin JTAG header. The 20-pin JTAG header terminals EMU2, EMU3, and EMU4 are not used and should be grounded.

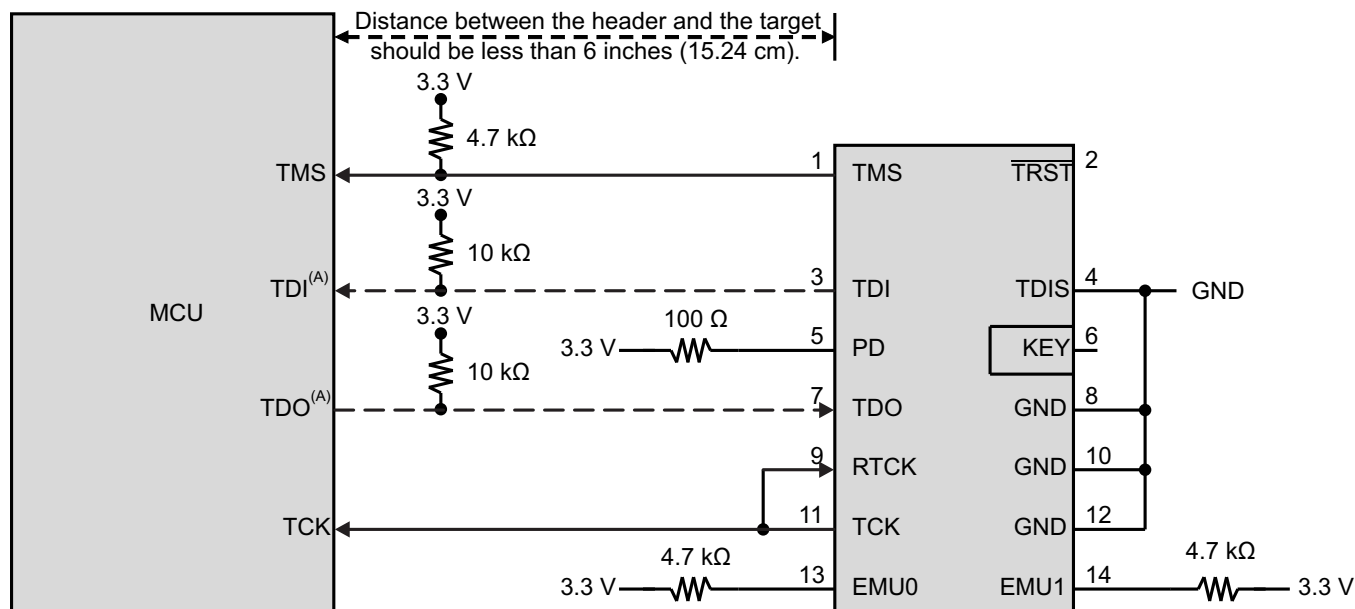
For more information about hardware breakpoints and watchpoints, see [Hardware Breakpoints and Watchpoints for C28x in CCS](#).

For more information about JTAG emulation, see the [XDS Target Connection Guide](#).

NOTE

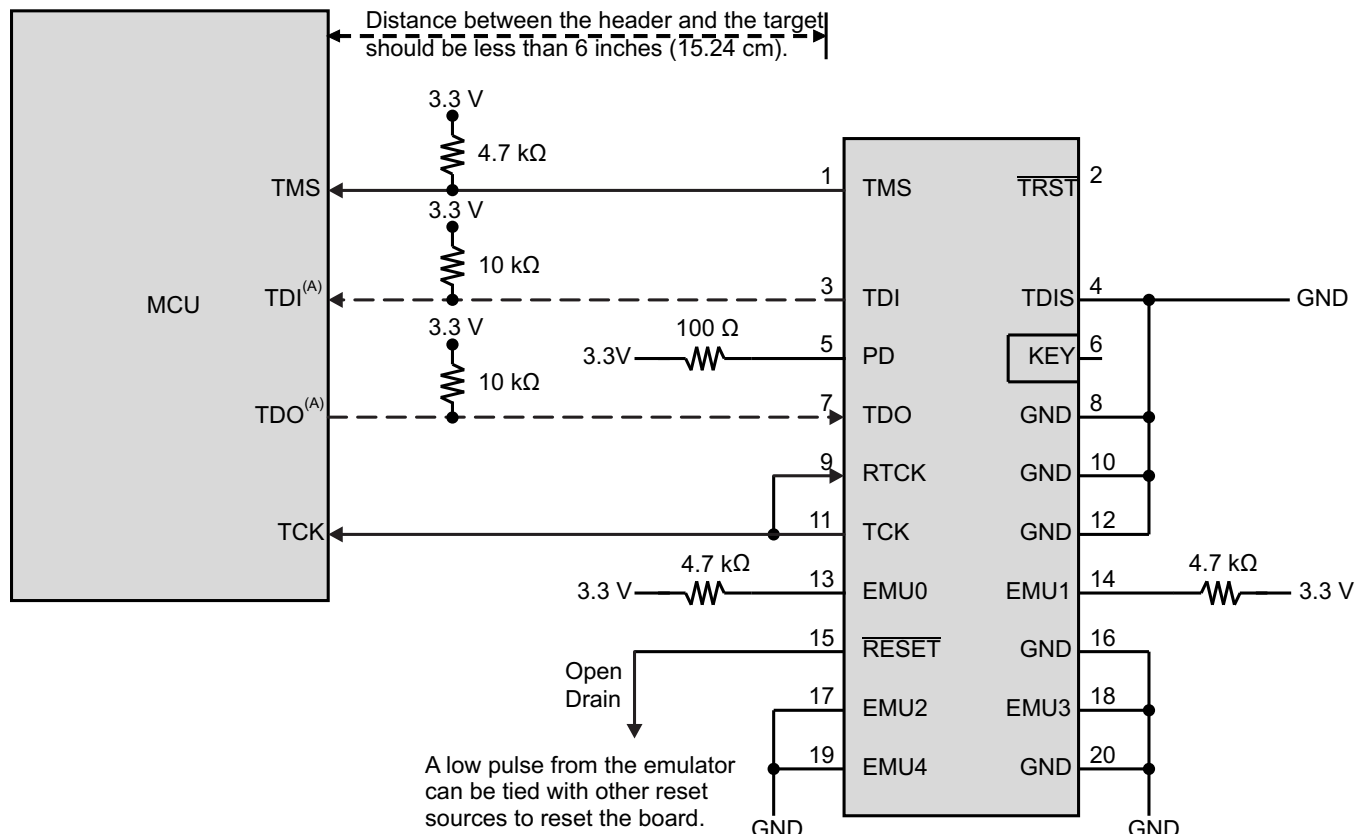
JTAG Test Data Input (TDI) is the default mux selection for the pin. The internal pullup is disabled by default. If this pin is used as JTAG TDI, the internal pullup should be enabled or an external pullup added on the board to avoid a floating input. In the cJTAG option, this pin can be used as GPIO.

JTAG Test Data Output (TDO) is the default mux selection for the pin. The internal pullup is disabled by default. The TDO function will be in a tri-state condition when there is no JTAG activity, leaving this pin floating. The internal pullup should be enabled or an external pullup added on the board to avoid a floating GPIO input. In the cJTAG option, this pin can be used as GPIO.



A. TDI and TDO connections are not required for cJTAG option and these pins can be used as GPIOs instead.

Figure 5-16. Connecting to the 14-Pin JTAG Header



A. TDI and TDO connections are not required for cJTAG option and these pins can be used as GPIOs instead.

Figure 5-17. Connecting to the 20-Pin JTAG Header

5.8.5.1 JTAG Electrical Data and Timing

Table 5-29 lists the JTAG timing requirements. Table 5-30 lists the JTAG switching characteristics. Figure 5-18 shows the JTAG timing.

Table 5-29. JTAG Timing Requirements

NO.			MIN	MAX	UNIT
1	$t_c(\text{TCK})$	Cycle time, TCK	66.66		ns
1a	$t_w(\text{TCKH})$	Pulse duration, TCK high (40% of t_c)	26.66		ns
1b	$t_w(\text{TCKL})$	Pulse duration, TCK low (40% of t_c)	26.66		ns
3	$t_{su}(\text{TDI-TCKH})$	Input setup time, TDI valid to TCK high	13		ns
	$t_{su}(\text{TMS-TCKH})$	Input setup time, TMS valid to TCK high	13		
4	$t_h(\text{TCKH-TDI})$	Input hold time, TDI valid from TCK high	7		ns
	$t_h(\text{TCKH-TMS})$	Input hold time, TMS valid from TCK high	7		

Table 5-30. JTAG Switching Characteristics

over recommended operating conditions (unless otherwise noted)

NO.	PARAMETER	MIN	MAX	UNIT
2	$t_d(\text{TCKL-TDO})$	6	25	ns

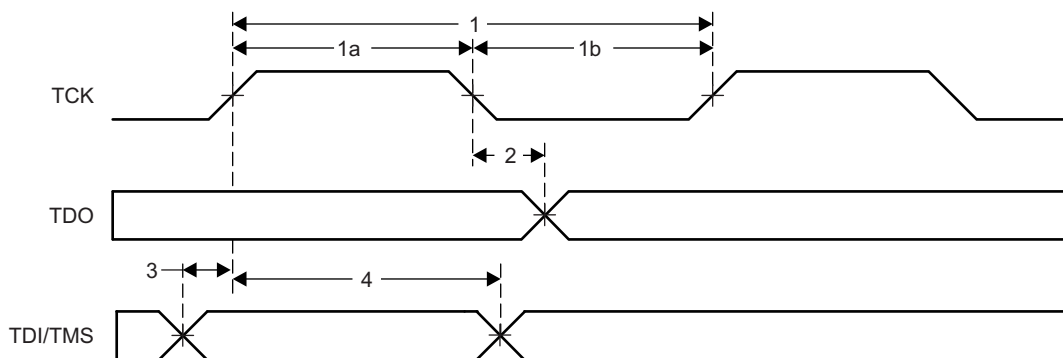


Figure 5-18. JTAG Timing

5.8.5.2 cJTAG Electrical Data and Timing

Table 5-31 lists the cJTAG timing requirements. Table 5-32 lists the cJTAG switching characteristics. Figure 5-19 shows the cJTAG timing.

Table 5-31. cJTAG Timing Requirements

NO.			MIN	MAX	UNIT
1	$t_c(\text{TCK})$	Cycle time, TCK	100		ns
1a	$t_w(\text{TCKH})$	Pulse duration, TCK high (40% of t_c)	40		ns
1b	$t_w(\text{TCKL})$	Pulse duration, TCK low (40% of t_c)	40		ns
3	$t_{su}(\text{TMS-TCKH})$	Input setup time, TMS valid to TCK high	15		ns
	$t_{su}(\text{TMS-TCKL})$	Input setup time, TMS valid to TCK low	15		ns
4	$t_h(\text{TCKH-TMS})$	Input hold time, TMS valid from TCK high	2		ns
	$t_h(\text{TCKL-TMS})$	Input hold time, TMS valid from TCK low	2		ns

Table 5-32. cJTAG Switching Characteristics

over recommended operating conditions (unless otherwise noted)

NO.	PARAMETER	MIN	MAX	UNIT
2	$t_d(\text{TCKL-TMS})$	6	20	ns
5	$t_{dis}(\text{TCKH-TMS})$		20	ns

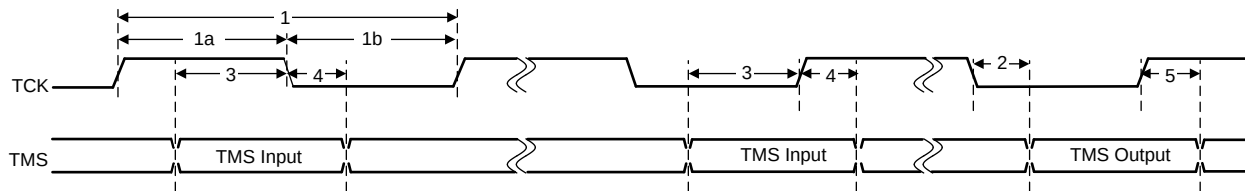


Figure 5-19. cJTAG Timing

5.8.6 GPIO Electrical Data and Timing

The peripheral signals are multiplexed with general-purpose input/output (GPIO) signals. On reset, GPIO pins are configured as inputs. For specific inputs, the user can also select the number of input qualification cycles to filter unwanted noise glitches.

The GPIO module contains an Output X-BAR which allows an assortment of internal signals to be routed to a GPIO in the GPIO mux positions denoted as OUTPUTXBARx. The GPIO module also contains an Input X-BAR which is used to route signals from any GPIO input to different IP blocks such as the ADCs, eCAPs, ePWMs, and external interrupts. For more details, see the X-BAR chapter in the [TMS320F28004x Piccolo Microcontrollers Technical Reference Manual](#).

5.8.6.1 GPIO – Output Timing

Table 5-33 lists the general-purpose output switching characteristics. Figure 5-20 shows the general-purpose output timing.

Table 5-33. General-Purpose Output Switching Characteristics

over recommended operating conditions (unless otherwise noted)

PARAMETER			MIN	MAX	UNIT
$t_{r(GPIO)}$	Rise time, GPIO switching low to high	All GPIOs except GPIO23_VSW		8 ⁽¹⁾	ns
$t_{f(GPIO)}$	Fall time, GPIO switching high to low	All GPIOs except GPIO23_VSW		8 ⁽¹⁾	ns
f_{GPIO}	Toggling frequency, all GPIOs except GPIO23_VSW			25	MHz

(1) Rise time and fall time vary with load. These values assume a 40-pF load.

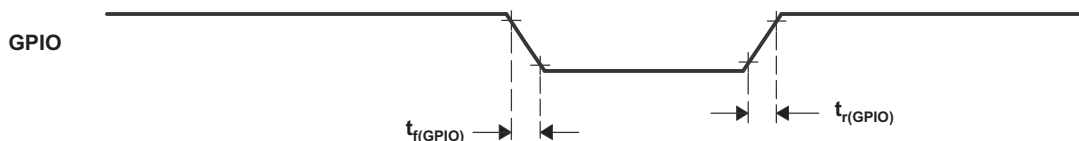


Figure 5-20. General-Purpose Output Timing

5.8.6.2 GPIO – Input Timing

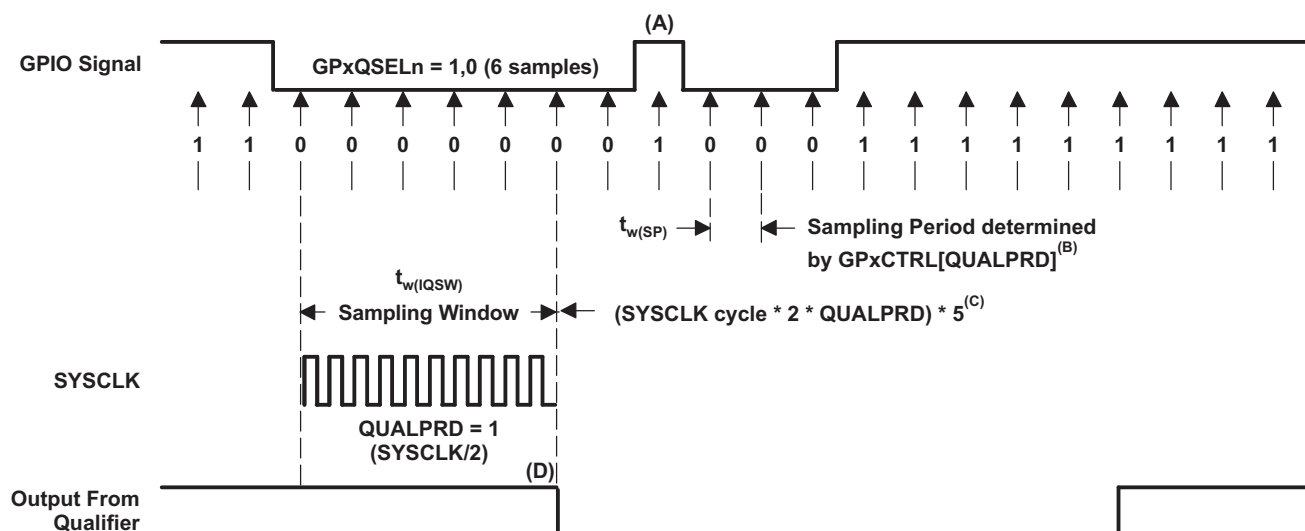
Table 5-34 lists the general-purpose input timing requirements. Figure 5-21 shows the sampling mode.

Table 5-34. General-Purpose Input Timing Requirements

			MIN	MAX	UNIT
$t_{w(SP)}$	Sampling period	QUALPRD = 0	$1t_{c(SYSCLK)}$		cycles
		QUALPRD $\neq$ 0	$2t_{c(SYSCLK)} * QUALPRD$		
$t_{w(IQSW)}$	Input qualifier sampling window		$t_{w(SP)} * (n^{(1)} - 1)$		cycles
$t_{w(GPI)}^{(2)}$	Pulse duration, GPIO low/high	Synchronous mode	$2t_{c(SYSCLK)}$		cycles
		With input qualifier	$t_{w(IQSW)} + t_{w(SP)} + 1t_{c(SYSCLK)}$		

(1) "n" represents the number of qualification samples as defined by GPxQSELn register.

(2) For $t_{w(GPI)}$, pulse width is measured from V_{IL} to V_{IL} for an active low signal and V_{IH} to V_{IH} for an active high signal.



- This glitch will be ignored by the input qualifier. The QUALPRD bit field specifies the qualification sampling period. It can vary from 00 to 0xFF. If QUALPRD = 00, then the sampling period is 1 SYSCLK cycle. For any other value "n", the qualification sampling period is 2n SYSCLK cycles (that is, at every 2n SYSCLK cycles, the GPIO pin will be sampled).
- The qualification period selected through the GPxCTRL register applies to groups of eight GPIO pins.
- The qualification block can take either three or six samples. The GPxQSELn Register selects which sample mode is used.
- In the example shown, for the qualifier to detect the change, the input should be stable for 10 SYSCLK cycles or greater. In other words, the inputs should be stable for $(5 * QUALPRD * 2)$ SYSCLK cycles. This would ensure 5 sampling periods for detection to occur. Because external signals are driven asynchronously, an 13-SYSCLK-wide pulse ensures reliable recognition.

Figure 5-21. Sampling Mode

5.8.6.3 Sampling Window Width for Input Signals

The following section summarizes the sampling window width for input signals for various input qualifier configurations.

Sampling frequency denotes how often a signal is sampled with respect to SYSCLK.

Sampling frequency = $\text{SYSCLK} / (2 \times \text{QUALPRD})$, if $\text{QUALPRD} \neq 0$

Sampling frequency = SYSCLK , if $\text{QUALPRD} = 0$

Sampling period = $\text{SYSCLK cycle} \times 2 \times \text{QUALPRD}$, if $\text{QUALPRD} \neq 0$

In the previous equations, SYSCLK cycle indicates the time period of SYSCLK.

Sampling period = SYSCLK cycle , if $\text{QUALPRD} = 0$

In a given sampling window, either 3 or 6 samples of the input signal are taken to determine the validity of the signal. This is determined by the value written to GPxQSELn register.

Case 1:

Qualification using 3 samples

Sampling window width = $(\text{SYSCLK cycle} \times 2 \times \text{QUALPRD}) \times 2$, if $\text{QUALPRD} \neq 0$

Sampling window width = $(\text{SYSCLK cycle}) \times 2$, if $\text{QUALPRD} = 0$

Case 2:

Qualification using 6 samples

Sampling window width = $(\text{SYSCLK cycle} \times 2 \times \text{QUALPRD}) \times 5$, if $\text{QUALPRD} \neq 0$

Sampling window width = $(\text{SYSCLK cycle}) \times 5$, if $\text{QUALPRD} = 0$

Figure 5-22 shows the general-purpose input timing.

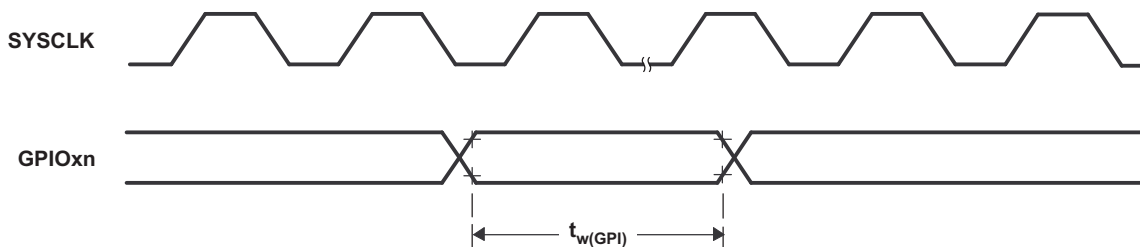


Figure 5-22. General-Purpose Input Timing

5.8.7 Interrupts

The C28x CPU has fourteen peripheral interrupt lines. Two of them (INT13 and INT14) are connected directly to CPU timers 1 and 2, respectively. The remaining twelve are connected to peripheral interrupt signals through the enhanced Peripheral Interrupt Expansion (ePIE) module. The ePIE multiplexes up to sixteen peripheral interrupts into each CPU interrupt line. It also expands the vector table to allow each interrupt to have its own ISR. This allows the CPU to support a large number of peripherals.

An interrupt path is divided into three stages—the peripheral, the ePIE, and the CPU. Each stage has its own enable and flag registers. This system allows the CPU to handle one interrupt while others are pending, implement and prioritize nested interrupts in software, and disable interrupts during certain critical tasks.

Figure 5-23 shows the interrupt architecture for this device.

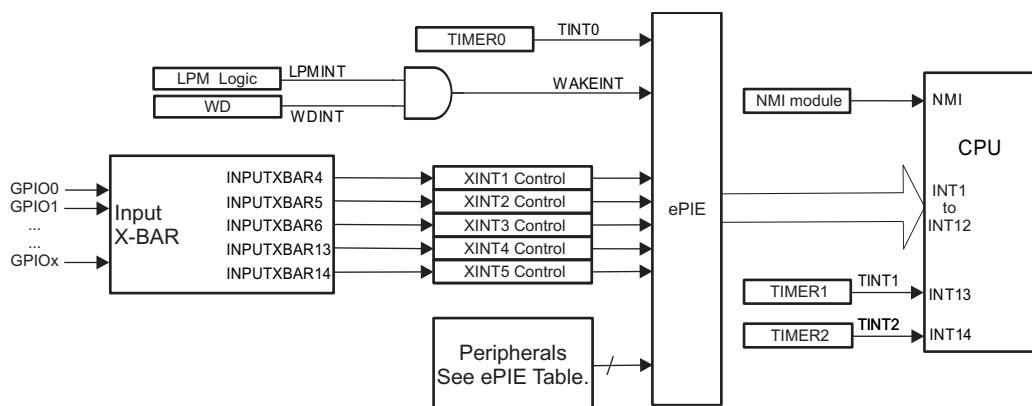


Figure 5-23. Device Interrupt Architecture

5.8.7.1 External Interrupt (XINT) Electrical Data and Timing

Table 5-35 lists the external interrupt timing requirements. Table 5-36 lists the external interrupt switching characteristics. Figure 5-24 shows the external interrupt timing.

Table 5-35. External Interrupt Timing Requirements⁽¹⁾

		MIN	MAX	UNIT
$t_{w(INT)}$	Pulse duration, INT input low/high	Synchronous	$2t_{c(SYCLK)}$	cycles
		With qualifier	$t_{w(IQSW)} + t_{w(SP)} + 1t_{c(SYCLK)}$	

(1) For an explanation of the input qualifier parameters, see Table 5-34.

Table 5-36. External Interrupt Switching Characteristics⁽¹⁾

over recommended operating conditions (unless otherwise noted)

PARAMETER	MIN	MAX	UNIT
$t_{d(INT)}$ Delay time, INT low/high to interrupt-vector fetch ⁽²⁾	$t_{w(IQSW)} + 14t_{c(SYCLK)}$	$t_{w(IQSW)} + t_{w(SP)} + 14t_{c(SYCLK)}$	cycles

(1) For an explanation of the input qualifier parameters, see Table 5-34.

(2) This assumes that the ISR is in a single-cycle memory.

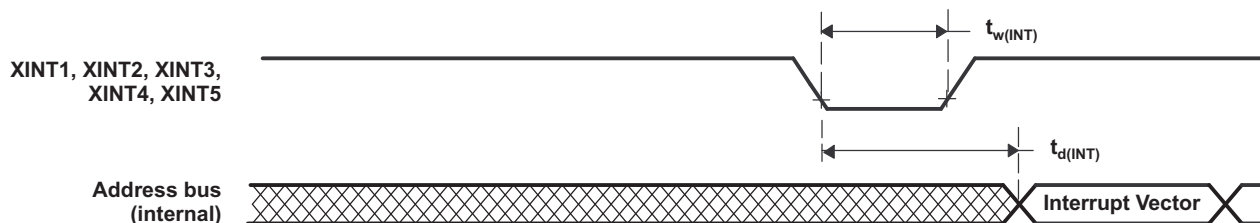


Figure 5-24. External Interrupt Timing

5.8.8 Low-Power Modes

This device has three clock-gating low-power modes.

Further details, as well as the entry and exit procedure, for all of the low-power modes can be found in the Low Power Modes section of the [TMS320F28004x Piccolo Microcontrollers Technical Reference Manual](#).

5.8.8.1 Clock-Gating Low-Power Modes

IDLE, STANDBY, and HALT modes on this device are similar to those on other C28x devices. [Table 5-37](#) describes the effect on the system when any of the clock-gating low-power modes are entered.

Table 5-37. Effect of Clock-Gating Low-Power Modes on the Device

MODULES/ CLOCK DOMAIN	IDLE	STANDBY	HALT
SYSCCLK	Active	Gated	Gated
CPUCCLK	Gated	Gated	Gated
Clock to modules connected to PERx.SYSCCLK	Active	Gated	Gated
WDCLK	Active	Active	Gated if CLKSRCCTL1.WDHALTI = 0
PLL	Powered	Powered	Software must power down PLL before entering HALT.
INTOSC1	Powered	Powered	Powered down if CLKSRCCTL1.WDHALTI = 0
INTOSC2	Powered	Powered	Powered down if CLKSRCCTL1.WDHALTI = 0
Flash ⁽¹⁾	Powered	Powered	Powered
XTAL ⁽²⁾	Powered	Powered	Powered

- (1) The Flash module is not powered down by hardware in any LPM. It may be powered down using software if required by the application. For more information, see the Flash and OTP Memory section of the System Control chapter in the [TMS320F28004x Piccolo Microcontrollers Technical Reference Manual](#).
- (2) The XTAL is not powered down by hardware in any LPM. It may be powered down by software setting the XTALCR.OSCOFF bit to 1. This can be done at any time during the application if the XTAL is not required.

5.8.8.2 Low-Power Mode Wake-up Timing

Table 5-38 lists the IDLE mode timing requirements, Table 5-39 lists the switching characteristics, and Figure 5-25 shows the timing diagram for IDLE mode.

Table 5-38. IDLE Mode Timing Requirements⁽¹⁾

			MIN	MAX	UNIT
t _{w(WAKE)}	Pulse duration, external wake-up signal	Without input qualifier	2t _{c(SYCLK)}		cycles
		With input qualifier	2t _{c(SYCLK)} + t _{w(IOSW)}		

(1) For an explanation of the input qualifier parameters, see Table 5-34.

Table 5-39. IDLE Mode Switching Characteristics⁽¹⁾

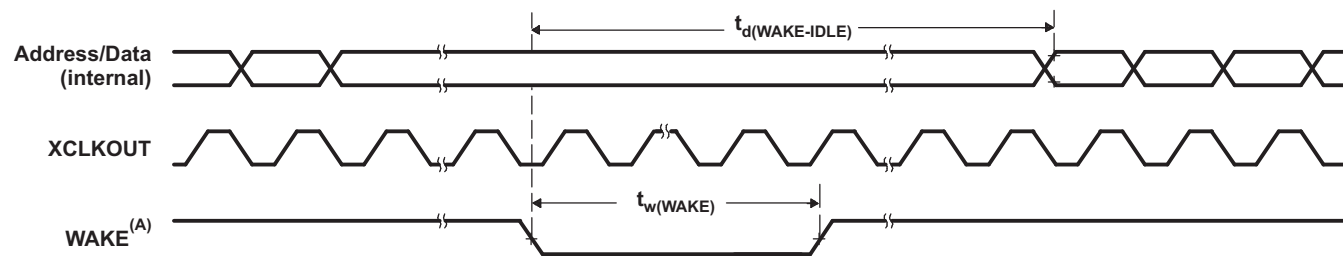
over recommended operating conditions (unless otherwise noted)

PARAMETER		TEST CONDITIONS	MIN	MAX	UNIT
t _{d(WAKE-IDLE)}	Delay time, external wake signal to program execution resume ⁽²⁾				cycles
	• Wake up from flash – Flash module in active state	Without input qualifier	40t _{c(SYCLK)}		
		With input qualifier	40t _{c(SYCLK)} + t _{w(WAKE)}		
	• Wake up from flash – Flash module in sleep state	Without input qualifier	6700t _{c(SYCLK)} ⁽³⁾		
		With input qualifier	6700t _{c(SYCLK)} ⁽³⁾ + t _{w(WAKE)}		
	• Wake up from RAM	Without input qualifier	25t _{c(SYCLK)}		
		With input qualifier	25t _{c(SYCLK)} + t _{w(WAKE)}		

(1) For an explanation of the input qualifier parameters, see Table 5-34.

(2) This is the time taken to begin execution of the instruction that immediately follows the IDLE instruction. Execution of an ISR (triggered by the wake-up signal) involves additional latency.

(3) This value is based on the flash power-up time, which is a function of the SYCLK frequency, flash wait states (RWAIT), and FPAC1[PSLEEP]. For more information, see the Flash/OTP and Pump Power Modes and Wakeup section of the [TMS320F28004x Piccolo Microcontrollers Technical Reference Manual](#).



A. WAKE can be any enabled interrupt, $\overline{WDINT}$ or $XRSn$. After the IDLE instruction is executed, a delay of five OSCCLK cycles (minimum) is needed before the wake-up signal could be asserted.

Figure 5-25. IDLE Entry and Exit Timing Diagram

Table 5-40 lists the STANDBY mode timing requirements, Table 5-41 lists the switching characteristics, and Figure 5-26 shows the timing diagram for STANDBY mode.

Table 5-40. STANDBY Mode Timing Requirements

		MIN	MAX	UNIT
$t_{w(WAKE-INT)}$	Pulse duration, external wake-up signal	QUALSTDBY = 0 $2t_{c(OSCCLK)}$	$3t_{c(OSCCLK)}$	cycles
		QUALSTDBY > 0 $(2 + QUALSTDBY)t_{c(OSCCLK)}$ ⁽¹⁾	$(2 + QUALSTDBY) * t_{c(OSCCLK)}$	

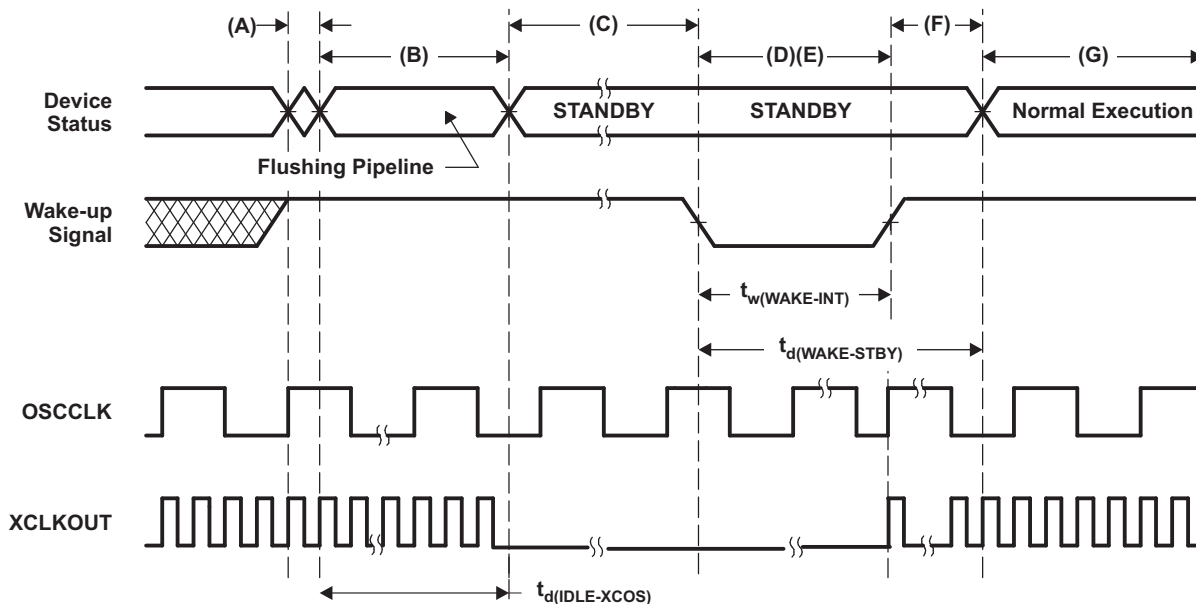
(1) QUALSTDBY is a 6-bit field in the LPMCRR register.

Table 5-41. STANDBY Mode Switching Characteristics

over recommended operating conditions (unless otherwise noted)

PARAMETER	TEST CONDITIONS	MIN	MAX	UNIT
$t_{d(IDLE-XCOS)}$	Delay time, IDLE instruction executed to XCLKOUT stop		$16t_{c(INTOSC1)}$	cycles
$t_{d(WAKE-STBY)}$	Delay time, external wake signal to program execution resume ⁽¹⁾			cycles
	• Wake up from flash – Flash module in active state		$175t_{c(SYSCCLK)} + t_{w(WAKE-INT)}$	
	• Wake up from flash – Flash module in sleep state		$6700t_{c(SYSCCLK)}^{(2)} + t_{w(WAKE-INT)}$	
	• Wake up from RAM		$3t_{c(OSC)} + 15t_{c(SYSCCLK)} + t_{w(WAKE-INT)}$	

- (1) This is the time taken to begin execution of the instruction that immediately follows the IDLE instruction. Execution of an ISR (triggered by the wake-up signal) involves additional latency.
- (2) This value is based on the flash power-up time, which is a function of the SYSCCLK frequency, flash wait states (RWAIT), and FPAC1[PSLEEP]. For more information, see the Flash/OTP and Pump Power Modes and Wakeup section of the [TMS320F28004x Piccolo Microcontrollers Technical Reference Manual](#).



- IDLE instruction is executed to put the device into STANDBY mode.
- The LPM block responds to the STANDBY signal, SYSCCLK is held for a maximum 16 INTOSC1 clock cycles before being turned off. This delay enables the CPU pipeline and any other pending operations to flush properly.
- Clock to the peripherals are turned off. However, the PLL and watchdog are not shut down. The device is now in STANDBY mode. After the IDLE instruction is executed, a delay of five OSCCLK cycles (minimum) is needed before the wake-up signal could be asserted.
- The external wake-up signal is driven active.
- The wake-up signal fed to a GPIO pin to wake up the device must meet the minimum pulse width requirement. Furthermore, this signal must be free of glitches. If a noisy signal is fed to a GPIO pin, the wake-up behavior of the device will not be deterministic and the device may not exit low-power mode for subsequent wake-up pulses.
- After a latency period, the STANDBY mode is exited.
- Normal execution resumes. The device will respond to the interrupt (if enabled).

Figure 5-26. STANDBY Entry and Exit Timing Diagram

Table 5-42 lists the HALT mode timing requirements, Table 5-43 lists the switching characteristics, and Figure 5-27 shows the timing diagram for HALT mode.

Table 5-42. HALT Mode Timing Requirements

		MIN	MAX	UNIT
$t_{w(WAKE-GPIO)}$	Pulse duration, GPIO wake-up signal ⁽¹⁾	$t_{oscst} + 2t_{c(OSCCLK)}$		cycles
$t_{w(WAKE-XRS)}$	Pulse duration, XRSn wake-up signal ⁽¹⁾	$t_{oscst} + 8t_{c(OSCCLK)}$		cycles

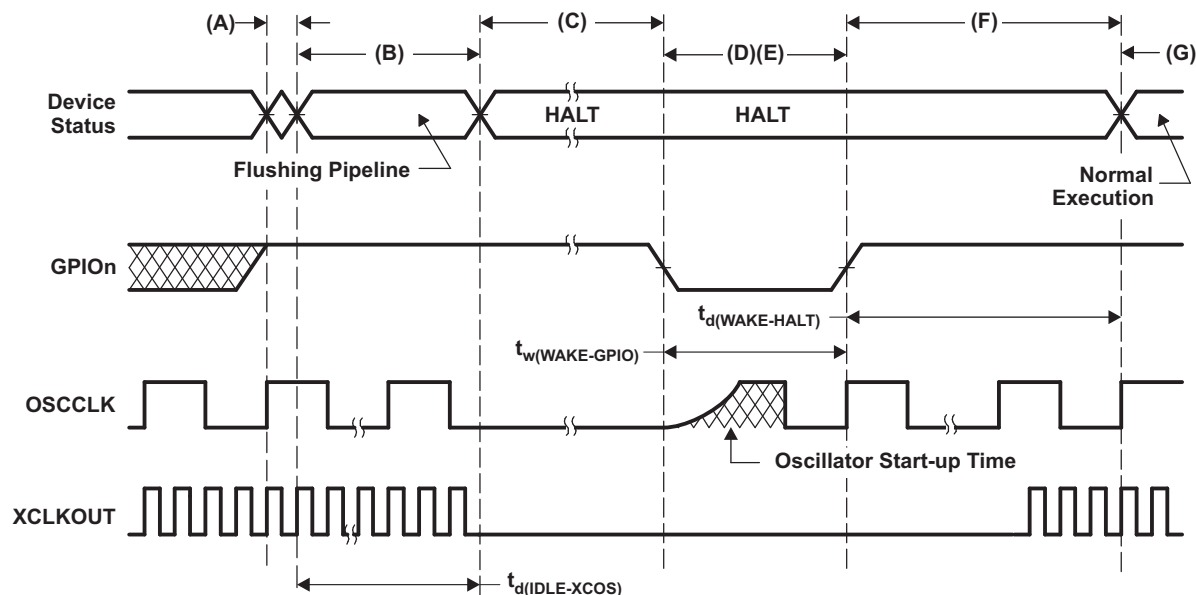
- (1) For applications using X1/X2 for OSCCLK, the user must characterize their specific oscillator start-up time as it is dependent on circuit/layout external to the device. See Table 5-25 for more information. For applications using INTOSC1 or INTOSC2 for OSCCLK, see Section 5.8.3.5 for t_{oscst} . Oscillator start-up time does not apply to applications using a single-ended crystal on the X1 pin, as it is powered externally to the device.

Table 5-43. HALT Mode Switching Characteristics

over recommended operating conditions (unless otherwise noted)

PARAMETER		MIN	MAX	UNIT
$t_{d(IDLE-XCOS)}$	Delay time, IDLE instruction executed to XCLKOUT stop		$16t_{c(INTOSC1)}$	cycles
$t_{d(WAKE-HALT)}$	Delay time, external wake signal end to CPU program execution resume			cycles
	- Wake up from flash – Flash module in active state		$75t_{c(OSCCLK)}$	
	- Wake up from flash – Flash module in sleep state		$17500t_{c(OSCCLK)}^{(1)}$	
	Wake up from RAM		$75t_{c(OSCCLK)}$	

- (1) This value is based on the flash power-up time, which is a function of the SYSCLK frequency, flash wait states (RWAIT), and FPAC1[PSLEEP]. For more information, see the Flash/OTP and Pump Power Modes and Wakeup section of the [TMS320F28004x Piccolo Microcontrollers Technical Reference Manual](#).



- A. IDLE instruction is executed to put the device into HALT mode.
- B. The LPM block responds to the HALT signal, SYSCLK is held for a maximum 16 INTOSC1 clock cycles before being turned off. This delay enables the CPU pipeline and any other pending operations to flush properly.
- C. Clocks to the peripherals are turned off and the PLL is shut down. If a quartz crystal or ceramic resonator is used as the clock source, the internal oscillator is shut down as well. The device is now in HALT mode and consumes very little power. It is possible to keep the zero-pin internal oscillators (INTOSC1 and INTOSC2) and the watchdog alive in HALT MODE. This is done by writing 1 to CLKSRCCTL1.WDHALTI. After the IDLE instruction is executed, a delay of five OSCCLK cycles (minimum) is needed before the wake-up signal could be asserted.
- D. When the GPIO pin (used to bring the device out of HALT) is driven low, the oscillator is turned on and the oscillator wake-up sequence is initiated. The GPIO pin should be driven high only after the oscillator has stabilized. This enables the provision of a clean clock signal during the PLL lock sequence. Because the falling edge of the GPIO pin asynchronously begins the wake-up procedure, care should be taken to maintain a low noise environment before entering and during HALT mode.
- E. The wake-up signal fed to a GPIO pin to wake up the device must meet the minimum pulse width requirement. Furthermore, this signal must be free of glitches. If a noisy signal is fed to a GPIO pin, the wake-up behavior of the device will not be deterministic and the device may not exit low-power mode for subsequent wake-up pulses.
- F. When CLKIN to the core is enabled, the device will respond to the interrupt (if enabled), after some latency. The HALT mode is now exited.
- G. Normal operation resumes.
- H. The user must relock the PLL upon HALT wakeup to ensure a stable PLL lock.

Figure 5-27. HALT Entry and Exit Timing Diagram

5.9 Analog Peripherals

The analog subsystem module is described in this section.

The analog modules on this device include the ADC, PGA, temperature sensor, buffered DAC, and CMPSS.

The analog subsystem has the following features:

- Flexible voltage references
 - The ADCs are referenced to VREFH_{ix} and VREFLO_x pins.
 - VREFH_{ix} pin voltage can be driven in externally or can be generated by an internal bandgap voltage reference.
 - The internal voltage reference range can be selected to be 0 V to 3.3 V or 0 V to 2.5 V.
- The buffered DACs are referenced to VREFH_{ix} and VREFLO_x.
 - Alternately, these DACs can be referenced to the VDAC pin and VSSA.
- The comparator DACs are referenced to VDDA and VSSA.
 - Alternately, these DACs can be referenced to the VDAC pin and VSSA.
- Flexible pin usage
 - Buffered DAC outputs, comparator subsystem inputs, PGA functions, and digital inputs are multiplexed with ADC inputs
 - Internal connection to VREFLO on all ADCs for offset self-calibration

[Figure 5-28](#) shows the Analog Subsystem Block Diagram for the 100-pin PZ LQFP.

[Figure 5-29](#) shows the Analog Subsystem Block Diagram for the 64-pin PM LQFP.

[Figure 5-30](#) shows the Analog Subsystem Block Diagram for the 56-pin RSH VQFN.

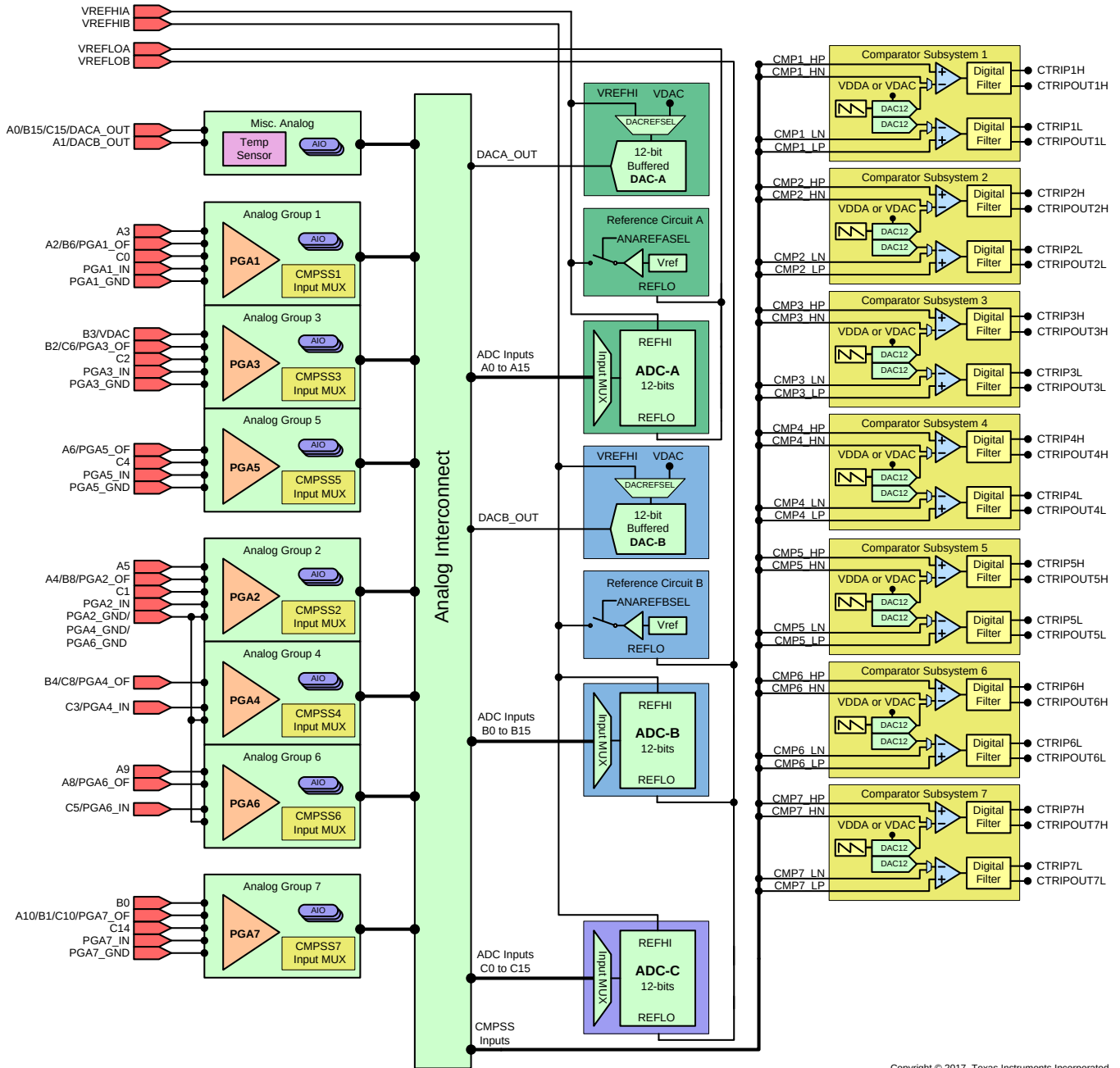
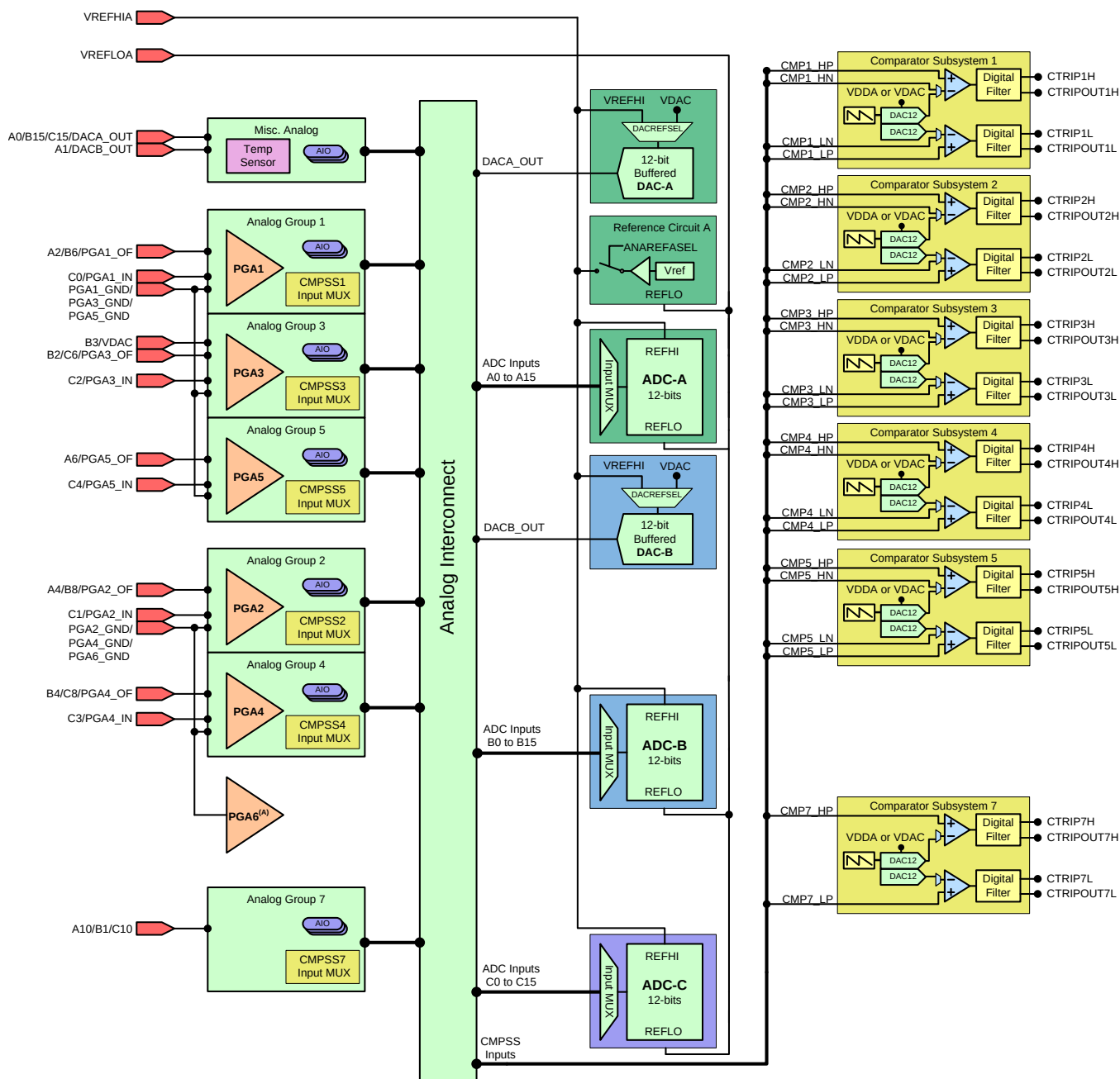


Figure 5-28. Analog Subsystem Block Diagram (100-Pin PZ LQFP)

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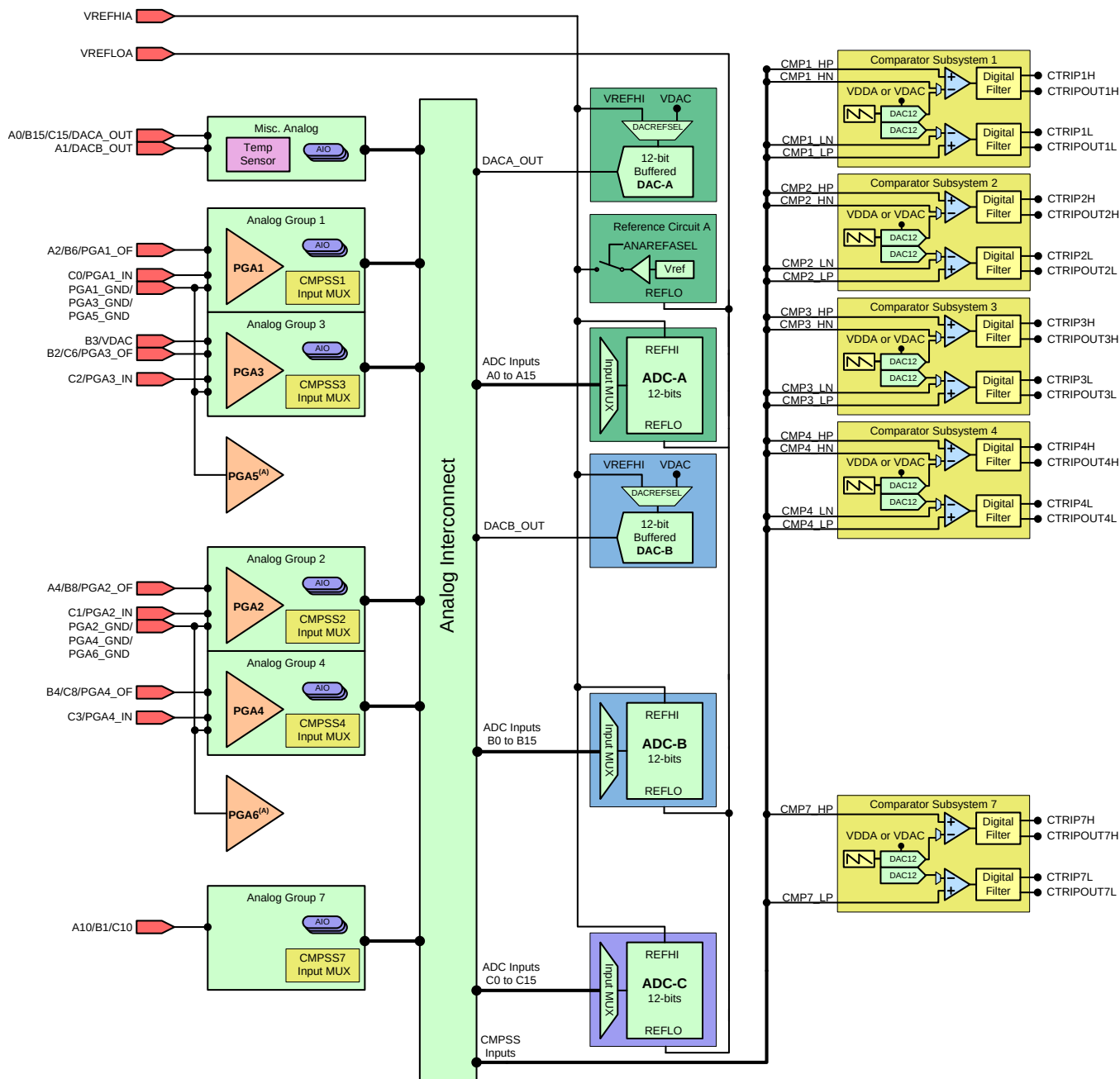
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- A. This PGA has no input/output connections on this package, but should be enabled and disabled at the same time as other PGAs with a shared PGA ground.

Figure 5-29. Analog Subsystem Block Diagram (64-Pin PM LQFP)



- A. This PGA has no input/output connections on this package, but should be enabled and disabled at the same time as other PGAs with a shared PGA ground.

Figure 5-30. Analog Subsystem Block Diagram (56-Pin RSH VQFN)

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ADVANCE INFORMATION

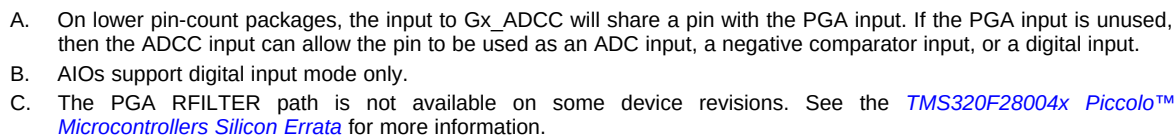
100 *Specifications*

Table 5-44. Analog Pins and Internal Connections

PIN NAME	GROUP NAME	PACKAGE			ALWAYS CONNECTED (NO MUX)					COMPARATOR SUBSYSTEM (MUX)				AIO INPUT	
		100 PZ	64 PM	56 RSH	ADCA	ADCB	ADCC	PGA	DAC	HIGH POSITIVE	HIGH NEGATIVE	LOW POSITIVE	LOW NEGATIVE		
VREFHIA	-	25	16	14											
VREFHIB	-	24													
VREFHIC	-														
VREFLOA	-	27	17	15	A13										
VREFLOB	-					B13									
VREFLOC	-	26					C13								
Analog Group 1															
A3	G1_ADCAB	10			A3					CMP1_HP3	CMP1_HN0	CMP1_LP3	CMP1_LN0	AIO233	
A2/B6/PGA1_OF	PGA1_OF	9	9	8	A2	B6		PGA1_OF		CMP1_HP0		CMP1_LP0		AIO224	
C0	G1_ADCC	19	12	10			C0			CMP1_HP1	CMP1_HN1	CMP1_LP1	CMP1_LN1	AIO237	
PGA1_IN	PGA1_IN	18						PGA1_IN							
PGA1_GND	PGA1_GND	14	10	9				PGA1_GND							
-	PGA1_OUT ⁽¹⁾				A11	B7		PGA1_OUT		CMP1_HP4		CMP1_LP4			
Analog Group 2															
A5	G2_ADCAB	35			A5					CMP2_HP3	CMP2_HN0	CMP2_LP3	CMP2_LN0	AIO234	
A4/B8/PGA2_OF	PGA2_OF	36	23	21	A4	B8		PGA2_OF		CMP2_HP0		CMP2_LP0		AIO225	
C1	G2_ADCC	29	18	16			C1			CMP2_HP1	CMP2_HN1	CMP2_LP1	CMP2_LN1	AIO238	
PGA2_IN	PGA2_IN	30						PGA2_IN							
PGA2_GND	PGA2_GND	32	20	18				PGA2_GND							
-	PGA2_OUT ⁽¹⁾				A12	B9		PGA2_OUT		CMP2_HP4		CMP2_LP4			
Analog Group 3															
B3/VDAC	G3_ADCAB	8	8	7		B3			VDAC	CMP3_HP3	CMP3_HN0	CMP3_LP3	CMP3_LN0	AIO242	
B2/C6/PGA3_OF	PGA3_OF	7	7	6		B2	C6	PGA3_OF		CMP3_HP0		CMP3_LP0		AIO226	
C2	G3_ADCC	21	13	11			C2			CMP3_HP1	CMP3_HN1	CMP3_LP1	CMP3_LN1	AIO244	
PGA3_IN	PGA3_IN	20						PGA3_IN							
PGA3_GND	PGA3_GND	15	10	9				PGA3_GND							
-	PGA3_OUT ⁽¹⁾					B10	C7	PGA3_OUT		CMP3_HP4		CMP3_LP4			
Analog Group 4															
B5	G4_ADCAB					B5				CMP4_HP3	CMP4_HN0	CMP4_LP3	CMP4_LN0	AIO243	
B4/C8/PGA4_OF	PGA4_OF	39	24	22		B4	C8	PGA4_OF		CMP4_HP0		CMP4_LP0		AIO227	
C3	G4_ADCC	31	19	17			C3			CMP4_HP1	CMP4_HN1	CMP4_LP1	CMP4_LN1	AIO245	
PGA4_IN	PGA4_IN							PGA4_IN							
PGA4_GND	PGA4_GND	32	20	18				PGA4_GND							
-	PGA4_OUT ⁽¹⁾					B11	C9	PGA4_OUT		CMP4_HP4		CMP4_LP4			

(1) Internal connection only; does not come to a device pin.

Table 5-44. Analog Pins and Internal Connections (continued)

PIN NAME	GROUP NAME	PACKAGE			ALWAYS CONNECTED (NO MUX)					COMPARATOR SUBSYSTEM (MUX)				AIO INPUT
		100 PZ	64 PM	56 RSH	ADCA	ADCB	ADCC	PGA	DAC	HIGH POSITIVE	HIGH NEGATIVE	LOW POSITIVE	LOW NEGATIVE	
Analog Group 5														
A7	G5_ADCAB				A7					CMP5_HP3	CMP5_HN0	CMP5_LP3	CMP5_LN0	AIO235
A6/PGA5_OF	PGA5_OF	6	6		A6			PGA5_OF		CMP5_HP0		CMP5_LP0		AIO228
C4	G5_ADCC	17	11				C4			CMP5_HP1	CMP5_HN1	CMP5_LP1	CMP5_LN1	AIO239
PGA5_IN	PGA5_IN	16						PGA5_IN						
PGA5_GND	PGA5_GND	13	10	9				PGA5_GND						
-	PGA5_OUT ⁽¹⁾				A14			PGA5_OUT		CMP5_HP4		CMP5_LP4		
Analog Group 6														
A9	G6_ADCAB	38			A9					CMP6_HP3	CMP6_HN0	CMP6_LP3	CMP6_LN0	AIO236
A8/PGA6_OF	PGA6_OF	37			A8			PGA6_OF		CMP6_HP0		CMP6_LP0		AIO229
C5	G6_ADCC	28					C5			CMP6_HP1	CMP6_HN1	CMP6_LP1	CMP6_LN1	AIO240
PGA6_IN	PGA6_IN							PGA6_IN						
PGA6_GND	PGA6_GND	32	20	18				PGA6_GND						
-	PGA6_OUT ⁽¹⁾				A15			PGA6_OUT		CMP6_HP4		CMP6_LP4		
Analog Group 7														
B0	G7_ADCAB	41				B0				CMP7_HP3	CMP7_HN0	CMP7_LP3	CMP7_LN0	AIO241
A10/B1/C10/PGA7_OF	PGA7_OF ⁽²⁾	40	25	23	A10	B1	C10	PGA7_OF		CMP7_HP0		CMP7_LP0		AIO230
C14	G7_ADCC	44					C14			CMP7_HP1	CMP7_HN1	CMP7_LP1	CMP7_LN1	AIO246
PGA7_IN	PGA7_IN	43						PGA7_IN						
PGA7_GND	PGA7_GND	42						PGA7_GND						
-	PGA7_OUT ⁽¹⁾					B12	C11	PGA7_OUT		CMP7_HP4		CMP7_LP4		
Other Analog														
A0/B15/C15/DACA_OUT		23	15	13	A0	B15	C15		DACA_OUT					AIO231
A1/DACB_OUT		22	14	12	A1				DACB_OUT					AIO232
C12							C12							AIO247
-	TempSensor ⁽¹⁾					B14								

(2) PGA functionality not available on 64-pin and 56-pin packages.

Table 5-45. Analog Signal Descriptions

SIGNAL NAME	DESCRIPTION
AIOx	Digital input on ADC pin
Ax	ADC A Input
Bx	ADC B Input
Cx	ADC C Input
CMPx_DACH	Comparator subsystem high DAC output
CMPx_DACL	Comparator subsystem low DAC output
CMPx_HNy	Comparator subsystem high comparator negative input
CMPx_HPy	Comparator subsystem high comparator positive input
CMPx_LNy	Comparator subsystem low comparator negative input
CMPx_LPy	Comparator subsystem low comparator positive input
DACx_OUT	Buffered DAC Output
PGAx_GND	PGA Ground
PGAx_IN	PGA Input
PGAx_OF	PGA Output for filter
PGAx_OUT	PGA Output to internal ADC
TempSensor	Internal temperature sensor
VDAC	Optional external reference voltage for on-chip DACs. There is a 100-pF capacitor to VSSA on this pin whether used for ADC input or DAC reference which cannot be disabled. If this pin is used as a reference for the on-chip DACs, place at least a 1-μF capacitor on this pin.

5.9.1 Analog-to-Digital Converter (ADC)

The ADC module described here is a successive approximation (SAR) style ADC with resolution of 12 bits. This section refers to the analog circuits of the converter as the “core,” and includes the channel-select MUX, the sample-and-hold (S/H) circuit, the successive approximation circuits, voltage reference circuits, and other analog support circuits. The digital circuits of the converter are referred to as the “wrapper” and include logic for programmable conversions, result registers, interfaces to analog circuits, interfaces to the peripheral buses, post-processing circuits, and interfaces to other on-chip modules.

Each ADC module consists of a single sample-and-hold (S/H) circuit. The ADC module is designed to be duplicated multiple times on the same chip, allowing simultaneous sampling or independent operation of multiple ADCs. The ADC wrapper is start-of-conversion (SOC)-based (see the SOC Principle of Operation section of the Analog-to-Digital Converter (ADC) chapter in the [TMS320F28004x Piccolo Microcontrollers Technical Reference Manual](#)).

Each ADC has the following features:

- Resolution of 12 bits
- Ratiometric external reference set by VREFHI/VREFLO
- Selectable internal reference of 2.5 V or 3.3 V
- Single-ended signaling
- Input multiplexer with up to 16 channels
- 16 configurable SOC
- 16 individually addressable result registers
- Multiple trigger sources
 - S/W: software immediate start
 - All ePWMs: ADCSOC A or B
 - GPIO XINT2
 - CPU Timers 0/1/2
 - ADCINT1/2
- Four flexible PIE interrupts
- Burst-mode triggering option
- Four post-processing blocks, each with:
 - Saturating offset calibration
 - Error from setpoint calculation
 - High, low, and zero-crossing compare, with interrupt and ePWM trip capability
 - Trigger-to-sample delay capture

NOTE

Not every channel may be pinned out from all ADCs. See [Section 4](#) to determine which channels are available.

The block diagram for the ADC core and ADC wrapper are shown in Figure 5-32.

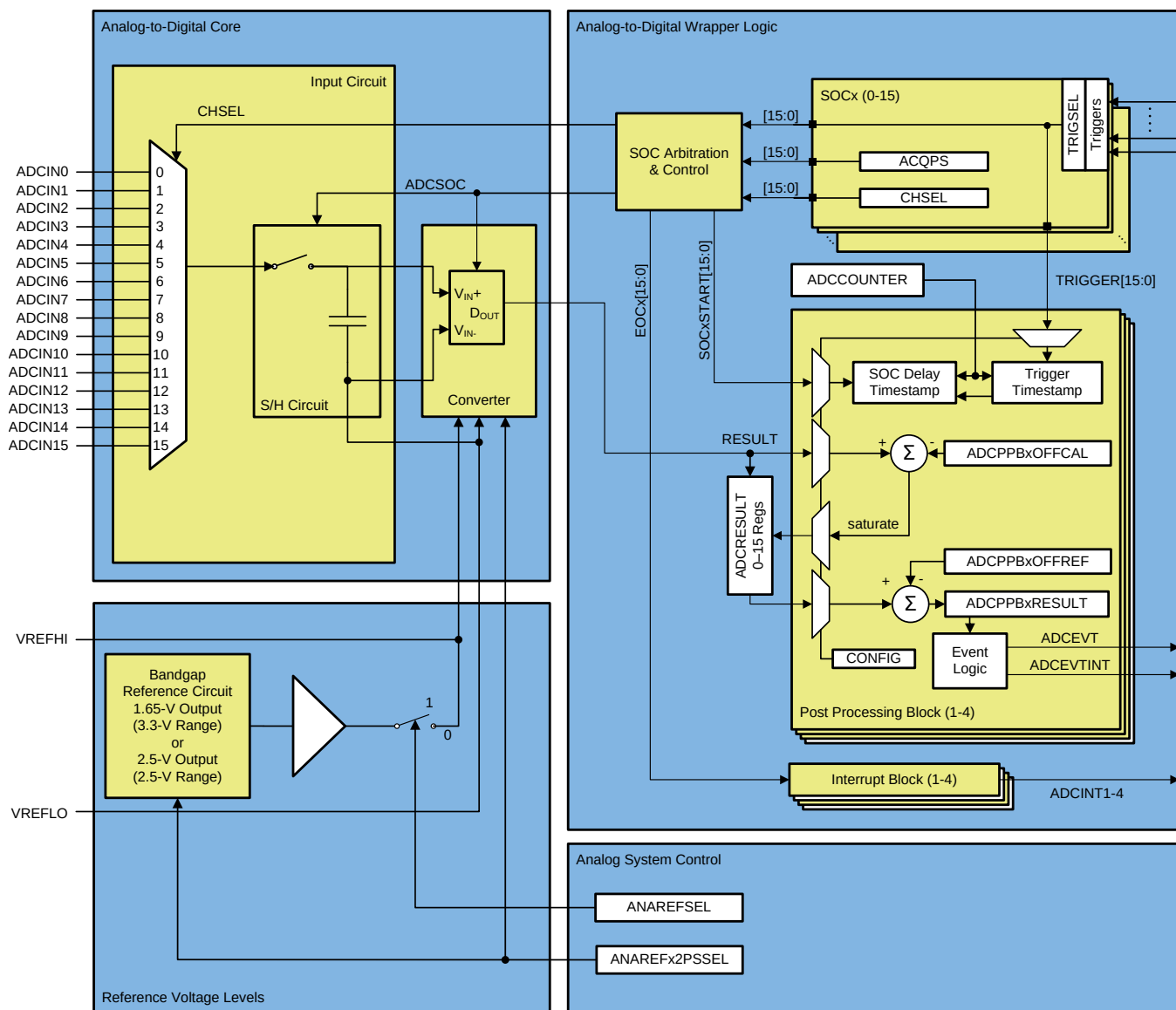


Figure 5-32. ADC Module Block Diagram

ADVANCE INFORMATION

5.9.1.1 ADC Configurability

Some ADC configurations are individually controlled by the SOC's, while others are globally controlled per ADC module. [Table 5-46](#) summarizes the basic ADC options and their level of configurability.

Table 5-46. ADC Options and Configuration Levels

OPTIONS	CONFIGURABILITY
Clock	Per module ⁽¹⁾
Resolution	Not configurable (12-bit resolution only)
Signal mode	Not configurable (single-ended signal mode only)
Reference voltage source	Per module
Trigger source	Per SOC ⁽¹⁾
Converted channel	Per SOC
Acquisition window duration	Per SOC ⁽¹⁾
EOC location	Per module
Burst mode	Per module ⁽¹⁾

- (1) Writing these values differently to different ADC modules could cause the ADCs to operate asynchronously. For guidance on when the ADCs are operating synchronously or asynchronously, see the Ensuring Synchronous Operation section of the Analog-to-Digital Converter (ADC) chapter in the [TMS320F28004x Piccolo Microcontrollers Technical Reference Manual](#).

5.9.1.2 ADC Electrical Data and Timing

Table 5-47 lists the ADC operating conditions. Table 5-48 lists the ADC electrical characteristics.

Table 5-47. ADC Operating Conditions

over operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
ADCCLK (derived from PERx.SYSCLK)		5		50	MHz
Sample rate	100-MHz SYSCLK			3.45	MSPS
Sample window duration (set by ACQPS and PERx.SYSCLK) ⁽¹⁾	With 50 Ω or less R_s	75			ns
VREFHI		2.4	2.5 or 3.0	VDDA	V
VREFLO		VSSA	VSSA	VSSA	V
VREFHI - VREFLO		2.4	3.3	VDDA	V
Conversion range	Internal reference = 3.3 V	0		3.3	V
Conversion range	Internal reference = 2.5 V	0		2.5	V
Conversion range	External reference	VREFLO		VREFHI	V

(1) The sample window must also be at least as long as 1 ADCCLK cycle for correct ADC operation.

NOTE

The ADC inputs should be kept below VDDA + 0.3 V during operation. If an ADC input exceeds this level, the V_{REF} internal to the device may be disturbed, which can impact results for other ADC or DAC inputs using the same V_{REF} .

Table 5-48. ADC Characteristics

over operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
General					
ADCCLK Conversion Cycles	100-MHz SYSCLK	10.1		11	ADCCLKs
Power Up Time	External Reference mode			500	μs
	Internal Reference mode			5000	μs
	Internal Reference mode, when switching between 2.5-V range and 3.3-V range.			5000	μs
VREFHI input current ⁽¹⁾			130		μA
Internal Reference Capacitor Value ⁽²⁾		2.2			μF
External Reference Capacitor Value ⁽²⁾		2.2			μF
DC Characteristics					
Gain Error	Internal reference	−45		45	LSB
	External reference	−7	±3	7	
Offset Error		−5	±2	5	LSB
Channel-to-Channel Gain Error			±2		LSB
Channel-to-Channel Offset Error			±2		LSB
ADC-to-ADC Gain Error	Identical VREFHI and VREFLO for all ADCs		±4		LSB
ADC-to-ADC Offset Error	Identical VREFHI and VREFLO for all ADCs		±2		LSB
DNL Error		>−1	±0.5	1	LSB
INL Error		−2	±1.0	2	LSB
ADC-to-ADC Isolation	VREFHI = 2.5 V, synchronous ADCs	−1		1	LSBs
	VREFHI = 2.5 V, asynchronous ADCs	Not Supported			
AC Characteristics					
SNR ⁽³⁾	VREFHI = 2.5 V, fin = 100 kHz, SYSCLK from X1		68.8		dB
	VREFHI = 2.5 V, fin = 100 kHz, SYSCLK from INTOSC		60.1		
	VREFHI = 2.5 V, fin = 100 kHz, SYSCLK from X1, VDD supplied from internal DC-DC regulator ⁽⁴⁾		67.5		
THD ⁽³⁾	VREFHI = 2.5 V, fin = 100 kHz		−80.6		dB
SFDR ⁽³⁾	VREFHI = 2.5 V, fin = 100 kHz		79.2		dB
SINAD ⁽³⁾	VREFHI = 2.5 V, fin = 100 kHz, SYSCLK from X1		68.5		dB
	VREFHI = 2.5 V, fin = 100 kHz, SYSCLK from INTOSC		60.0		
ENOB ⁽³⁾	VREFHI = 2.5 V, fin = 100 kHz, SYSCLK from X1, Single ADC		11.0		bits
	VREFHI = 2.5 V, fin = 100 kHz, SYSCLK from X1, synchronous ADCs		11.0		
	VREFHI = 2.5 V, fin = 100 kHz, SYSCLK from X1, asynchronous ADCs		Not Supported		

(1) Load current on VREFHI increases when ADC input is greater than VDDA. This causes inaccurate conversions.

(2) A ceramic capacitor with package size of 0805 or smaller is preferred. Up to ±20% tolerance is acceptable.

(3) IO activity is minimized on pins adjacent to ADC input and VREFHI pins as part of best practices to reduce capacitive coupling and crosstalk.

(4) Noise impact from the DCDC regulator to the ADC will be strongly dependent on PCB layout.

Table 5-48. ADC Characteristics (continued)

over operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
PSRR	VDD = 1.2-V DC + 100mV DC up to Sine at 1 kHz		60		dB
	VDD = 1.2-V DC + 100 mV DC up to Sine at 300 kHz		57		
	VDDA = 3.3-V DC + 200 mV DC up to Sine at 1 kHz		60		
	VDDA = 3.3-V DC + 200 mV Sine at 900 kHz		57		

5.9.1.2.1 ADC Input Model

The ADC input characteristics are given by [Table 5-49](#) and [Figure 5-33](#).

Table 5-49. Input Model Parameters

	DESCRIPTION	REFERENCE MODE	VALUE
C_p	Parasitic input capacitance	All	See Table 5-50
R_{on}	Sampling switch resistance	External Reference, 2.5-V Internal Reference	500 Ω
		3.3-V Internal Reference	860 Ω
C_h	Sampling capacitor	External Reference, 2.5-V Internal Reference	12.5 pF
		3.3-V Internal Reference	7.5 pF
R_s	Nominal source impedance	All	50 Ω

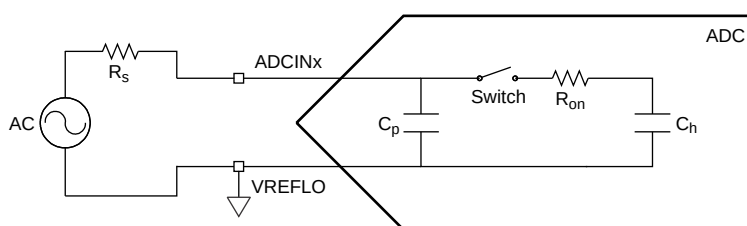


Figure 5-33. Input Model

This input model should be used with actual signal source impedance to determine the acquisition window duration. For more information, see the Choosing an Acquisition Window Duration section of the Analog-to-Digital Converter (ADC) chapter in the [TMS320F28004x Piccolo Microcontrollers Technical Reference Manual](#).

[Table 5-50](#) lists the parasitic capacitance on each channel.

Table 5-50. Per-Channel Parasitic Capacitance

ADC CHANNEL	C _p (pF)	
	COMPARATOR DISABLED	COMPARATOR ENABLED
ADCINA0	12.7	15.2
ADCINA1	13.7	16.2
ADCINA2	9.2	11.7
ADCINA3	6.9	9.4
ADCINA4	9.2	11.7
ADCINA5	7.5	10
ADCINA6	8.0	10.5
ADCINA7	7.0	9.5
ADCINA8	10.0	12.5
ADCINA9	8.1	10.6
ADCINA10	9.3	11.8
ADCINB0	7.1	9.6
ADCINB1	9.3	11.8
ADCINB2	9.6	12.1
ADCINB3 ⁽¹⁾	125.6	128.1
ADCINB4	8.8	11.3
ADCINB5	7.1	9.6
ADCINB6	9.2	11.7
ADCINB8	9.2	11.7
ADCINB15	12.7	15.2
ADCINC0	6.4	8.9
ADCINC1	6.1	8.6
ADCINC2	5.24	7.74
ADCINC3	5.5	8
ADCINC4	6.2	8.7
ADCINC5	5.6	8.1
ADCINC6	9.6	12.1
ADCINC8	8.8	11.3
ADCINC10	9.3	11.8
ADCINC12	4.1	6.6
ADCINC14	4.5	7
ADCINC15	12.7	15.2

(1) This pin is also used to supply reference voltage for COMPDAC and GPDAC, and includes an internal decoupling capacitor.

5.9.1.2.2 ADC Timing Diagrams

Figure 5-34 shows the ADC conversion timings for two SOC's given the following assumptions:

- SOC0 and SOC1 are configured to use the same trigger.
- No other SOC's are converting or pending when the trigger occurs.
- The round-robin pointer is in a state that causes SOC0 to convert first.
- ADCINTSEL is configured to set an ADCINT flag upon end of conversion for SOC0 (whether this flag propagates through to the CPU to cause an interrupt is determined by the configurations in the PIE module).

The following parameters are identified in the timing diagrams:

- The parameter t_{SH} is the duration of the S+H window. At the end of this window, the value on the S+H capacitor becomes the voltage to be converted into a digital value. The duration is given by (ACQPS + 1) SYSCLK cycles. ACQPS can be configured individually for each SOC, so t_{SH} will not necessarily be the same for different SOC's.
- The parameter t_{LAT} is the time from the end of the S+H window until the ADC conversion results latch in the ADCRESULTx register. If the ADCRESULTx register is read before this time, the previous conversion results will be returned.
- The parameter t_{EOC} is the time from the end of the S+H window until the next ADC conversion S+H window can begin. The subsequent sample can start before the conversion results are latched.
- The parameter t_{INT} is the time from the end of the S+H window until an ADCINT flag is set (if configured). If the INTPULSEPOS bit in the ADCCTL1 register is set, this will coincide with the conversion results being latched into the result register. If the bit is cleared to 0, this will coincide with the end of the S+H window and early interrupt mode may be invoked to trigger t_{INT} by SYSCLK cycles immediately. The number of SYSCLK cycles is determined by what is written to the OFFSET field in the ADCINTCYCLE register.

Table 5-51 lists the ADC timings.

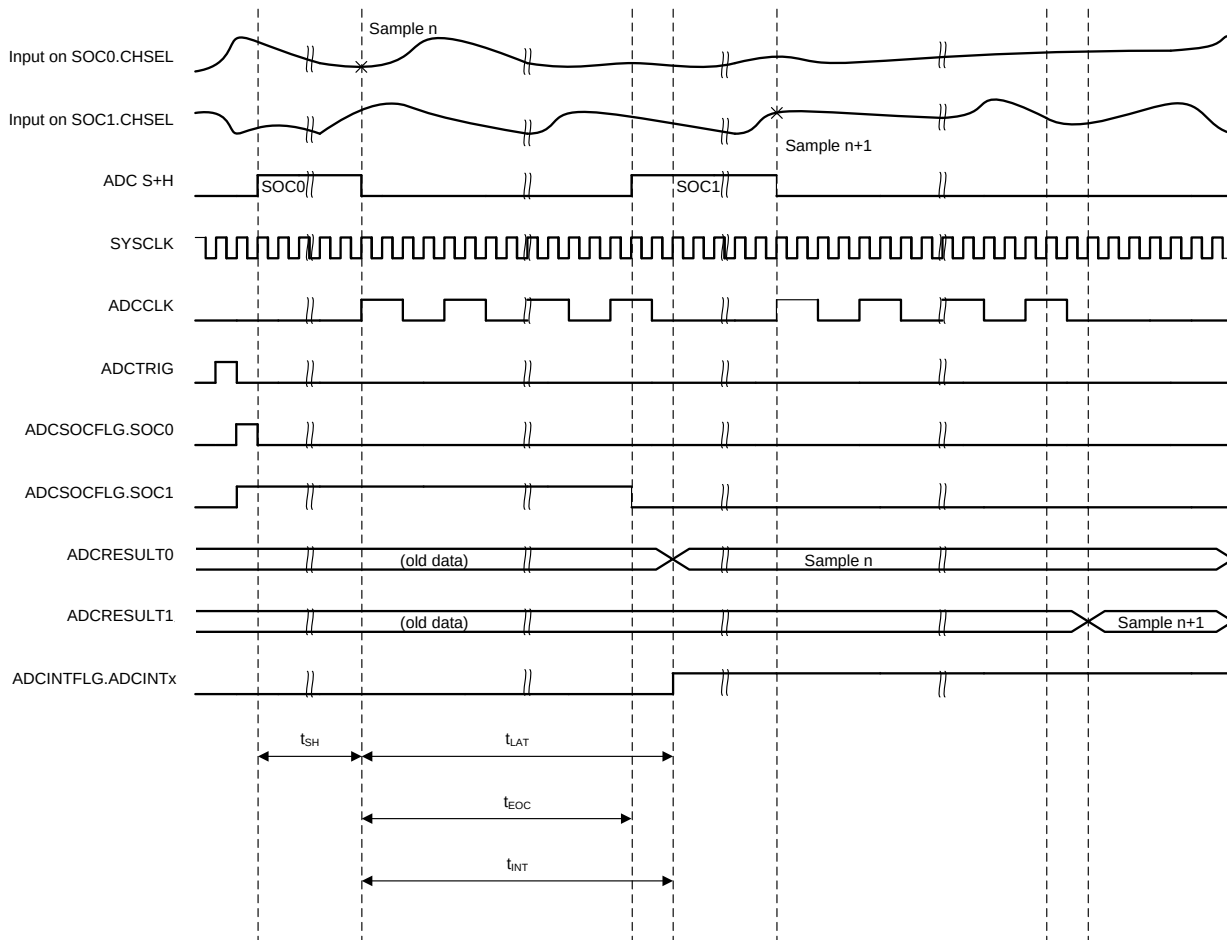


Figure 5-34. ADC Timings

Table 5-51. ADC Timings

ADCCLK PRESCALE		SYSCLK CYCLES				ADCCLK CYCLES
ADCCTL2 [PRESCALE]	RATIO ADCCLK:SYSCLK	t_{EOC}	t_{LAT}	$t_{INT(EARLY)}^{(1)}$	$t_{INT(LATE)}$	t_{EOC}
0	1	11	13	1	11	11
2	2	21	23	1	21	10.5
4	3	31	34	1	31	10.3
6	4	41	44	1	41	10.3
8	5	51	55	1	51	10.2
10	6	61	65	1	61	10.2
12	7	71	76	1	71	10.1
14	8	81	86	1	81	10.1

(1) By default, t_{INT} occurs one SYSCLK cycle after the S+H window if INTPULSEPOS is 0. This can be changed by writing to the OFFSET field in the ADCINTCYCLE register.

5.9.2 Programmable Gain Amplifier (PGA)

The Programmable Gain Amplifier (PGA) is used to amplify an input voltage for the purpose of increasing the effective resolution of the downstream ADC and CMPSS modules.

The integrated PGA helps to reduce cost and design effort for many control applications that traditionally require external, stand-alone amplifiers. On-chip integration ensures that the PGA is compatible with the downstream ADC and CMPSS modules. Software-selectable gain and filter settings make the PGA adaptable to various performance needs.

The PGA has the following features:

- Four programmable gain modes: 3x, 6x, 12x, 24x
- Internally powered by VDDA and VSSA
- Support for Kelvin ground connections using PGA_GND pin
- Embedded series resistors for RC filtering

The active component in the PGA is an embedded operational amplifier (op amp) that is configured as a noninverting amplifier with internal feedback resistors. These internal feedback resistor values are paired to produce software selectable voltage gains.

Three PGA signals are available at the device pins:

- PGA_IN is the positive input to the PGA op amp. The signal applied to this pin will be amplified by the PGA.
- PGA_GND is the Kelvin ground reference for the PGA_IN signal. Ideally, the PGA_GND reference is equal to VSSA; however, the PGA can tolerate small voltage offsets from VSSA.
- PGA_OF supports op amp output filtering with RC components. The filtered signal is available for sampling and monitoring by internal ADC and CMPSS modules. The PGA RFILTER path is not available on some device revisions. See the [TMS320F28004x Piccolo™ Microcontrollers Silicon Errata](#) for more information.

PGA_OUT is an internal signal at the op amp output. It is available for sampling and monitoring by the internal ADC and CMPSS modules. [Figure 5-35](#) shows the PGA block diagram.

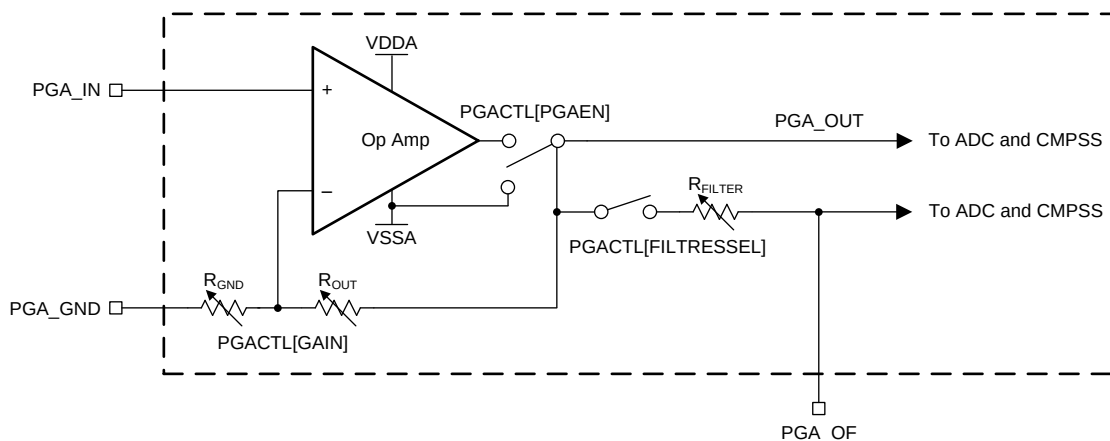


Figure 5-35. PGA Block Diagram

5.9.2.1 PGA Electrical Data and Timing

Table 5-52 lists the PGA characteristics.

Table 5-52. PGA Characteristics

over recommended operating conditions (unless otherwise noted)

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
PGA Output Range ⁽¹⁾		VSSA + 0.35		VDDA – 0.35	V
PGA GND Range		–50		200	mV
Gain Settings			3, 6, 12, 24		
Input Bias Current			<400		nA
Offset Error ⁽²⁾	Input referred	–1.5		1.5	mV
Offset Temp Coefficient	Input referred		±5.5		μV/C
Gain Error ⁽³⁾	Gain = 3, 6, 12	–0.5%		0.5%	
	Gain = 24	–0.8%		0.8%	
Gain Temp Coefficient			±0.004		%/C
Short Circuit Current			35		mA
Min ADC S+H (No Filter; Gain = 3, 6, 12)	Settling within ±1 ADC LSB Accuracy	160			ns
Min ADC S+H (No Filter; Gain = 24)	Settling within ±2 ADC LSB Accuracy	200			ns
Full Scale Step Response (No Filter)	Settling within ±2 ADC LSB Accuracy			450	ns
Slew Rate	Gain = 3	15	20		V/μs
	Gain = 6	31	37		V/μs
	Gain = 12	61	73		V/μs
	Gain = 24	78	98		V/μs
Bandwidth	All gain modes		7		MHz
Settling Time	Gain Switching			10	μs
Integrated Noise (Input referred) ⁽⁴⁾			100		μV
DC Code Spread			2.5		12b LSB
Noise PSD ⁽⁴⁾	1 kHz		200		nV/sqrt(Hz)
THD ⁽⁴⁾	DC		–80		dB
	Up to 100 kHz		–70		dB
PSRR ⁽⁴⁾	DC		–75		dB
	Up to 100 kHz		–50		dB
CMRR	DC		–60		dB
	Up to 100 kHz		–50		dB
R _{GND}	Gain = 3		9		kΩ
	Gain = 6		4.5		kΩ
	Gain = 12		2.25		kΩ
	Gain = 24		1.125		kΩ
R _{OUT}	Gain = 3		18		kΩ
	Gain = 6		22.5		kΩ
	Gain = 12		24.75		kΩ
	Gain = 24		25.875		kΩ

(1) This is the linear output range of the PGA. The PGA can output voltages outside this range, but the voltages will not be linear.

(2) Includes ADC offset error.

(3) Includes ADC gain error.

(4) Performance of PGA alone.

Table 5-52. PGA Characteristics (continued)

over recommended operating conditions (unless otherwise noted)

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Filter Resistor Targets	$R_{FILT} = 200\ \Omega$		190		Ω
	$R_{FILT} = 160\ \Omega$		151		Ω
	$R_{FILT} = 130\ \Omega$		122		Ω
	$R_{FILT} = 100\ \Omega$		93		Ω
	$R_{FILT} = 80\ \Omega$		74		Ω
	$R_{FILT} = 50\ \Omega$		45		Ω
Power-up Time				500	μs

5.9.3 Temperature Sensor

5.9.3.1 Temperature Sensor Electrical Data and Timing

The temperature sensor can be used to measure the device junction temperature. The temperature sensor is sampled through an internal connection to the ADC and translated into a temperature through TI-provided software. When sampling the temperature sensor, the ADC must meet the acquisition time in [Table 5-53](#).

Table 5-53. Temperature Sensor Characteristics

over recommended operating conditions (unless otherwise noted)

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
T_{acc}	Temperature Accuracy	External reference		± 15		$^{\circ}\text{C}$
$t_{startup}$	Start-up time (TSNSCTL[ENABLE] to sampling temperature sensor)			500		μs
t_{acq}	ADC acquisition time		450			ns

5.9.4 Buffered Digital-to-Analog Converter (DAC)

The buffered DAC module consists of an internal 12-bit DAC and an analog output buffer that can drive an external load. For driving even higher loads than typical, a trade-off can be made between load size and output voltage swing. For the load conditions of the buffered DAC, see [Section 5.9.4.1](#). The buffered DAC is a general-purpose DAC that can be used to generate a DC voltage or AC waveforms such as sine waves, square waves, triangle waves and so forth. Software writes to the DAC value register can take effect immediately or can be synchronized with PWMxSYNC events.

Each buffered DAC has the following features:

- 12-bit resolution
- Selectable reference voltage source
- x1 and x2 gain modes when using internal VREFHI
- Ability to synchronize with EPWMxSYNCO

The block diagram for the buffered DAC is shown in [Figure 5-36](#).

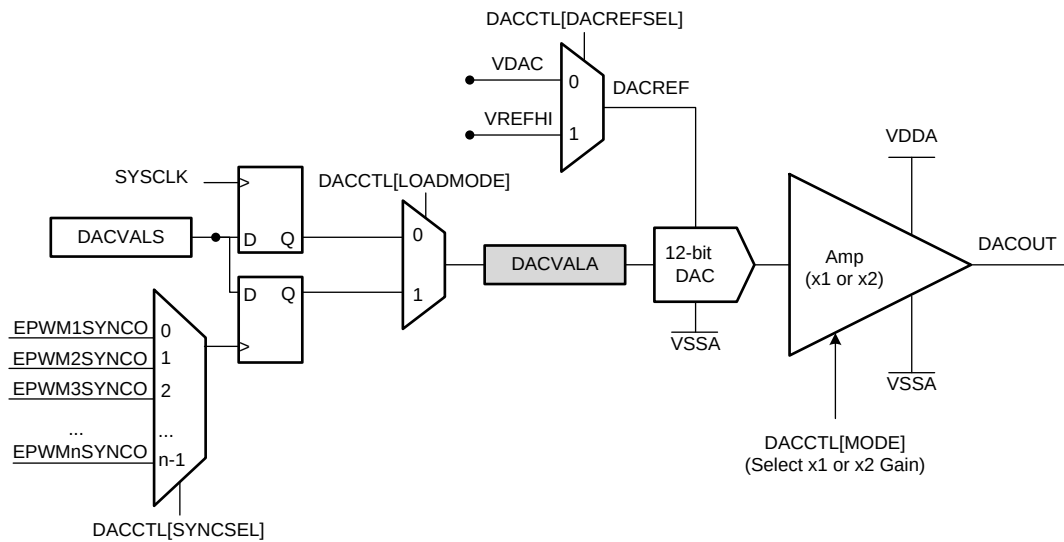


Figure 5-36. DAC Module Block Diagram

5.9.4.1 Buffered DAC Electrical Data and Timing

Table 5-54 lists the buffered DAC electrical characteristics. Figure 5-37 shows the buffered DAC offset. Figure 5-38 shows the buffered DAC gain. Figure 5-39 shows the buffered DAC linearity.

Table 5-54. Buffered DAC Electrical Characteristics

over recommended operating conditions (unless otherwise noted)⁽¹⁾

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
Resolution			12			bits
R _L	Resistive Load ⁽²⁾		5			kΩ
C _L	Capacitive Load		100			pF
V _{OUT}	Valid Output Voltage Range ⁽³⁾	R _L = 5 kΩ	0.3	VDDA – 0.3		V
		R _L = 1 kΩ	0.6	VDDA – 0.6		V
PSRR	Power Supply Rejection Ratio ⁽⁴⁾	DC	70			dB
		100 kHz	30			
Offset	Offset Error	Midpoint	–10	10		mV
Gain	Gain Error ⁽⁵⁾		–2.5	2.5		% of FSR
DNL	Differential Non Linearity ⁽⁶⁾	Endpoint corrected	–1	±0.4	1	LSB
INL	Integral Non Linearity	Endpoint corrected	–5	±2	5	LSB
Load Regulation			–1	1		mV/V
Glitch Energy			1.5			V-ns
Voltage Output Settling Time Full-Scale		Settling to 2 LSBs after 0.3V-to-3V transition	2			μs
Voltage Output Settling Time 1/4 th Full-Scale		Settling to 2 LSBs after 0.3V-to-0.75V transition	1.6			μs
Voltage Output Slew Rate		Slew rate from 0.3V-to-3V transition	2.8	4.5		V/μs
Load Transient Settling Time		5-kΩ Load	328			ns
		1-kΩ Load	557			ns
Output Noise		Integrated noise from 100 Hz to 100 kHz	600			μVrms
		Noise density at 10 kHz	800			nVrms/√Hz
Reference Voltage ⁽⁷⁾		VDAC or VREFHI	2.4	2.5 or 3.0	VDDA	V
Reference Input Resistance ⁽⁸⁾		VDAC or VREFHI	160	200	240	kΩ
SNR	Signal to Noise Ratio	1 kHz, 200 KSPS	64			dB
THD	Total Harmonic Distortion	1 kHz, 200 KSPS	–64.2			dB
SFDR	Spurious Free Dynamic Range	1 kHz, 200 KSPS	66			dB
SINAD	Signal to Noise and Distortion Ratio	1 kHz, 200 KSPS	61.7			dB
TPU	Power Up Time	External Reference mode	500			μs
		Internal Reference mode	5000			μs

- (1) Typical values are measured with VREFHI = 3.3 V and VREFLO = 0 V unless otherwise noted. Minimum and Maximum values are tested or characterized with VREFHI = 2.5 V and VREFLO = 0 V.
- (2) DAC can drive a minimum resistive load of 1 kΩ but output range will be limited.
- (3) This is the linear output range of the DAC. The DAC can generate voltages outside this range, but the output voltage will not be linear due to the buffer.
- (4) VREFHI = 3.2 V, VDDA = 3.3 V DC + 100 mV Sine.
- (5) Gain error is calculated for linear output range.
- (6) The DAC output is monotonic.
- (7) For best PSRR performance, VDAC or VREFHI should be less than VDDA.
- (8) Per active Buffered DAC module.

NOTE

The VDAC pin must be kept below $V_{DDA} + 0.3\text{ V}$ to ensure proper functional operation. If the VDAC pin exceeds this level, a blocking circuit may activate, and the internal value of VDAC may float to 0 V internally, giving improper DAC output.

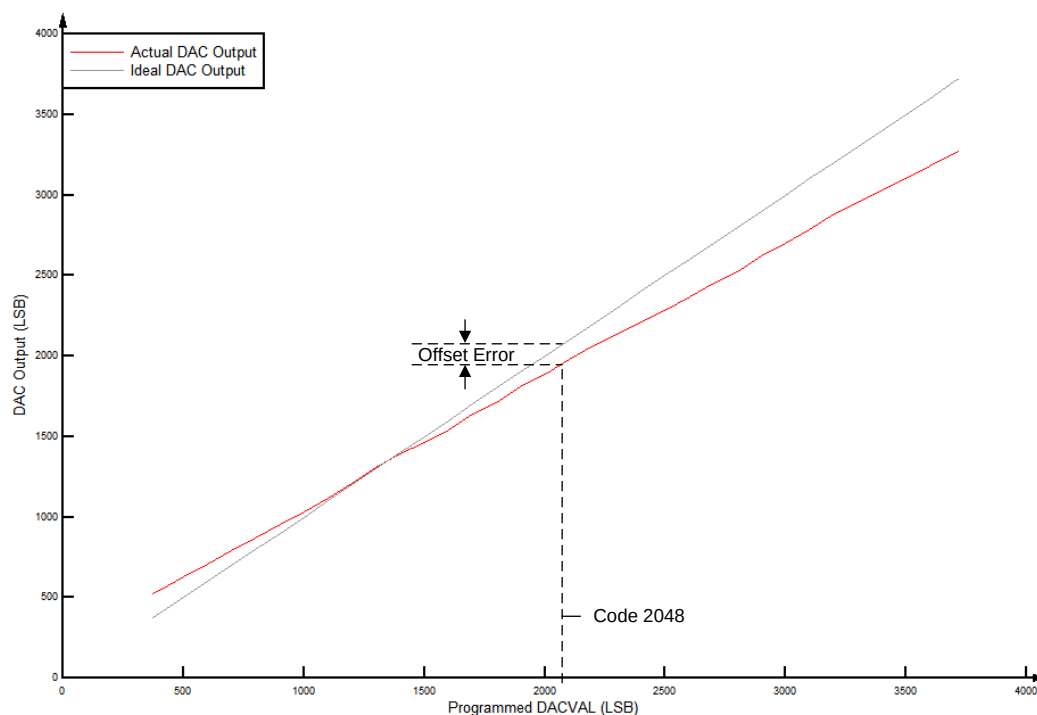


Figure 5-37. Buffered DAC Offset

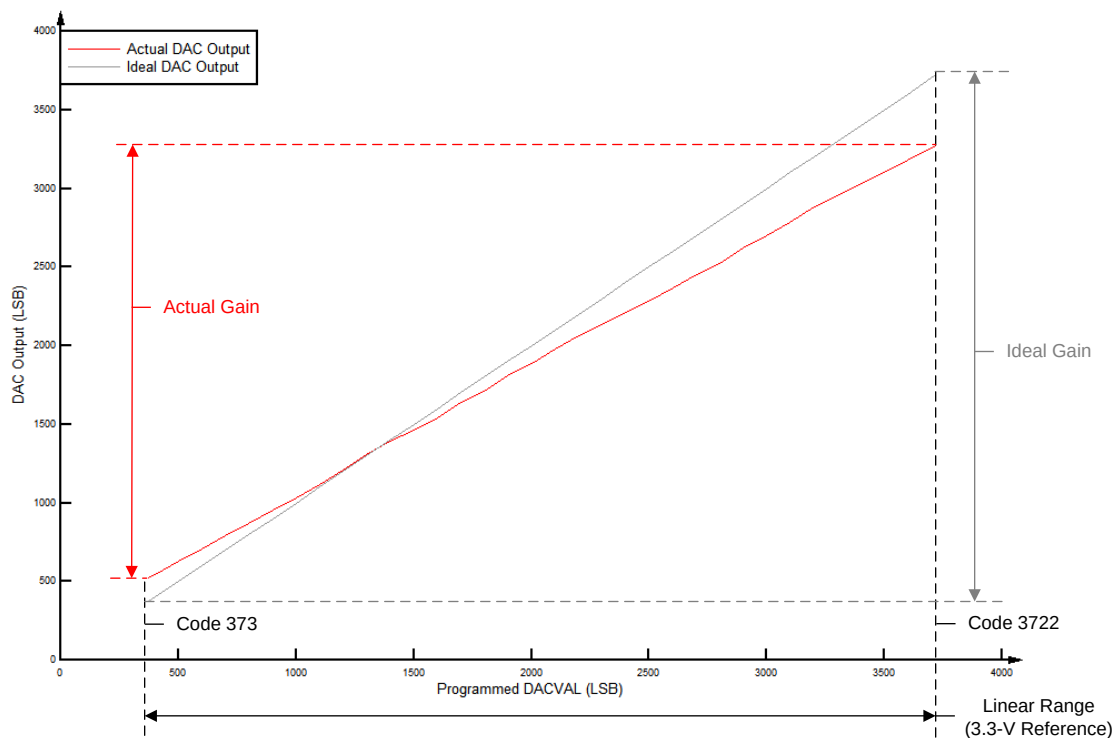


Figure 5-38. Buffered DAC Gain

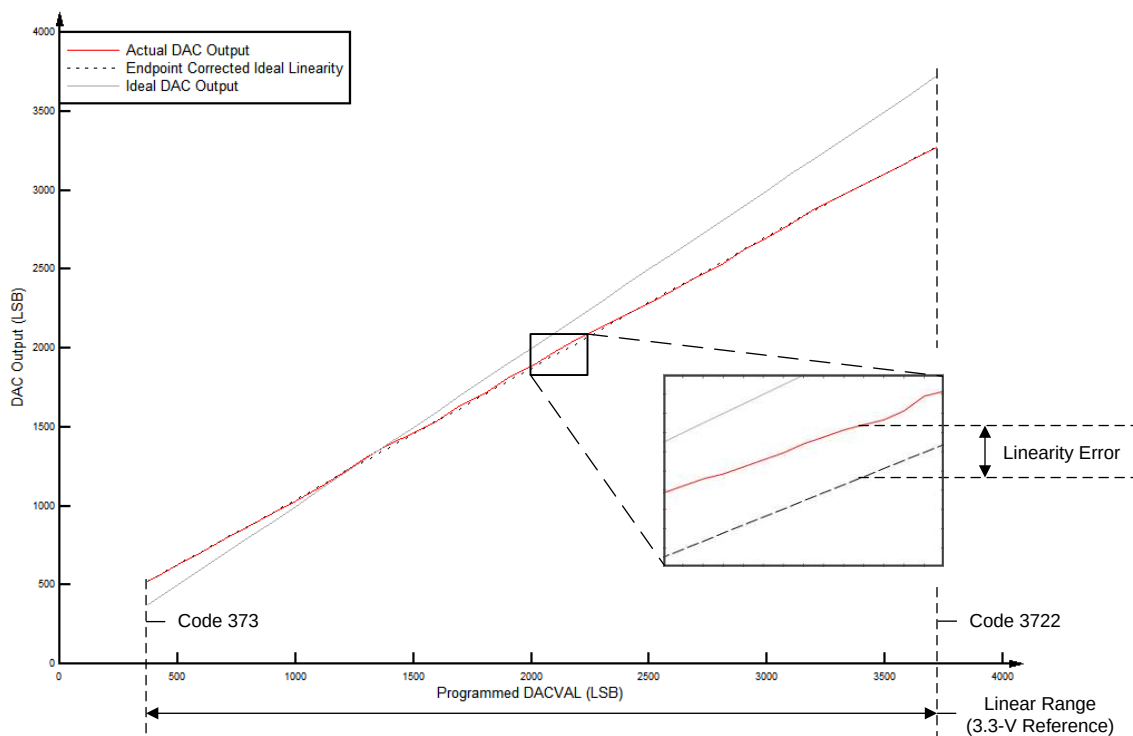


Figure 5-39. Buffered DAC Linearity

5.9.5 Comparator Subsystem (CMPSS)

Each CMPSS contains two comparators, two reference 12-bit DACs, two digital filters, and one ramp generator. Comparators are denoted "H" or "L" within each module, where "H" and "L" represent high and low, respectively. Each comparator generates a digital output that indicates whether the voltage on the positive input is greater than the voltage on the negative input. The positive input of the comparator can be driven from an external pin or by the PGA. The negative input can be driven by an external pin or by the programmable reference 12-bit DAC. Each comparator output passes through a programmable digital filter that can remove spurious trip signals. An unfiltered output is also available if filtering is not required. A ramp generator circuit is optionally available to control the reference 12-bit DAC value for the high comparator in the subsystem. There are two outputs from each CMPSS module. These two outputs pass through the digital filters and crossbar before connecting to the ePWM modules or GPIO pin. Figure 5-40 shows the CMPSS connectivity on the 100-pin PZ package. shows the CMPSS connectivity on the 64-pin PM package. shows the CMPSS connectivity on the 56-pin RSH package.

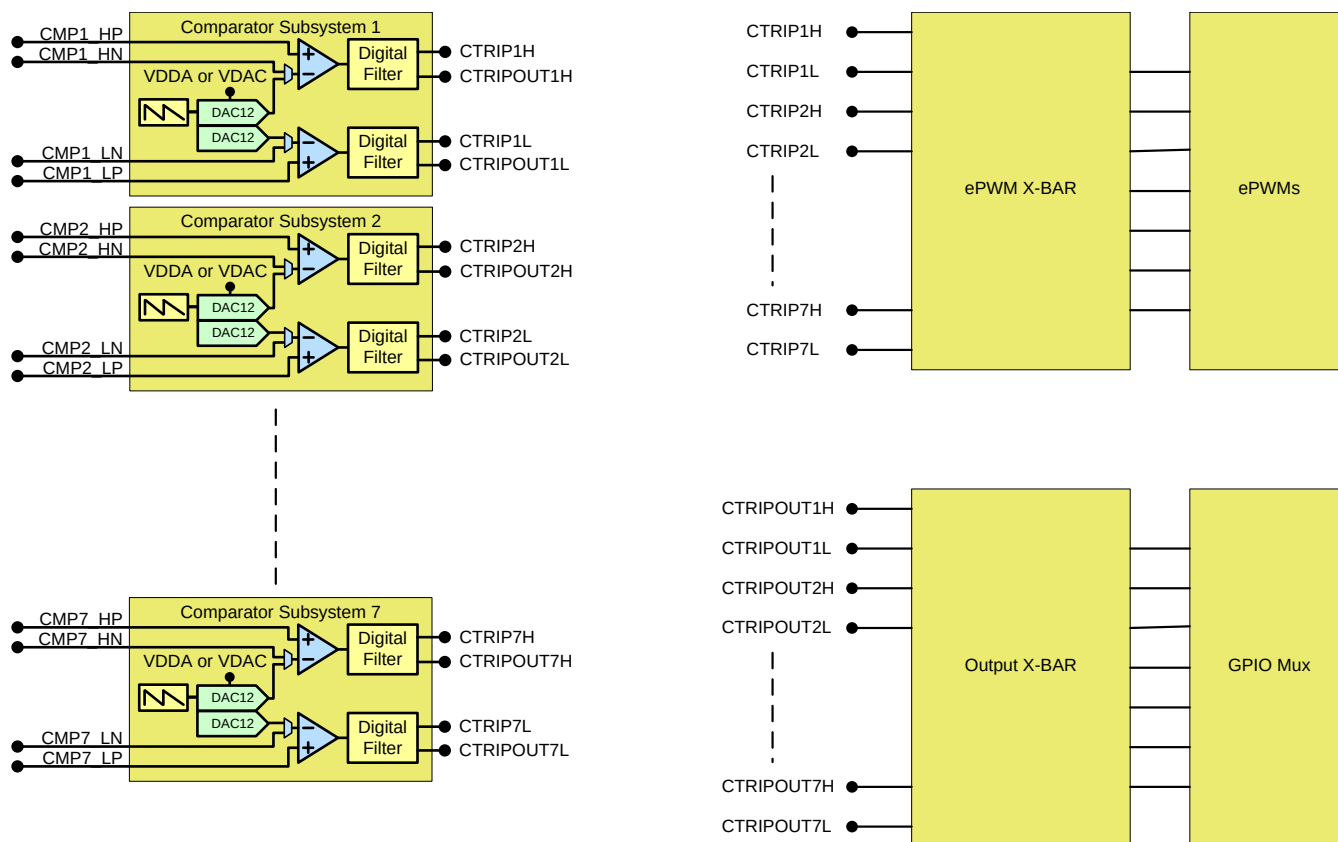


Figure 5-40. CMPSS Connectivity

NOTE

Not all packages have all CMPSS pins. See [Table 5-44](#).

5.9.5.1 CMPSS Electrical Data and Timing

Table 5-55 lists the comparator electrical characteristics. Figure 5-41 shows the CMPSS comparator input referred offset. Figure 5-42 shows the CMPSS comparator hysteresis.

Table 5-55. Comparator Electrical Characteristics

over recommended operating conditions (unless otherwise noted)

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
TPU Power-up time				500	μs
Comparator input (CMPINxx) range		0		VDDA	V
Input referred offset error		–20		20	mV
Hysteresis ⁽¹⁾	1x		12		LSB
	2x		24		
	3x		36		
	4x		48		
Response time (delay from CMPINx input change to output on ePWM X-BAR or Output X-BAR)	Step response		21	60	ns
	Ramp response (1.65V/μs)		26		
	Ramp response (8.25mV/μs)		30		
PSRR Power Supply Rejection Ratio	Up to 250 kHz		46		dB
CMRR Common Mode Rejection Ratio		40			dB

- (1) The CMPSS DAC is used as the reference to determine how much hysteresis to apply. Therefore, hysteresis will scale with the CMPSS DAC reference voltage. Hysteresis is available for all comparator input source configurations.

NOTE

The CMPSS inputs must be kept below VDDA + 0.3 V to ensure proper functional operation. If a CMPSS input exceeds this level, an internal blocking circuit isolates the internal comparator from the external pin until the external pin voltage returns below VDDA + 0.3 V. During this time, the internal comparator input is floating and can decay below VDDA within approximately 0.5 μs. After this time, the comparator could begin to output an incorrect result depending on the value of the other comparator input.

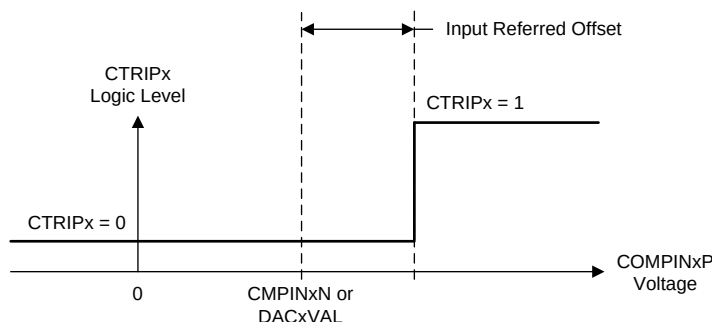


Figure 5-41. CMPSS Comparator Input Referred Offset

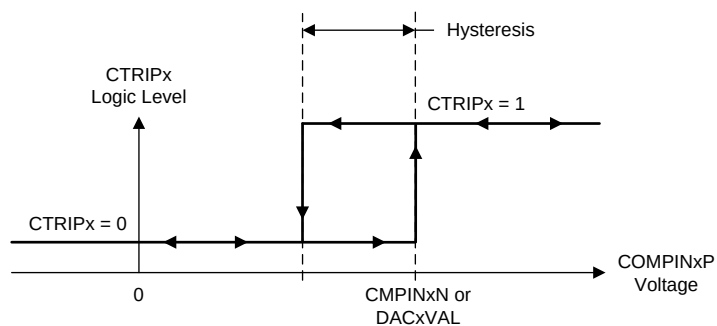


Figure 5-42. CMPSS Comparator Hysteresis

Table 5-56 lists the CMPSS DAC static electrical characteristics. Figure 5-43 shows the CMPSS DAC static offset. Figure 5-44 shows the CMPSS DAC static gain. Figure 5-45 shows the CMPSS DAC static linearity.

Table 5-56. CMPSS DAC Static Electrical Characteristics

over recommended operating conditions (unless otherwise noted)

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
CMPSS DAC output range	Internal reference	0		VDDA	V
	External reference	0		VDAC ⁽¹⁾	
Static offset error ⁽²⁾		–25		25	mV
Static gain error ⁽²⁾		–2		2	% of FSR
Static DNL	Endpoint corrected	>–1		4	LSB
Static INL	Endpoint corrected	–16		16	LSB
Settling time	Settling to 1LSB after full-scale output change			1	μs
Resolution			12		bits
CMPSS DAC output disturbance ⁽³⁾	Error induced by comparator trip or CMPSS DAC code change within the same CMPSS module	–100		100	LSB
CMPSS DAC disturbance time ⁽³⁾				200	ns
VDAC reference voltage	When VDAC is reference	2.4	2.5 or 3.0	VDDA	V
VDAC load ⁽⁴⁾	When VDAC is reference	6	8	10	kΩ

- (1) The maximum output voltage is VDDA when VDAC > VDDA.
(2) Includes comparator input referred errors.
(3) Disturbance error may be present on the CMPSS DAC output for a certain amount of time after a comparator trip.
(4) Per active CMPSS module.

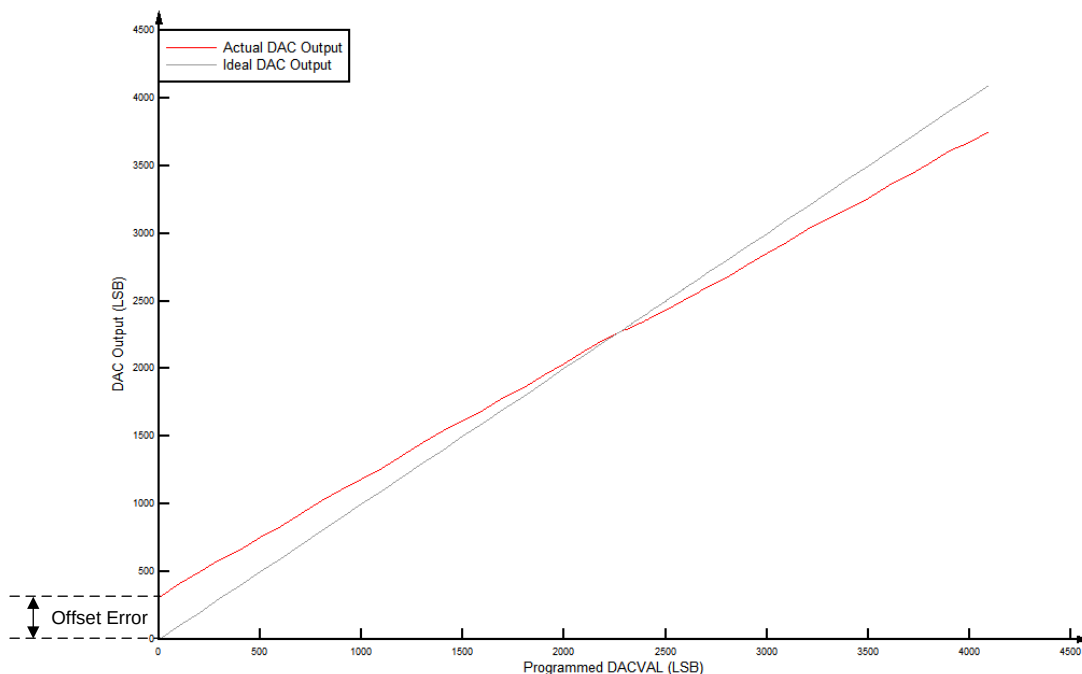


Figure 5-43. CMPSS DAC Static Offset

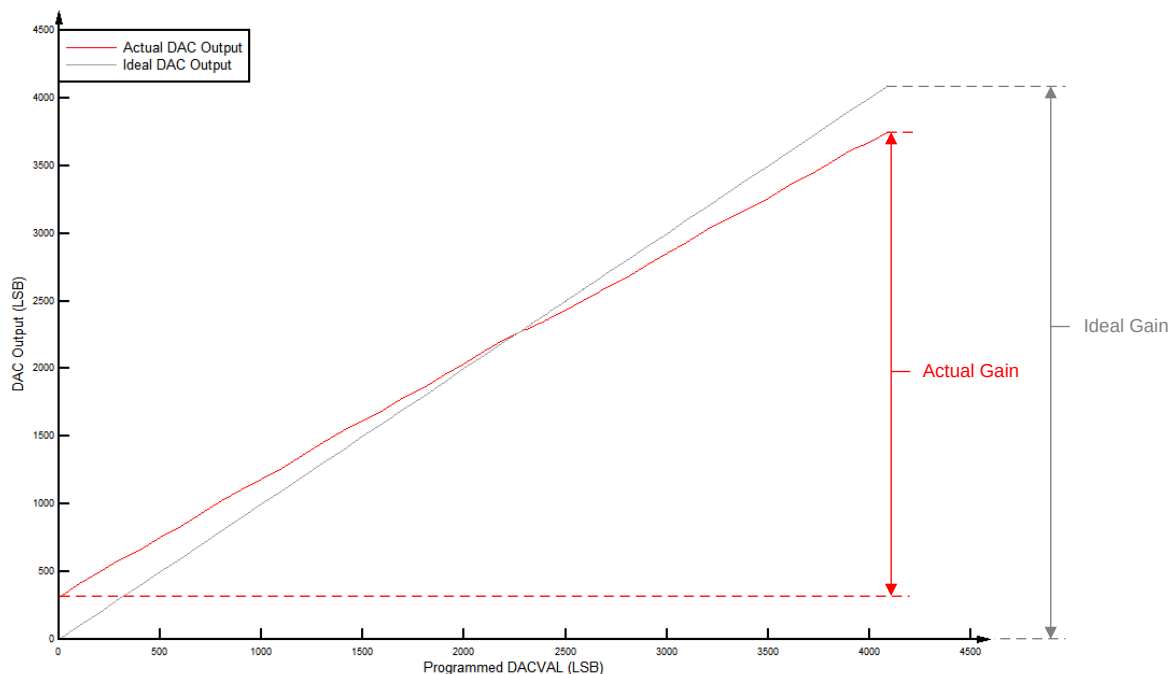


Figure 5-44. CMPSS DAC Static Gain

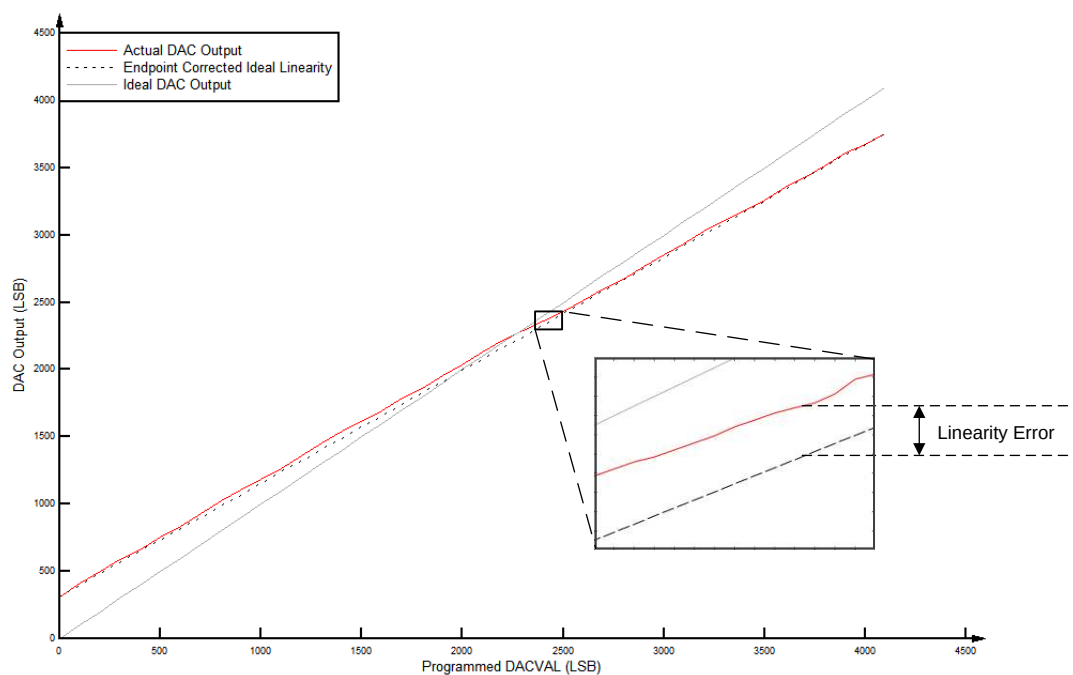


Figure 5-45. CMPSS DAC Static Linearity

5.10 Control Peripherals

5.10.1 Enhanced Capture (eCAP)

The Type 1 enhanced capture (eCAP) module is used in systems where accurate timing of external events is important.

Applications for the eCAP module include:

- Speed measurements of rotating machinery (for example, toothed sprockets sensed through Hall sensors)
- Elapsed time measurements between position sensor pulses
- Period and duty cycle measurements of pulse train signals
- Decoding current or voltage amplitude derived from duty cycle encoded current/voltage sensors

The eCAP module includes the following features:

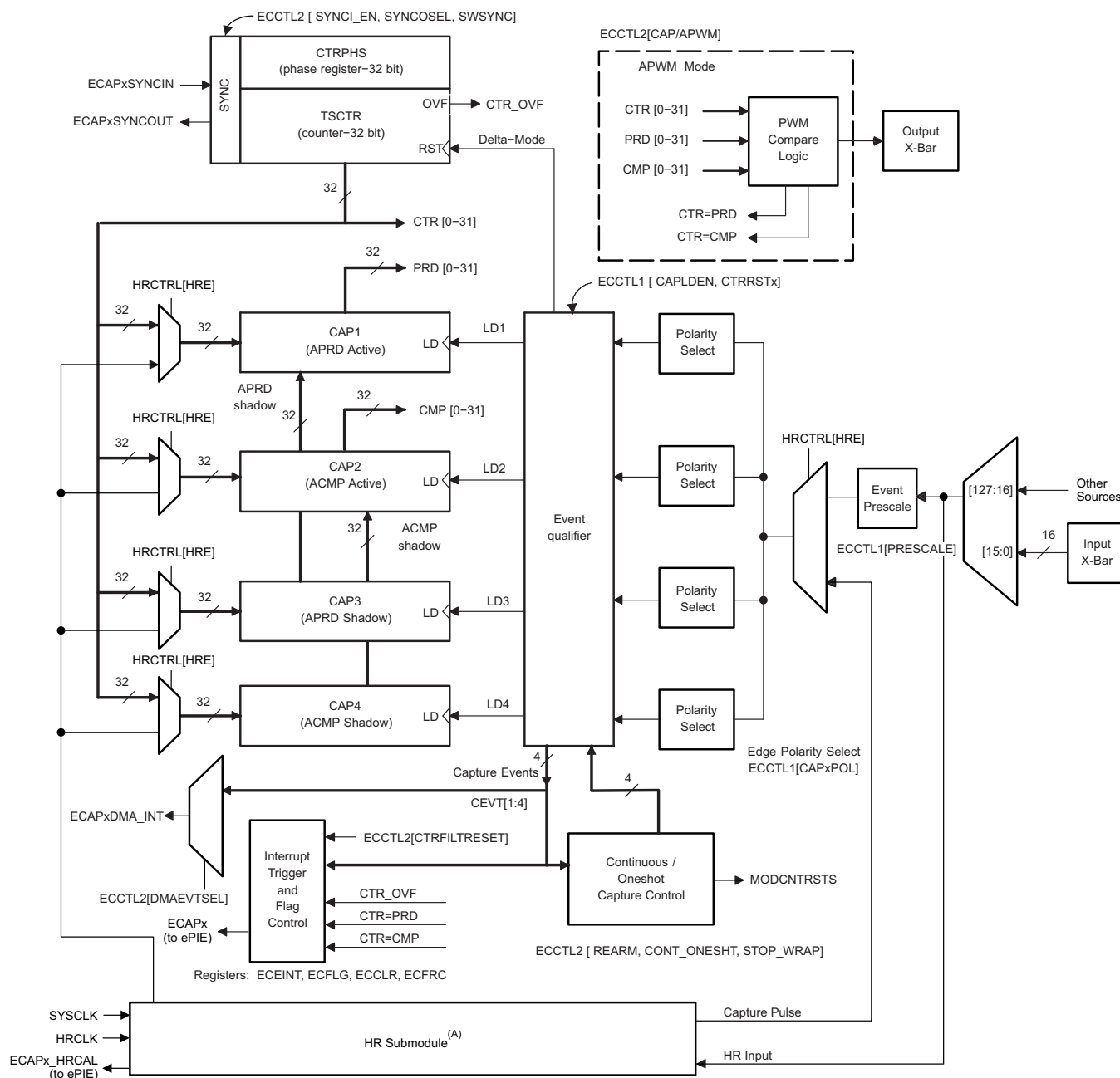
- 4-event time-stamp registers (each 32 bits)
- Edge polarity selection for up to four sequenced time-stamp capture events
- CPU interrupt on any one of the four events
- Independent DMA trigger
- Single-shot capture of up to four event timestamps
- Continuous mode capture of timestamps in a 4-deep circular buffer
- Absolute time-stamp capture
- Difference (Delta) mode time-stamp capture
- 128:1 input multiplexer
- Event Prescaler
- When not used in capture mode, the eCAP module can be configured as a single channel PWM output.

The capture functionality of the Type-1 eCAP is enhanced from the Type-0 eCAP with the following added features:

- Event filter reset bit
 - Writing a 1 to ECCTL2[CTRFILTRERESET] will clear the event filter, the modulo counter, and any pending interrupts flags. This is useful for initialization and debug.
- Modulo counter status bits
 - The modulo counter (ECCTL2[MODCTRSTS]) indicates which capture register will be loaded next. In the Type-0 eCAP, it was not possible to know the current state of modulo counter.
- DMA trigger source
 - eCAPxDMA was added as a DMA trigger. CEVT[1–4] can be configured as the source for eCAPxDMA.
- Input multiplexer
 - ECCTL0[INPUTSEL] selects one of 128 input signals.
- EALLOW protection
 - EALLOW protection was added to critical registers.

The Input X-BAR must be used to connect the device input pins to the module. The Output X-BAR must be used to connect output signals to the OUTPUTXBARx output locations. See [Section 4.4.3](#) and [Section 4.4.4](#).

[Figure 5-46](#) shows the eCAP block diagram.



A. The HRCAP submodule is available on all eCAP modules; in this case, the high-resolution muxes and hardware are not implemented.

Figure 5-46. eCAP Block Diagram

5.10.1.1 eCAP Electrical Data and Timing

[Table 5-57](#) lists the eCAP timing requirements. [Table 5-58](#) lists the eCAP switching characteristics.

Table 5-57. eCAP Timing Requirements

		MIN	NOM	MAX	UNIT
$t_{W(CAP)}$	Capture input pulse width	Asynchronous			ns
		Synchronous			
		With input qualifier			
		$1t_{c(SCO)} + t_w \text{ (OSW)}$			

Table 5-58. eCAP Switching Characteristics

over recommended operating conditions (unless otherwise noted)

PARAMETER	MIN	TYP	MAX	UNIT
$t_{W(APWM)}$ Pulse duration, APWMx output high/low	20			ns

5.10.2 High-Resolution Capture Submodule (HRCAP6–HRCAP7)

The device contains up to two high-resolution capture (HRCAP) submodules. The HRCAP submodule measures the difference, in time, between pulses asynchronously to the system clock. This submodule is new to the eCAP Type 1 module, and features many enhancements over the Type 0 HRCAP module.

Applications for the HRCAP include:

- Capacitive touch applications
- High-resolution period and duty-cycle measurements of pulse train cycles
- Instantaneous speed measurements
- Instantaneous frequency measurements
- Voltage measurements across an isolation boundary
- Distance/sonar measurement and scanning
- Flow measurements

The HRCAP submodule includes the following features:

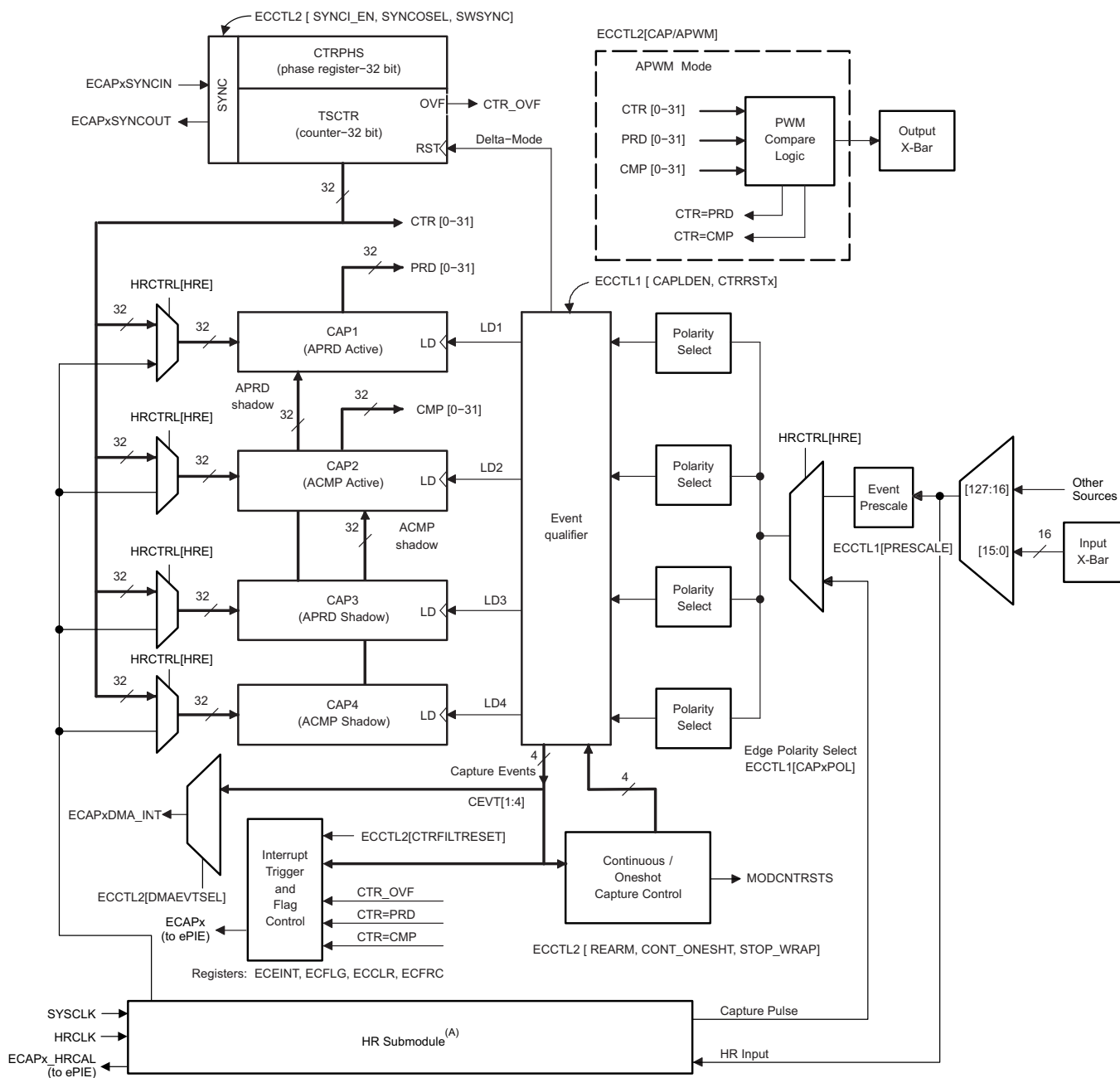
- Pulse-width capture in either non-high-resolution or high-resolution modes
- Absolute mode pulse-width capture
- Continuous or "one-shot" capture
- Capture on either falling or rising edge
- Continuous mode capture of pulse widths in 4-deep buffer
- Hardware calibration logic for precision high-resolution capture
- All of the resources in this list are available on any pin using the Input X-BAR.

The HRCAP submodule includes one high-resolution capture channel in addition to a calibration block. The calibration block allows the HRCAP submodule to be continually recalibrated, at a set interval, with no "down time". Because the HRCAP submodule now uses the same hardware as its respective eCAP, if the HRCAP is used, the corresponding eCAP will be unavailable.

Each high-resolution-capable channel has the following independent key resources.

- All hardware of the respective eCAP
- High-resolution calibration logic
- Dedicated calibration interrupt

[Figure 5-47](#) shows the HRCAP block diagram.



A. The HRCAP submodule is available on all eCAP modules; in this case, the high-resolution muxes and hardware are not implemented.

Figure 5-47. HRCAP Block Diagram

5.10.2.1 HRCAP Electrical Data and Timing

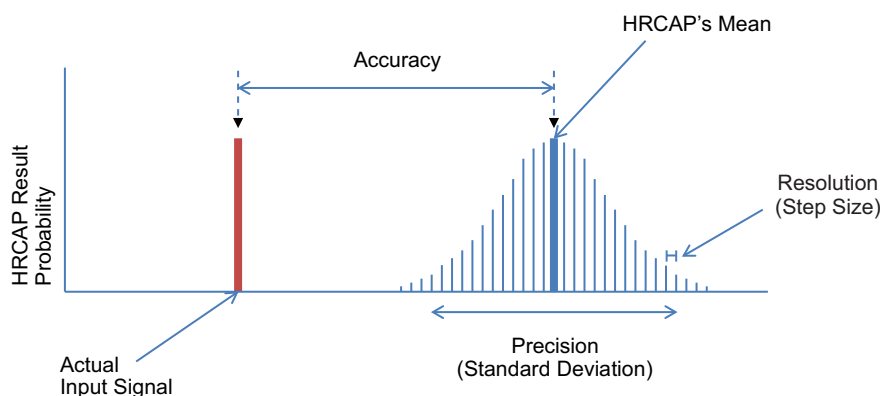
Table 5-59 lists the HRCAP switching characteristics. Figure 5-48 shows the HRCAP accuracy precision and resolution. Figure 5-49 shows the HRCAP standard deviation characteristics.

Table 5-59. HRCAP Switching Characteristics

over recommended operating conditions (unless otherwise noted)

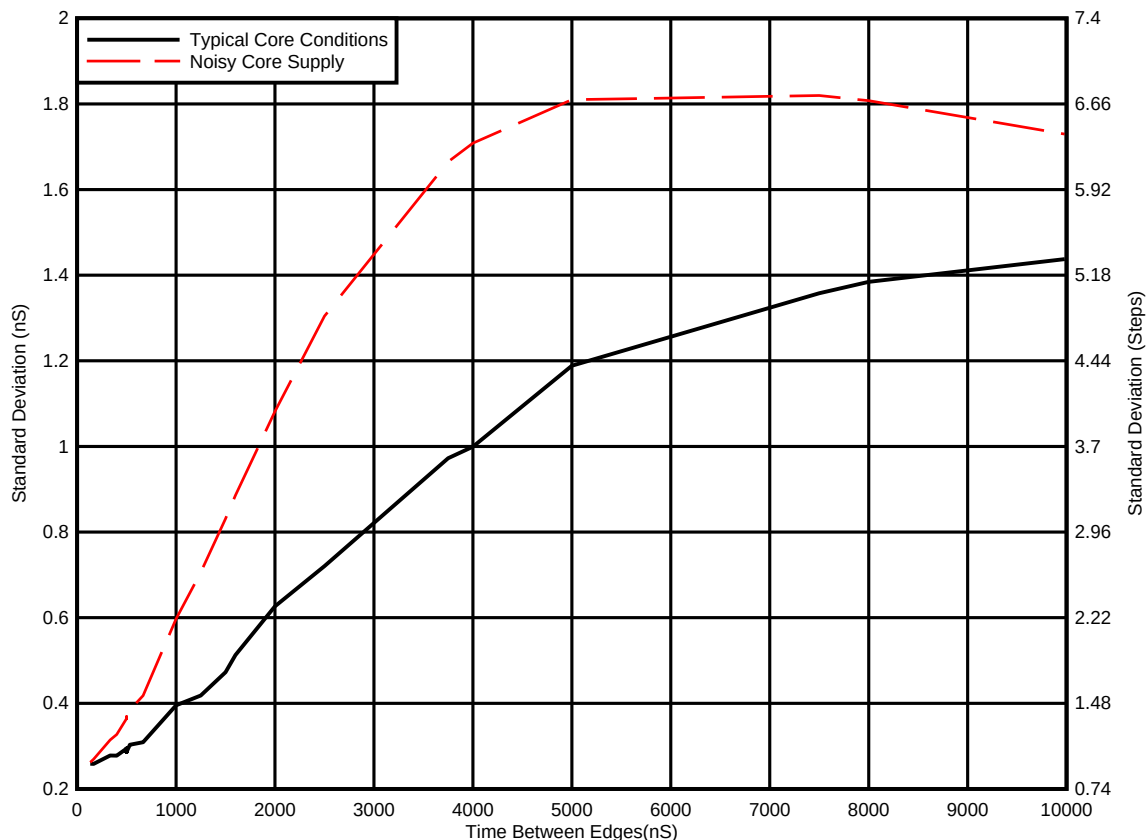
PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Input pulse width		110			ns
Accuracy ⁽¹⁾⁽²⁾⁽³⁾⁽⁴⁾	Measurement length $\leq 5 \mu\text{s}$		± 390	540	ps
	Measurement length $> 5 \mu\text{s}$		± 450	1450	ps
Standard deviation		See Figure 5-49			
Resolution			300		ps

- (1) Value obtained using an oscillator of 100 PPM, oscillator accuracy directly affects the HRCAP accuracy.
- (2) Measurement is completed using rising-rising or falling-falling edges
- (3) Opposite polarity edges will have an additional inaccuracy due to the difference between V_{IH} and V_{IL} . This effect is dependent on the signal's slew rate.
- (4) Accuracy only applies to time-converted measurements.



- A. The HRCAP has some variation in performance, this results in a probability distribution which is described using the following terms:
- Accuracy: The time difference between the input signal and the mean of the HRCAP's distribution.
 - Precision: The width of the HRCAP's distribution, this is given as a standard deviation.
 - Resolution: The minimum measurable increment.

Figure 5-48. HRCAP Accuracy Precision and Resolution



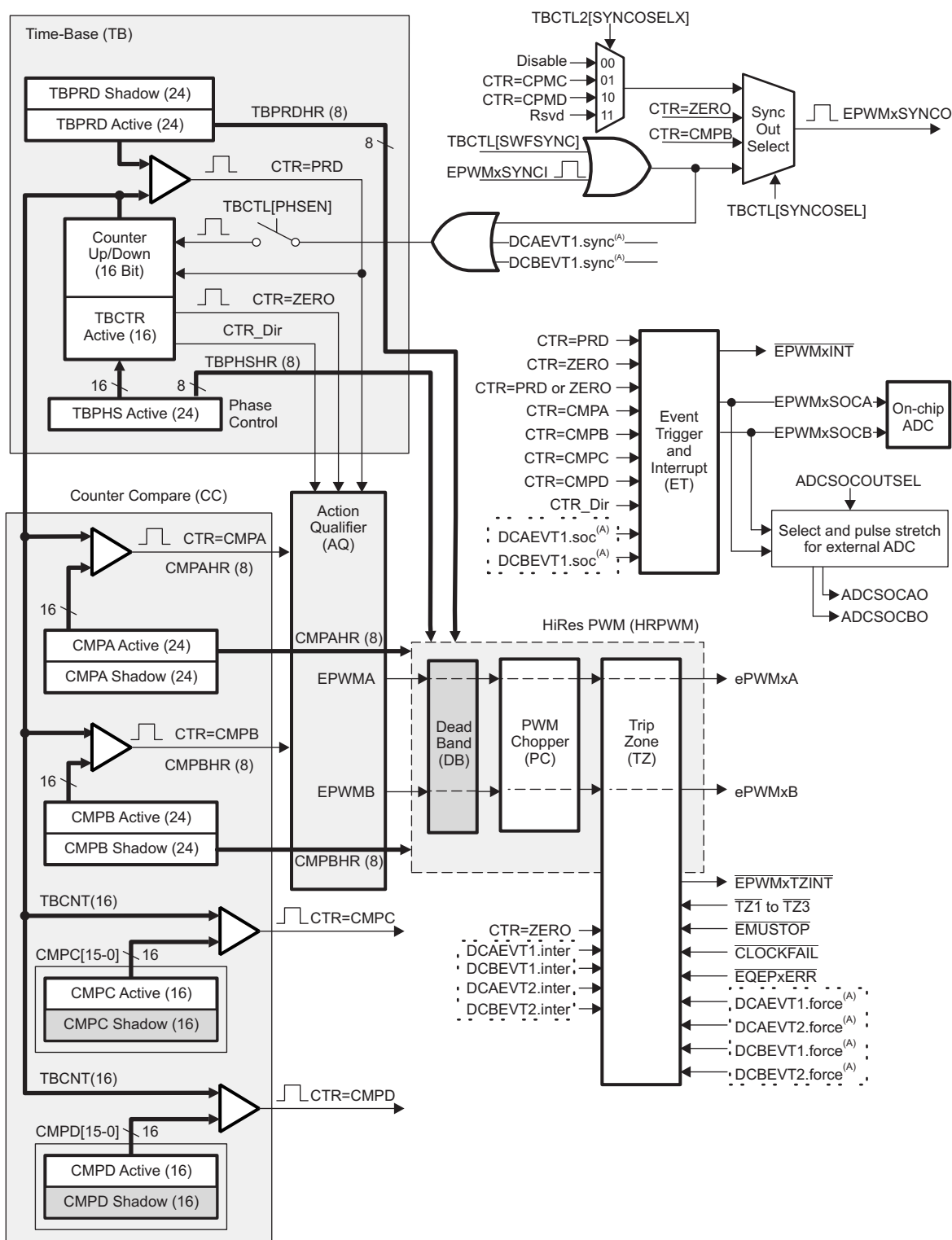
- Typical core conditions: All peripheral clocks are enabled.
- Noisy core supply: All core clocks are enabled and disabled with a regular period during the measurement. This resulted in the 1.2-V rail experiencing a 18.5-mA swing during the measurement.
- Fluctuations in current and voltage on the 1.2-V rail cause the standard deviation of the HRCAP to rise. Care should be taken to ensure that the 1.2-V supply is clean, and that noisy internal events, such as enabling and disabling clock trees, have been minimized while using the HRCAP.

Figure 5-49. HRCAP Standard Deviation Characteristics

5.10.3 Enhanced Pulse Width Modulator (ePWM)

The ePWM peripheral is a key element in controlling many of the power electronic systems found in both commercial and industrial equipment. The ePWM type-4 module generates complex pulse width waveforms with minimal CPU overhead. Some of the highlights of the ePWM type-4 module include complex waveform generation, dead-band generation, a flexible synchronization scheme, advanced trip-zone functionality, and global register reload capabilities.

[Figure 5-50](#) shows the signal interconnections with the ePWM. [Figure 5-51](#) shows the ePWM trip input connectivity.

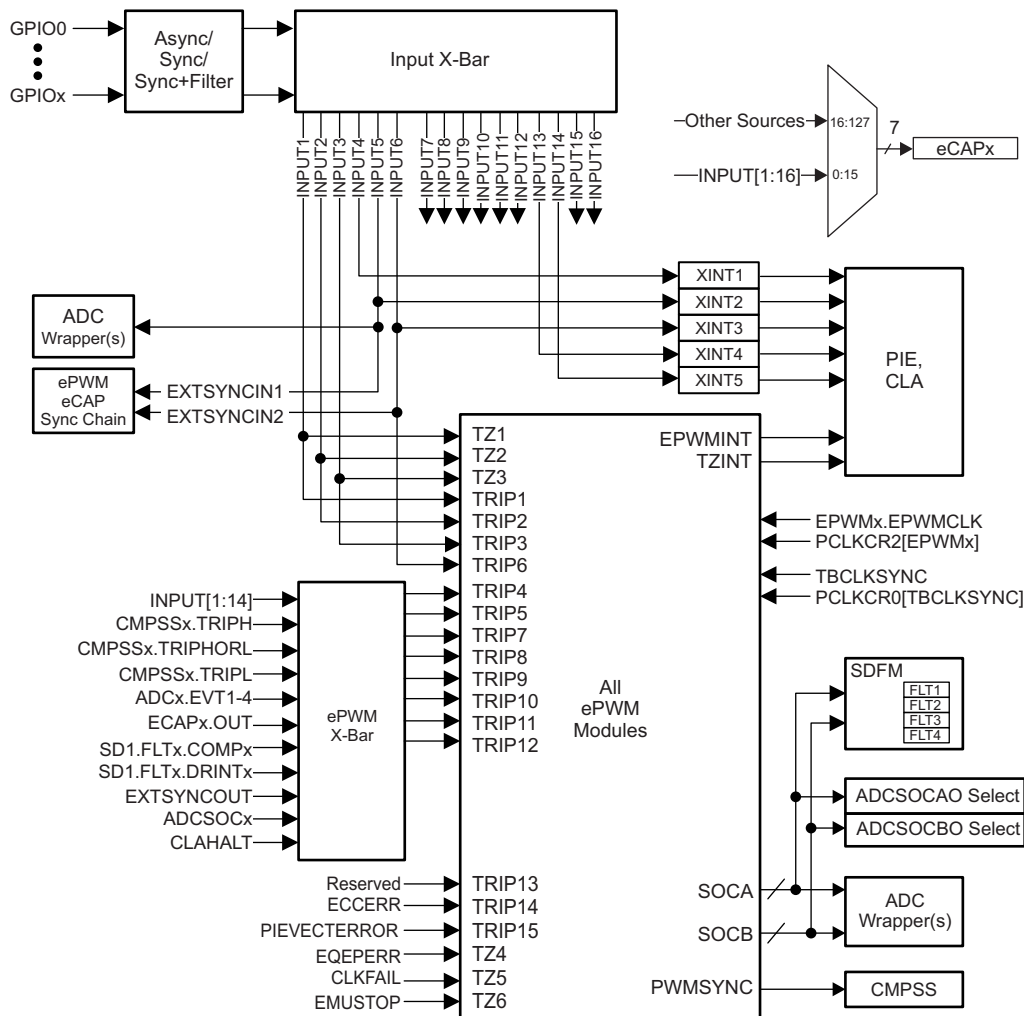


ADVANCE INFORMATION

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- A. These events are generated by the ePWM digital compare (DC) submodule based on the levels of the TRIPIN inputs.

Figure 5-50. ePWM Submodules and Critical Internal Signal Interconnects



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Figure 5-51. ePWM Trip Input Connectivity

5.10.3.1 Control Peripherals Synchronization

The ePWM and eCAP Synchronization Chain allows synchronization between multiple modules for the system. Figure 5-52 shows the Synchronization Chain Architecture.

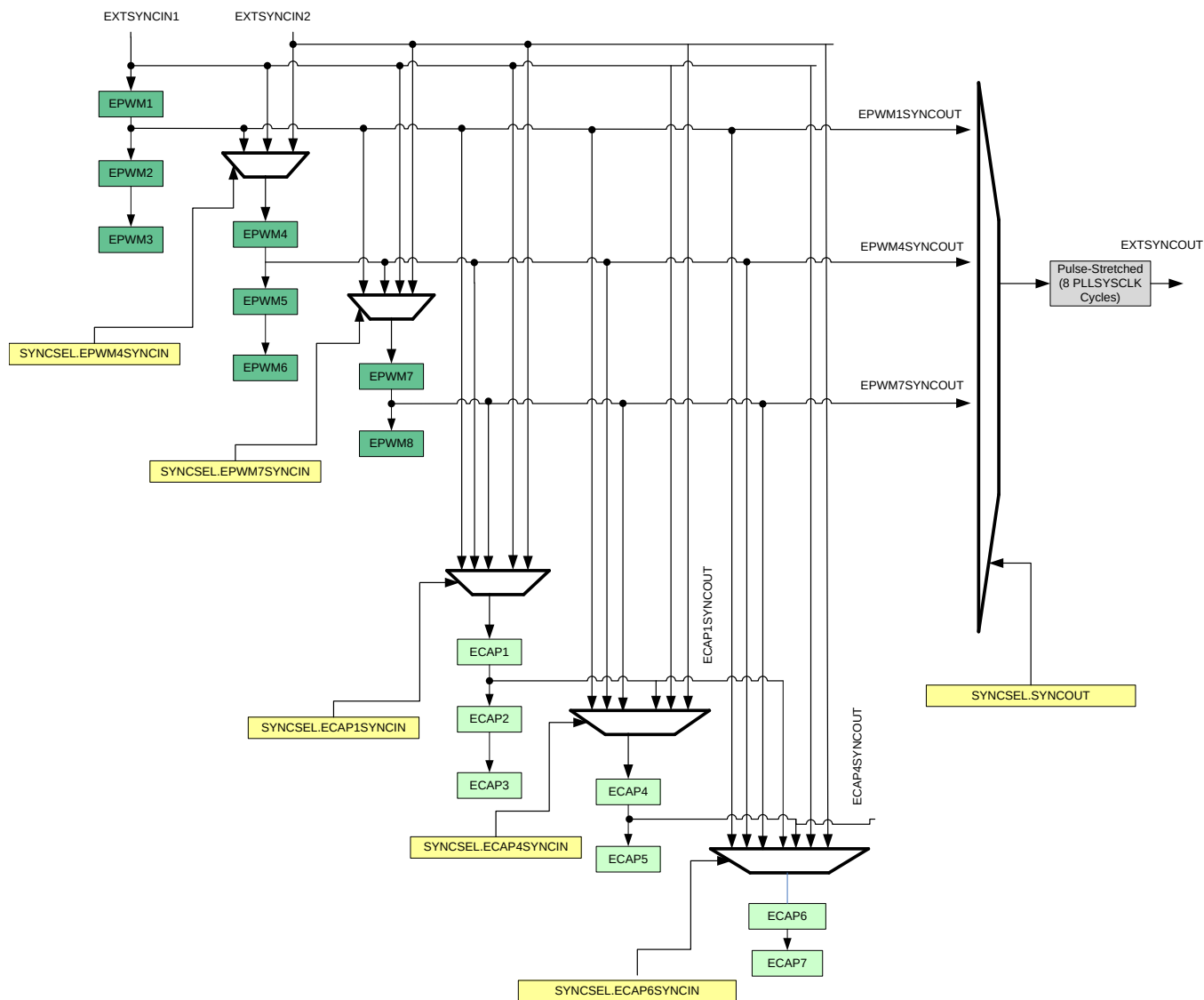


Figure 5-52. Synchronization Chain Architecture

5.10.3.2 ePWM Electrical Data and Timing

Table 5-60 lists the ePWM timing requirements and Table 5-61 lists the ePWM switching characteristics.

Table 5-60. ePWM Timing Requirements⁽¹⁾

		MIN	MAX	UNIT
$t_{w(SYNCIN)}$	Sync input pulse width			cycles
	Asynchronous	$2t_{c(EPWMCLK)}$		
	Synchronous	$2t_{c(EPWMCLK)}$		
	With input qualifier	$1t_{c(EPWMCLK)} + t_{w(IQSW)}$		

(1) For an explanation of the input qualifier parameters, see Table 5-34.

Table 5-61. ePWM Switching Characteristics

over recommended operating conditions (unless otherwise noted)

PARAMETER		MIN	MAX	UNIT
$t_{w(PWM)}$	Pulse duration, PWMx output high/low	20		ns
$t_{w(SYNCOUT)}$	Sync output pulse width	$8t_{c(SYSCLK)}$		cycles
$t_{d(TZ-PWM)}$	Delay time, trip input active to PWM forced high Delay time, trip input active to PWM forced low Delay time, trip input active to PWM Hi-Z		25	ns

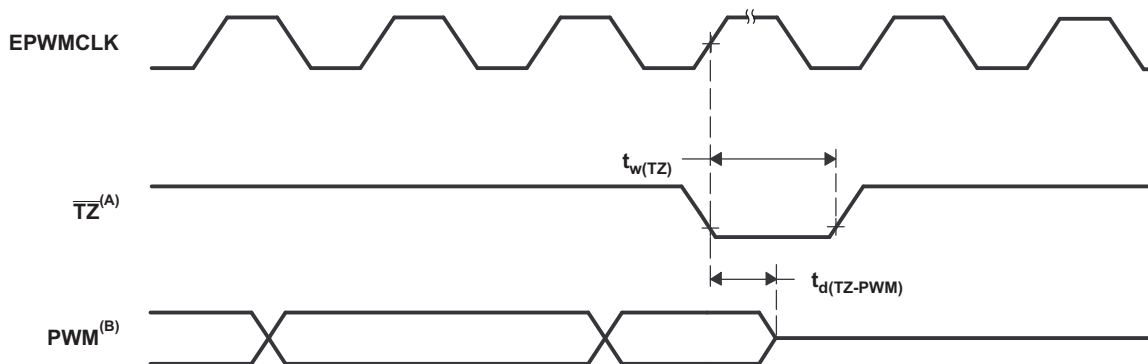
5.10.3.2.1 Trip-Zone Input Timing

Table 5-62 lists the trip-zone input timing requirements. Figure 5-53 shows the PWM Hi-Z characteristics.

Table 5-62. Trip-Zone Input Timing Requirements⁽¹⁾

		MIN	MAX	UNIT
$t_{w(TZ)}$	Pulse duration, $\overline{TZx}$ input low			cycles
	Asynchronous	$1t_{c(EPWMCLK)}$		
	Synchronous	$2t_{c(EPWMCLK)}$		
	With input qualifier	$1t_{c(EPWMCLK)} + t_{w(IQSW)}$		

(1) For an explanation of the input qualifier parameters, see Table 5-34.



A. $\overline{TZ}$: $\overline{TZ1}$, $\overline{TZ2}$, $\overline{TZ3}$, TRIP1–TRIP12

B. PWM refers to all the PWM pins in the device. The state of the PWM pins after $\overline{TZ}$ is taken high depends on the PWM recovery software.

Figure 5-53. PWM Hi-Z Characteristics

5.10.3.3 External ADC Start-of-Conversion Electrical Data and Timing

Table 5-63 lists the external ADC start-of-conversion switching characteristics. Figure 5-54 shows the ADCSOCAO or ADCSOCBO timing.

Table 5-63. External ADC Start-of-Conversion Switching Characteristics

over recommended operating conditions (unless otherwise noted)

PARAMETER	MIN	MAX	UNIT
$t_{w(ADCSOCL)}$ Pulse duration, ADCSOCxO low	$32t_{c(SYSCLK)}$		cycles

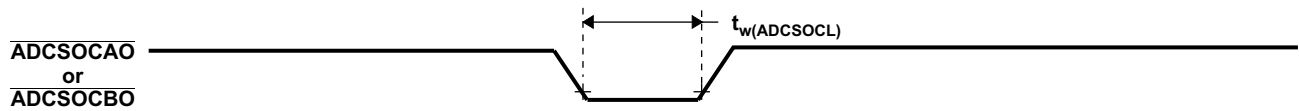


Figure 5-54. ADCSOCAO or ADCSOCBO Timing

5.10.4 High-Resolution Pulse Width Modulator (HRPWM)

The HRPWM combines multiple delay lines in a single module and a simplified calibration system by using a dedicated calibration delay line. For each ePWM module, there are two HR outputs:

- HR Duty and Deadband control on Channel A
- HR Duty and Deadband control on Channel B

The HRPWM module offers PWM resolution (time granularity) that is significantly better than what can be achieved using conventionally derived digital PWM methods. The key points for the HRPWM module are:

- Significantly extends the time resolution capabilities of conventionally derived digital PWM
- This capability can be used in both single edge (duty cycle and phase-shift control) as well as dual-edge control for frequency/period modulation.
- Finer time granularity control or edge positioning is controlled through extensions to the Compare A, B, phase, period, and deadband registers of the ePWM module.

NOTE

The minimum HRPWMCLK frequency allowed for HRPWM is 60 MHz.

5.10.4.1 HRPWM Electrical Data and Timing

[Table 5-64](#) lists the high-resolution PWM switching characteristics.

Table 5-64. High-Resolution PWM Characteristics

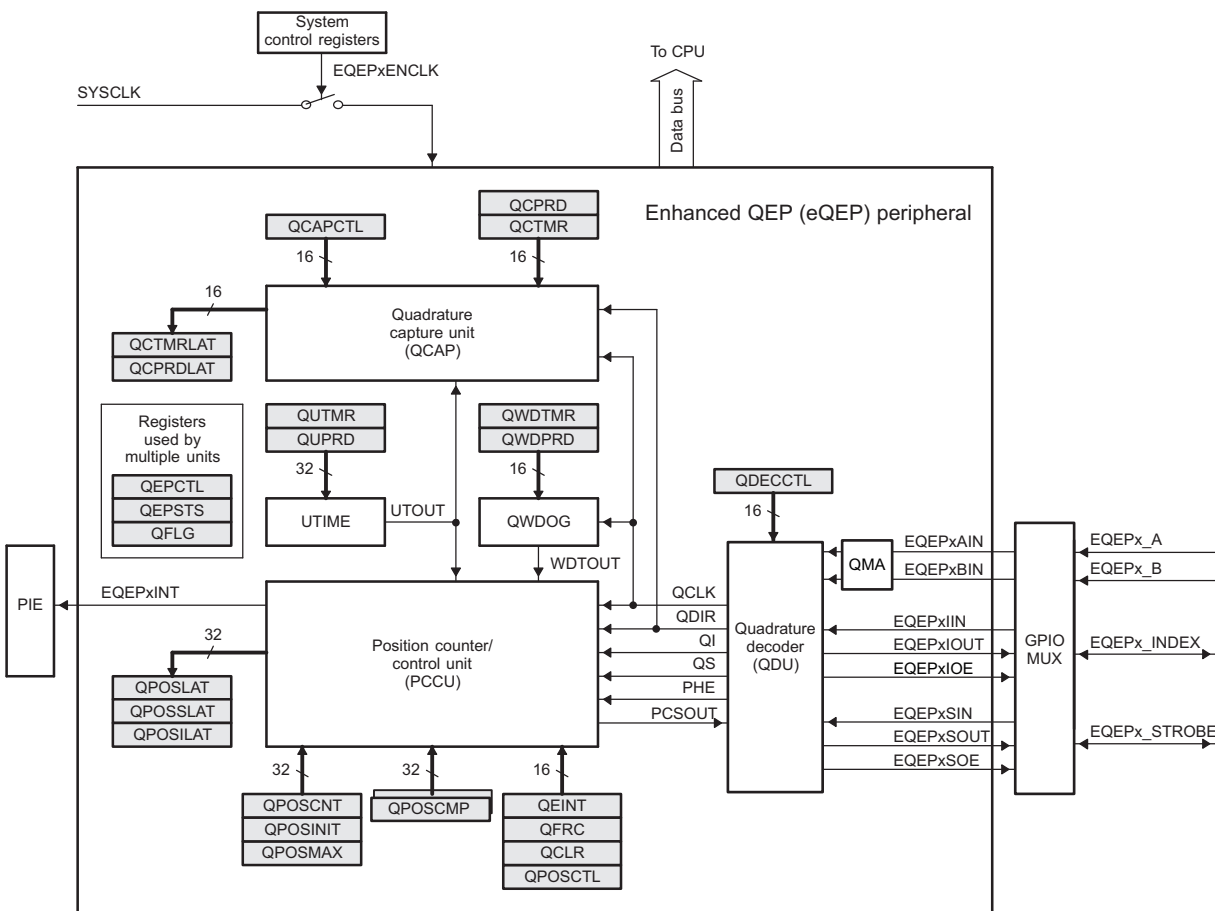
PARAMETER	MIN	TYP	MAX	UNIT
Micro Edge Positioning (MEP) step size ⁽¹⁾		150	310	ps

- (1) The MEP step size will be largest at high temperature and minimum voltage on VDD. MEP step size will increase with higher temperature and lower voltage and decrease with lower temperature and higher voltage. Applications that use the HRPWM feature should use MEP Scale Factor Optimizer (SFO) estimation software functions. See the TI software libraries for details of using SFO function in end applications. SFO functions help to estimate the number of MEP steps per SYSCLK period dynamically while the HRPWM is in operation.

5.10.5 Enhanced Quadrature Encoder Pulse (eQEP)

The Type-1 eQEP peripheral contains the following major functional units (see Figure 5-55):

- Programmable input qualification for each pin (part of the GPIO MUX)
- Quadrature decoder unit (QDU)
- Position counter and control unit for position measurement (PCCU)
- Quadrature edge-capture unit for low-speed measurement (QCAP)
- Unit time base for speed/frequency measurement (UTIME)
- Watchdog timer for detecting stalls (QWDOG)



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Figure 5-55. eQEP Block Diagram

5.10.5.1 eQEP Electrical Data and Timing

Table 5-65 lists the eQEP timing requirements and Table 5-66 lists the eQEP switching characteristics.

Table 5-65. eQEP Timing Requirements⁽¹⁾

			MIN	MAX	UNIT
t _w (QEPP)	QEP input period	Synchronous	2t _c (SYSCCLK)		cycles
		With input qualifier	2[1t _c (SYSCCLK) + t _w (IQSW)]		
t _w (INDEXH)	QEP Index Input High time	Synchronous	2t _c (SYSCCLK)		cycles
		With input qualifier	2t _c (SYSCCLK) + t _w (IQSW)		
t _w (INDEXL)	QEP Index Input Low time	Synchronous	2t _c (SYSCCLK)		cycles
		With input qualifier	2t _c (SYSCCLK) + t _w (IQSW)		
t _w (STROBH)	QEP Strobe High time	Synchronous	2t _c (SYSCCLK)		cycles
		With input qualifier	2t _c (SYSCCLK) + t _w (IQSW)		
t _w (STROBL)	QEP Strobe Input Low time	Synchronous	2t _c (SYSCCLK)		cycles
		With input qualifier	2t _c (SYSCCLK) + t _w (IQSW)		

(1) For an explanation of the input qualifier parameters, see Table 5-34.

Table 5-66. eQEP Switching Characteristics

over recommended operating conditions (unless otherwise noted)

PARAMETER		MIN	MAX	UNIT
$t_{d(CNTR)_{xin}}$	Delay time, external clock to counter increment	$5t_{c(SYSCCLK)}$		cycles
$t_{d(PCS-OUT)_{QEP}}$	Delay time, QEP input edge to position compare sync output	$7t_{c(SYSCCLK)}$		cycles

5.10.6 Sigma-Delta Filter Module (SDFM)

The SDFM is a 4-channel digital filter designed specifically for current measurement and resolver position decoding in motor control applications. Each channel can receive an independent sigma-delta ($\Sigma\Delta$) modulated bit stream. The bit streams are processed by four individually programmable digital decimation filters. The filter set includes a fast comparator for immediate digital threshold comparisons for overcurrent and undercurrent monitoring.

The SDFM features include:

- 8 external pins per SDFM module
 - 4 sigma-delta data input pins per SDFM module (SDx_D1-4)
 - 4 sigma-delta clock input pins per SDFM module (SDx_C1-4)
- 4 different configurable modulator clock modes:
 - Mode 0: Modulator clock rate equals modulator data rate
 - Mode 1: Modulator clock rate running at half the modulator data rate
 - Mode 2: Modulator data is Manchester encoded. Modulator clock not required.
 - Mode 3: Modulator clock rate is double that of modulator data rate
- 4 independent configurable secondary filter (comparator) units per SDFM module:
 - 4 different filter type selection (Sinc1/Sinc2/Sincfast/Sinc3) options available
 - Ability to detect over-value, under-value, and zero-crossing conditions
 - OSR value for comparator filter unit (COSR) programmable from 1 to 32
- 4 independent configurable primary filter (data filter) units per SDFM module:
 - 4 different filter type selection (Sinc1/Sinc2/Sincfast/Sinc3) options available
 - OSR value for data filter unit (DOSR) programmable from 1 to 256
 - Ability to enable individual filter modules
 - Ability to synchronize all the 4 independent filters of an SDFM module using Master Filter Enable (MFE) bit or using PWM signals
- Data filter unit has programmable FIFO to reduce interrupt overhead. FIFO has the following features:
 - Primary filter (data filter) has 16 deep $\times$ 32-bit FIFO
 - FIFO can interrupt CPU after programmable number of data ready events
 - FIFO Wait-for-Sync feature: Ability to ignore data ready events until PWM synchronization signal (SDSYNCR) is received. Once SDSYNCR event is received, FIFO is populated on every data ready event
 - Data filter output can be represented in either 16 bits or 32 bits
- PWMx.SOCA/SOCB can be configured to serve as SDSYNCR source on per data filter channel basis
- PWMs can be used to generate a modulator clock for sigma delta modulators

Figure 5-56 shows the SDFM block diagram.

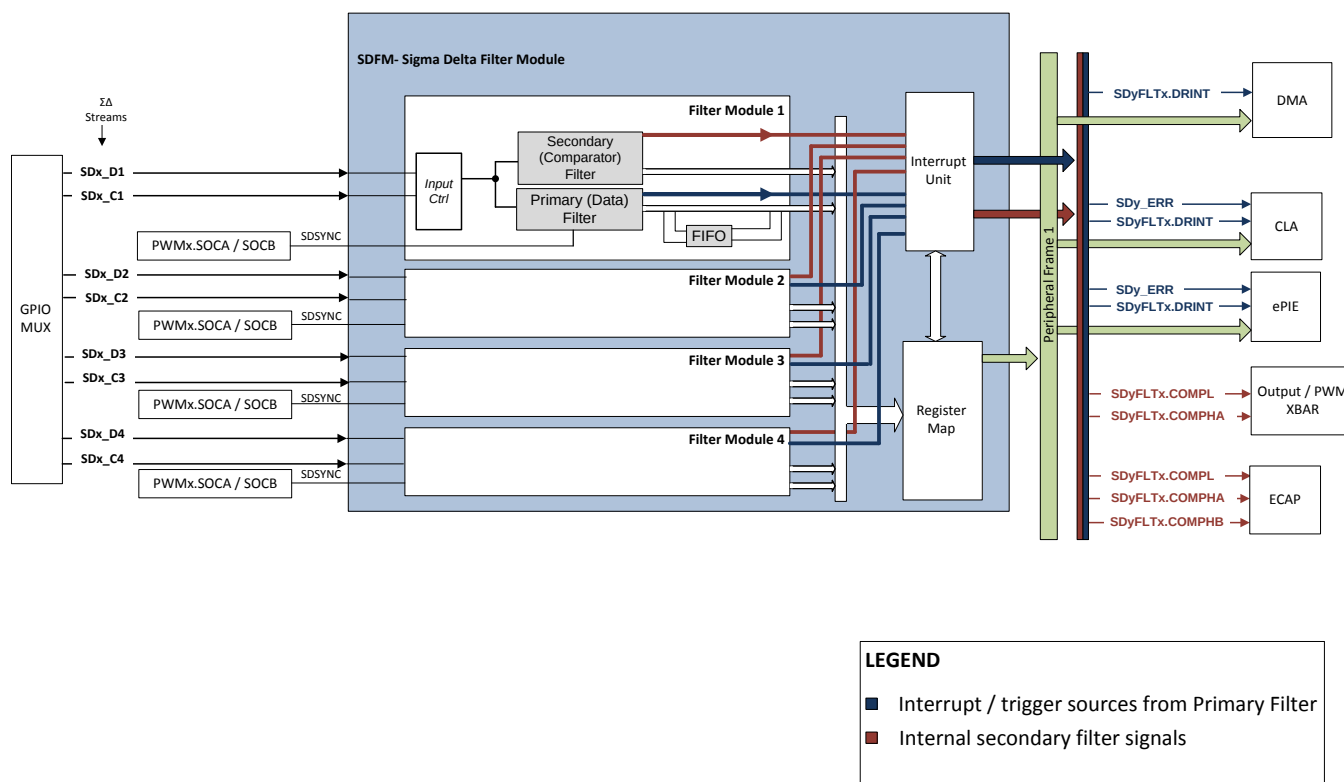


Figure 5-56. SDFM Block Diagram

5.10.6.1 SDFM Electrical Data and Timing

Table 5-67 lists the SDFM timing requirements. Figure 5-57, Figure 5-58, Figure 5-59, and Figure 5-60 show the SDFM timing diagrams.

Table 5-67. SDFM Timing Requirements

		MIN	MAX	UNIT
Mode 0				
$t_{c(SDC)M0}$	Cycle time, SDx_Cy	40	256 * SYSCLK period	ns
$t_{w(SDCH)M0}$	Pulse duration, SDx_Cy high	10	$t_{c(SDC)M0} - 10$	ns
$t_{su(SDDV-SDCH)M0}$	Setup time, SDx_Dy valid before SDx_Cy goes high	5		ns
$t_{h(SDCH-SDD)M0}$	Hold time, SDx_Dy wait after SDx_Cy goes high	5		ns
Mode 1				
$t_{c(SDC)M1}$	Cycle time, SDx_Cy	80	256 * SYSCLK period	ns
$t_{w(SDCH)M1}$	Pulse duration, SDx_Cy high	10	$t_{c(SDC)M1} - 10$	ns
$t_{su(SDDV-SDCL)M1}$	Setup time, SDx_Dy valid before SDx_Cy goes low	5		ns
$t_{su(SDDV-SDCH)M1}$	Setup time, SDx_Dy valid before SDx_Cy goes high	5		ns
$t_{h(SDCL-SDD)M1}$	Hold time, SDx_Dy wait after SDx_Cy goes low	5		ns
$t_{h(SDCH-SDD)M1}$	Hold time, SDx_Dy wait after SDx_Cy goes high	5		ns
Mode 2				
$t_{c(SDD)M2}$	Cycle time, SDx_Dy	8 * $t_{c(SYSCLK)}$	20 * $t_{c(SYSCLK)}$	ns
$t_{w(SDDH)M2}$	Pulse duration, SDx_Dy high	10		ns
Mode 3				
$t_{c(SDC)M3}$	Cycle time, SDx_Cy	40	256 * SYSCLK period	ns
$t_{w(SDCH)M3}$	Pulse duration, SDx_Cy high	10	$t_{c(SDC)M3} - 5$	ns
$t_{su(SDDV-SDCH)M3}$	Setup time, SDx_Dy valid before SDx_Cy goes high	5		ns
$t_{h(SDCH-SDD)M3}$	Hold time, SDx_Dy wait after SDx_Cy goes high	5		ns

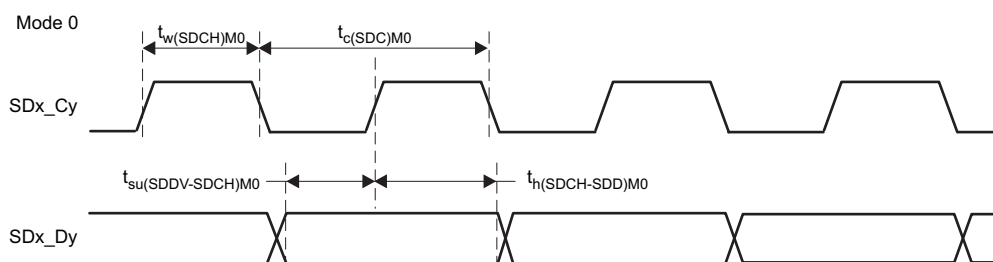


Figure 5-57. SDFM Timing Diagram – Mode 0

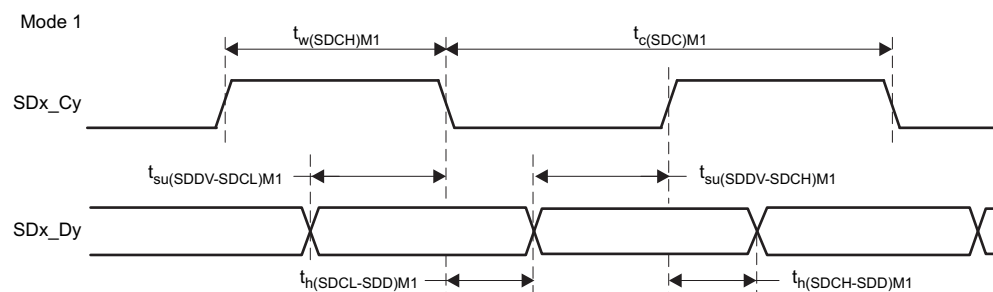


Figure 5-58. SDFM Timing Diagram – Mode 1

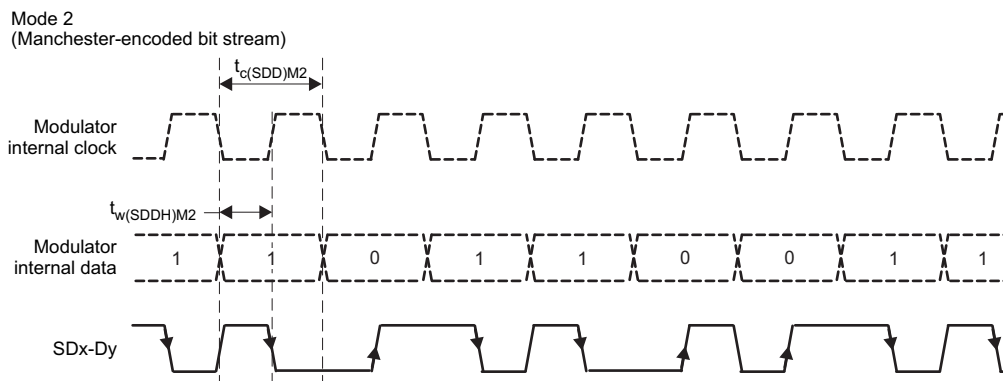


Figure 5-59. SDFM Timing Diagram – Mode 2

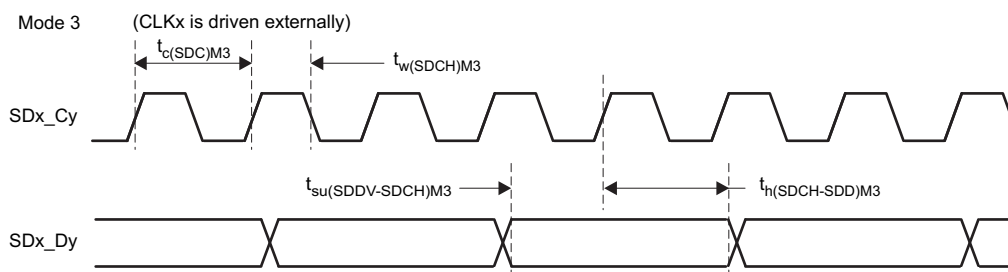


Figure 5-60. SDFM Timing Diagram – Mode 3

5.11 Communications Peripherals

5.11.1 Controller Area Network (CAN)

NOTE

The CAN module uses the IP known as *DCAN*. This document uses the names *CAN* and *DCAN* interchangeably to reference this peripheral.

The CAN module implements the following features:

- Complies with ISO11898-1 (Bosch® CAN protocol specification 2.0 A and B)
- Bit rates up to 1 Mbps
- Multiple clock sources
- 32 message objects (mailboxes), each with the following properties:
 - Configurable as receive or transmit
 - Configurable with standard (11-bit) or extended (29-bit) identifier
 - Supports programmable identifier receive mask
 - Supports data and remote frames
 - Holds 0 to 8 bytes of data
 - Parity-checked configuration and data RAM
- Individual identifier mask for each message object
- Programmable FIFO mode for message objects
- Programmable loopback modes for self-test operation
- Suspend mode for debug support
- Software module reset
- Automatic bus on after bus-off state by a programmable 32-bit timer
- Two interrupt lines
- DMA support

NOTE

For a CAN bit clock of 100 MHz, the smallest bit rate possible is 3.90625 kbps.

NOTE

The accuracy of the on-chip zero-pin oscillator is in [Table 5-26](#). Depending on parameters such as the CAN bit timing settings, bit rate, bus length, and propagation delay, the accuracy of this oscillator may not meet the requirements of the CAN protocol. In this situation, an external clock source must be used.

[Figure 5-61](#) shows the CAN block diagram.

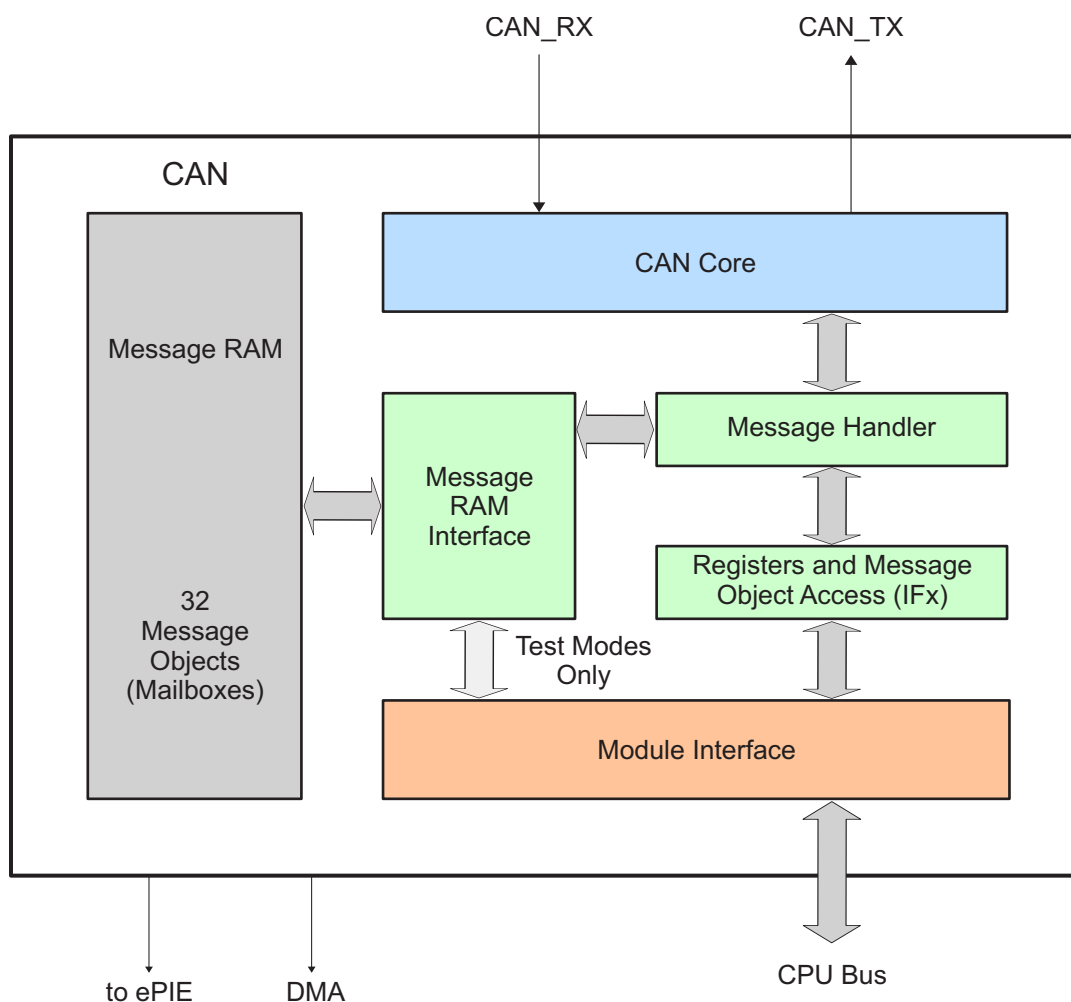


Figure 5-61. CAN Block Diagram

5.11.2 Inter-Integrated Circuit (I2C)

The I2C module has the following features:

- Compliance with the NXP Semiconductors I²C-bus specification (version 2.1):
 - Support for 8-bit format transfers
 - 7-bit and 10-bit addressing modes
 - General call
 - START byte mode
 - Support for multiple master-transmitters and slave-receivers
 - Support for multiple slave-transmitters and master-receivers
 - Combined master transmit/receive and receive/transmit mode
 - Data transfer rate from 10 kbps up to 400 kbps (Fast-mode)
- One 16-byte receive FIFO and one 16-byte transmit FIFO
- Supports two ePIE interrupts
 - I2Cx interrupt – Any of the below conditions can be configured to generate an I2Cx interrupt:
 - Transmit Ready
 - Receive Ready
 - Register-Access Ready
 - No-Acknowledgment
 - Arbitration-Lost
 - Stop Condition Detected
 - Addressed-as-Slave
 - I2Cx_FIFO interrupts:
 - Transmit FIFO interrupt
 - Receive FIFO interrupt
- Module enable and disable capability
- Free data format mode

Figure 5-62 shows how the I2C peripheral module interfaces within the device.

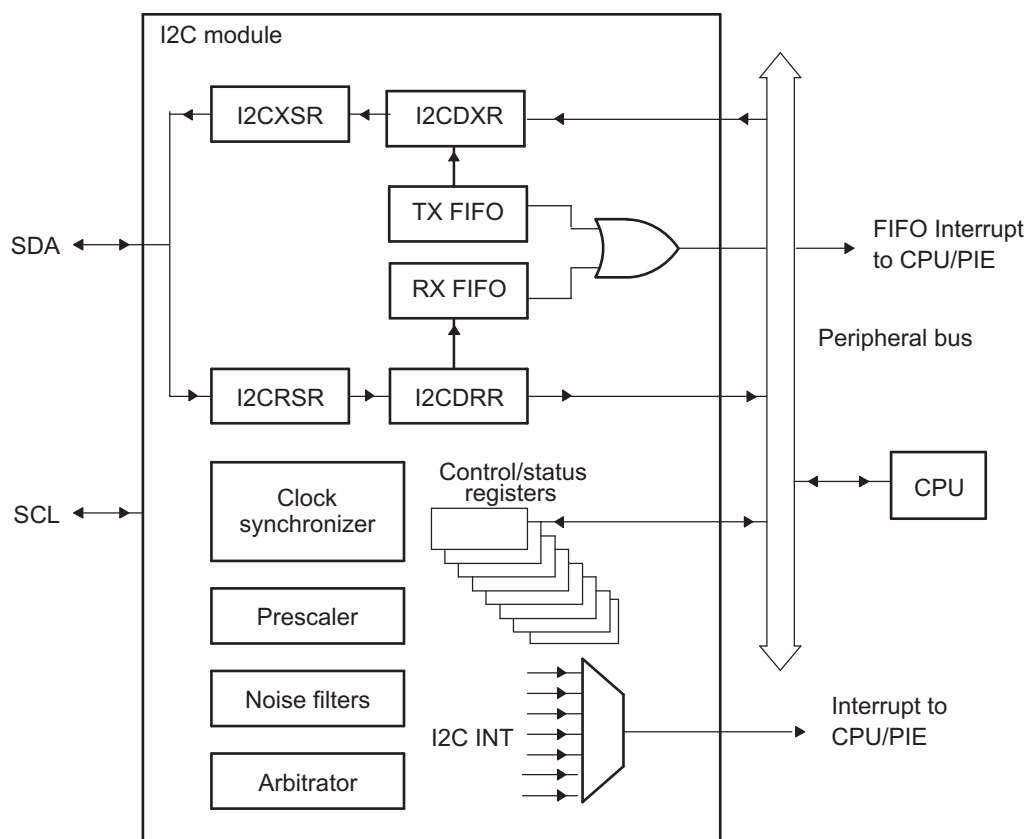


Figure 5-62. I2C Peripheral Module Interfaces

5.11.2.1 I2C Electrical Data and Timing

Table 5-68 lists the I2C timing requirements. Table 5-69 lists the I2C switching characteristics.

Table 5-68. I2C Timing Requirements

		MIN	MAX	UNIT
$t_{h(SDA-SCL)START}$	Hold time, START condition, SCL fall delay after SDA fall	0.6		μs
$t_{su(SCL-SDA)START}$	Setup time, Repeated START, SCL rise before SDA fall delay	0.6		μs
$t_{h(SCL-DAT)}$	Hold time, data after SCL fall	0		μs
$t_{su(DAT-SCL)}$	Setup time, data before SCL rise	100		ns
$t_r(SDA)$	Rise time, SDA	20	300	ns
$t_r(SCL)$	Rise time, SCL	20	300	ns
$t_f(SDA)$	Fall time, SDA	11.4	300	ns
$t_f(SCL)$	Fall time, SCL	11.4	300	ns
$t_{su(SCL-SDA)STOP}$	Setup time, STOP condition, SCL rise before SDA rise delay	0.6		μs

Table 5-69. I2C Switching Characteristics

over recommended operating conditions (unless otherwise noted)

PARAMETER	TEST CONDITIONS	MIN	MAX	UNIT
f_{SCL}	SCL clock frequency	0	400	kHz
$t_w(SCLL)$	Pulse duration, SCL clock low	1.3		μs
$t_w(SCLH)$	Pulse duration, SCL clock high	0.6		μs
$t_w(SP)$	Pulse duration of spikes that will be suppressed by the input filter	0	50	ns
t_{BUF}	Bus free time between STOP and START conditions	1.3		μs
$t_v(SCL-DAT)$	Valid time, data after SCL fall		0.9	μs
$t_v(SCL-ACK)$	Valid time, Acknowledge after SCL fall		0.9	μs
V_{IL}	Valid low-level input voltage	–0.3	$0.3 * V_{DDIO}$	V
V_{IH}	Valid high-level input voltage	$0.7 * V_{DDIO}$	$V_{DDIO} + 0.3$	V
V_{OL}	Low-level output voltage	Sinking 3 mA	0.4	V
I_I	Input current on pins	$0.1 V_{bus} < V_i < 0.9 V_{bus}$	10	μA

5.11.3 Power Management Bus (PMBus) Interface

The PMBus module has the following features:

- Compliance with the SMI Forum PMBus Specification (Part I v1.0 and Part II v1.1)
- Support for master and slave modes
- Support for I2C mode
- Support for three speeds:
 - Standard Mode: Up to 100 kHz
 - Fast Mode: 400 kHz
 - Fast Mode+: 1000 kHz. This mode applies only to the PMBus module operating in I2C mode, with an input clock frequency of 20 MHz.
- Packet error checking
- CONTROL and ALERT signals
- Clock high and low time-outs
- Four-byte transmit and receive buffers
- One maskable interrupt, which can be generated by several conditions:
 - Receive data ready
 - Transmit buffer empty
 - Slave address received
 - End of message
 - ALERT input asserted
 - Clock low time-out
 - Clock high time-out
 - Bus free

Figure 5-63 shows the PMBus block diagram.

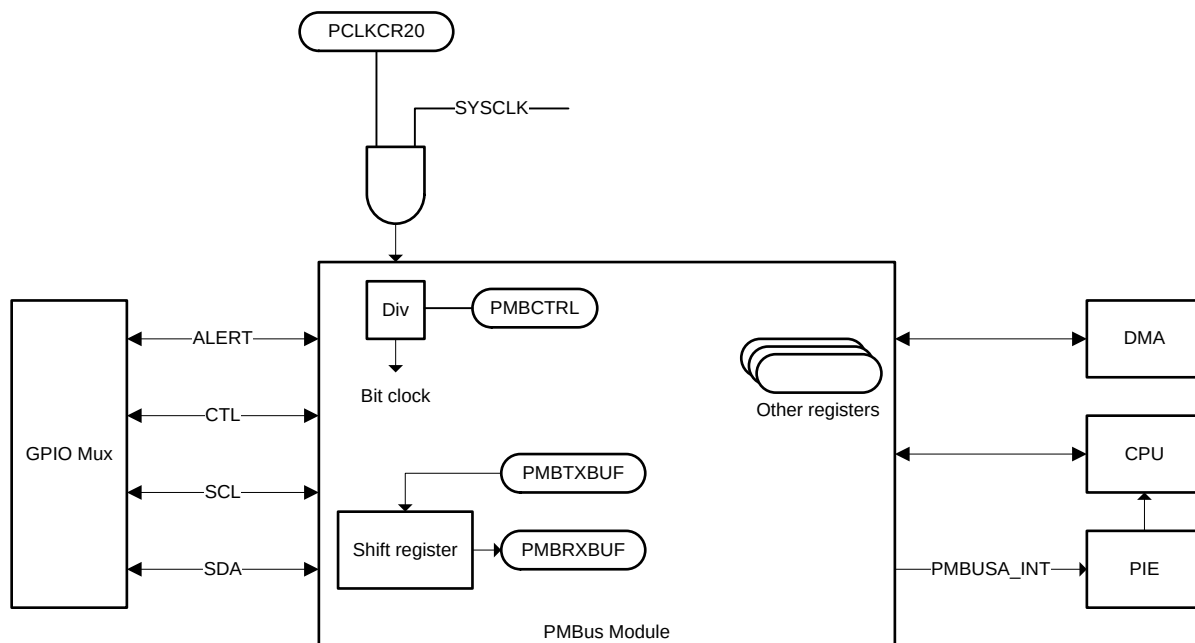


Figure 5-63. PMBus Block Diagram

5.11.3.1 PMBus Electrical Data and Timing

Table 5-70 lists the PMBus electrical characteristics. Table 5-71 lists the PMBUS fast mode switching characteristics. Table 5-72 lists the PMBUS standard mode switching characteristics.

Table 5-70. PMBus Electrical Characteristics

over recommended operating conditions (unless otherwise noted)

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
V _{IL}	Valid low-level input voltage			0.8	V
V _{IH}	Valid high-level input voltage	2.1		VDDIO	V
V _{OL}	Low-level output voltage		At I _{pullup} = 4 mA	0.4	V
I _{OL}	Low-level output current	4			mA
t _{SP}	Pulse width of spikes that must be suppressed by the input filter	0		50	ns
I _i	Input leakage current on each pin	–10		10	μA
C _i	Capacitance on each pin			10	pF

Table 5-71. PMBus Fast Mode Switching Characteristics

over recommended operating conditions (unless otherwise noted)

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
f _{SCL}	SCL clock frequency	10		400	kHz
t _{BUF}	Bus free time between STOP and START conditions	1.3			μs
t _{HD;STA}	START condition hold time -- SDA fall to SCL fall delay	0.6			μs
t _{SU;STA}	Repeated START setup time -- SCL rise to SDA fall delay	0.6			μs
t _{SU;STO}	STOP condition setup time -- SCL rise to SDA rise delay	0.6			μs
t _{HD;DAT}	Data hold time after SCL fall	300			ns
t _{SU;DAT}	Data setup time before SCL rise	100			ns
t _{Timeout}	Clock low time-out	25		35	ms
t _{LOW}	Low period of the SCL clock	1.3			μs
t _{HIGH}	High period of the SCL clock	0.6		50	μs
t _{LOW;SEXT}	Cumulative clock low extend time (slave device)	From START to STOP		25	ms
t _{LOW;MEXT}	Cumulative clock low extend time (master device)	Within each byte		10	ms
t _r	Rise time of SDA and SCL	5% to 95%	20	300	ns
t _f	Fall time of SDA and SCL	95% to 5%	20	300	ns

Table 5-72. PMBus Standard Mode Switching Characteristics

over recommended operating conditions (unless otherwise noted)

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
f_{SCL}	SCL clock frequency		10		100	kHz
t_{BUF}	Bus free time between STOP and START conditions		4.7			μ s
$t_{HD;STA}$	START condition hold time -- SDA fall to SCL fall delay		4			μ s
$t_{SU;STA}$	Repeated START setup time -- SCL rise to SDA fall delay		4.7			μ s
$t_{SU;STO}$	STOP condition setup time -- SCL rise to SDA rise delay		4			μ s
$t_{HD;DAT}$	Data hold time after SCL fall		300			ns
$t_{SU;DAT}$	Data setup time before SCL rise		250			ns
$t_{Timeout}$	Clock low time-out		25		35	ms
t_{LOW}	Low period of the SCL clock		4.7			μ s
t_{HIGH}	High period of the SCL clock		4		50	μ s
$t_{LOW;SEXT}$	Cumulative clock low extend time (slave device)	From START to STOP			25	ms
$t_{LOW;MEXT}$	Cumulative clock low extend time (master device)	Within each byte			10	ms
t_r	Rise time of SDA and SCL				1000	ns
t_f	Fall time of SDA and SCL				300	ns

5.11.4 Serial Communications Interface (SCI)

The SCI is a 2-wire asynchronous serial port, commonly known as a UART. The SCI module supports digital communications between the CPU and other asynchronous peripherals that use the standard non-return-to-zero (NRZ) format

The SCI receiver and transmitter each have a 16-level-deep FIFO for reducing servicing overhead, and each has its own separate enable and interrupt bits. Both can be operated independently for half-duplex communication, or simultaneously for full-duplex communication. To specify data integrity, the SCI checks received data for break detection, parity, overrun, and framing errors. The bit rate is programmable to different speeds through a 16-bit baud-select register.

Features of the SCI module include:

- Two external pins:
 - SCITXD: SCI transmit-output pin
 - SCIRXD: SCI receive-input pin

NOTE: Both pins can be used as GPIO if not used for SCI.

- Baud rate programmable to 64K different rates
- Data-word format
 - 1 start bit
 - Data-word length programmable from 1 to 8 bits
 - Optional even/odd/no parity bit
 - 1 or 2 stop bits
- Four error-detection flags: parity, overrun, framing, and break detection
- Two wake-up multiprocessor modes: idle-line and address bit
- Half- or full-duplex operation
- Double-buffered receive and transmit functions
- Transmitter and receiver operations can be accomplished through interrupt-driven or polled algorithms with status flags.
 - Transmitter: TXRDY flag (transmitter-buffer register is ready to receive another character) and TX EMPTY flag (transmitter-shift register is empty)
 - Receiver: RXRDY flag (receiver-buffer register is ready to receive another character), BRKDT flag (break condition occurred), and RX ERROR flag (monitoring four interrupt conditions)
- Separate enable bits for transmitter and receiver interrupts (except BRKDT)
- NRZ format
- Auto baud-detect hardware logic
- 16-level transmit and receive FIFO

NOTE

All registers in this module are 8-bit registers. When a register is accessed, the register data is in the lower byte (bits 7–0), and the upper byte (bits 15–8) is read as zeros. Writing to the upper byte has no effect.

Figure 5-64 shows the SCI block diagram.

156 *Specifications*

5.11.5 Serial Peripheral Interface (SPI)

The serial peripheral interface (SPI) is a high-speed synchronous serial input and output (I/O) port that allows a serial bit stream of programmed length (1 to 16 bits) to be shifted into and out of the device at a programmed bit-transfer rate. The SPI is normally used for communications between the MCU controller and external peripherals or another controller. Typical applications include external I/O or peripheral expansion through devices such as shift registers, display drivers, and analog-to-digital converters (ADCs). Multidevice communications are supported by the master or slave operation of the SPI. The port supports a 16-level, receive and transmit FIFO for reducing CPU servicing overhead.

The SPI module features include:

- SPISOMI: SPI slave-output/master-input pin
- SPISIMO: SPI slave-input/master-output pin
- $\overline{\text{SPISTE}}$: SPI slave transmit-enable pin
- SPICLK: SPI serial-clock pin

NOTE

All four pins can be used as GPIO, if the SPI module is not used.

- Two operational modes: Master and Slave
- Baud rate: 125 different programmable rates. The maximum baud rate that can be employed is limited by the maximum speed of the I/O buffers used on the SPI pins.
- Data word length: 1 to 16 data bits
- Four clocking schemes (controlled by clock polarity and clock phase bits) include:
 - Falling edge without phase delay: SPICLK active-high. SPI transmits data on the falling edge of the SPICLK signal and receives data on the rising edge of the SPICLK signal.
 - Falling edge with phase delay: SPICLK active-high. SPI transmits data one half-cycle ahead of the falling edge of the SPICLK signal and receives data on the falling edge of the SPICLK signal.
 - Rising edge without phase delay: SPICLK inactive-low. SPI transmits data on the rising edge of the SPICLK signal and receives data on the falling edge of the SPICLK signal.
 - Rising edge with phase delay: SPICLK inactive-low. SPI transmits data one half-cycle ahead of the rising edge of the SPICLK signal and receives data on the rising edge of the SPICLK signal.
- Simultaneous receive and transmit operation (transmit function can be disabled in software)
- Transmitter and receiver operations are accomplished through either interrupt-driven or polled algorithm
- 16-level transmit/receive FIFO
- DMA support
- High-speed mode
- Delayed transmit control
- 3-wire SPI mode
- $\overline{\text{SPISTE}}$ inversion for digital audio interface receive mode on devices with two SPI modules

Figure 5-65 shows the SPI CPU interfaces.

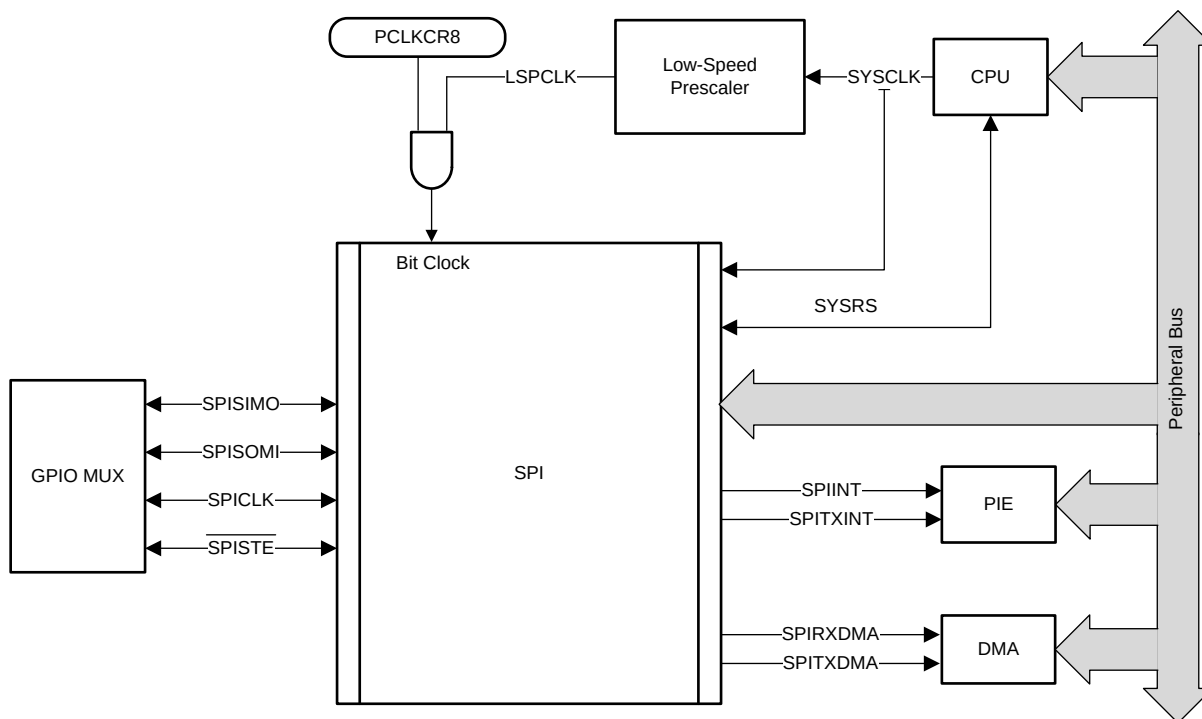


Figure 5-65. SPI CPU Interface

5.11.5.1 SPI Electrical Data and Timing

The following sections contain the SPI External Timings in Non-High-Speed Mode:

[Section 5.11.5.1.1](#) Non-High-Speed Master Mode Timings

[Section 5.11.5.1.2](#) Non-High-Speed Slave Mode Timings

The following sections contain the SPI External Timings in High-Speed Mode:

[Section 5.11.5.1.3](#) High-Speed Master Mode Timings

[Section 5.11.5.1.4](#) High-Speed Slave Mode Timings

NOTE

All timing parameters for SPI High-Speed Mode assume a load capacitance of 5 pF on SPICLK, SPISIMO, and SPISOMI.

For more information about the SPI in High-Speed mode, see the Serial Peripheral Interface (SPI) chapter of the [TMS320F28004x Piccolo Microcontrollers Technical Reference Manual](#).

5.11.5.1.1 Non-High-Speed Master Mode Timings

Table 5-73 lists the SPI master mode switching characteristics where the clock phase = 0. Figure 5-66 shows the SPI master mode external timing where the clock phase = 0.

Table 5-74 lists the SPI master mode switching characteristics where the clock phase = 1. Figure 5-67 shows the SPI master mode external timing where the clock phase = 1.

Table 5-75 lists the SPI master mode timing requirements.

Table 5-73. SPI Master Mode Switching Characteristics (Clock Phase = 0)

over recommended operating conditions (unless otherwise noted)

NO.	PARAMETER	(BRR + 1) CONDITION ⁽¹⁾	MIN	MAX	UNIT
1	$t_{c(SPC)M}$ Cycle time, SPICLK	Even	$4t_{c(LSPCLK)}$	$128t_{c(LSPCLK)}$	ns
		Odd	$5t_{c(LSPCLK)}$	$127t_{c(LSPCLK)}$	
2	$t_{w(SPC1)M}$ Pulse duration, SPICLK, first pulse	Even	$0.5t_{c(SPC)M} - 3$	$0.5t_{c(SPC)M} + 3$	ns
		Odd	$0.5t_{c(SPC)M} + 0.5t_{c(LSPCLK)} - 3$	$0.5t_{c(SPC)M} + 0.5t_{c(LSPCLK)} + 3$	
3	$t_{w(SPC2)M}$ Pulse duration, SPICLK, second pulse	Even	$0.5t_{c(SPC)M} - 3$	$0.5t_{c(SPC)M} + 3$	ns
		Odd	$0.5t_{c(SPC)M} - 0.5t_{c(LSPCLK)} - 3$	$0.5t_{c(SPC)M} - 0.5t_{c(LSPCLK)} + 3$	
4	$t_{d(SIMO)M}$ Delay time, SPICLK to SPISIMO valid	Even, Odd		5	ns
5	$t_{v(SIMO)M}$ Valid time, SPISIMO valid after SPICLK	Even	$0.5t_{c(SPC)M} - 3$		ns
		Odd	$0.5t_{c(SPC)M} - 0.5t_{c(LSPCLK)} - 3$		
23	$t_{d(SPC)M}$ Delay time, $\overline{SPISTE}$ valid to SPICLK	Even	$0.5t_{c(SPC)M} - 3$		ns
		Odd	$0.5t_{c(SPC)M} - 0.5t_{c(LSPCLK)} - 3$		
24	$t_{d(STE)M}$ Delay time, SPICLK to $\overline{SPISTE}$ invalid	Even	$0.5t_{c(SPC)M} - 3$		ns
		Odd	$0.5t_{c(SPC)M} - 0.5t_{c(LSPCLK)} - 3$		

(1) The (BRR + 1) condition is Even when (SPIBRR + 1) is even or SPIBRR is 0 or 2. It is Odd when (SPIBRR + 1) is odd and SPIBRR is greater than 3.

Table 5-74. SPI Master Mode Switching Characteristics (Clock Phase = 1)

over recommended operating conditions (unless otherwise noted)

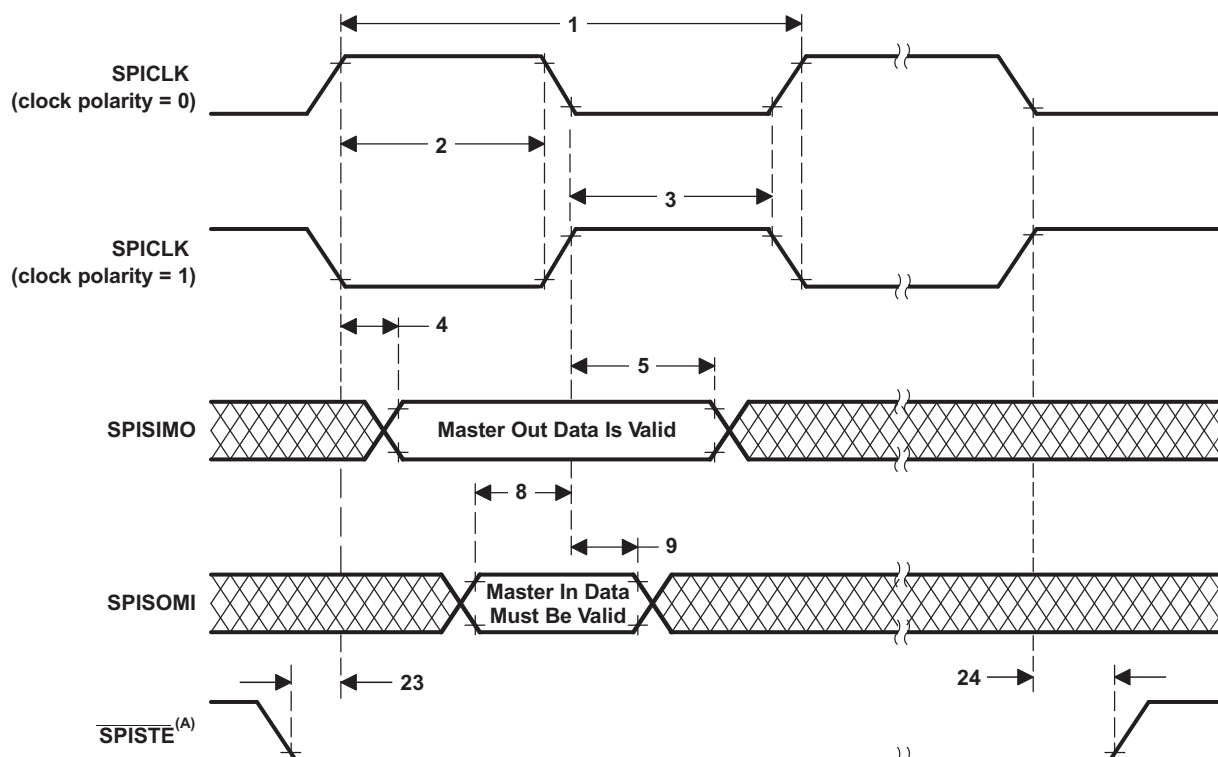
NO.	PARAMETER	(BRR + 1) CONDITION ⁽¹⁾	MIN	MAX	UNIT
1	$t_{c(SPC)M}$ Cycle time, SPICLK	Even	$4t_{c(LSPCLK)}$	$128t_{c(LSPCLK)}$	ns
		Odd	$5t_{c(LSPCLK)}$	$127t_{c(LSPCLK)}$	
2	$t_{w(SPC1)M}$ Pulse duration, SPICLK, first pulse	Even	$0.5t_{c(SPC)M} - 3$	$0.5t_{c(SPC)M} + 3$	ns
		Odd	$0.5t_{c(SPC)M} - 0.5t_{c(LSPCLK)} - 3$	$0.5t_{c(SPC)M} - 0.5t_{c(LSPCLK)} + 3$	
3	$t_{w(SPC2)M}$ Pulse duration, SPICLK, second pulse	Even	$0.5t_{c(SPC)M} - 3$	$0.5t_{c(SPC)M} + 3$	ns
		Odd	$0.5t_{c(SPC)M} + 0.5t_{c(LSPCLK)} - 3$	$0.5t_{c(SPC)M} + 0.5t_{c(LSPCLK)} + 3$	
4	$t_{d(SIMO)M}$ Delay time, SPISIMO valid to SPICLK	Even	$0.5t_{c(SPC)M} - 3$		ns
		Odd	$0.5t_{c(SPC)M} + 0.5t_{c(LSPCLK)} - 3$		
5	$t_{v(SIMO)M}$ Valid time, SPISIMO valid after SPICLK	Even	$0.5t_{c(SPC)M} - 3$		ns
		Odd	$0.5t_{c(SPC)M} - 0.5t_{c(LSPCLK)} - 3$		
23	$t_{d(SPC)M}$ Delay time, $\overline{SPISTE}$ valid to SPICLK	Even, Odd	$t_{c(SPC)M} - 3$		ns
24	$t_{d(STE)M}$ Delay time, SPICLK to $\overline{SPISTE}$ invalid	Even	$0.5t_{c(SPC)M} - 3$		ns
		Odd	$0.5t_{c(SPC)M} - 0.5t_{c(LSPCLK)} - 3$		

(1) The (BRR + 1) condition is Even when (SPIBRR + 1) is even or SPIBRR is 0 or 2. It is Odd when (SPIBRR + 1) is odd and SPIBRR is greater than 3.

Table 5-75. SPI Master Mode Timing Requirements

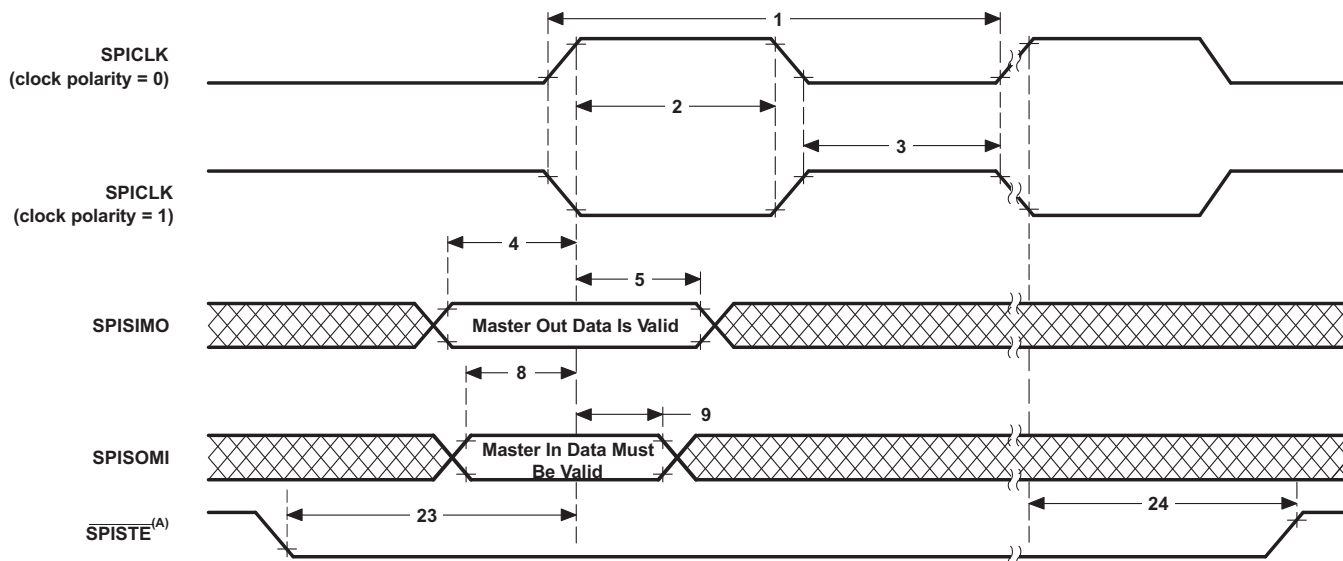
NO.	PARAMETER	(BRR + 1) CONDITION ⁽¹⁾	MIN	MAX	UNIT
8	$t_{su(SOMI)M}$ Setup time, SPISOMI valid before SPICLK	Even, Odd	20		ns
9	$t_{h(SOMI)M}$ Hold time, SPISOMI valid after SPICLK	Even, Odd	0		ns

(1) The (BRR + 1) condition is Even when (SPIBRR + 1) is even or SPIBRR is 0 or 2. It is Odd when (SPIBRR + 1) is odd and SPIBRR is greater than 3.



- A. On the trailing end of the word, $\overline{\text{SPISIMO}}$ will go inactive except between back-to-back transmit words in both FIFO and non-FIFO modes.

Figure 5-66. SPI Master Mode External Timing (Clock Phase = 0)



- A. On the trailing end of the word, $\overline{\text{SPISIMO}}$ will go inactive except between back-to-back transmit words in both FIFO and non-FIFO modes.

Figure 5-67. SPI Master Mode External Timing (Clock Phase = 1)

5.11.5.1.2 Non-High-Speed Slave Mode Timings

Table 5-76 lists the SPI slave mode switching characteristics. Table 5-77 lists the SPI slave mode timing requirements.

Figure 5-68 shows the SPI slave mode external timing where the clock phase = 0. Figure 5-69 shows the SPI slave mode external timing where the clock phase = 1.

Table 5-76. SPI Slave Mode Switching Characteristics

over recommended operating conditions (unless otherwise noted)

NO.	PARAMETER		MIN	MAX	UNIT
15	$t_{d(SOMI)S}$	Delay time, SPICLK to SPISOMI valid		16	ns
16	$t_{v(SOMI)S}$	Valid time, SPISOMI valid after SPICLK	0		ns

Table 5-77. SPI Slave Mode Timing Requirements

NO.			MIN	MAX	UNIT
12	$t_{c(SPC)S}$	Cycle time, SPICLK	$4t_{c(SYSCLK)}$		ns
13	$t_{w(SPC1)S}$	Pulse duration, SPICLK, first pulse	$2t_{c(SYSCLK)} - 1$		ns
14	$t_{w(SPC2)S}$	Pulse duration, SPICLK, second pulse	$2t_{c(SYSCLK)} - 1$		ns
19	$t_{su(SIMO)S}$	Setup time, SPISIMO valid before SPICLK	$1.5t_{c(SYSCLK)}$		ns
20	$t_{h(SIMO)S}$	Hold time, SPISIMO valid after SPICLK	$1.5t_{c(SYSCLK)}$		ns
25	$t_{su(STE)S}$	Setup time, $\overline{SPISTE}$ valid before SPICLK	$1.5t_{c(SYSCLK)}$		ns
26	$t_{h(STE)S}$	Hold time, $\overline{SPISTE}$ invalid after SPICLK	$1.5t_{c(SYSCLK)}$		ns

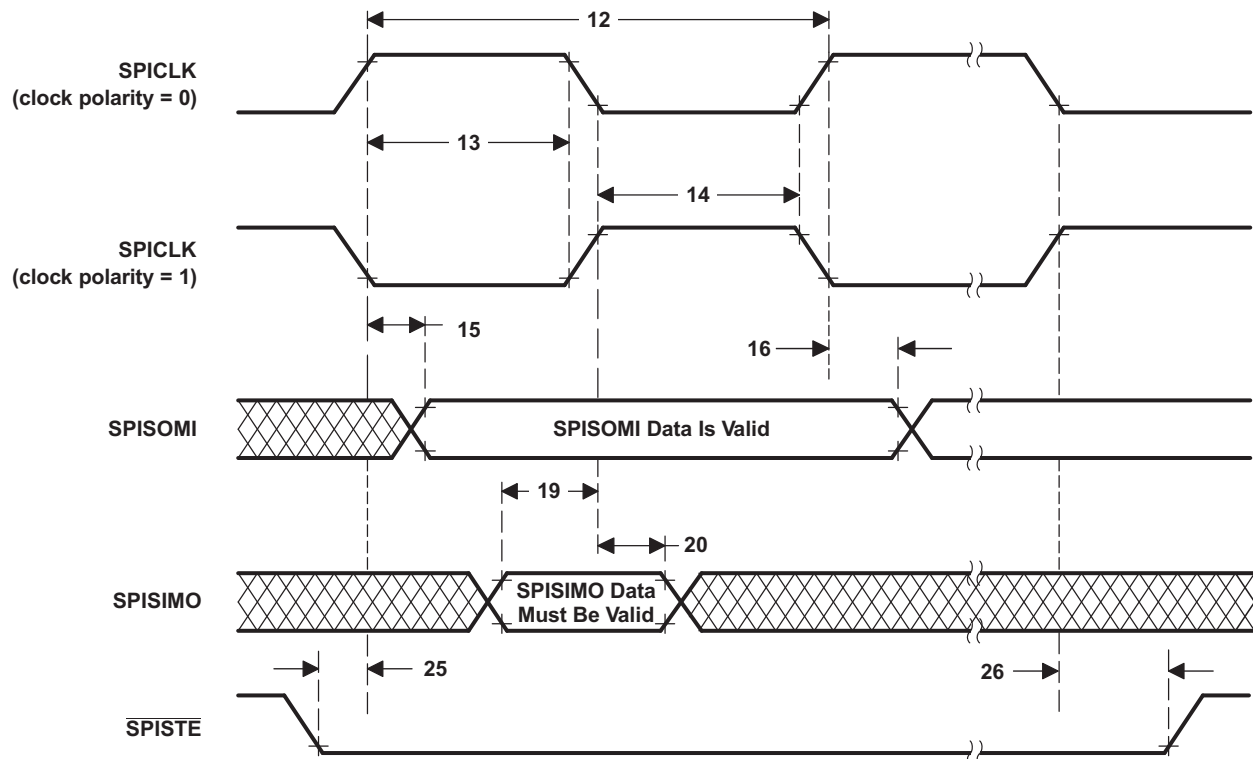


Figure 5-68. SPI Slave Mode External Timing (Clock Phase = 0)

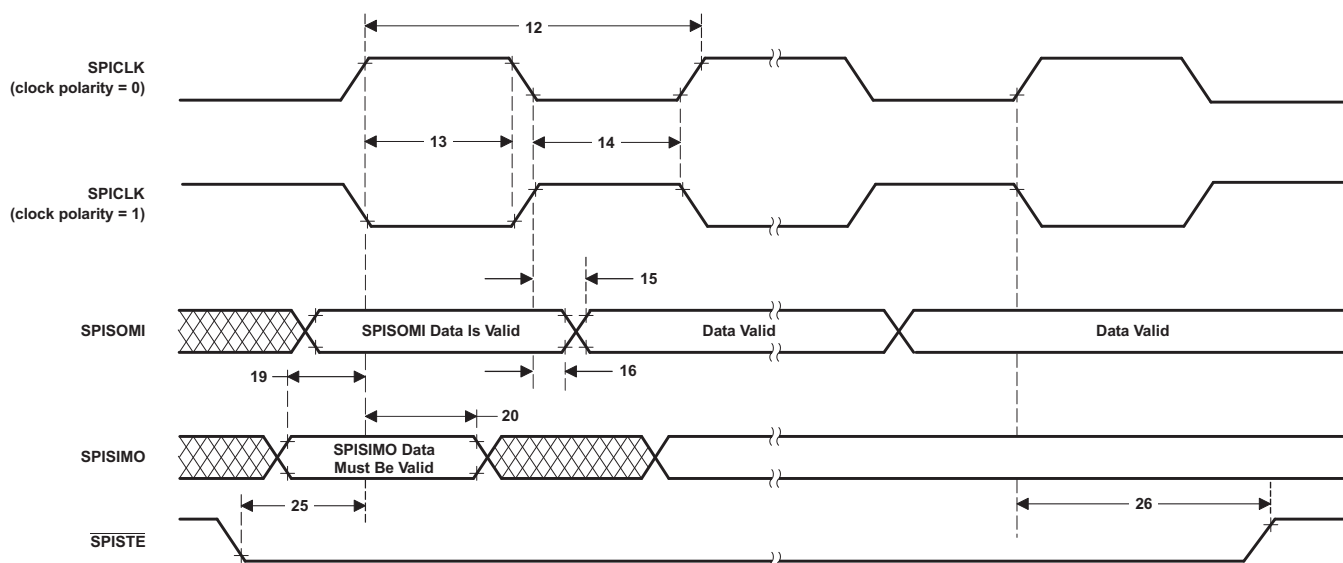


Figure 5-69. SPI Slave Mode External Timing (Clock Phase = 1)

5.11.5.1.3 High-Speed Master Mode Timings

Table 5-78 lists the SPI high-speed master mode switching characteristics where the clock phase = 0. Figure 5-70 shows the high-speed SPI master mode external timing where the clock phase = 0.

Table 5-79 lists the SPI high-speed master mode switching characteristics where the clock phase = 1. Figure 5-71 shows the high-speed SPI master mode external timing where the clock phase = 1.

Table 5-80 lists the SPI high-speed master mode timing requirements.

Table 5-78. SPI High-Speed Master Mode Switching Characteristics (Clock Phase = 0)

over recommended operating conditions (unless otherwise noted)

NO.	PARAMETER	(BRR + 1) CONDITION ⁽¹⁾	MIN	MAX	UNIT
1	$t_{c(SPC)M}$ Cycle time, SPICLK	Even	$4t_{c(LSPCLK)}$	$128t_{c(LSPCLK)}$	ns
		Odd	$5t_{c(LSPCLK)}$	$127t_{c(LSPCLK)}$	
2	$t_{w(SPC1)M}$ Pulse duration, SPICLK, first pulse	Even	$0.5t_{c(SPC)M} - 1$	$0.5t_{c(SPC)M} + 1$	ns
		Odd	$0.5t_{c(SPC)M} + 0.5t_{c(LSPCLK)} - 1$	$0.5t_{c(SPC)M} + 0.5t_{c(LSPCLK)} + 1$	
3	$t_{w(SPC2)M}$ Pulse duration, SPICLK, second pulse	Even	$0.5t_{c(SPC)M} - 1$	$0.5t_{c(SPC)M} + 1$	ns
		Odd	$0.5t_{c(SPC)M} - 0.5t_{c(LSPCLK)} - 1$	$0.5t_{c(SPC)M} - 0.5t_{c(LSPCLK)} + 1$	
4	$t_{d(SIMO)M}$ Delay time, SPICLK to SPISIMO valid	Even, Odd		3	ns
5	$t_{v(SIMO)M}$ Valid time, SPISIMO valid after SPICLK	Even	$0.5t_{c(SPC)M} - 1$		ns
		Odd	$0.5t_{c(SPC)M} - 0.5t_{c(LSPCLK)} - 1$		
23	$t_{d(SPC)M}$ Delay time, $\overline{SPISTE}$ valid to SPICLK	Even	$0.5t_{c(SPC)M} - 1$		ns
		Odd	$0.5t_{c(SPC)M} - 0.5t_{c(LSPCLK)} - 1$		
24	$t_{d(STE)M}$ Delay time, SPICLK to $\overline{SPISTE}$ invalid	Even	$0.5t_{c(SPC)M} - 1$		ns
		Odd	$0.5t_{c(SPC)M} - 0.5t_{c(LSPCLK)} - 1$		

(1) The (BRR + 1) condition is Even when (SPIBRR + 1) is even or SPIBRR is 0 or 2. It is Odd when (SPIBRR + 1) is odd and SPIBRR is greater than 3.

Table 5-79. SPI High-Speed Master Mode Switching Characteristics (Clock Phase = 1)

over recommended operating conditions (unless otherwise noted)

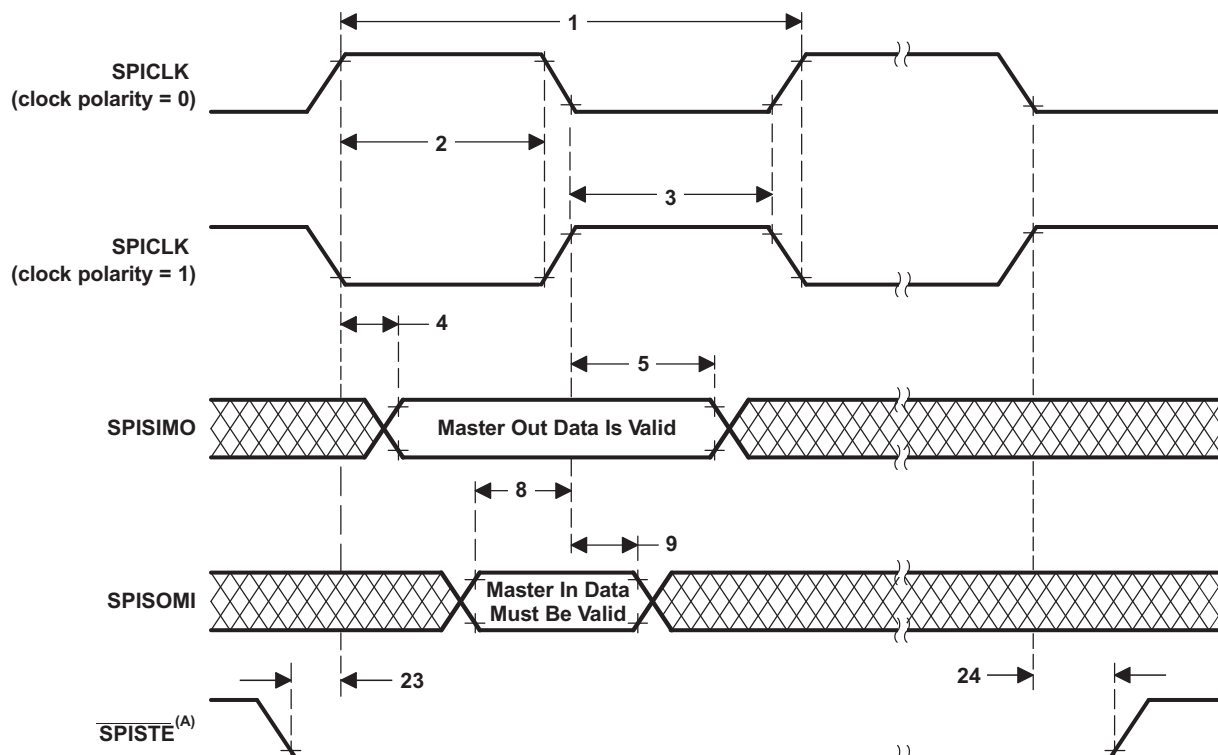
NO.	PARAMETER	(BRR + 1) CONDITION ⁽¹⁾	MIN	MAX	UNIT
1	$t_{c(SPC)M}$ Cycle time, SPICLK	Even	$4t_{c(LSPCLK)}$	$128t_{c(LSPCLK)}$	ns
		Odd	$5t_{c(LSPCLK)}$	$127t_{c(LSPCLK)}$	
2	$t_{w(SPCH)M}$ Pulse duration, SPICLK, first pulse	Even	$0.5t_{c(SPC)M} - 1$	$0.5t_{c(SPC)M} + 1$	ns
		Odd	$0.5t_{c(SPC)M} - 0.5t_{c(LSPCLK)} - 1$	$0.5t_{c(SPC)M} - 0.5t_{c(LSPCLK)} + 1$	
3	$t_{w(SPC2)M}$ Pulse duration, SPICLK, second pulse	Even	$0.5t_{c(SPC)M} - 1$	$0.5t_{c(SPC)M} + 1$	ns
		Odd	$0.5t_{c(SPC)M} + 0.5t_{c(LSPCLK)} - 1$	$0.5t_{c(SPC)M} + 0.5t_{c(LSPCLK)} + 1$	
4	$t_{d(SIMO)M}$ Delay time, SPISIMO valid to SPICLK	Even	$0.5t_{c(SPC)M} - 1$		ns
		Odd	$0.5t_{c(SPC)M} + 0.5t_{c(LSPCLK)} - 1$		
5	$t_{v(SIMO)M}$ Valid time, SPISIMO valid after SPICLK	Even	$0.5t_{c(SPC)M} - 1$		ns
		Odd	$0.5t_{c(SPC)M} - 0.5t_{c(LSPCLK)} - 1$		
23	$t_{d(SPC)M}$ Delay time, $\overline{SPISTE}$ valid to SPICLK	Even, Odd	$t_{c(SPC)M} - 1$		ns
24	$t_{d(STE)M}$ Delay time, SPICLK to $\overline{SPISTE}$ invalid	Even	$0.5t_{c(SPC)M} - 1$		ns
		Odd	$0.5t_{c(SPC)M} - 0.5t_{c(LSPCLK)} - 1$		

(1) The (BRR + 1) condition is Even when (SPIBRR + 1) is even or SPIBRR is 0 or 2. It is Odd when (SPIBRR + 1) is odd and SPIBRR is greater than 3.

Table 5-80. SPI High-Speed Master Mode Timing Requirements

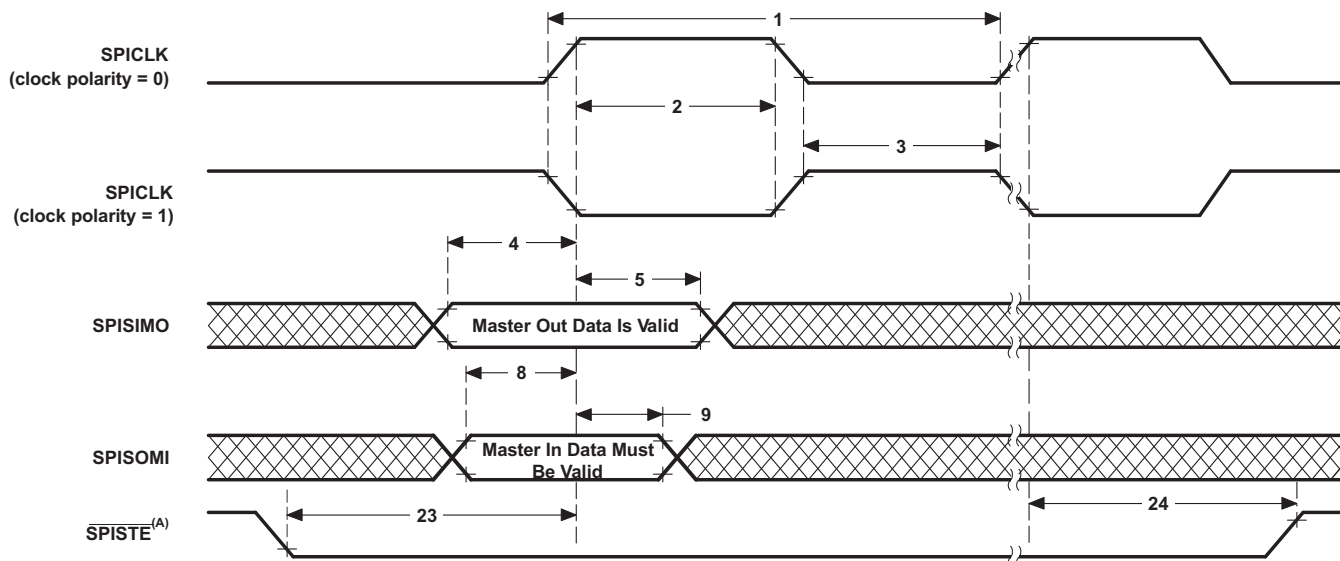
NO.	PARAMETER	(BRR + 1) CONDITION ⁽¹⁾	MIN	MAX	UNIT
8	$t_{su(SOMI)M}$ Setup time, SPISOMI valid before SPICLK	Even, Odd	2		ns
9	$t_{h(SOMI)M}$ Hold time, SPISOMI valid after SPICLK	Even, Odd	4		ns

(1) The (BRR + 1) condition is Even when (SPIBRR + 1) is even or SPIBRR is 0 or 2. It is Odd when (SPIBRR + 1) is odd and SPIBRR is greater than 3.



- A. On the trailing end of the word, $\overline{\text{SPISTE}}$ will go inactive except between back-to-back transmit words in both FIFO and non-FIFO modes.

Figure 5-70. High-Speed SPI Master Mode External Timing (Clock Phase = 0)



- A. On the trailing end of the word, $\overline{\text{SPISTE}}$ will go inactive except between back-to-back transmit words in both FIFO and non-FIFO modes.

Figure 5-71. High-Speed SPI Master Mode External Timing (Clock Phase = 1)

5.11.5.1.4 High-Speed Slave Mode Timings

Table 5-81 lists the SPI high-speed slave mode switching characteristics. Table 5-82 lists the SPI high-speed slave mode timing requirements.

Figure 5-72 shows the high-speed SPI slave mode external timing where the clock phase = 0. Figure 5-73 shows the high-speed SPI slave mode external timing where the clock phase = 1.

Table 5-81. SPI High-Speed Slave Mode Switching Characteristics

over recommended operating conditions (unless otherwise noted)

NO.	PARAMETER	MIN	MAX	UNIT
15	$t_{d(SOMI)S}$ Delay time, SPICLK to SPISOMI valid		13	ns
16	$t_{v(SOMI)S}$ Valid time, SPISOMI valid after SPICLK	0		ns

Table 5-82. SPI High-Speed Slave Mode Timing Requirements

NO.	PARAMETER	MIN	MAX	UNIT
12	$t_{c(SPC)S}$ Cycle time, SPICLK	$4t_{c(SYSCLK)}$		ns
13	$t_{w(SPC1)S}$ Pulse duration, SPICLK, first pulse	$2t_{c(SYSCLK)} - 1$		ns
14	$t_{w(SPC2)S}$ Pulse duration, SPICLK, second pulse	$2t_{c(SYSCLK)} - 1$		ns
19	$t_{su(SIMO)S}$ Setup time, SPISIMO valid before SPICLK	$1.5t_{c(SYSCLK)}$		ns
20	$t_{h(SIMO)S}$ Hold time, SPISIMO valid after SPICLK	$1.5t_{c(SYSCLK)}$		ns
25	$t_{su(STE)S}$ Setup time, $\overline{SPISTE}$ valid before SPICLK	$1.5t_{c(SYSCLK)}$		ns
26	$t_{h(STE)S}$ Hold time, $\overline{SPISTE}$ invalid after SPICLK	$1.5t_{c(SYSCLK)}$		ns

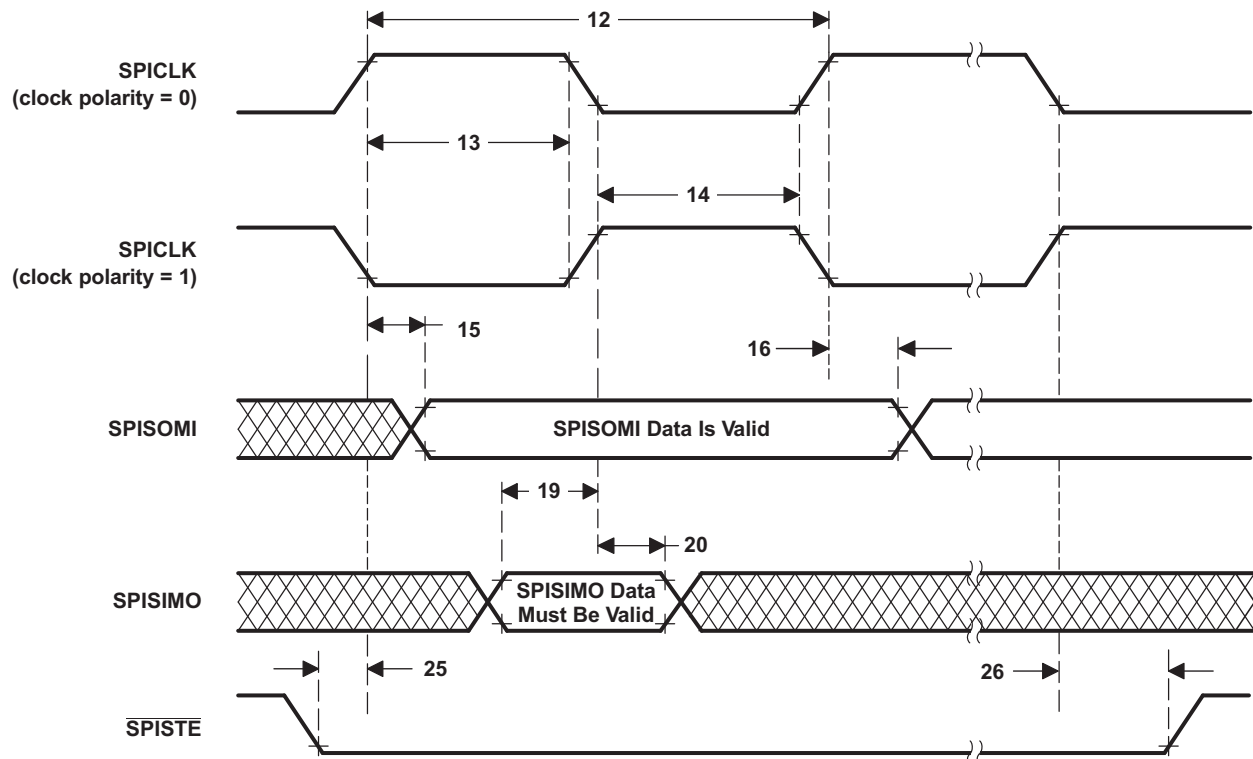


Figure 5-72. High-Speed SPI Slave Mode External Timing (Clock Phase = 0)

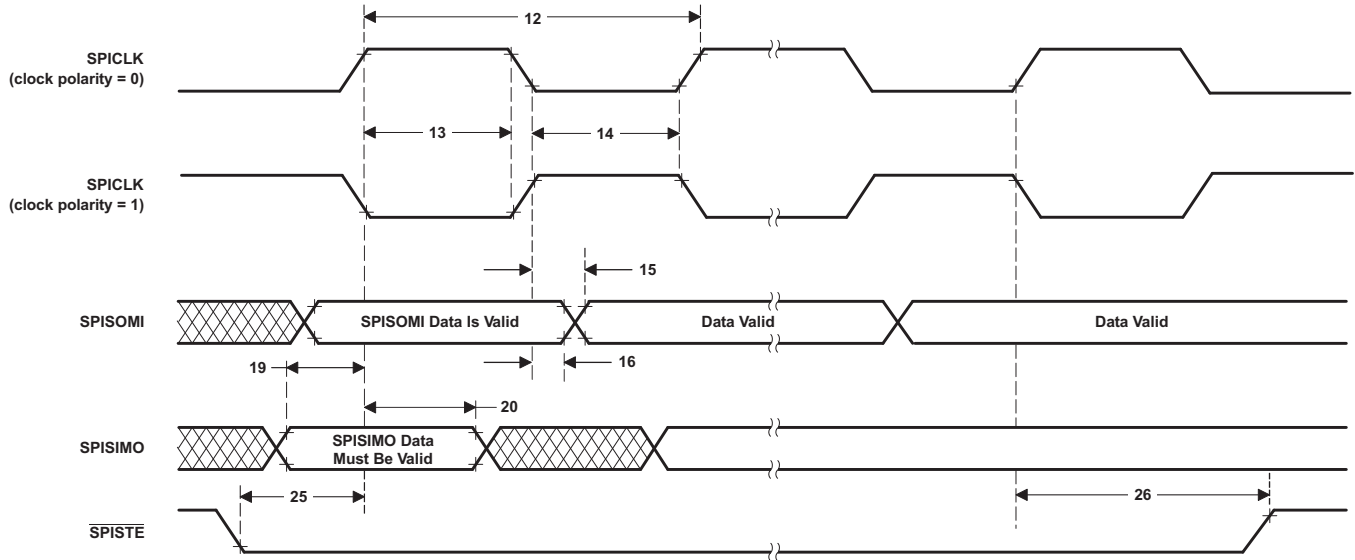


Figure 5-73. High-Speed SPI Slave Mode External Timing (Clock Phase = 1)

5.11.6 Local Interconnect Network (LIN)

This device contains one Local Interconnect Network (LIN) module. The LIN module adheres to the LIN 2.1 standard as defined by the *LIN Specification Package Revision 2.1*. The LIN is a low-cost serial interface designed for applications where the CAN protocol may be too expensive to implement, such as small subnetworks for cabin comfort functions like interior lighting or window control in an automotive application.

The LIN standard is based on the SCI (UART) serial data link format. The communication concept is single-master and multiple-slave with a message identification for multicast transmission between any network nodes.

The LIN module can be programmed to work either as an SCI or as a LIN as the core of the module is an SCI. The hardware features of the SCI are augmented to achieve LIN compatibility. The SCI module is a universal asynchronous receiver-transmitter (UART) that implements the standard non-return-to-zero format.

Though the registers are common for LIN and SCI, the register descriptions have notes to identify the register/bit usage in different modes. Because of this, code written for this module cannot be directly ported to the stand-alone SCI module and vice versa.

The LIN module has the following features:

- Compatibility with LIN 1.3, 2.0 and 2.1 protocols
- Configurable baud rate up to 20 kbps (as per LIN 2.1 protocol)
- Two external pins: LINRX and LINTX
- Multibuffered receive and transmit units
- Identification masks for message filtering
- Automatic master header generation
 - Programmable synchronization break field
 - Synchronization field
 - Identifier field
- Slave automatic synchronization
 - Synchronization break detection
 - Optional baud rate update
 - Synchronization validation
- 2^{31} programmable transmission rates with 7 fractional bits
- Wakeup on LINRX dominant level from transceiver
- Automatic wakeup support
 - Wakeup signal generation
 - Expiration times on wakeup signals
- Automatic bus idle detection
- Error detection
 - Bit error
 - Bus error
 - No-response error
 - Checksum error
 - Synchronization field error
 - Parity error
- Capability to use direct memory access (DMA) for transmit and receive data

- Two interrupt lines with priority encoding for:
 - Receive
 - Transmit
 - ID, error, and status
- Support for LIN 2.0 checksum
- Enhanced synchronizer finite state machine (FSM) support for frame processing
- Enhanced handling of extended frames
- Enhanced baud rate generator
- Update wakeup/go to sleep

Figure 5-74 shows the LIN block diagram.

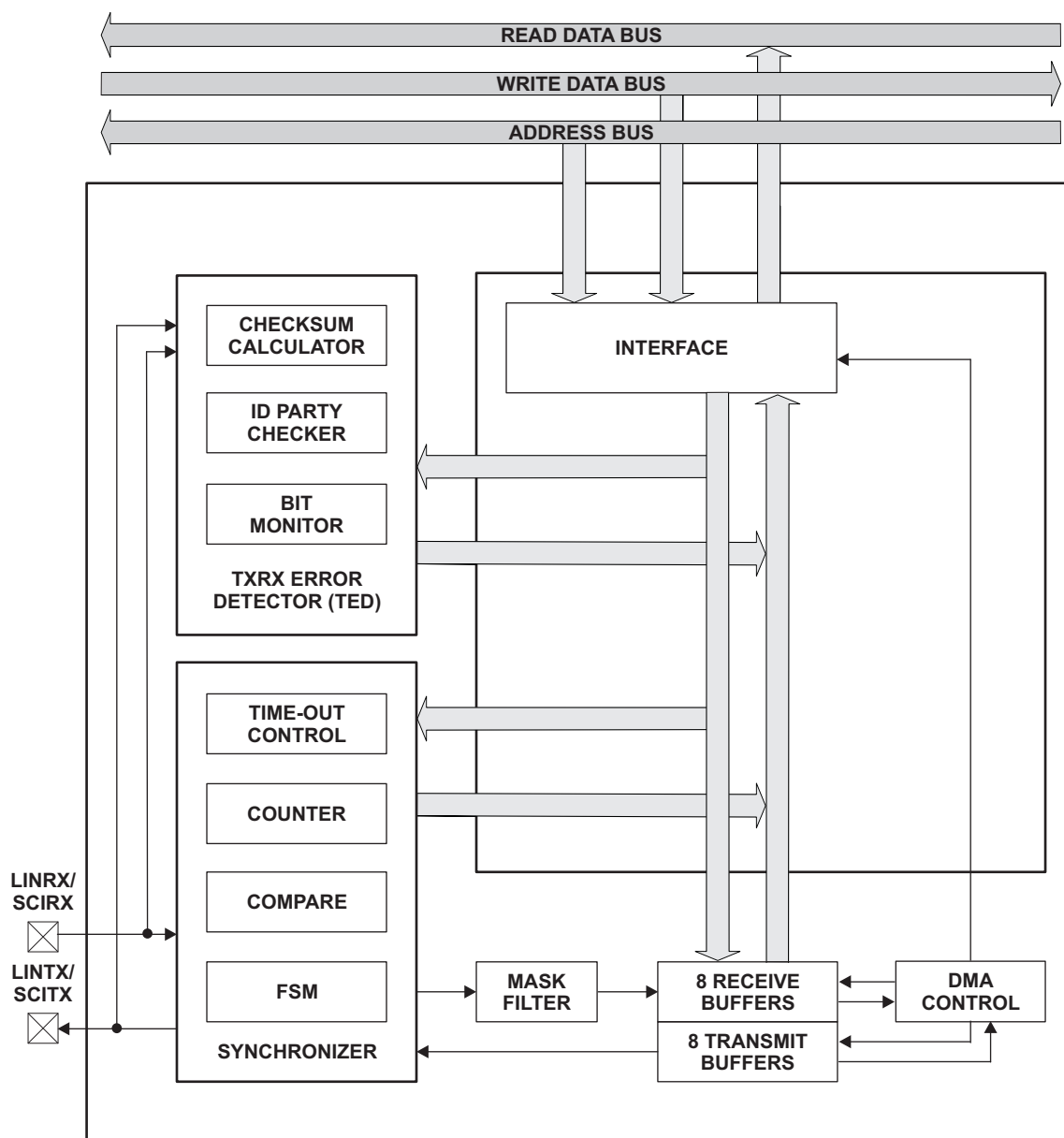


Figure 5-74. LIN Block Diagram

5.11.7 Fast Serial Interface (FSI)

The Fast Serial Interface (FSI) module is a serial communication peripheral capable of reliable and robust high-speed communications. The FSI is designed to ensure data robustness across many system conditions such as chip-to-chip as well as board-to-board across an isolation barrier. Payload integrity checks such as CRC, start- and end-of-frame patterns, and user-defined tags, are encoded before transmit and then verified after receipt using without additional CPU interaction. Line breaks can be detected using periodic transmissions, all managed and monitored by hardware. The FSI is also tightly integrated with other control peripherals on the device. To ensure that the latest sensor data or control parameters are available, frames can be transmitted on every control loop period. An integrated skew-compensation block has been added on the receiver to handle skew that may occur between the clock and data signals due to a variety of factors, including trace-length mismatch and skews induced by an isolation chip. With embedded data robustness checks, data-link integrity checks, skew compensation, and integration with control peripherals, the FSI can enable high-speed, robust communication in any system. These and many other features of the FSI follow.

The FSI module includes the following features:

- Independent transmitter and receiver cores
- Source-synchronous transmission
- Dual data rate (DDR)
- One or two data lines
- Programmable data length
- Skew adjustment block to compensate for board and system delay mismatches
- Frame error detection
- Programmable frame tagging for message filtering
- Hardware ping to detect line breaks during communication (ping watchdog)
- Two interrupts per FSI core
- Externally triggered frame generation
- Hardware- or software-calculated CRC
- Embedded ECC computation module
- Register write protection
- DMA support
- CLA task triggering
- SPI compatibility mode (limited features available)

The FSI consists of independent transmitter (FSITX) and receiver (FSIRX) cores. The FSITX and FSIRX cores are configured and operated independently. The features available on the FSITX and FSIRX are described in [Section 5.11.7.1](#) and [Section 5.11.7.2](#), respectively.

5.11.7.1 FSI Transmitter

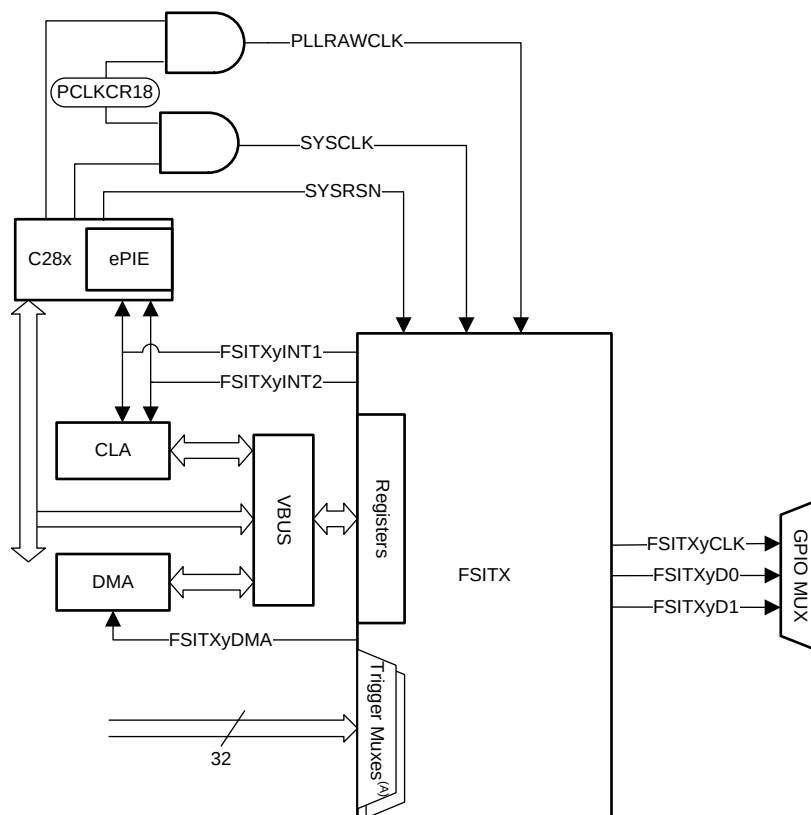
The FSI transmitter module handles the framing of data, CRC generation, signal generation of TXCLK, TXD0, and TXD1, as well as interrupt generation. The operation of the transmitter core is controlled and configured through programmable control registers. The transmitter control registers let the CPU (or the CLA) program, control, and monitor the operation of the FSI transmitter. The transmit data buffer is accessible by the CPU, CLA, and the DMA.

The transmitter has the following features:

- Automated ping frame generation
- Externally triggered ping frames
- Externally triggered data frames
- Software-configurable frame lengths
- 16-word data buffer

- Data buffer underrun and overrun detection
- Hardware-generated CRC on data bits
- Software ECC calculation on select data
- DMA support
- CLA task triggering

Figure 5-75 shows the FSITX CPU interface. Figure 5-76 shows the high-level block diagram of the FSITX. Not all data paths and internal connections are shown. This diagram provides a high-level overview of the internal modules present in the FSITX.



- A. The signals connected to the trigger muxes are described in the External Frame Trigger Mux section of the Fast Serial Interface (FSI) chapter in the [TMS320F28004x Piccolo Microcontrollers Technical Reference Manual](#).

Figure 5-75. FSITX CPU Interface

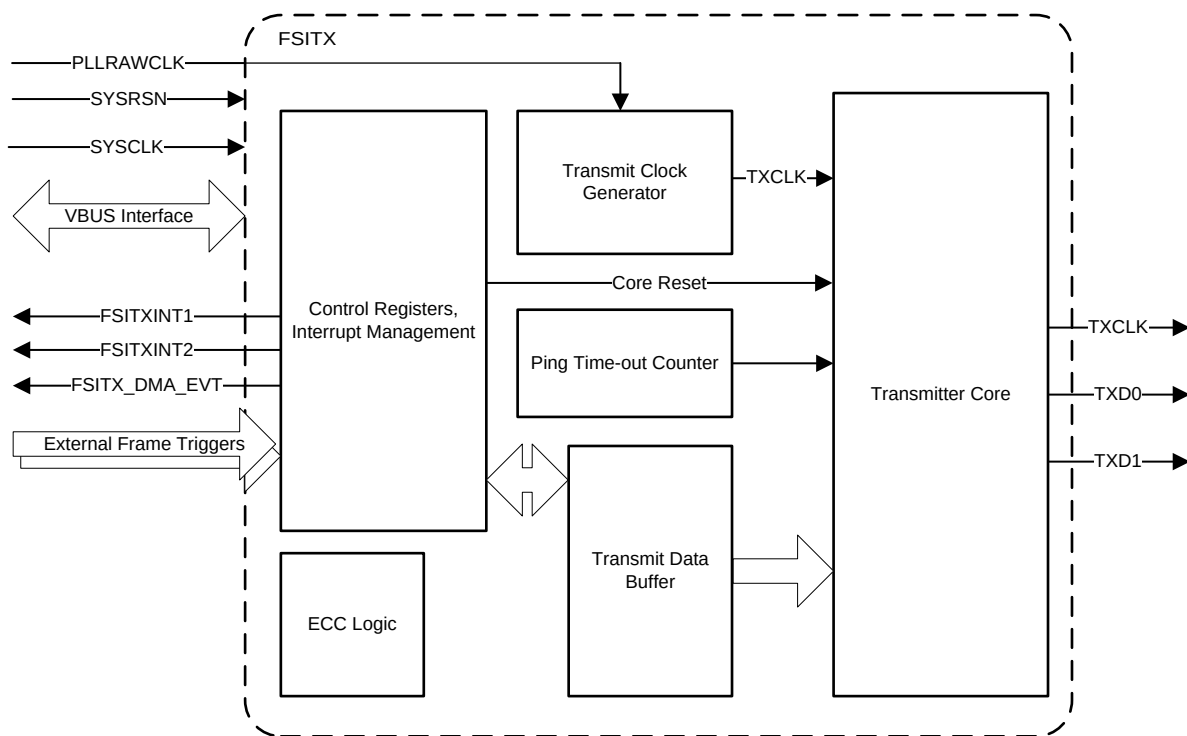


Figure 5-76. FSITX Block Diagram

5.11.7.1.1 FSITX Electrical Data and Timing

Table 5-83 lists the FSITX switching characteristics. Figure 5-77 shows the FSITX timings.

Table 5-83. FSITX Switching Characteristics

over operating free-air temperature range (unless otherwise noted)

NO.	PARAMETER	MIN	MAX	UNIT
1	$t_{c(TXCLK)}$ Cycle time, TXCLK	20		ns
2	$t_{w(TXCLK)}$ Pulse width, TXCLK low or TXCLK high	$(0.5t_{c(TXCLK)}) - 1$	$(0.5t_{c(TXCLK)}) + 1$	ns
3	$t_{d(TXCLKL-TXD)}$ Delay time, Data valid after TXCLK low	$(0.25t_{c(TXCLK)}) - 1$	$(0.25t_{c(TXCLK)}) + 1$	ns
4	$t_{d(TXCLKH-TXD)}$ Delay time, Data valid after TXCLK high	$(0.25t_{c(TXCLK)}) - 1$	$(0.25t_{c(TXCLK)}) + 1$	ns

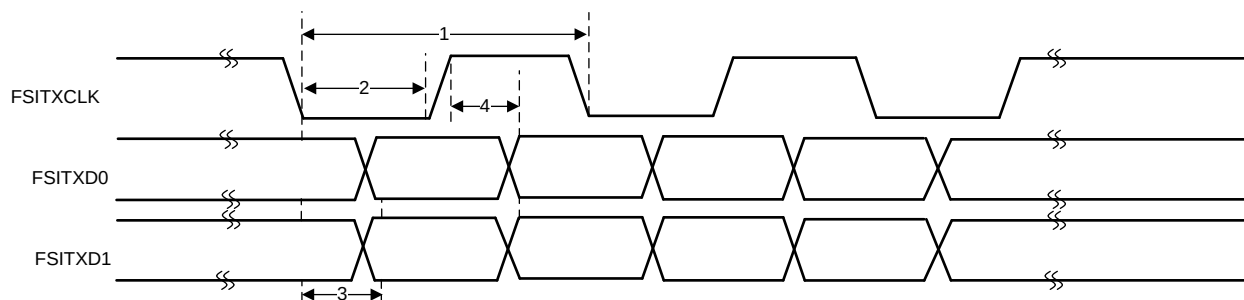


Figure 5-77. FSITX Timings

5.11.7.2 FSI Receiver

The receiver module interfaces to the FSI clock (RXCLK), and data lines (RXD0 and RXD1) after they pass through an optional programmable delay line. The receiver core handles the data framing, CRC computation, and frame-related error checking. The receiver bit clock and state machine are run by the RXCLK input, which is asynchronous to the device system clock.

The receiver control registers let the CPU (or the CLA) program, control, and monitor the operation of the FSIRX. The receive data buffer is accessible by the CPU, CLA, and the DMA.

The receiver core has the following features:

- 16-word data buffer
- Multiple supported frame types
- Ping frame watchdog
- Frame watchdog
- CRC calculation and comparison in hardware
- ECC detection
- Programmable delay line control on incoming signals
- DMA support
- CLA task triggering
- SPI compatibility mode

Figure 5-78 shows the FSIRX CPU interface. Figure 5-79 provides a high-level overview of the internal modules present in the FSIRX. Not all data paths and internal connections are shown.

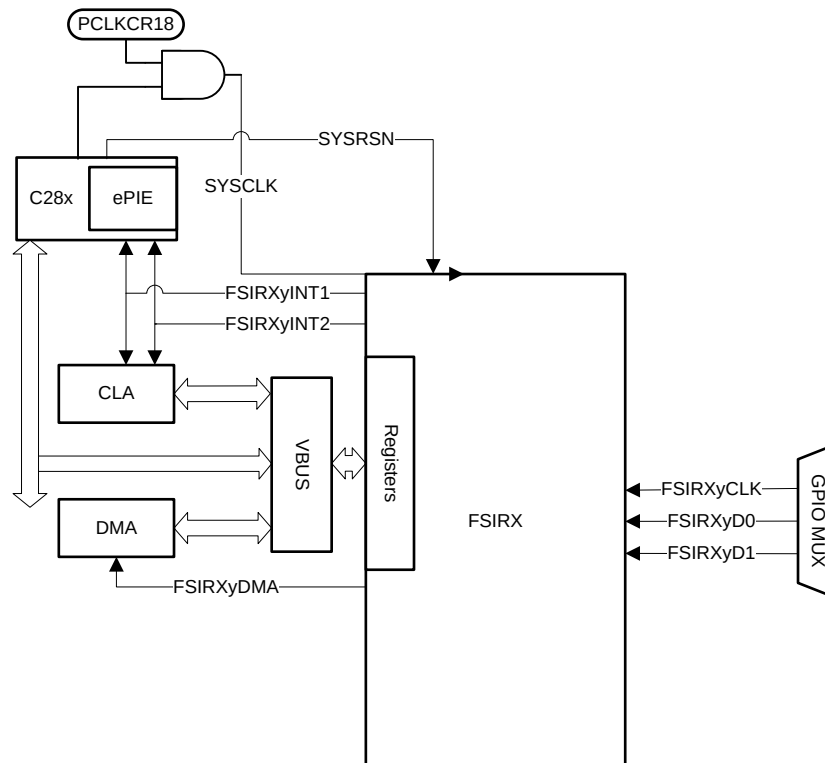


Figure 5-78. FSIRX CPU Interface

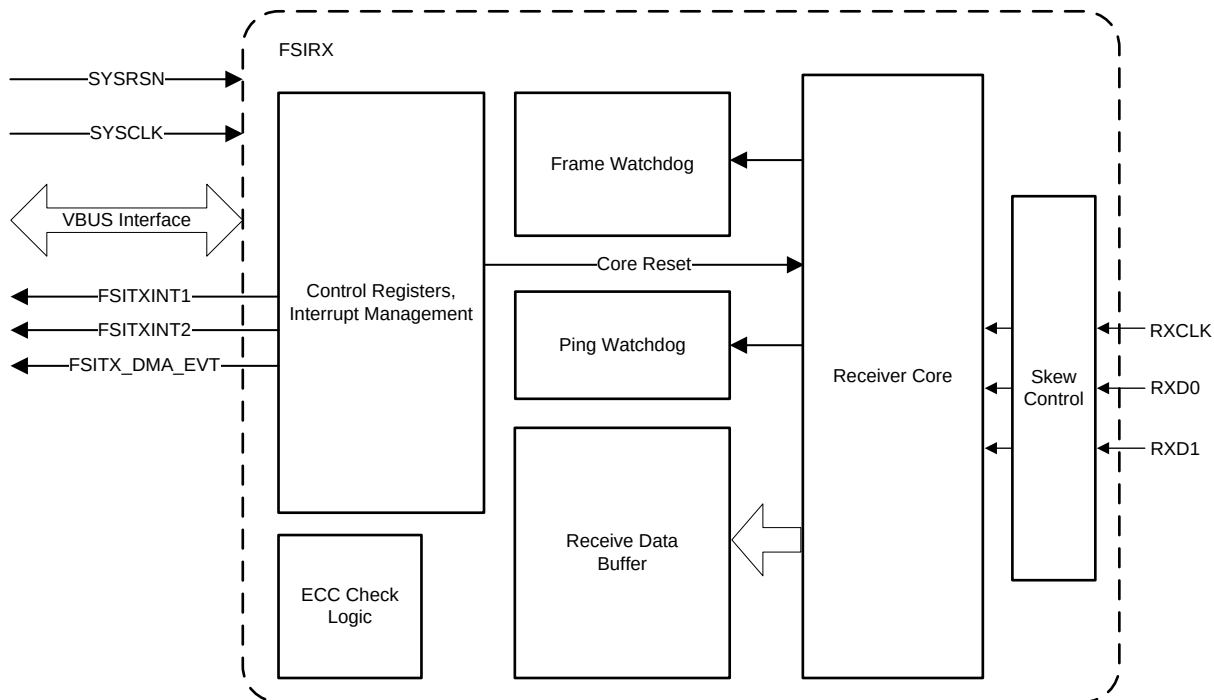


Figure 5-79. FSIRX Block Diagram

5.11.7.2.1 FSIRX Electrical Data and Timing

Table 5-84 lists the FSIRX timing requirements. Figure 5-80 shows the FSIRX timings.

Table 5-84. FSIRX Timing Requirements

NO.			MIN	MAX	UNIT
1	$t_{c(RXCLK)}$	Cycle time, RXCLK	20		ns
2	$t_{w(RXCLK)}$	Pulse width, RXCLK low or RXCLK high. This implies a duty cycle of 35/65.	$(0.5t_{c(RXCLK)}) - 1$	$(0.5t_{c(RXCLK)}) + 1$	ns
3	$t_{su(RXCLK-RXD)}$	Setup time with respect to RXCLK, applies to both edges of the clock	2		ns
4	$t_{h(RXCLK-RXD)}$	Hold time with respect to RXCLK, applies to both edges of the clock	2		ns

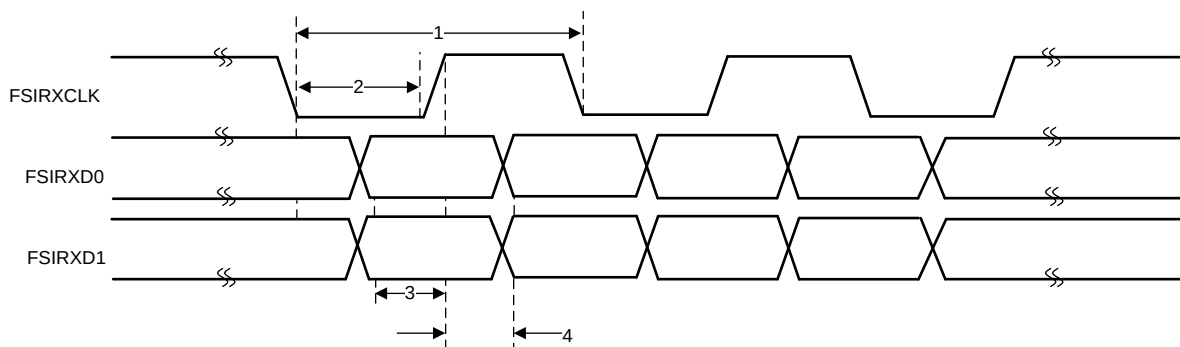


Figure 5-80. FSIRX Timings

5.11.7.3 FSI SPI Compatibility Mode

The FSI supports a SPI compatibility mode to enable communication with programmable SPI devices. In this mode, the FSI transmits its data in the same manner as a SPI in a single clock configuration mode. While the FSI is able to physically interface with a SPI in this mode, the external device must be able to encode and decode an FSI frame to communicate successfully. This is because the FSI transmits all SPI frame phases with the exception of the preamble and postamble. The FSI provides the same data validation and frame checking as if it was in standard FSI mode, allowing for more robust communication without consuming CPU cycles. The external SPI is required to send all relevant information and can access standard FSI features such as the ping frame watchdog on the FSIRX, frame tagging, or custom CRC values. The list of features of SPI compatibility mode follows:

- Data will transmit on rising edge and receive on falling edge of the clock.
- Only 16-bit word size is supported.
- TXD1 will be driven like an active-low chip-select signal. The signal will be low for the duration of the full frame transmission.
- No receiver chip-select input is required. RXD1 is not used. Data is shifted into the receiver on every active clock edge.
- No preamble or postamble clocks will be transmitted. All signals return to the idle state after the frame phase is finished.
- It is not possible to transmit in the SPI slave configuration because the FSI TXCLK cannot take an external clock source.

5.11.7.3.1 FSITX SPI Mode Electrical Data and Timing

Table 5-85 lists the FSITX SPI mode switching characteristics. Figure 5-81 shows the FSITX SPI mode timings. Special timings are not required for the FSIRX in SPI mode. FSIRX timings listed in Table 5-84 are applicable in SPI compatibility mode. Setup and Hold times are only valid on the falling edge of FSIRXCLK because this is the active edge in SPI mode.

Table 5-85. FSITX SPI Mode Switching Characteristics

over operating free-air temperature range (unless otherwise noted)

NO.	PARAMETER	MIN	MAX	UNIT
1	$t_c(\text{TXCLK})$ Cycle time, TXCLK	20		ns
2	$t_w(\text{TXCLK})$ Pulse width, TXCLK low or TXCLK high	10		ns
3	$t_d(\text{TXCLKH-TXD0})$ Delay time, Data valid after TXCLK high		3	ns
4	$t_d(\text{TXD1-TXCLK})$ Delay time, TXCLK high after TXD1 low	$t_w(\text{TXCLK})$		ns
5	$t_d(\text{TXCLK-TXD1})$ Delay time, TXD1 high after TXCLK low	$t_w(\text{TXCLK})$		ns

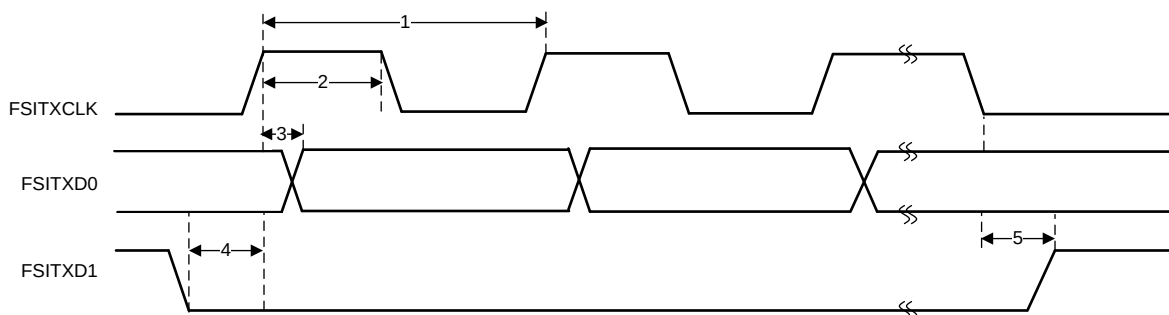


Figure 5-81. FSITX SPI Mode Timings

6 Detailed Description

6.1 Overview

The Piccolo™ TMS320F28004x (F28004x) is a powerful 32-bit floating-point microcontroller unit (MCU) that lets designers incorporate crucial control peripherals, differentiated analog, and nonvolatile memory on a single device.

The real-time control subsystem is based on TI's 32-bit C28x CPU, which provides 100 MHz of signal processing performance. The C28x CPU is further boosted by the new TMU extended instruction set, which enables fast execution of algorithms with trigonometric operations commonly found in transforms and torque loop calculations; and the VCU-I extended instruction set, which reduces the latency for complex math operations commonly found in encoded applications.

The CLA allows significant offloading of common tasks from the main C28x CPU. The CLA is an independent 32-bit floating-point math accelerator that executes in parallel with the CPU. Additionally, the CLA has its own dedicated memory resources and it can directly access the key peripherals that are required in a typical control system. Support of a subset of ANSI C is standard, as are key features like hardware breakpoints and hardware task-switching.

The F28004x supports up to 256KB (128KW) of flash memory divided into two 128KB (64KW) banks, which enables programming and execution in parallel. Up to 100KB (50KW) of on-chip SRAM is also available in blocks of 4KB (2KW) and 16KB (8KW) for efficient system partitioning. Flash ECC, SRAM ECC/parity, and dual-zone security are also supported.

High-performance analog blocks are integrated on the F28004x MCU to further enable system consolidation. Three separate 12-bit ADCs provide precise and efficient management of multiple analog signals, which ultimately boosts system throughput. Seven PGAs on the analog front end enable on-chip voltage scaling before conversion. Seven analog comparator modules provide continuous monitoring of input voltage levels for trip conditions.

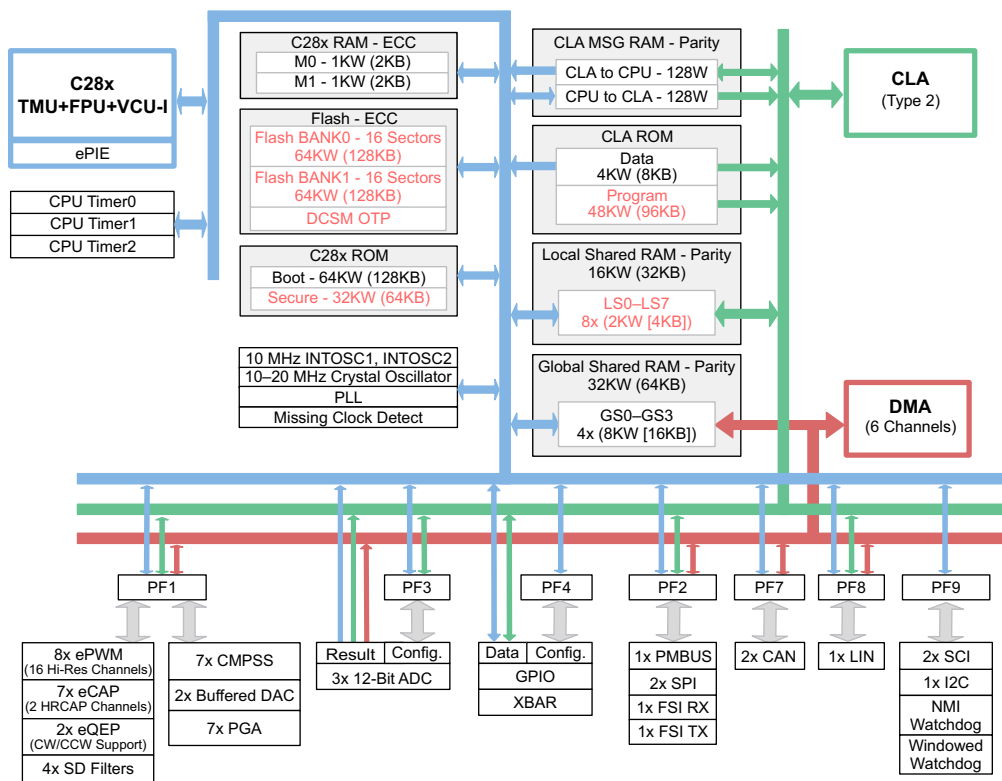
The TMS320C2000™ devices contain industry-leading control peripherals with frequency-independent ePWM/HRPWM and eCAP allow for a best-in-class level of control to the system. The built-in 4-channel SDFM allows for seamless integration of an oversampling sigma-delta modulator across an isolation barrier.

Connectivity is supported through various industry-standard communication ports (such as SPI, SCI, I2C, LIN, and CAN) and offers multiple muxing options for optimal signal placement in a variety of applications. New to the C2000™ platform is the fully compliant PMBus. Additionally, in an industry first, the FSI enables high-speed, robust communication to complement the rich set of peripherals that are embedded in the device.

Specially enabled device variants, TMS320F28004xC and TMS320F28004xM, allow access to the Configurable Logic Block (CLB) for additional interfacing features and allow access to the secure ROM, which includes libraries to enable InstaSPIN-FOC™ and InstaSPIN-MOTION™. See [Device Comparison](#) for more information.

6.2 Functional Block Diagram

Figure 6-1 shows the CPU system and associated peripherals.



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Figure 6-1. Functional Block Diagram

6.3 Memory

6.3.1 C28x Memory Map

Table 6-1 describes the C28x memory map. Memories accessible by the CLA or DMA (direct memory access) are also noted. See the Memory Controller Module section of the System Control chapter in the *TMS320F28004x Piccolo Microcontrollers Technical Reference Manual*.

Table 6-1. C28x Memory Map

MEMORY	SIZE	START ADDRESS	END ADDRESS	CLA ACCESS	DMA ACCESS	ECC-CAPABLE	PARITY	MEMORY ACCESS PROTECTION	SECURE
M0 RAM	1K × 16	0x0000 0000	0x0000 03FF			Yes			
M1 RAM	1K × 16	0x0000 0400	0x0000 07FF			Yes			
PieVectTable	512 × 16	0x0000 0D00	0x0000 0EFF						
CLA-to-CPU MSGRAM	128 × 16	0x0000 1480	0x0000 14FF	Read/Write			Yes		
CPU-to-CLA MSGRAM	128 × 16	0x0000 1500	0x0000 157F	Read			Yes		
LS0 RAM	2K × 16	0x0000 8000	0x0000 87FF	Configurable			Yes	Yes	Yes
LS1 RAM	2K × 16	0x0000 8800	0x0000 8FFF	Configurable			Yes	Yes	Yes
LS2 RAM	2K × 16	0x0000 9000	0x0000 97FF	Configurable			Yes	Yes	Yes
LS3 RAM	2K × 16	0x0000 9800	0x0000 9FFF	Configurable			Yes	Yes	Yes
LS4 RAM	2K × 16	0x0000 A000	0x0000 A7FF	Configurable			Yes	Yes	Yes
LS5 RAM	2K × 16	0x0000 A800	0x0000 AFFF	Configurable			Yes	Yes	Yes
LS6 RAM	2K × 16	0x0000 B000	0x0000 B7FF	Configurable			Yes	Yes	Yes
LS7 RAM	2K × 16	0x0000 B800	0x0000 BFFF	Configurable			Yes	Yes	Yes
GS0 RAM	8K × 16	0x0000 C000	0x0000 DFFF		Yes		Yes	Yes	
GS1 RAM	8K × 16	0x0000 E000	0x0000 FFFF		Yes		Yes	Yes	
GS2 RAM	8K × 16	0x0001 0000	0x0001 1FFF		Yes		Yes	Yes	
GS3 RAM	8K × 16	0x0001 2000	0x0001 3FFF		Yes		Yes	Yes	
CAN A Message RAM	2K × 16	0x0004 9000	0x0004 97FF		Yes				
CAN B Message RAM	2K × 16	0x0004 B000	0x0004 B7FF		Yes				
Flash Bank 0	64K × 16	0x0008 0000	0x0008 FFFF			Yes		N/A	Yes
Flash Bank 1	64K × 16	0x0009 0000	0x0009 FFFF			Yes		N/A	Yes
Secure ROM	32K × 16	0x003E 8000	0x003E FFFF						Yes
Boot ROM	64K × 16	0x003F 0000	0x003F FFBF						
Vectors	64 × 16	0x003F FFC0	0x003F FFFF						
CLA Data ROM	4K × 16	0x0100 1000	0x0100 1FFF	Read					
CLA Program ROM	48K × 16	0x0102 0000	0x0102 BFFF	Read					Yes

6.3.2 Flash Memory Map

On the F28004x devices, up to two flash banks (each 128KB [64KW]) are available. The flash banks are controlled by a single FMC (flash module controller). On the devices in which there is only one flash bank (F280041 and F280040), the code to program the flash should be executed out of RAM. On the devices in which there are two flash banks (F280049, F280048, and F280045), only one bank at a time can be programmed or erased. In the dual-bank devices, the code to program the flash can be executed from one flash bank to erase or program the other flash bank, or the code can be executed from RAM. There should not be any kind of access to the flash bank on which an erase/program operation is in progress. [Table 6-2](#) lists the addresses of flash sectors for F280049, F280048, and F280045. [Table 6-3](#) lists the addresses of flash sectors for F280041 and F280040.

Table 6-2. Addresses of Flash Sectors for F280049, F280048, and F280045

SECTOR	SIZE	START ADDRESS	END ADDRESS
OTP SECTORS			
TI OTP Bank 0	1K × 16	0x0007 0000	0x0007 03FF
User-configurable DCSM OTP Bank 0	1K × 16	0x0007 8000	0x0007 83FF
TI OTP Bank 1	1K × 16	0x0007 0400	0x0007 07FF
User-configurable DCSM OTP Bank 1	1K × 16	0x0007 8400	0x0007 87FF
BANK 0 SECTORS			
Sector 0	4K × 16	0x0008 0000	0x0008 0FFF
Sector 1	4K × 16	0x0008 1000	0x0008 1FFF
Sector 2	4K × 16	0x0008 2000	0x0008 2FFF
Sector 3	4K × 16	0x0008 3000	0x0008 3FFF
Sector 4	4K × 16	0x0008 4000	0x0008 4FFF
Sector 5	4K × 16	0x0008 5000	0x0008 5FFF
Sector 6	4K × 16	0x0008 6000	0x0008 6FFF
Sector 7	4K × 16	0x0008 7000	0x0008 7FFF
Sector 8	4K × 16	0x0008 8000	0x0008 8FFF
Sector 9	4K × 16	0x0008 9000	0x0008 9FFF
Sector 10	4K × 16	0x0008 A000	0x0008 AFFF
Sector 11	4K × 16	0x0008 B000	0x0008 BFFF
Sector 12	4K × 16	0x0008 C000	0x0008 CFFF
Sector 13	4K × 16	0x0008 D000	0x0008 DFFF
Sector 14	4K × 16	0x0008 E000	0x0008 EFFF
Sector 15	4K × 16	0x0008 F000	0x0008 FFFF
BANK 1 SECTORS			
Sector 0	4K × 16	0x0009 0000	0x0009 0FFF
Sector 1	4K × 16	0x0009 1000	0x0009 1FFF
Sector 2	4K × 16	0x0009 2000	0x0009 2FFF
Sector 3	4K × 16	0x0009 3000	0x0009 3FFF
Sector 4	4K × 16	0x0009 4000	0x0009 4FFF
Sector 5	4K × 16	0x0009 5000	0x0009 5FFF
Sector 6	4K × 16	0x0009 6000	0x0009 6FFF
Sector 7	4K × 16	0x0009 7000	0x0009 7FFF
Sector 8	4K × 16	0x0009 8000	0x0009 8FFF
Sector 9	4K × 16	0x0009 9000	0x0009 9FFF
Sector 10	4K × 16	0x0009 A000	0x0009 AFFF
Sector 11	4K × 16	0x0009 B000	0x0009 BFFF
Sector 12	4K × 16	0x0009 C000	0x0009 CFFF
Sector 13	4K × 16	0x0009 D000	0x0009 DFFF

Table 6-2. Addresses of Flash Sectors for F280049, F280048, and F280045 (continued)

SECTOR	SIZE	START ADDRESS	END ADDRESS
Sector 14	4K × 16	0x0009 E000	0x0009 EFFF
Sector 15	4K × 16	0x0009 F000	0x0009 FFFF
FLASH ECC LOCATIONS			
TI OTP ECC Bank 0	128 × 16	0x0107 0000	0x0107 007F
TI OTP ECC Bank 1	128 × 16	0x0107 0080	0x0107 00FF
User-configurable DCSM OTP ECC Bank 0	128 × 16	0x0107 1000	0x0107 107F
User-configurable DCSM OTP ECC Bank 1	128 × 16	0x0107 1080	0x0107 10FF
Flash ECC Bank 0	8K × 16	0x0108 0000	0x0108 1FFF
Flash ECC Bank 1	8K × 16	0x0108 2000	0x0108 3FFF

Table 6-3. Addresses of Flash Sectors for F280041 and F280040

SECTOR	SIZE	START ADDRESS	END ADDRESS
OTP SECTORS			
TI OTP Bank 0	1K × 16	0x0007 0000	0x0007 03FF
User-configurable DCSM OTP Bank 0	1K × 16	0x0007 8000	0x0007 83FF
BANK 0 SECTORS			
Sector 0	4K × 16	0x0008 0000	0x0008 0FFF
Sector 1	4K × 16	0x0008 1000	0x0008 1FFF
Sector 2	4K × 16	0x0008 2000	0x0008 2FFF
Sector 3	4K × 16	0x0008 3000	0x0008 3FFF
Sector 4	4K × 16	0x0008 4000	0x0008 4FFF
Sector 5	4K × 16	0x0008 5000	0x0008 5FFF
Sector 6	4K × 16	0x0008 6000	0x0008 6FFF
Sector 7	4K × 16	0x0008 7000	0x0008 7FFF
Sector 8	4K × 16	0x0008 8000	0x0008 8FFF
Sector 9	4K × 16	0x0008 9000	0x0008 9FFF
Sector 10	4K × 16	0x0008 A000	0x0008 AFFF
Sector 11	4K × 16	0x0008 B000	0x0008 BFFF
Sector 12	4K × 16	0x0008 C000	0x0008 CFFF
Sector 13	4K × 16	0x0008 D000	0x0008 DFFF
Sector 14	4K × 16	0x0008 E000	0x0008 EFFF
Sector 15	4K × 16	0x0008 F000	0x0008 FFFF
FLASH ECC LOCATIONS			
TI OTP ECC Bank 0	128 × 16	0x0107 0000	0x0107 007F
User-configurable DCSM OTP ECC Bank 0	128 × 16	0x0107 1000	0x0107 107F
Flash ECC Bank 0	8K × 16	0x0108 0000	0x0108 1FFF

6.3.3 Peripheral Registers Memory Map

Table 6-4 lists the peripheral registers.

Table 6-4. Peripheral Registers Memory Map

REGISTER	STRUCTURE NAME	START ADDRESS	END ADDRESS	PIPELINE PROTECTION ⁽¹⁾	CLA ACCESS	DMA ACCESS
Peripheral Frame 0						
AdcaResultRegs ⁽²⁾	ADC_RESULT_REGS	0x0000 0B00	0x0000 0B1F		Yes	Yes
AdcbResultRegs ⁽²⁾	ADC_RESULT_REGS	0x0000 0B20	0x0000 0B3F		Yes	Yes
AdccResultRegs ⁽²⁾	ADC_RESULT_REGS	0x0000 0B40	0x0000 0B5F		Yes	Yes
Cla1OnlyRegs	CLA_ONLY_REGS	0x0000 0C00	0x0000 0CFF		Yes - CLA only no CPU access	
CpuTimer0Regs	CPUTIMER_REGS	0x0000 0C00	0x0000 0C07			
CpuTimer1Regs	CPUTIMER_REGS	0x0000 0C08	0x0000 0C0F			
CpuTimer2Regs	CPUTIMER_REGS	0x0000 0C10	0x0000 0C17			
PieCtrlRegs	PIE_CTRL_REGS	0x0000 0CE0	0x0000 0CFF			
Cla1SoftIntRegs	CLA_SOFTINT_REGS	0x0000 0CE0	0x0000 0CFF		Yes - CLA only no CPU access	
DmaRegs	DMA_REGS	0x0000 1000	0x0000 11FF			
Cla1Regs	CLA_REGS	0x0000 1400	0x0000 147F	Yes		
Peripheral Frame 1						
EPwm1Regs	EPWM_REGS	0x0000 4000	0x0000 40FF	Yes	Yes	Yes
EPwm2Regs	EPWM_REGS	0x0000 4100	0x0000 41FF	Yes	Yes	Yes
EPwm3Regs	EPWM_REGS	0x0000 4200	0x0000 42FF	Yes	Yes	Yes
EPwm4Regs	EPWM_REGS	0x0000 4300	0x0000 43FF	Yes	Yes	Yes
EPwm5Regs	EPWM_REGS	0x0000 4400	0x0000 44FF	Yes	Yes	Yes
EPwm6Regs	EPWM_REGS	0x0000 4500	0x0000 45FF	Yes	Yes	Yes
EPwm7Regs	EPWM_REGS	0x0000 4600	0x0000 46FF	Yes	Yes	Yes
EPwm8Regs	EPWM_REGS	0x0000 4700	0x0000 47FF	Yes	Yes	Yes
EQep1Regs	EQEP_REGS	0x0000 5100	0x0000 513F	Yes	Yes	Yes
EQep2Regs	EQEP_REGS	0x0000 5140	0x0000 517F	Yes	Yes	Yes
ECap1Regs	ECAP_REGS	0x0000 5200	0x0000 521F	Yes	Yes	Yes
ECap2Regs	ECAP_REGS	0x0000 5240	0x0000 525F	Yes	Yes	Yes
ECap3Regs	ECAP_REGS	0x0000 5280	0x0000 529F	Yes	Yes	Yes
ECap4Regs	ECAP_REGS	0x0000 52C0	0x0000 52DF	Yes	Yes	Yes
ECap5Regs	ECAP_REGS	0x0000 5300	0x0000 531F	Yes	Yes	Yes
ECap6Regs	ECAP_REGS	0x0000 5340	0x0000 535F	Yes	Yes	Yes
Hrcap6Regs	HRCAP_REGS	0x0000 5360	0x0000 537F	Yes	Yes	Yes
ECap7Regs	ECAP_REGS	0x0000 5380	0x0000 539F	Yes	Yes	Yes
Hrcap7Regs	HRCAP_REGS	0x0000 53A0	0x0000 53BF	Yes	Yes	Yes
Pga1Regs	PGA_REGS	0x0000 5B00	0x0000 5B0F	Yes	Yes	Yes
Pga2Regs	PGA_REGS	0x0000 5B10	0x0000 5B1F	Yes	Yes	Yes
Pga3Regs	PGA_REGS	0x0000 5B20	0x0000 5B2F	Yes	Yes	Yes
Pga4Regs	PGA_REGS	0x0000 5B30	0x0000 5B3F	Yes	Yes	Yes

- (1) The CPU (not applicable for CLA or DMA) contains a write-followed-by-read protection mode to ensure that any read operation that follows a write operation within a protected address range is executed as written by delaying the read operation until the write is initiated.

- (2) ADC result register has no arbitration. Each master can access any ADC result register without any arbitration.

Table 6-4. Peripheral Registers Memory Map (continued)

REGISTER	STRUCTURE NAME	START ADDRESS	END ADDRESS	PIPELINE PROTECTION ⁽¹⁾	CLA ACCESS	DMA ACCESS
Pga5Regs	PGA_REGS	0x0000 5B40	0x0000 5B4F	Yes	Yes	Yes
Pga6Regs	PGA_REGS	0x0000 5B50	0x0000 5B5F	Yes	Yes	Yes
Pga7Regs	PGA_REGS	0x0000 5B60	0x0000 5B6F	Yes	Yes	Yes
DacaRegs	DAC_REGS	0x0000 5C00	0x0000 5C0F	Yes	Yes	Yes
DacbRegs	DAC_REGS	0x0000 5C10	0x0000 5C1F	Yes	Yes	Yes
Cmpss1Regs	CMPSS_REGS	0x0000 5C80	0x0000 5C9F	Yes	Yes	Yes
Cmpss2Regs	CMPSS_REGS	0x0000 5CA0	0x0000 5CBF	Yes	Yes	Yes
Cmpss3Regs	CMPSS_REGS	0x0000 5CC0	0x0000 5CDF	Yes	Yes	Yes
Cmpss4Regs	CMPSS_REGS	0x0000 5CE0	0x0000 5CFF	Yes	Yes	Yes
Cmpss5Regs	CMPSS_REGS	0x0000 5D00	0x0000 5D1F	Yes	Yes	Yes
Cmpss6Regs	CMPSS_REGS	0x0000 5D20	0x0000 5D3F	Yes	Yes	Yes
Cmpss7Regs	CMPSS_REGS	0x0000 5D40	0x0000 5D5F	Yes	Yes	Yes
Sdfm1Regs	SDFM_REGS	0x0000 5E00	0x0000 5E7F	Yes	Yes	Yes
Peripheral Frame 2						
SpiaRegs ⁽³⁾	SPI_REGS	0x0000 6100	0x0000 610F	Yes	Yes	Yes
SpibRegs ⁽³⁾	SPI_REGS	0x0000 6110	0x0000 611F	Yes	Yes	Yes
PmbusaRegs	PMBUS_REGS	0x0000 6400	0x0000 641F	Yes	Yes	Yes
FsiTxaRegs	FSI_TX_REGS	0x0000 6600	0x0000 667F	Yes	Yes	Yes
FsiRxaRegs	FSI_RX_REGS	0x0000 6680	0x0000 66FF	Yes	Yes	Yes
Peripheral Frame 3						
AdcaRegs	ADC_REGS	0x0000 7400	0x0000 747F	Yes	Yes	
AdcbRegs	ADC_REGS	0x0000 7480	0x0000 74FF	Yes	Yes	
AdccRegs	ADC_REGS	0x0000 7500	0x0000 757F	Yes	Yes	
Peripheral Frame 4						
InputXbarRegs	INPUT_XBAR_REGS	0x0000 7900	0x0000 791F	Yes		
XbarRegs	XBAR_REGS	0x0000 7920	0x0000 793F	Yes		
SyncSocRegs	SYNC_SOC_REGS	0x0000 7940	0x0000 794F	Yes		
DmaClaSrcSelRegs	DMA_CLA_SRC_SEL_REGS	0x0000 7980	0x0000 79BF	Yes		
EPwmXbarRegs	EPWM_XBAR_REGS	0x0000 7A00	0x0000 7A3F	Yes		
OutputXbarRegs	OUTPUT_XBAR_REGS	0x0000 7A80	0x0000 7ABF	Yes		
GpioCtrlRegs	GPIO_CTRL_REGS	0x0000 7C00	0x0000 7EFF	Yes		
GpioDataRegs ⁽⁴⁾	GPIO_DATA_REGS	0x0000 7F00	0x0000 7FFF	Yes	Yes	
Peripheral Frame 5						
DevCfgRegs	DEV_CFG_REGS	0x0005 D000	0x0005 D17F	Yes		
ClkCfgRegs	CLK_CFG_REGS	0x0005 D200	0x0005 D2FF	Yes		
CpuSysRegs	CPU_SYS_REGS	0x0005 D300	0x0005 D3FF	Yes		
PeriphAcRegs	PERIPH_AC_REGS	0x0005 D500	0x0005 D6FF	Yes		
AnalogSubsysRegs	ANALOG_SUBSYS_REGS	0x0005 D700	0x0005 D7FF	Yes		
Peripheral Frame 6						
EradGlobalRegs	ERAD_GLOBAL_REGS	0x0005 E800	0x0005 E8FF			
EradHwbpRegs	ERAD_HWBP_REGS	0x0005 E900	0x0005 E97F			
EradCounterRegs	ERAD_COUNTER_REGS	0x0005 E980	0x0005 E9FF			
EradCrcRegs	ERAD_CRC_REGS	0x0005 EA00	0x0005 EACF			
DcsmBank0Z1Regs	DCSM_BANK0_Z1_REGS	0x0005 F000	0x0005 F022	Yes		

(3) Registers with 16-bit access only.

(4) Both CPU and CLA have their own copy of GPIO_DATA_REGS, and hence, no arbitration is required between CPU and CLA. For more details, see the General-Purpose Input/Output (GPIO) chapter of the [TMS320F28004x Piccolo Microcontrollers Technical Reference Manual](#).

Table 6-4. Peripheral Registers Memory Map (continued)

REGISTER	STRUCTURE NAME	START ADDRESS	END ADDRESS	PIPELINE PROTECTION ⁽¹⁾	CLA ACCESS	DMA ACCESS
DcsmBank0Z2Regs	DCSM_BANK0_Z2_REGS	0x0005 F040	0x0005 F062	Yes		
DcsmBank1Z1Regs	DCSM_BANK1_Z1_REGS	0x0005 F100	0x0005 F122	Yes		
DcsmBank1Z2Regs	DCSM_BANK1_Z2_REGS	0x0005 F140	0x0005 F162	Yes		
DcsmCommonRegs	DCSM_COMMON_REGS	0x0005 F070	0x0005 F07F	Yes		
DcsmCommon2Regs	DCSM_COMMON_REGS	0x0005 F080	0x0005 F087	Yes		
MemCfgRegs	MEM_CFG_REGS	0x0005 F400	0x0005 F47F	Yes		
AccessProtectionRegs	ACCESS_PROTECTION_REGS	0x0005 F4C0	0x0005 F4FF	Yes		
MemoryErrorRegs	MEMORY_ERROR_REGS	0x0005 F500	0x0005 F53F	Yes		
Flash0CtrlRegs	FLASH_CTRL_REGS	0x0005 F800	0x0005 FAFF	Yes		
Flash0EccRegs	FLASH_ECC_REGS	0x0005 FB00	0x0005 FB3F	Yes		
Peripheral Frame 7						
CanaRegs	CAN_REGS	0x0004 8000	0x0004 87FF	Yes		Yes
CanbRegs	CAN_REGS	0x0004 A000	0x0004 A7FF	Yes		Yes
RomPrefetchRegs	ROM_PREFETCH_REGS	0x0005 E608	0x0005 E609	Yes		
DccRegs	DCC_REGS	0x0005 E700	0x0005 E73F	Yes		
Peripheral Frame 8						
LinaRegs	LIN_REGS	0x0000 6A00	0x0000 6AFF	Yes	Yes	Yes
Peripheral Frame 9						
WdRegs ⁽³⁾	WD_REGS	0x0000 7000	0x0000 703F	Yes		
NmiIntruptRegs ⁽³⁾	NMI_INTRUPT_REGS	0x0000 7060	0x0000 706F	Yes		
XintRegs ⁽³⁾	XINT_REGS	0x0000 7070	0x0000 707F	Yes		
SciaRegs ⁽³⁾	SCI_REGS	0x0000 7200	0x0000 720F	Yes		
ScibRegs ⁽³⁾	SCI_REGS	0x0000 7210	0x0000 721F	Yes		
I2caRegs ⁽³⁾	I2C_REGS	0x0000 7300	0x0000 733F	Yes		

6.3.4 Memory Types

6.3.4.1 Dedicated RAM (Mx RAM)

The CPU subsystem has two dedicated ECC-capable RAM blocks: M0 and M1. These memories are small nonsecure blocks that are tightly coupled with the CPU (that is, only the CPU has access to them).

6.3.4.2 Local Shared RAM (LSx RAM)

RAM blocks which are dedicated to each subsystem and are accessible only to its CPU and CLA, are called local shared RAMs (LSx RAMs).

All LSx RAM blocks have parity. These memories are secure and have the access protection (CPU write/CPU fetch) feature.

By default, these memories are dedicated only to the CPU, and the user could choose to share these memories with the CLA by configuring the MSEL_LSx bit field in the LSxMSEL registers appropriately (see [Table 6-5](#)).

**Table 6-5. Master Access for LSx RAM
(With Assumption That all Other Access Protections are Disabled)**

MSEL_LSx	CLAPGM_LSx	CPU ALLOWED ACCESS	CLA1 ALLOWED ACCESS	COMMENT
00	X	All	–	LSx memory is configured as CPU dedicated RAM.
01	0	All	Data Read Data Write Emulation Data Read Emulation Data Write	LSx memory is shared between CPU and CLA1.
01	1	Emulation Read Emulation Write	Fetch Only Emulation Program Read Emulation Program Write	LSx memory is CLA1 program memory.

6.3.4.3 Global Shared RAM (GSx RAM)

RAM blocks which are accessible from both the CPU and DMA are called global shared RAMs (GSx RAMs). Both the CPU and DMA have full read and write access to these memories. [Table 6-6](#) shows the features of the GSx RAM.

Table 6-6. Global Shared RAM

CPU (FETCH)	CPU (READ)	CPU (WRITE)	CPU.DMA (READ)	CPU.DMA (WRITE)
Yes	Yes	Yes	Yes	Yes

All GSx RAM blocks have parity.

The GSx RAMs have access protection (CPU write/CPU fetch/DMA write).

6.3.4.4 CLA Message RAM (CLA MSGRAM)

These RAM blocks can be used to share data between the CPU and CLA. The CLA has read and write access to the "CLA to CPU MSGRAM." The CPU has read and write access to the "CPU to CLA MSGRAM." The CPU and CLA both have read access to both MSGRAMs.

This RAM has parity.

6.4 Identification

Table 6-7 lists the Device Identification Registers. Additional information on device identification can be found in the [TMS320F28004x Piccolo Microcontrollers Technical Reference Manual](#). See the register descriptions of PARTIDH and PARTIDL for identification of production status (TMX or TMS); availability of InstaSPIN-MOTION™ or InstaSPIN-FOC™; and other device information.

Table 6-7. Device Identification Registers

NAME	ADDRESS	SIZE (x16)	DESCRIPTION
PARTIDH	0x0005 D00A	2	Device part identification number
			TMS320F280049 0x01FF 0500
			TMS320F280049C 0x01FF 0500
			TMS320F280049M 0x01FF 0500
			TMS320F280048 0x01FE 0500
			TMS320F280048C 0x01FE 0500
			TMS320F280045 0x01FB 0500
			TMS320F280041 0x01F7 0500
			TMS320F280041C 0x01F7 0500
			TMS320F280040 0x01F6 0500
REVID	0x0005 D00C	2	Silicon revision number
			Revision 0 0x0000 0000
			Revision A 0x0000 0001
			Revision B 0x0000 0002

6.5 Bus Architecture – Peripheral Connectivity

Table 6-8 lists a broad view of the peripheral and configuration register accessibility from each bus master.

Table 6-8. Bus Master Peripheral Access

PERIPHERALS	DMA	CLA	CPU
SYSTEM PERIPHERALS			
CPU Timers			Y
System Configuration (WD, NMIWD, LPM, Peripheral Clock Gating)			Y
Device Capability, Peripheral Reset			Y
Clock and PLL Configuration			Y
Flash Configuration			Y
Reset Configuration			Y
GPIO Pin Mapping and Configuration			Y
GPIO Data ⁽¹⁾		Y	Y
DMA and CLA Trigger Source Select			Y
CONTROL PERIPHERALS			
ePWM/HRPWM	Y	Y	Y
eCAP/HRCAP	Y	Y	Y
eQEP ⁽²⁾	Y	Y	Y
SDFM	Y	Y	Y
ANALOG PERIPHERALS			
Analog System Control			Y
ADC Configuration		Y	Y
ADC Result ⁽³⁾	Y	Y	Y
CMPSS ⁽²⁾	Y	Y	Y
DAC ⁽²⁾	Y	Y	Y
PGA ⁽²⁾	Y	Y	Y
COMMUNICATION PERIPHERALS			
CAN	Y		Y
SPI	Y	Y	Y
I2C			Y
PMBus	Y	Y	Y
SCI			Y
LIN	Y	Y	Y

- (1) The GPIO Data Registers are unique for the CPU and CLA. When the GPIO Pin Mapping Register is configured to assign a GPIO to a particular master, the respective GPIO Data Register will control the GPIO. See the General-Purpose Input/Output (GPIO) chapter of the [TMS320F28004x Piccolo Microcontrollers Technical Reference Manual](#) for more details.
- (2) These modules are accessible from DMA but cannot trigger a DMA transfer.
- (3) ADC result registers are duplicated for each master. This allows them to be read with 0-wait states with no arbitration from any or all masters.

6.6 C28x Processor

The CPU is a 32-bit fixed-point processor which draws from the best features of digital signal processing; reduced instruction set computing (RISC); and microcontroller architectures, firmware, and tool sets.

The features include:

- CPU – modified Harvard architecture and circular addressing. The modified Harvard architecture of the CPU enables instruction and data fetches to be performed in parallel. The CPU can read instructions and data while it writes data simultaneously to maintain the single-cycle instruction operation across the pipeline. The CPU does this over six separate address and data buses.
- RISC – single-cycle instruction execution, register-to-register operations, and modified Harvard architecture.
- Microcontroller – ease of use through an intuitive instruction set, byte packing and unpacking, and bit manipulation.

For more information on CPU architecture and instruction set, see the [TMS320C28x CPU and Instruction Set Reference Guide](#). For more information on the C28x Floating-Point Unit (FPU), see the [TMS320C28x Extended Instruction Sets Technical Reference Guide](#). All of the features of the C28x documented in the [TMS320C28x DSP CPU and Instruction Set Reference Guide](#) apply to the C28x+VCU. All features documented in the [TMS320C28x Floating Point Unit and Instruction Set Reference Guide](#) apply to the C28x+FPU+VCU. A brief overview of the FPU, TMU, and VCU-Type 0 is provided here.

An overview of the VCU-I instructions can be found in the [TMS320C28x Extended Instruction Sets Technical Reference Manual](#).

6.6.1 Floating-Point Unit (FPU)

The C28x plus floating-point (C28x+FPU) processor extends the capabilities of the C28x fixed-point CPU by adding registers and instructions to support IEEE single-precision floating-point operations.

Devices with the C28x+FPU include the standard C28x register set plus an additional set of floating-point unit registers. The additional floating-point unit registers are the following:

- Eight floating-point result registers, RnH (where n = 0–7)
- Floating-point Status Register (STF)
- Repeat Block Register (RB)

All of the floating-point registers, except the RB, are shadowed. This shadowing can be used in high-priority interrupts for fast context save and restore of the floating-point registers.

6.6.2 Trigonometric Math Unit (TMU)

The TMU extends the capabilities of a C28x+FPU by adding instructions and leveraging existing FPU instructions to speed up the execution of common trigonometric and arithmetic operations listed in [Table 6-9](#).

Table 6-9. TMU Supported Instructions

INSTRUCTIONS	C EQUIVALENT OPERATION	PIPELINE CYCLES
MPY2PIF32 RaH,RbH	$a = b * 2\pi$	2/3
DIV2PIF32 RaH,RbH	$a = b / 2\pi$	2/3
DIVF32 RaH,RbH,RcH	$a = b/c$	5
SQRTF32 RaH,RbH	$a = \sqrt{b}$	5
SINPUF32 RaH,RbH	$a = \sin(b*2\pi)$	4
COSPUF32 RaH,RbH	$a = \cos(b*2\pi)$	4
ATANPUF32 RaH,RbH	$a = \tan(b)/2\pi$	4
QUADF32 RaH,RbH,RcH,RdH	Operation to assist in calculating ATANPU2	5

No changes have been made to existing instructions, pipeline or memory bus architecture. All TMU instructions use the existing FPU register set (R0H to R7H) to carry out their operations.

6.6.3 Viterbi, Complex Math and CRC Unit (VCU-I)

The C28x with VCU (C28x+VCU) processor extends the capabilities of the C28x fixed-point or floating-point CPU by adding registers and instructions to support the following algorithm types:

- **Viterbi decoding**

Viterbi decoding is commonly used in baseband communications applications. The viterbi decode algorithm consists of three main parts: branch metric calculations, compare-select (viterbi butterfly), and a traceback operation. [Table 6-10](#) lists a summary of the VCU-I performance for each of these operations.

Table 6-10. Viterbi Decode Performance

VITERBI OPERATION	VCU CYCLES
Branch Metric Calculation (code rate = 1/2)	1
Branch Metric Calculation (code rate = 1/3)	2p
Viterbi Butterfly (add-compare-select)	2 ⁽¹⁾
Traceback per Stage	3 ⁽²⁾

(1) C28x CPU takes 15 cycles per butterfly.

(2) C28x CPU takes 22 cycles per stage.

- **Cyclic redundancy check (CRC)**

CRC algorithms provide a straightforward method for verifying data integrity over large data blocks, communication packets, or code sections. The C28x+VCU can perform 8-, 16-, and 32-bit CRCs. For example, the VCU can compute the CRC for a block length of 10 bytes in 10 cycles. A CRC result register contains the current CRC which is updated whenever a CRC instruction is executed.

- **Complex math**

Complex math is used in many applications; a few of which are:

- Fast fourier transform (FFT)

The complex FFT is used in spread spectrum communications, as well as many signal processing algorithms.

- Complex filters

Complex filters improve data reliability, transmission distance, and power efficiency. The C28x+VCU can perform a complex I and Q multiply with coefficients (four multiplies) in a single cycle. In addition, the C28x+VCU can read/write the real and imaginary parts of 16-bit complex data to memory in a single cycle.

[Table 6-11](#) lists a summary of a few complex math operations enabled by the VCU.

Table 6-11. Complex Math Performance

COMPLEX MATH OPERATION	VCU CYCLES	NOTES
Add or Subtract	1	$32 \pm 32 = 32$ -bit (Useful for filters)
Add or Subtract	1	$16 \pm 32 = 15$ -bit (Useful for FFT)
Multiply	2p	$16 \times 16 = 32$ -bit
Multiply and Accumulate (MAC)	2p	$32 + 32 = 32$ -bit, $16 \times 16 = 32$ -bit
RPT MAC	2p+N	Repeat MAC. Single cycle after the first operation.

6.7 Control Law Accelerator (CLA)

The CLA Type-2 is an independent, fully programmable, 32-bit floating-point math processor that brings concurrent control-loop execution to the C28x family. The low interrupt-latency of the CLA allows it to read ADC samples "just-in-time." This significantly reduces the ADC sample to output delay to enable faster system response and higher MHz control loops. By using the CLA to service time-critical control loops, the main CPU is free to perform other system tasks such as communications and diagnostics.

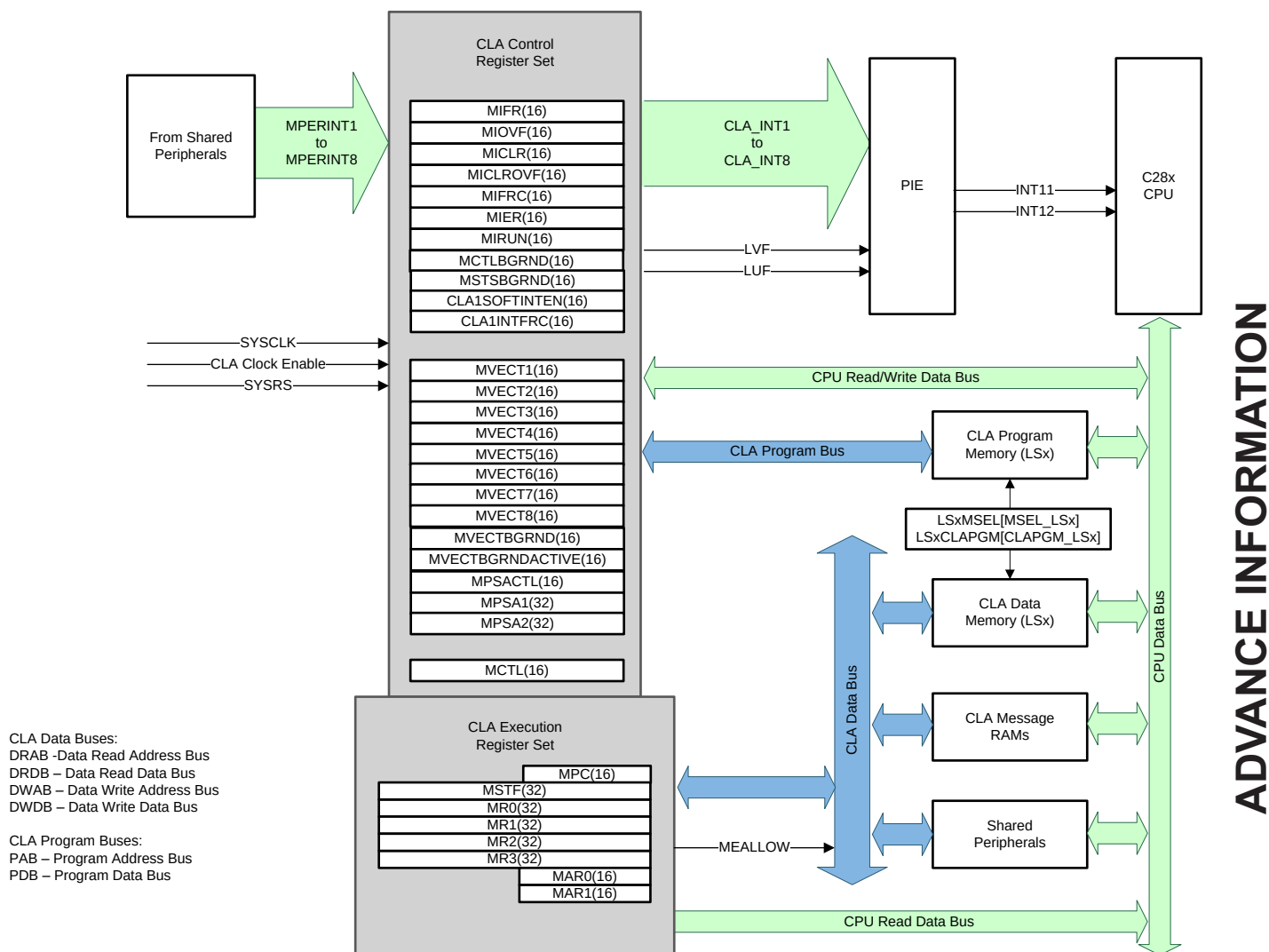
The control law accelerator extends the capabilities of the C28x CPU by adding parallel processing. Time-critical control loops serviced by the CLA can achieve low ADC sample to output delay. Thus, the CLA enables faster system response and higher frequency control loops. Using the CLA for time-critical tasks frees up the main CPU to perform other system and communication functions concurrently.

The following is a list of major features of the CLA:

- Clocked at the same rate as the main CPU (SYSCLKOUT).
- An independent architecture allowing CLA algorithm execution independent of the main C28x CPU.
 - Complete bus architecture:
 - Program Address Bus (PAB) and Program Data Bus (PDB)
 - Data Read Address Bus (DRAB), Data Read Data Bus (DRDB), Data Write Address Bus (DWAB), and Data Write Data Bus (DWDB)
 - Independent 8-stage pipeline.
 - 16-bit program counter (MPC)
 - Four 32-bit result registers (MR0 to MR3)
 - Two 16-bit auxiliary registers (MAR0, MAR1)
 - Status register (MSTF)
- Instruction set includes:
 - IEEE single-precision (32-bit) floating-point math operations
 - Floating-point math with parallel load or store
 - Floating-point multiply with parallel add or subtract
 - 1/X and 1/sqrt(X) estimations
 - Data type conversions
 - Conditional branch and call
 - Data load/store operations
- The CLA program code can consist of up to eight tasks or interrupt service routines, or seven tasks and a main background task.
 - The start address of each task is specified by the MVECT registers.
 - No limit on task size as long as the tasks fit within the configurable CLA program memory space.
 - One task is serviced at a time until its completion. There is no nesting of tasks.
 - Upon task completion a task-specific interrupt is flagged within the PIE.
 - When a task finishes the next highest-priority pending task is automatically started.
 - The Type-2 CLA can have a main task that runs continuously in the background, while other high-priority events trigger a foreground task.
- Task trigger mechanisms:
 - C28x CPU through the IACK instruction
 - Task1 to Task8: up to 256 possible trigger sources from peripherals connected to the shared bus on which the CLA assumes secondary ownership.
 - Task8 can be set to be the background task, while Tasks 1 to 7 take peripheral triggers.

- Memory and Shared Peripherals:
 - Two dedicated message RAMs for communication between the CLA and the main CPU.
 - The C28x CPU can map CLA program and data memory to the main CPU space or CLA space.
 - The CLA, on reset, is the secondary master for all peripherals which can have either the CLA or DMA as their secondary master.

Figure 6-2 shows the CLA block diagram.



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Figure 6-2. CLA Block Diagram

6.8 Direct Memory Access (DMA)

The DMA module provides a hardware method of transferring data between peripherals and/or memory without intervention from the CPU, thereby freeing up bandwidth for other system functions. Additionally, the DMA has the capability to orthogonally rearrange the data as it is transferred as well as “ping-pong” data between buffers. These features are useful for structuring data into blocks for optimal CPU processing.

DMA features include:

- Six channels with independent PIE interrupts
- Peripheral interrupt trigger sources
 - ADC interrupts and EVT signals
 - External Interrupts
 - ePWM SOC signals
 - CPU timers
 - eCAP
 - Sigma-Delta Filter Module
 - SPI transmit and receive
 - CAN transmit and receive
 - LIN transmit and receive
- Data sources and destinations:
 - GSx RAM
 - ADC result registers
 - Control peripheral registers (ePWM, eQEP, eCAP, SDFM)
 - DAC and PGA registers
 - SPI, LIN, CAN, and PMBus registers
- Word Size: 16-bit or 32-bit (SPI limited to 16-bit)
- Throughput: Four cycles per word without arbitration

Figure 6-3 shows a device-level block diagram of the DMA.

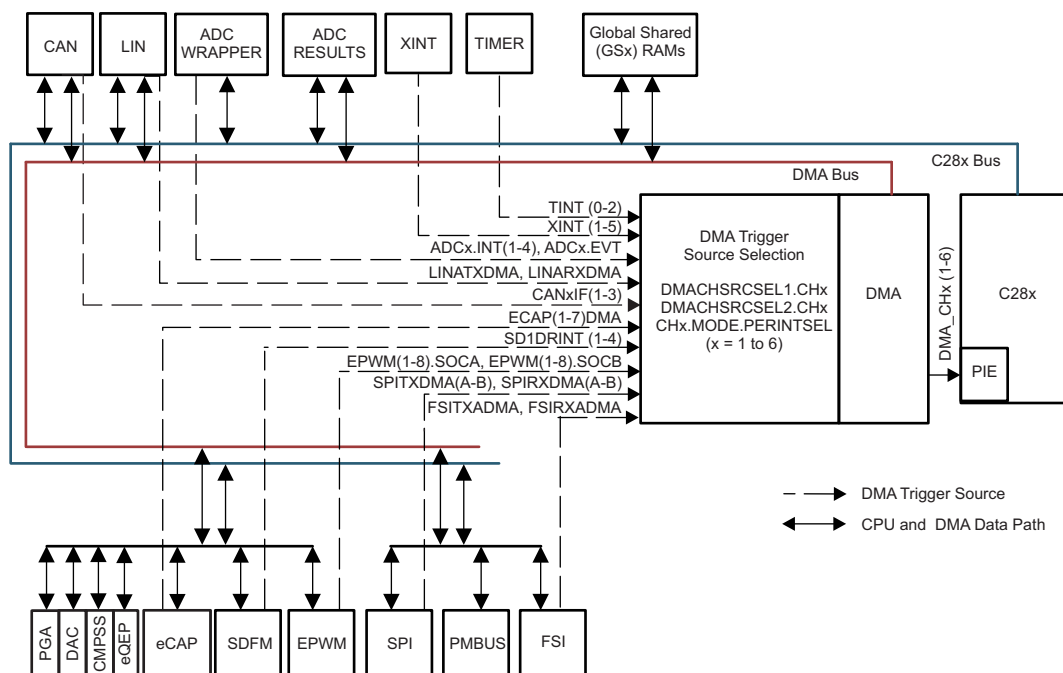


Figure 6-3. DMA Block Diagram

6.9 Boot ROM and Peripheral Booting

The device boot ROM contains bootloading software. The device ROM has an internal bootloader (programmed by TI) that is executed when the device is powered ON, and each time the device is reset. The bootloader is used as an initial program to load the application on to device RAM through any of the bootable peripherals, or it is configured to start the application in flash, if any.

Table 6-12 lists the default boot mode options. Users have the option to customize the boot modes supported as well as the boot mode select pins.

Table 6-12. Device Default Boot Modes

BOOT MODE	GPIO24 (DEFAULT BOOT MODE SELECT PIN 1)	GPIO32 (DEFAULT BOOT MODE SELECT PIN 0)
Parallel IO	0	0
SCI/Wait boot	0	1
CAN	1	0
Flash	1	1

Table 6-13 lists the possible boot modes supported on the device. The default boot mode pins are GPIO24 (boot mode pin 1) and GPIO32 (boot mode pin 0). Users may choose to have weak pullups for boot mode pins if they use a peripheral on these pins as well, so the pullups can be overdriven. On this device, customers can change the factory default boot mode pins by programming user-configurable Dual Code Security Module (DCSM) OTP locations.

Table 6-13. All Available Boot Modes

BOOT MODE NUMBER	BOOT MODE
0	Parallel IO
1	SCI/Wait boot
2	CAN
3	Flash
4	Wait
5	RAM
6	SPI Master
7	I2C Master
8	PLC

NOTE

All the peripheral boot modes supported use the first instance of the peripheral module (SCIA, SPIA, I2CA, CANA, and so forth). Whenever these boot modes are referred to in this section, such as SCI boot, it is actually referring to the first module instance, meaning SCI boot on the SCIA port. The same applies to the other peripheral boots.

6.9.1 Configuring Alternate Boot Mode Pins

This section explains how the boot mode select pins can be customized by the user, by programming the BOOTPIN_CONFIG location in user-configurable DCSM OTP. The location in user DCSM OTP is Z1-OTP-BOOTPIN-CONFIG. When debugging, EMU-BOOTPIN-CONFIG is the emulation equivalent of Z1-OTP-BOOTPIN-CONFIG, and can be programmed to experiment with different boot modes without writing to OTP. The device can be programmed to use 0, 1, 2, or 3 boot mode select pins as needed.

Table 6-14. BOOTPIN_CONFIG Bit Fields

BIT	NAME	DESCRIPTION
31-24	Key	Write 0x5A to these 8 bits to tell the boot ROM code that the bits in this register are valid
23-16	Boot Mode Select Pin 2 (BMSP2)	See BMPS0 description except for BMPS2
15-8	Boot Mode Select Pin 1 (BMSP1)	See BMSP0 description except for BMSP1
7-0	Boot Mode Select Pin 0 (BMSP0)	Set to the GPIO pin to be used during boot (up to 255). 0x0 = GPIO0; 0x01 = GPIO1 and so on 0xFF is invalid and selects the factory default chosen BMSP0, if all other BMSPs are also set to 0xFF. If any other BMSPs are not set to 0xFF, then setting a BMSP to 0xFF will disable that particular BMSP.

NOTE

The following GPIOs cannot be used as a BMSP. If selected for a particular BMSP, the boot ROM automatically selects the factory default GPIO (the factory default for BMSP2 is 0xFF, which disables the BMSP).

- GPIO 20 to 23
- GPIO 36
- GPIO 38
- GPIO 60 to 223

Table 6-15. Stand-alone Boot Mode Select Pin Decoding

BOOTPIN_CONFIG KEY	BMSP0	BMSP1	BMSP2	REALIZED BOOT MODE
!= 0x5A	Don't Care	Don't Care	Don't Care	Boot as defined by the factory default BMSPs (GPIO24, GPIO32)
= 0x5A	0xFF	0xFF	0xFF	Boot as defined in the boot table for boot mode 0 (All BMSPs disabled)
	Valid GPIO	0xFF	0xFF	Boot as defined by the value of BMSP0 (BMSP1 and BMSP2 disabled)
	0xFF	Valid GPIO	0xFF	Boot as defined by the value of BMSP1 (BMSP0 and BMSP2 disabled)
	0xFF	0xFF	Valid GPIO	Boot as defined by the value of BMSP2 (BMSP0 and BMSP1 disabled)
	Valid GPIO	Valid GPIO	0xFF	Boot as defined by the values of BMSP0 and BMSP1 (BMSP2 disabled)
	Valid GPIO	0xFF	Valid GPIO	Boot as defined by the values of BMSP0 and BMSP2 (BMSP1 disabled)
	0xFF	Valid GPIO	Valid GPIO	Boot as defined by the values of BMSP1 and BMSP2 (BMSP0 disabled)
	Valid GPIO	Valid GPIO	Valid GPIO	Boot as defined by the values of BMSP0, BMSP1, and BMSP2

6.9.2 Configuring Alternate Boot Mode Options

This section explains how to configure the boot definition table, BOOTDEF, for the device and the associated boot options. The 64-bit location is in user-configurable DCSM OTP in the Z1-OTP-BOOTDEF-LOW and Z1-OTP-BOOTDEF-HIGH locations. When debugging, EMU-BOOTDEF-LOW and EMU-BOOTDEF-HIGH are the emulation equivalents of Z1-OTP-BOOTDEF-LOW and Z1-OTP-BOOTDEF-HIGH, and can be programmed to experiment with different boot mode options without writing to OTP. The range of customization to the boot definition table depends on how many boot mode select pins are being used. For examples on how to use the BOOTPIN_CONFIG and BOOTDEF values, see the Boot Mode Example Use Cases section of the ROM Code and Peripheral Booting chapter in the [TMS320F28004x Piccolo Microcontrollers Technical Reference Manual](#).

Table 6-16. BOOTDEF Bit Fields

BOOTDEF NAME	BYTE POSITION	BIT	NAME	DESCRIPTION
BOOT_DEF0	7-0	4-0	BOOT_DEF0 mode	Set the boot mode number from Table 6-13 . An unsupported boot mode will cause the device to reset.
		7-5	BOOT_DEF0 options	Set the alternative or additional boot options. This can include changing the GPIOs for a particular boot peripheral or specifying a different flash entry point. See GPIO Assignments for boot options.
BOOT_DEF1	15-8	BOOT_DEF1 mode and options		See BOOT_DEF0 descriptions
BOOT_DEF2	23-16	BOOT_DEF2 mode and options		
BOOT_DEF3	31-24	BOOT_DEF3 mode and options		
BOOT_DEF4	39-32	BOOT_DEF4 mode and options		
BOOT_DEF5	47-40	BOOT_DEF5 mode and options		
BOOT_DEF6	55-48	BOOT_DEF6 mode and options		
BOOT_DEF7	63-56	BOOT_DEF7 mode and options		

6.9.3 GPIO Assignments

This section details the GPIOs and boot options used for each boot mode set in BOOT_DEFx at Z1-OTP-BOOTDEF-LOW and Z1-OTP-BOOTDEF-HIGH. See [Configuring Alternate Boot Mode Pins](#) on how to manipulate BOOT_DEFx.

Table 6-17. SCI Boot Options

OPTION	BOOTDEFx VALUE	SCIATX GPIO	SCIARX GPIO
1	0x01	GPIO29	GPIO28
2	0x21	GPIO16	GPIO17
3	0x41	GPIO8	GPIO9
4	0x61	GPIO48	GPIO49
5	0x81	GPIO24	GPIO25

NOTE

Pullups are enabled on the SCIATX and SCIARX pins.

Table 6-18. CAN Boot Options

OPTION	BOOTDEFx VALUE	CANTXA GPIO	CANRXA GPIO
1	0x02	GPIO32	GPIO33
2	0x22	GPIO4	GPIO5
3	0x42	GPIO31	GPIO30
4	0x62	GPIO37	GPIO35

NOTE

Pullups are enabled on the CANTXA and SCIARX pins.

Table 6-19. Flash Boot Options

OPTION	BOOTDEFx VALUE	FLASH ENTRY POINT (ADDRESS)	FLASH BANK, SECTOR
1	0x03	Flash – Default Option 1 (0x00080000)	Bank 0, Sector 0
2	0x23	Flash – Option 2 (0x0008EFF0)	Bank 0, Sector 14
3	0x43	Flash – Option 3 (0x00090000)	Bank 1, Sector 0
4	0x63	Flash – Option 4 (0x0009EFF0)	Bank 1, Sector 14

Table 6-20. Wait Boot Options

OPTION	BOOTDEFx VALUE	WATCHDOG STATUS
1	0x04	Enabled
2	0x24	Disabled

Table 6-21. SPI Boot Options

OPTION	BOOTDEFx VALUE	SPIA_SIMO	SPIA_SOMI	SPIA_CLK	SPIA_STE
1	0x26	GPIO8	GPIO10	GPIO9	GPIO11
2	0x46	GPIO54	GPIO55	GPIO56	GPIO57
3	0x66	GPIO16	GPIO17	GPIO56	GPIO57
4	0x86	GPIO8	GPIO17	GPIO9	GPIO11

NOTE

Pullups are enabled on the SPIA_SIMO, SPIA_SOMI, SPIA_CLK, and SPIA_STE pins.

Table 6-22. I2C Boot Options

OPTION	BOOTDEFx VALUE	SDAA GPIO	SCLA GPIO
1	0x02	GPIO32	GPIO33
2	0x42	GPIO26	GPIO27
3	0x62	GPIO42	GPIO43

NOTE

Pullups are enabled on the SDAA and SCLA pins.

Table 6-23. Parallel Boot Options

OPTION	BOOTDEFx VALUE	D0 to D7 GPIO	DSP CONTROL GPIO	HOST CONTROL GPIO
1	0x00	GPIO0 to GPIO7	GPIO16	GPIO11

NOTE

Pullups are enabled on GPIO0 to GPIO7.

6.10 Configurable Logic Block (CLB)

TI uses the CLB to offer additional interfacing and control features for select C2000 devices. Functions that would otherwise be accomplished using external logic devices are now provided by on-chip TI solutions. For example, absolute encoder master protocol interfaces such as EnDat and BiSS are now provided as [Position Manager](#) solutions. In some solutions, the TI-configured CLB is used with other on-chip resources, such as the SPI port or the C28x CPU, to perform more complex functionality. In some cases, external communications transceivers may need to be added.

7 Device and Documentation Support

7.1 Device and Development Support Tool Nomenclature

To designate the stages in the product development cycle, TI assigns prefixes to the part numbers of all TMS320 MCU devices and support tools. Each TMS320™ MCU commercial family member has one of three prefixes: TMX, TMP, or TMS (for example, **TMS320F280049M**). Texas Instruments recommends two of three possible prefix designators for its support tools: TMDX and TMDS. These prefixes represent evolutionary stages of product development from engineering prototypes (with TMX for devices and TMDX for tools) through fully qualified production devices and tools (with TMS for devices and TMDS for tools).

- TMX** Experimental device that is not necessarily representative of the final device's electrical specifications
- TMP** Final silicon die that conforms to the device's electrical specifications but has not completed quality and reliability verification
- TMS** Fully qualified production device

Support tool development evolutionary flow:

- TMDX** Development-support product that has not yet completed Texas Instruments internal qualification testing
- TMDS** Fully qualified development-support product

TMX and TMP devices and TMDX development-support tools are shipped against the following disclaimer:

"Developmental product is intended for internal evaluation purposes."

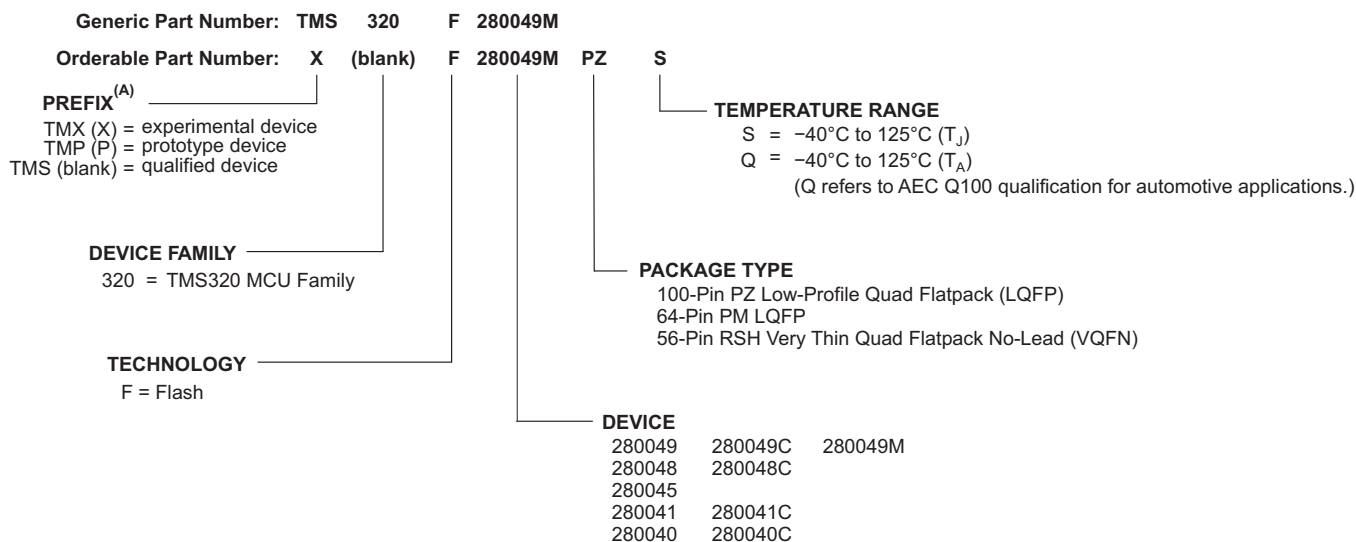
TMS devices and TMDS development-support tools have been characterized fully, and the quality and reliability of the device have been demonstrated fully. TI's standard warranty applies.

Predictions show that prototype devices (TMX or TMP) have a greater failure rate than the standard production devices. Texas Instruments recommends that these devices not be used in any production system because their expected end-use failure rate still is undefined. Only qualified production devices are to be used.

TI device nomenclature also includes a suffix with the device family name. This suffix indicates the package type (for example, PZ) and temperature range (for example, S).

For device part numbers and further ordering information, see the TI website (www.ti.com) or contact your TI sales representative.

For additional description of the device nomenclature markings on the die, see the [TMS320F28004x Piccolo™ Microcontrollers Silicon Errata](#).



A. Prefixes X and P are used in orderable part numbers.

Figure 7-1. Device Nomenclature

7.2 Tools and Software

TI offers an extensive line of development tools. Some of the tools and software to evaluate the performance of the device, generate code, and develop solutions follow. To view all available tools and software for C2000™ real-time control MCUs, visit the [Tools & software for C2000™ real-time control MCUs](#) page.

Development Tools

[F280049M Experimenter's Kit for C2000 Real-Time Control Development Kits](#)

The F280049M Experimenter's Kit from Texas Instruments is an ideal kit for software development and evaluation of the [TMS320F280049M](#) microcontroller. It is a board-level module that uses the HSEC controlCARD form factor, which is a common interface used in C2000 kits and can be used in conjunction with other C2000 application kits. The F280049M controlCARD can also be used in the creation of in-house system prototypes, test stands, and many other projects that require easy access to high-performance controllers. The baseboard, to which the controlCARD mates, must only provide a single 5-V power rail for the controlCARD to be fully functional.

Software Tools

[C2000Ware for C2000 MCUs](#)

C2000Ware for C2000™ microcontrollers is a cohesive set of development software and documentation designed to minimize software development time. From device-specific drivers and libraries to device peripheral examples, C2000Ware provides a solid foundation to begin development and evaluation of your product.

[Code Composer Studio™ \(CCS\) Integrated Development Environment \(IDE\) for C2000 Microcontrollers](#)

Code Composer Studio is an integrated development environment (IDE) that supports TI's Microcontroller and Embedded Processors portfolio. Code Composer Studio comprises a suite of tools used to develop and debug embedded applications. It includes an optimizing C/C++ compiler, source code editor, project build environment, debugger, profiler, and many other features. The intuitive IDE provides a single user interface taking the user through each step of the application development flow. Familiar tools and interfaces allow users to get started faster than ever before. Code Composer Studio combines the advantages of the Eclipse software framework with advanced embedded debug capabilities from TI resulting in a compelling feature-rich development environment for embedded developers.

[Pin Mux Tool](#)

The Pin Mux Utility is a software tool which provides a Graphical User Interface for configuring pin multiplexing settings, resolving conflicts and specifying I/O cell characteristics for TI MPUs.

[F021 Flash Application Programming Interface \(API\)](#)

The F021 Flash Application Programming Interface (API) provides a software library of functions to program, erase, and verify F021 on-chip Flash memory.

Training

[Technical Introduction to the New C2000 TMS320F28004x Device Family](#)

Discover the newest member to the C2000 MCU family. This presentation will cover the technical details of the Piccolo TMS320F28004x architecture and highlight the new improvements to various key peripherals, such as an enhanced Type 2 CLA capable of running a background task, and the inclusion of a set of high-speed programmable gain amplifiers. Also, a completely new boot mode flow enables expanded booting options. Where applicable, a comparison to the Piccolo TMS320F2807x MCU device series will be used, and some knowledge about the previous device architectures will be helpful in understanding the topics presented in this presentation.

[C2000 Multi-Day Workshop](#)

The C2000™ Microcontroller 3-Day Workshop will decrease the learning curve from months to days, reduce development time, and accelerate product time to market! The workshop is perfect for both the beginner and advanced users. Based on TI's latest F28x7x devices, this workshop combines many of the common features and peripherals found on the Piccolo™ and Delfino™ families, making it ideal for anyone interested in learning about the C2000 MCU family of devices.

7.3 Documentation Support

To receive notification of documentation updates, navigate to the device product folder on ti.com. In the upper right corner, click on *Alert me* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

The current documentation that describes the processor, related peripherals, and other technical collateral follows.

Errata

[TMS320F28004x Piccolo™ Microcontrollers Silicon Errata](#) describes known advisories on silicon and provides workarounds.

Technical Reference Manual

[TMS320F28004x Piccolo Microcontrollers Technical Reference Manual](#) details the integration, the environment, the functional description, and the programming models for each peripheral and subsystem in the F28004x microcontrollers.

InstaSPIN Technical Reference Manuals

[InstaSPIN-FOC™ and InstaSPIN-MOTION™ User's Guide](#) describes the InstaSPIN-FOC and InstaSPIN-MOTION devices.

CPU User's Guides

[TMS320C28x CPU and Instruction Set Reference Guide](#) describes the central processing unit (CPU) and the assembly language instructions of the TMS320C28x fixed-point digital signal processors (DSPs). This Reference Guide also describes emulation features available on these DSPs.

[TMS320C28x Extended Instruction Sets Technical Reference Manual](#) describes the architecture, pipeline, and instruction set of the TMU, VCU-II, and FPU accelerators.

Peripheral Guides

[C2000 Real-Time Control Peripherals Reference Guide](#) describes the peripheral reference guides of the 28x DSPs.

Tools Guides

[TMS320C28x Assembly Language Tools v17.6.0.STS User's Guide](#) describes the assembly language tools (assembler and other tools used to develop assembly language code), assembler directives, macros, common object file format, and symbolic debugging directives for the TMS320C28x device.

[TMS320C28x Optimizing C/C++ Compiler v17.6.0.STS User's Guide](#) describes the TMS320C28x C/C++ compiler. This compiler accepts ANSI standard C/C++ source code and produces TMS320 DSP assembly language source code for the TMS320C28x device.

[TMS320C28x Instruction Set Simulator Technical Overview](#) describes the simulator, available within the Code Composer Studio for TMS320C2000 IDE, that simulates the instruction set of the C28x core.

Application Reports

[Semiconductor Packing Methodology](#) describes the packing methodologies employed to prepare semiconductor devices for shipment to end users.

[Calculating Useful Lifetimes of Embedded Processors](#) provides a methodology for calculating the useful lifetime of TI embedded processors (EPs) under power when used in electronic systems. It is aimed at general engineers who wish to determine if the reliability of the TI EP meets the end system reliability requirement.

7.4 Related Links

The table below lists quick access links. Categories include technical documents, support and community resources, tools and software, and quick access to order now.

Table 7-1. Related Links

PARTS	PRODUCT FOLDER	ORDER NOW	TECHNICAL DOCUMENTS	TOOLS & SOFTWARE	SUPPORT & COMMUNITY
TMS320F280049	Click here	Click here	Click here	Click here	Click here
TMS320F280049C	Click here	Click here	Click here	Click here	Click here
TMS320F280049M	Click here	Click here	Click here	Click here	Click here
TMS320F280048	Click here	Click here	Click here	Click here	Click here
TMS320F280048C	Click here	Click here	Click here	Click here	Click here
TMS320F280045	Click here	Click here	Click here	Click here	Click here
TMS320F280041	Click here	Click here	Click here	Click here	Click here
TMS320F280041C	Click here	Click here	Click here	Click here	Click here
TMS320F280040	Click here	Click here	Click here	Click here	Click here
TMS320F280040C	Click here	Click here	Click here	Click here	Click here

7.5 Community Resources

The following links connect to TI community resources. Linked contents are provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's [Terms of Use](#).

TI E2E™ Online Community The TI engineer-to-engineer (E2E) community was created to foster collaboration among engineers. At e2e.ti.com, you can ask questions, share knowledge, explore ideas and help solve problems with fellow engineers.

TI Embedded Processors Wiki Established to help developers get started with Embedded Processors from Texas Instruments and to foster innovation and growth of general knowledge about the hardware and software surrounding these devices.

7.6 Trademarks

InstaSPIN-FOC, InstaSPIN-MOTION, Piccolo, TMS320C2000, C2000, InstaSPIN, Delfino, TMS320, Code Composer Studio, E2E are trademarks of Texas Instruments.

Bosch is a registered trademark of Robert Bosch GmbH Corporation.

All other trademarks are the property of their respective owners.

7.7 Electrostatic Discharge Caution



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

7.8 Glossary

TI Glossary This glossary lists and explains terms, acronyms, and definitions.

8 Mechanical Packaging and Orderable Information

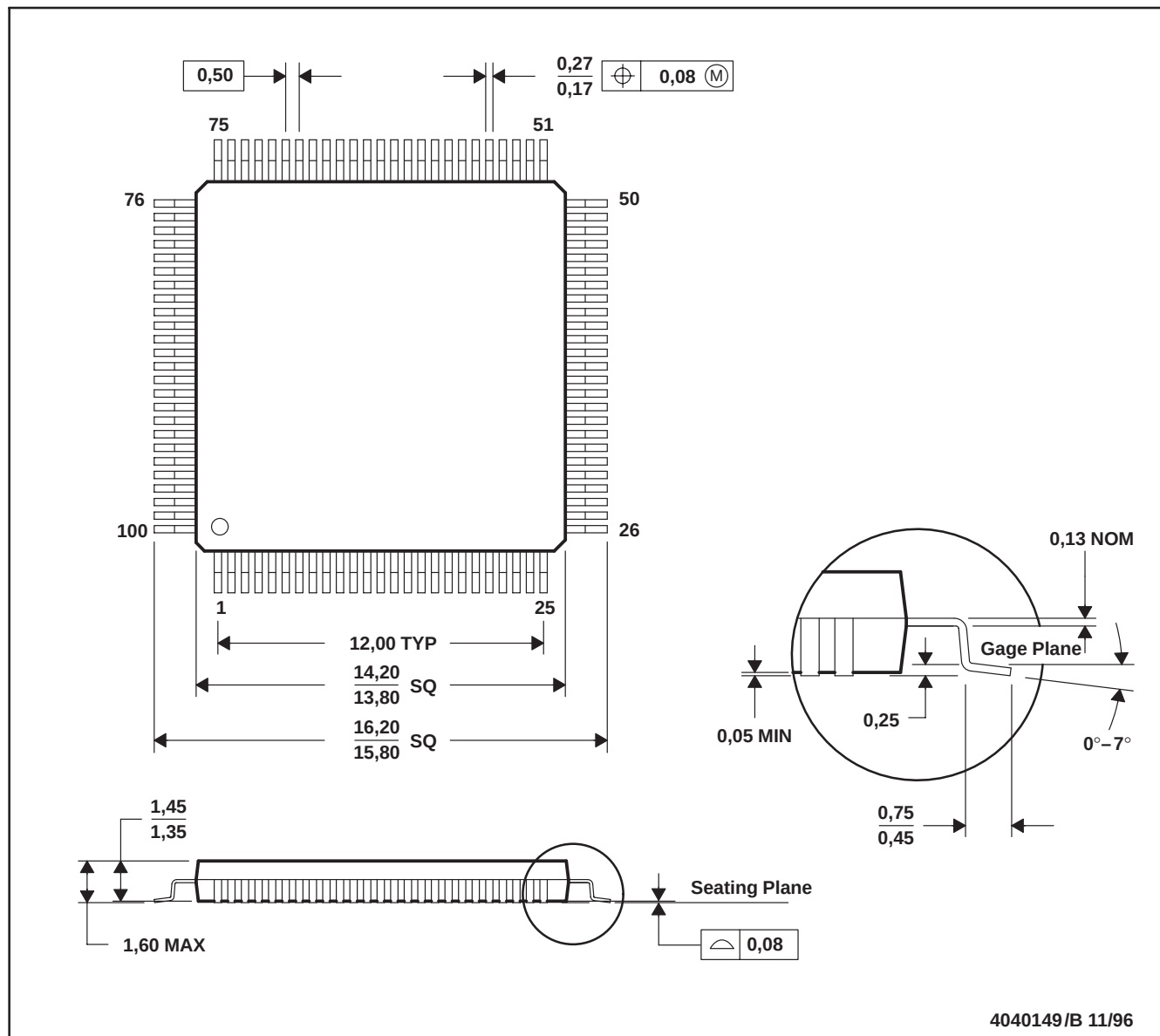
8.1 Packaging Information

The following pages include mechanical packaging and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

For packages with a thermal pad, the MECHANICAL DATA figure shows a generic thermal pad without dimensions. For the actual thermal pad dimensions that are applicable to this device, see the THERMAL PAD MECHANICAL DATA figure.

PZ (S-PQFP-G100)

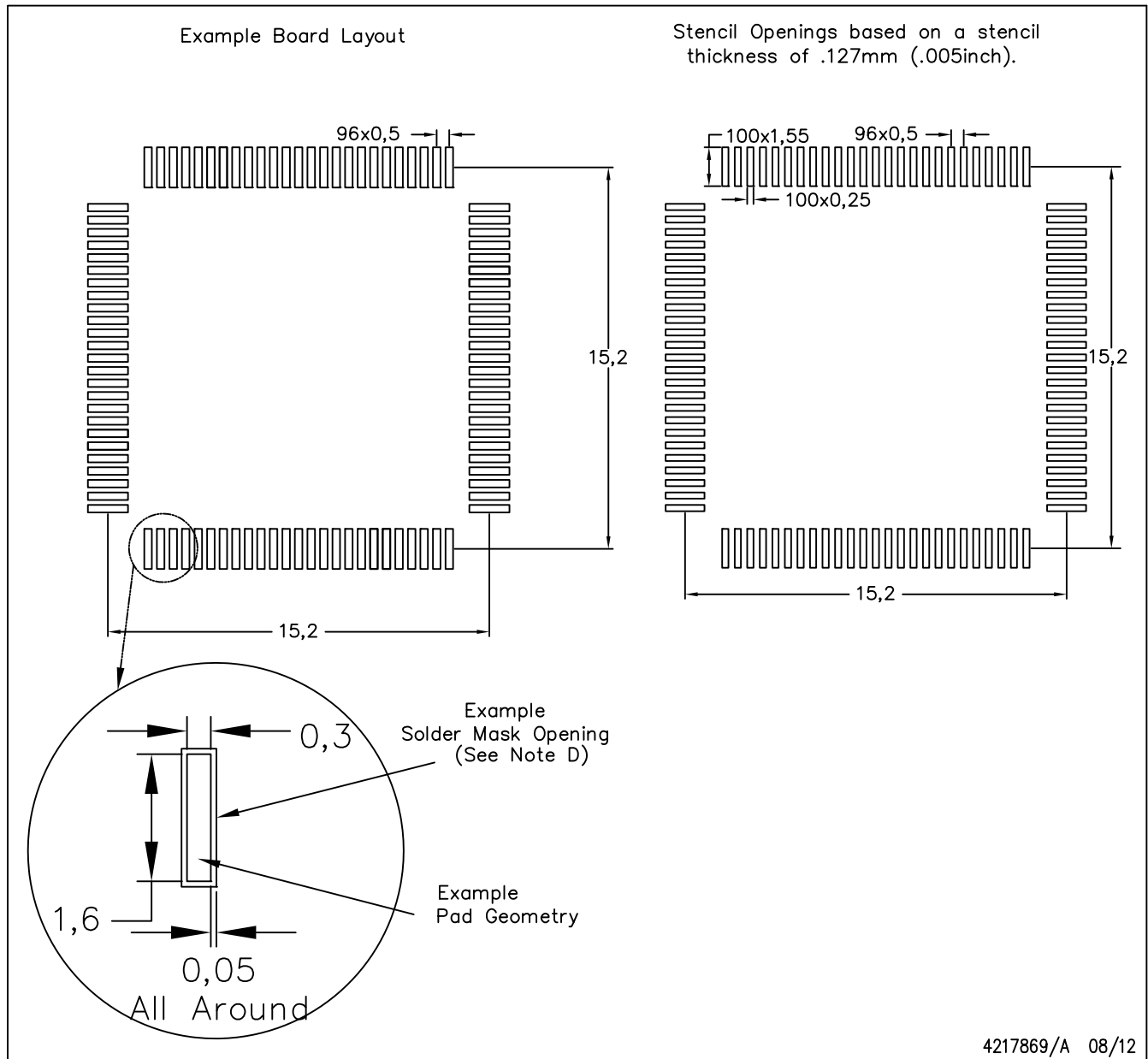
PLASTIC QUAD FLATPACK



- NOTES: A. All linear dimensions are in millimeters.
 B. This drawing is subject to change without notice.
 C. Falls within JEDEC MS-026

PZ (S-PQFP-G100)

PLASTIC QUAD FLAT PACK

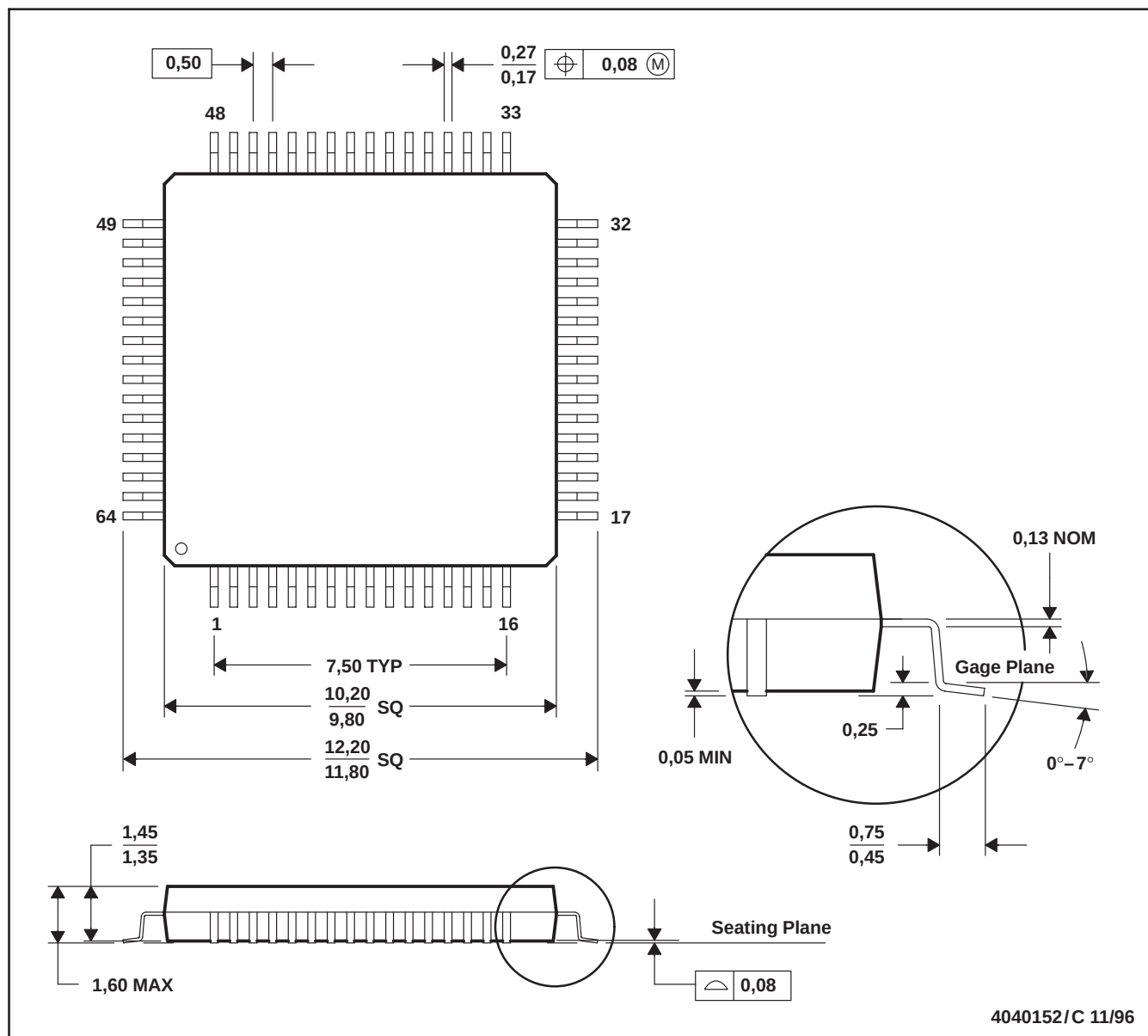


NOTES:

- All linear dimensions are in millimeters.
- This drawing is subject to change without notice.
- Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Example stencil design based on a 50% volumetric metal load solder paste. Refer to IPC-7525 for other stencil recommendations.
- Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.

PM (S-PQFP-G64)

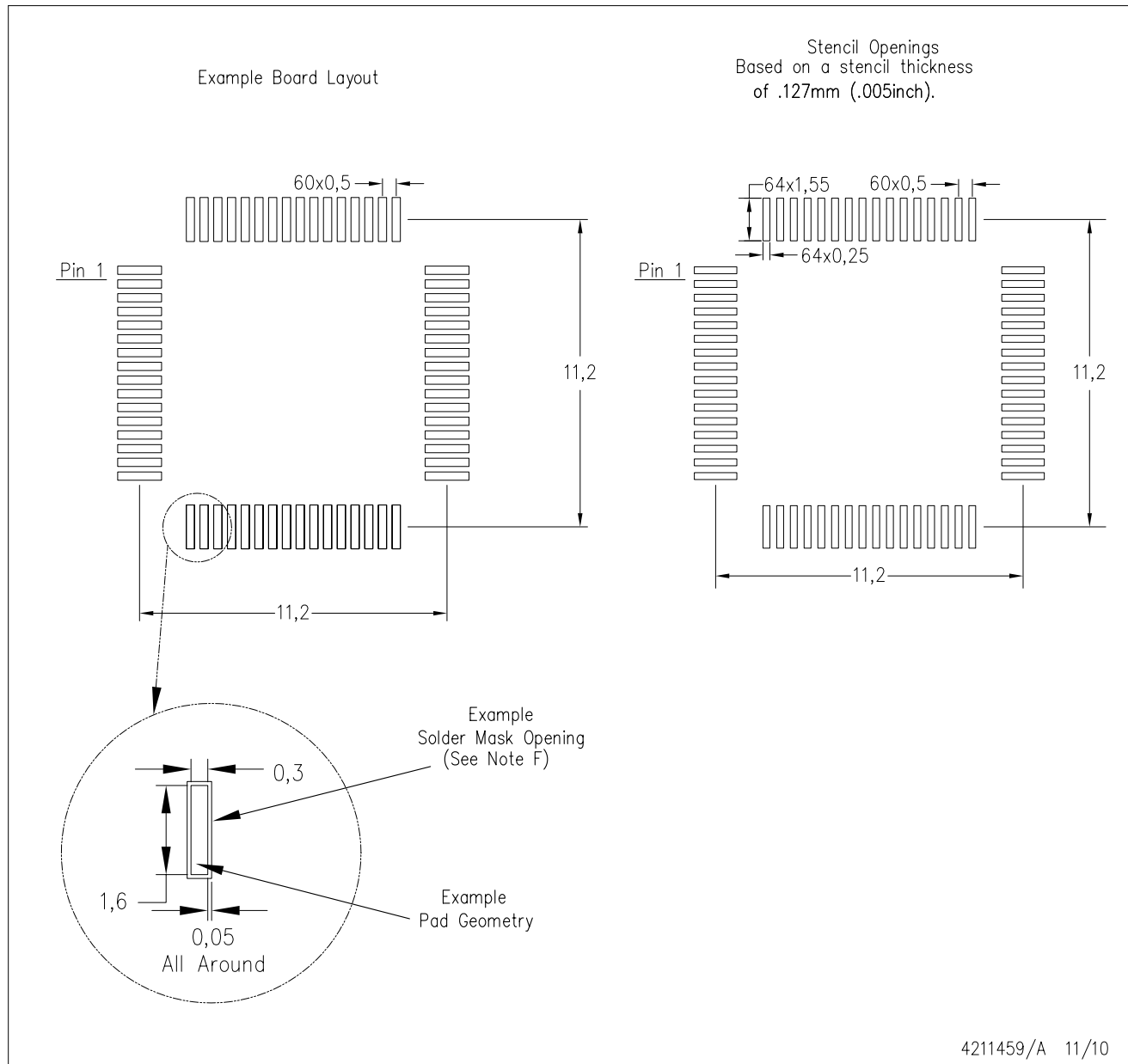
PLASTIC QUAD FLATPACK



- NOTES:
- A. All linear dimensions are in millimeters.
 - B. This drawing is subject to change without notice.
 - C. Falls within JEDEC MS-026
 - D. May also be thermally enhanced plastic with leads connected to the die pads.

PM (S-PQFP-G64)

PLASTIC QUAD FLATPACK



- NOTES:
- A. All linear dimensions are in millimeters.
 - B. This drawing is subject to change without notice.
 - C. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Example stencil design based on a 50% volumetric metal load solder paste. Refer to IPC-7525 for other stencil recommendations.
 - D. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.

VQFN - 1 mm max height

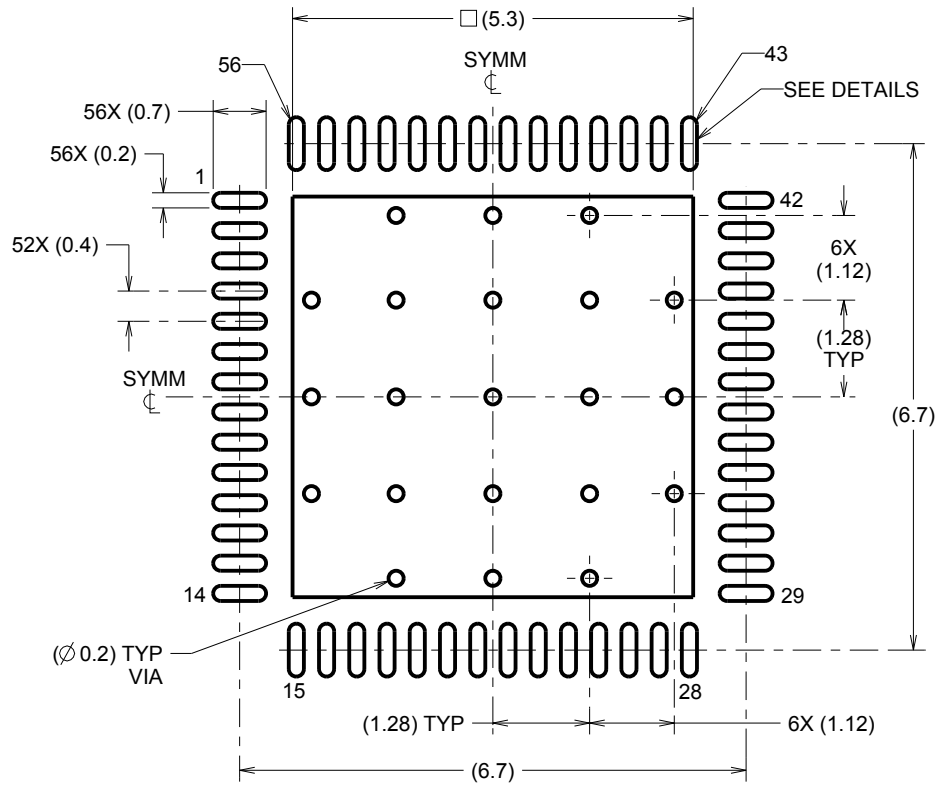
[illegible]

1. All linear dimensions are in millimeters. Dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. The package thermal pad must be soldered to the printed circuit board for thermal and mechanical performance.

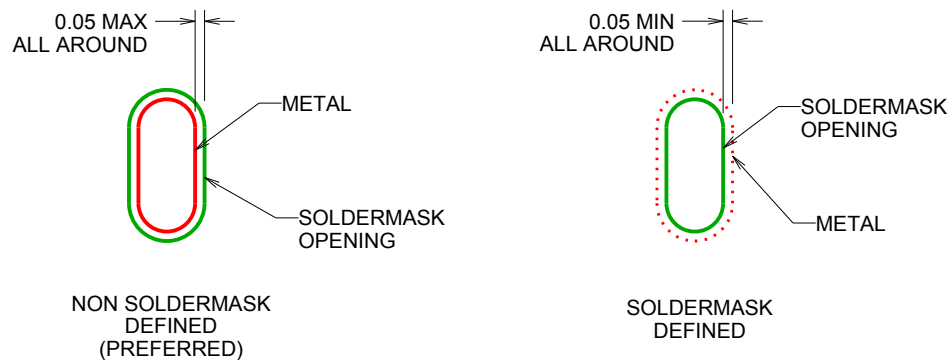
RSH0056D

VQFN - 1 mm max height

VQFN



LAND PATTERN EXAMPLE
SCALE:10X



SOLDERMASK DETAILS

4218794/A 07/2013

NOTES: (continued)

- This package is designed to be soldered to a thermal pad on the board. For more information, refer to QFN/SON PCB application note in literature No. SLUA271 (www.ti.com/lit/sluea271).

VQFN



PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead/Ball Finish (6)	MSL Peak Temp (3)	Op Temp (°C)	Device Marking (4/5)	Samples
F280040CPMQ	PREVIEW	LQFP	PM	64	90	TBD	Call TI	Call TI	-40 to 125		
F280040PMQ	PREVIEW	LQFP	PM	64	90	TBD	Call TI	Call TI	-40 to 125		
F280041CPMS	PREVIEW	LQFP	PM	64	90	TBD	Call TI	Call TI	-40 to 125		
F280041CPZQ	PREVIEW	LQFP	PZ	100	90	TBD	Call TI	Call TI	-40 to 125		
F280041CPZS	PREVIEW	LQFP	PZ	100	90	TBD	Call TI	Call TI	-40 to 125		
F280041CRSHS	PREVIEW	VQFN	RSH	56	90	TBD	Call TI	Call TI	-40 to 125		
F280041PMS	PREVIEW	LQFP	PM	64	90	TBD	Call TI	Call TI	-40 to 125		
F280041PZQ	PREVIEW	LQFP	PZ	100	90	TBD	Call TI	Call TI	-40 to 125		
F280041PZS	PREVIEW	LQFP	PZ	100	90	TBD	Call TI	Call TI	-40 to 125		
F280041RSHS	PREVIEW	VQFN	RSH	56	90	TBD	Call TI	Call TI	-40 to 125		
F280045PMS	PREVIEW	LQFP	PM	64	90	TBD	Call TI	Call TI	-40 to 125		
F280045PZS	PREVIEW	LQFP	PZ	100	90	TBD	Call TI	Call TI	-40 to 125		
F280045RSHS	PREVIEW	VQFN	RSH	56	90	TBD	Call TI	Call TI	-40 to 125		
F280048CPMQ	PREVIEW	LQFP	PM	64	90	TBD	Call TI	Call TI	-40 to 125		
F280048PMQ	PREVIEW	LQFP	PM	64	90	TBD	Call TI	Call TI	-40 to 125		
F280049CPMS	PREVIEW	LQFP	PM	64	90	TBD	Call TI	Call TI	-40 to 125		
F280049CPZQ	PREVIEW	LQFP	PZ	100	90	TBD	Call TI	Call TI	-40 to 125		
F280049CPZS	PREVIEW	LQFP	PZ	100	90	TBD	Call TI	Call TI	-40 to 125		
F280049CRSHS	PREVIEW	VQFN	RSH	100	90	TBD	Call TI	Call TI	-40 to 125		
F280049MPMS	PREVIEW	LQFP	PM	64	90	TBD	Call TI	Call TI	-40 to 125		
F280049MPZS	PREVIEW	LQFP	PZ	100	90	TBD	Call TI	Call TI	-40 to 125		
F280049MRSHS	PREVIEW	VQFN	RSH	100	90	TBD	Call TI	Call TI	-40 to 125		
F280049PMS	PREVIEW	LQFP	PM	64	90	TBD	Call TI	Call TI	-40 to 125		
F280049PZQ	PREVIEW	LQFP	PZ	100	90	TBD	Call TI	Call TI	-40 to 125		
F280049PZS	PREVIEW	LQFP	PZ	100	90	TBD	Call TI	Call TI	-40 to 125		
F280049RSHS	PREVIEW	VQFN	RSH	56	90	TBD	Call TI	Call TI	-40 to 125		
XF280049MPMS	ACTIVE	LQFP	PM	64	90	TBD	Call TI	Call TI	-40 to 125		Samples
XF280049MPZS	ACTIVE	LQFP	PZ	100	90	TBD	Call TI	Call TI	-40 to 125		Samples

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

⁽²⁾ **RoHS:** TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (Cl) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of ≤ 1000 ppm threshold. Antimony trioxide based flame retardants must also meet the ≤ 1000 ppm threshold requirement.

⁽³⁾ MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

⁽⁴⁾ There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

⁽⁵⁾ Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

⁽⁶⁾ Lead/Ball Finish - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.

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